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Chapter 1: Getting Started

Simulations

GENESYS supports several different types of analysis, allowing the exploration of a complete range of circuit performance. A simulation run is when you run an analysis on a circuit.

- DC Simulation (nonlinear) (a part of HARBEC)
- Linear S-Parameter Simulation
- Planar 3D Electromagnetic (EM) Simulation (EMPOWER)
- Planar 3D Electromagnetic (EM) Simulation (Momentum GX)
- Harmonic Balance Simulation (nonlinear) (HARBEC)
- Spectral Domain System Simulation (SPECTRASYS)
- Transient Simulation (nonlinear, time domain) (CAYENNE)

Additionally, the following items are available:

- Parameter Sweep
- TESTLINK (Covered in the User's Guide).

Several of these capabilities work together. EM co-simulates directly with the linear and DC circuit simulators and indirectly with HARBEC, SPECTRASYS, and CAYENNE; combining the accuracy of EM analysis with the generality and speed of circuit simulation. Parameters sweeps can be used with any analysis type as well as with other sweeps. Frequency, resistance, substrate height, and DC supply level are just a few of the parameters that are typically swept.

To create a new Analysis:

- 1. Click the New Item button (on the Workspace Tree toolbar and select **Analysis**.
- 2. Select which Analysis you want to add.
- 3. Define the analysis properties and click **OK** or Calculate Now to run the simulation.

Which Simulator Should I Use?

Often, we at Eagleware are asked which simulation method should be used in a particular circuit: Linear Analysis? Nonlinear (HARBEC)? SPICE (by exporting)? Electromagnetic (EMPOWER)? SPECTRASYS?

For most circuits, you will use a combination of the different simulations. We have developed several guidelines that should simplify the decision for most applications. First, each method has benefits and drawbacks:

	Linear	CAYENNE	Momentum GX	EMPOWER	HARBEC
	Extremely fast	Time domain	Extremely accurate	Extremely accurate	Steady-State Nonlinear
	Schematic or netlist	Schematic or netlist	Does not require an intimate knowledge of the circuit – simulator figures out coupling, etc.	Does not require an intimate knowledge of the circuit – simulator figures out coupling, etc.	Study mixing, compression and intermodulation
	Real-time tuning of circuits	Starting waveforms (e.g. oscillator startup)	Can predict radiation, current distribution.	Can predict radiation, current distribution.	DC biasing information
Benefits	Uses manufacturer- provided measured data	DC biasing information	Automatic deembedding	Automatic deembedding	Lots of vendor- supplied models
	Requires very little memory	Lots of vendor- supplied models	Predicts box mode effects (e.g. What happens if the circuit is placed in a box?)	Predicts box mode effects (e.g. What happens if the circuit is placed in a box?)	Use frequency dependent equations and post-processing
	Easily use equations and user functions	Non-linear modeling of crossover distortion, etc.	Can use arbitrary shapes – does not require an existing model for them	Can use arbitrary shapes – does not require an existing model for them	Use measured data in simulation
	No time domain	Very slow for near harmonic data	slow	Extremely slow	Much slower than linear
Drawbacks	No biasing information	Very hard to model frequency domain behavior (e.g. unloaded Q)	May require <u>lots</u> of memory	Requires <u>lots</u> of memory	Takes a lot of memory and time
	Everything is linear	Does not model noise performance	Discretizes metal patterns as polygons	Discretizes metal patterns to fit grid	Requires nonlinear models
	Requires knowledge of circuit – coupling factors, parasitics, etc.	Requires knowledge of circuit – coupling factors, parasitics, etc.	Can be difficult to correctly set up a circuit for simulation	Can be difficult to set up a circuit for simulation	Cannot study transient behavior (for example, oscillator startup)

In determining which simulation type to use, several points should be considered:

Linear or Electromagnetic?

- Should I use both circuit theory and EM simulation? Circuit theory simulation in GENESYS is amazingly fast and interactive. No other program at any price approaches the speed of GENESYS. EM simulations are more accurate and do not require the use of specific geometric objects for which circuit models have been developed. EM simulation complements rather than replaces circuit theory simulation.
- 2. What is the highest frequency used in the circuit? If below about 1 GHz, lumped elements are often used in place of distributed elements. In this case, the final board layout usually won't add any significant parasitics or coupling concerns. Often, however, customers use EMPOWER or Momentum to simulate the final board layout to make sure that it doesn't differ from the linear simulation.
- 3. How big is the circuit? If the circuit itself is very small compared to a wavelength at the highest frequency of concern, electromagnetic simulation may not be needed. This is because resonances occur at quarter wavelengths, and circuits much smaller than this usually behave as predicted by a complete linear simulation.
- 4. **Does the circuit have non-standard metal shapes, patterns, or geometries?** If so, electromagnetic simulation may be the only option. EM can simulate any arbitrary shape, such as ground plane pours. A linear simulator requires a netlist or schematic to describe the circuit, so models would have to exist for the pattern that you plan to simulate.
- 5. Do any of the models in the circuit exceed or come close to exceeding the published parameter ranges? If so, you may want to verify the simulation with EMPOWER or Momentum, or use EM exclusively. Most of the models in GENESYS were derived from measured data, which was only taken for particular parameter variations.

Linear or Harmonic Balance?

This question is the easiest to answer: for active circuits you will usually use both. For passive circuits (filters, couplers, power dividers, etc), you will only use linear. Passive circuits are linear-harmonic balance will not give you extra information that you could not get from linear simulation. Active circuits are inherently nonlinear. Harmonic balance will help you analyze DC operating points and nonlinear performance.

For both active and passive circuits, linear simulation is the workhorse of RF design. Matching, noise, and stability studies are all completed quickly using linear simulation. Harmonic balance is used to complete the analysis of most circuits. Examine mixer conversion gain, amplifier compression, and detector efficiency using harmonic balance.

Linear or CAYENNE (Transient)?

Often, this question does not have a quick answer. For example, many engineers associate CAYENNE with time domain simulation, and a linear simulator with frequency domain simulation. Actually, many circuits have data of interest in both the time and frequency

domains, which could warrant the use of both simulators. For example, an oscillator has phase noise, transmission, and phase characteristics, which are all frequency domain measurements. Oscillators also have waveform magnitude, starting time, and startup transients, which are all time domain measurements. In this case, <u>both</u> simulators can be used in the circuit design.

There are some guidelines for deciding between CAYENNE and linear simulation:

Does the circuit depend on time domain characteristics? If so, CAYENNE
must be used for this portion of the design. If the circuit depends entirely on the
time domain, CAYENNE can be used exclusively. However, if a frequency
domain response is also of interest, linear simulation may be used in addition to
CAYENNE.

Often, both CAYENNE and linear simulation are useful in a design. For example, in amplifier design, the linear portion (gain, matching) can be done in the linear simulator, and the device biasing can be done in CAYENNE.

Using Ports in the Design

Note: The information in this section does not apply to EMPOWER simulation.

In GENESYS, ports serve two different purposes:

- 1) In a top level design specified for simulation, ports used directly for simulation. The impedances of the ports define the impedances used in the simulator. Inputs with sources (such as INP_PAC [input port with power source] and INP_VDC [input port with DC voltage]) are in full effect when placed on the top level.
- 2) In lower level designs, single terminal ports are only used to provide connection information for subcircuits. Impedances and sources (such as INP_PAC and INP_VAC) are ignored. To place sources in subcircuits, you must use sources without ports (such as PAC and VAC). Note: Balanced (two-terminal) ports are retained from all levels in the design, essentially becoming top-level ports.

With this configuration, you can test a subcircuit in linear and nonlinear modes by putting the sources for test within the ports. When the subcircuit is then reused inside the larger circuits, those circuits and ports will be disabled. If you actually want to create a true port within a subcircuit, you can place a balanced port inside the subnetwork. If you only want a single-ended port, simply ground the negative terminal of the differential port.

New in GENESYS 2005: You can use equation variables to specify port numbers, plus you can create user models which contain ports. For an examples, load the system intermod source into a workspace: Use "Add From library" in the create new item button in the workspace tree. Select the system intermod source, then look at the design and equations.

New in GENESYS 2005: Balanced (differential) ports are supported in all simulators. To place a differential port, go to the part selected and search the Eagleware part library for "Balanced".

New in GENESYS 2007: Most ports also place an associated EM port in the associated layout. This can be bypassed by using @ for the footprint.

If ports are used on the master design, they must be placed in sequential order. Top-level ports are required for linear simulation and are strongly recommended for SPECTRASYS. Ports are optional for DC simulation, HARBEC, and CAYENNE. Other than the symbols, there is no difference between standard input and output ports. To use a complex port impedance, you can either directly use a complex number in the port termination or you can use a 1-port data file.

Device Data

Linear vs. Nonlinear Device Models

S-parameters for RF and microwave devices are commonly available and easy to measure with a network analyzer. They are the most accurate way to model the small-signal performance of circuits. However, they are only valid at a particular operating point (bias level). Nonlinear device models are also commonly available from manufacturers but they are harder to extract from measurements. The advantage of nonlinear models is that they model circuit performance at all bias levels and frequencies. Moreover, the model characterizes the complete linear and nonlinear performance of the devices, including effects such as compression and distortion.

Linear Data Overview

Within GENESYS are a wide range of element models. Also, the model and equation features provide for user creation of models. However, it is often necessary or desirable to characterize a device used in GENESYS by measured or externally computed data. This function is provided for by the use of the ONE, TWO, THR, FOU, NPO, and NPOD elements which read S, Y, G, H, or Z-parameter data. De-embedding is done with the NEGxx and NEGDxx elements.

Note: The information provided in this section applies to linear devices.

When using linear simulator, circuits are assumed time-invariant (element values are not a function of time) and thus sub-components are uniquely defined by a set of port parameter sets, such as two-port S-parameter data.

Although ONE, TWO, THR, FOU, and NPO are typically used for active devices, they may be used for any devices for which you can compute or measure data. For example, they could be used to characterize an antenna, a circuit with specified group delay data, or measured data for a broadband transformer or a pad.

Using a Data File in GENESYS

Data files can be used in GENESYS in two different ways:

- By overriding the simulation properties of a part. This allows measurements to refer directly to the data file without the need to create a design.
- By using ONE, TWO, THR, FOU, or NPO elements in a schematic. Use NEG in a schematic to deembed S-Data.

In both cases, you must know in advance how many ports the device data represents. For transistors, this is almost always 2.

When the datafile part is used in a design, and a simulation takes place, the datafile is imported into the workspace (it takes the short-name of the datafile) and that imported dataset becomes the cache for the datafile. To have the datafile re-imported delete the cache dataset.

The NPOD and NEGD elements use in-workspace datasets as input. These parts are recommended when using results of one linear simulation in another design. Search for dataset in the Eagleware part library to find the dataset part(s).

Provided Device Data

GENESYS includes over 25,000 data files for many different device types. Device data was provided directly by the manufacturers in electronic format.

Note: To reduce the size of the installation, all S-Parameter files are zipped to begin with. The user should unzip the needed libraries from the Genesys SData directory, which is by default C:\Program Files\Genesys20XX.XX\SData\; these files can then be referenced by N-Port linear blocks.

Caution: Eagleware could not test every file that was provided. Through random sampling, we edited errors found in some files. It is the user's responsibility to test each file for accuracy.

Creating New Linear Data Files

You may easily add other devices to the library by using a text editor (such as NOTEPAD) to type the data into a file with the name of your choice. Be sure to save the file in standard ASCII format.

The first line in the file after any initial comments is a format specifier in the form:

```
# units type format R impedance
```

where:

```
units is either Hz, kHz, MHz, or GHz type is the type of the data file, either S, Y, G, H, or Z format is DB for dB/angle data, MA for linear magnitude/angle data, or RI for
```

real/imaginary data impedance is the reference impedance in ohms, commonly 50 or 75

One of the most common format specifiers is:

```
# MHZ S MA R 50
```

This indicates that the data is in S parameter form normalized to 50 ohms. The data is given in linear polar format (magnitude & angle). The frequencies are in megahertz.

The data follows after the format specifier. A typical line for this two-port file is:

```
500 .64 -23 12.5 98 .03 70 .8 -37
```

In this case, 500 is the frequency in megahertz. The magnitudes of S11, S21, S12 and S22 are .64, 12.5, .03 and .8, respectively. The phases are -23, 98, 70 and -37 degrees, respectively.

Alternatively, Y-parameter data may be used. The format specifier could be:

```
#GHZYRIR1
```

This would indicate rectangular, unnormalized Y parameter data with frequencies in GHz. A typical line is:

```
30 0 3E-4 9E-3 -8E-3 2E-5 0 -1E-4 1E-3
```

In this case, the frequency in gigahertz is 30. The real values of Y11, Y21, Y12 and Y22 are 0, 9E-3, 2E-5 and -1E-4 mhos, respectively. The imaginary values are 3E-4, -8E-3, 0 and 1E-3 mhos, respectively.

A sample S-parameter data file is shown below. The only portion of the file required for GENESYS is the segment in the middle with frequencies and S-parameter data. Lines in the data file beginning with "!" are comments and are ignored. The noise data at the end of the file is used for noise figure analysis. (Noise is discussed in a later section.)

```
! AT41435 S AND NOISE PARAMETERS
! Vce=8V Ic=10mA
! LAST UPDATED 06-1-89
\# GHZ S MA R 50
!FREQ S11 S21 S12 S22
0.1 .80 -32 24.99 157 .011 82 .93 -12
0.5 .50 -110 1 2.30 108 .033 52 .61 -28
1.0 .40 -152 6.73 85 .049 56 .51 -30
1.5 .38 176 4.63 71 .063 59 .48 -32
2.0 .39 166 3.54 60 .080 58 .46 -37
2.5 .41 156 2.91 53 .095 61 44 -40
3.0 .44 145 2.47 43 .115 61 .43 -48
3.5 .46 137 2.15 33 .133 58 .43 -58
4.0 .46 127 1.91 23 .153 53 .45 -68
4.5 .47 116 1.72 13 .178 50 .46 -75
5.0 .49 104 1.58 3 .201 47 .48 -82
6.0 .59 81 1.34 -17 .247 36 .43 -101
! f Fmin Gammaopt Rn/Zo
```

MAG ANG

! GHz dB

```
0.1
      1.2
            .12 3
                       0.17
            10 14
      1.2
                       0.17
0.5
      1.3
            .05 28
                       0.17
1.0
2.0
      1.7
            .30 -154
                       0.16
4.0
      3.0
            .54
                 -118
                       0.35
```

A sample 1 port Z parameter data file is shown below. This data file could be used to specify a port impedance that varied over frequency. Notice that the data is real and imaginary (RI) impedance (Z) data taken across several frequency points (13.90 to 14.45 MHz) that has been normalized to 1 ohm (R 1).

```
# MHZ Z RI R 1 13.90 30.8 -29.2 14.00 31.6 -6.6 14.05 32.0 4.7 14.10 32.4 16.0 14.15 32.7 27.2 14.20 33.1 38.4 14.25 33.5 49.5 14.30 33.9 60.7 14.35 34.3 71.7 14.45 35.1 93.7
```

File Record Keeping

Most device files provided with GENESYS are S-parameter files in the usual device configuration, typically common emitter or common source. Devices you add to the library may use the ground terminal of your choice. However, if you always keep data in a consistent format, record keeping chores are greatly minimized.

Exporting Data Files

"Export/S-Parameters" in the File menu writes S-parameter data from any simulation or data source. This output data file has exactly the same format as S-parameter files used to import data. This allows the user to analyze, tune and optimize sub-networks which are then stored as S-parameter data files for use later in other circuit files. The S-parameter data file written by GENESYS has one line of data for each simulation frequency. If there are two or more available simulations or designs in the circuit file, GENESYS displays a dialog box to allow you to select the simulation or design to use.

Noise Data in Data Files

Some of the data files provided with GENESYS also include noise data used for noise figure analysis. This data includes the optimum noise figure (NFopt), the complex source impedance to present to the device to achieve the optimum noise figure (Gopt), and the effective noise resistance (Rn).

The best noise figure in a circuit is achieved when the device is presented with an optimum source impedance. The optimum input network to achieve this objective does not in general result in an excellent return loss match. Balanced amplifiers and isolators are sometimes used to achieve both the optimum noise figure and a good match.

Losses in the input network, feedback networks around the transistor, emitter feedback and multiple stages all effect the noise figure of the circuit. All of these effects are accurately simulated in GENESYS using the noise correlation matrix technique [5,6].

Noise parameters can be added to the two port data files after the S, Y, G, H, or Z parameters. See the section Creating New Data Files for information about entering S, Y, G, H, or Z parameters. Each line of a noise parameter has the following five entries:

Frequency NF(dB) Mag_Gamma_Opt Ang_Gamma_Opt Rn/Zo

Frequency - Frequency in units

NF(dB) - Minimum noise figure in dB

Mag_Gamma_Opt - Magnitude of the optimum source reflection coefficient for minimum noise figure

Ang_Gamma_Opt - Angle of the optimum source reflection coefficient for minimum noise figure

Rn/Zo - Normalized effective noise resistance

Here is an example of noise data in a file along with the device S parameters

```
! BFP620, Si-NPN RF-Transistor in SOT343
```

! Vce=2 V, Ic=8 mA

! Common Emitter S-Parameters: 01. February 2000

GHz S MA R 50

! f S11 S21 S12 S22

! GHz Mag Ang Mag Ang Mag Ang Mag Ang 0.010 0.8479 -1.3 21.960 179.3 0.0024 27.9 0.9851 0.4

0.020 0.8424 -1.9 21.606 178.2 0.0021 34.2 0.9676 -1.5

0.050 0.8509 -5.7 21.650 175.6 0.0047 66.0 0.9693 -3.8

0.100 0.8391 -10.7 21.434 171.7 0.0092 74.1 0.9662 -7.7

0.200 0.8312 -21.8 21.109 163.1 0.0183 76.1 0.9477 -15.4

 $0.250 \ 0.8150 \ -27.0 \ 20.679 \ 159.1 \ 0.0221 \ 72.0 \ 0.9326 \ -19.2$

0.300 0.8049 -32.8 20.328 155.0 0.0267 70.8 0.9157 -22.9

 $0.500 \ 0.7349 \ \textbf{-52.7} \ 18.378 \ 140.2 \ 0.0409 \ \ 63.9 \ 0.8256 \ \textbf{-36.4}$

```
0.700 \ 0.6653 \ -71.1 \ 16.211 \ 127.7 \ 0.0531 \ 57.2 \ 0.7212 \ -47.9
0.900 0.5930 -87.2 14.148 117.7 0.0614 52.2 0.6237 -57.4
1.100 0.5403 -101.2 12.427 109.4 0.0695 48.8 0.5440 -65.0
1.300 0.4982 -113.9 11.019 102.6 0.0747 46.1 0.4736 -72.0
1.500 0.4710 -125.4 9.834 96.5 0.0795 44.0 0.4168 -77.5
1.700 \ 0.4495 \ \hbox{-} 135.7 \quad 8.861 \quad 91.3 \quad 0.0850 \quad 41.9 \quad 0.3619 \ \hbox{-} 83.3
1.900 0.4312 -145.4 8.013 86.4 0.0893 40.4 0.3209 -88.2
2.000 0.4229 -150.0 7.670 84.1 0.0917 40.1 0.3021 -90.9
3.000 0.4130 172.7 5.243 64.8 0.1147 34.7 0.1662 -120.6
4.000 0.4749 144.9 3.914 48.5 0.1359 27.8 0.1538 -173.1
5.000 0.5311 125.9 3.037 34.4 0.1524 21.3 0.1899 151.8
6.000 \ 0.5797 \ 113.2 \ 2.457 \ 22.5 \ 0.1699 \ 15.8 \ 0.2239 \ 124.4
!
! f
                              Rn/Zo where Zo = 50
       Fmin
               Gammaopt
! GHz
          dB
                 MAG ANG -
 0.900
         0.64
               0.22
                       25 0.12
 1.800
         0.71
               0.09
                       97
                            0.08
 2.400
         0.75
               0.06
                       139
                            0.09
 3.000
         0.87
               0.09
                             0.10
                      -175
 4.000
         0.99
               0.19
                      -147
                             0.08
 5.000
         1.17
               0.26
                      -125
                             0.11
 6.000
         1.34
               0.38 -101 0.17
          INFINEON TECHNOLOGIES, Munich
```

See reference [38] for more information on the relationship between noise figure and noise parameters.

Measurements

Overview

Overview

GENESYS supports a rich set of output parameters. All parameters can be used for any purpose, including graphing, tabular display, optimization, yield, and post-processing.

Linear Measurements

The following table shows the available Measurements. Where i and j are shown in the chart, port numbers can be used to specify a port. Some parameters (such as Ai) use only one port, e.g., A1 or VSWR2. Or, on a tabular output, the ports can be omitted (ie, S or Y), and measurements for all ports will be given.

Tip: All available measurements and their operators for a given circuit or sub-circuit with their appropriate syntax are shown in the measurement wizard. To bring up the measurement wizard select "measurement wizard" from the graph properties dialog box.

The fundamental measurements (S, CS, Freq, ...) exist as arrays in the result datasets. The short form shown here (such as S12) is created by parsing a formula placed automatically into the dataset.

Note: The section in this manual on S Parameters contains detailed information about many of these parameters.

Meas.	Description	Default Operator	Shown on Smith Chart	
Sij	S Parameters	db	Sij	
Hij	H Parameters*	re		
ΥΡij	Y Parameters	re		
ZPij	Z Parameters re			
ZINi	Ni Impedance at port i with network terminations in place			
YINi	Admittance at port <i>i</i> with network terminations in place	Sii		
ZPORTi	Reference Impedance at port i	re		
VSWR <i>i</i>	VSWR at port i	Linear (real)	Sii	
E <i>ij</i>	Voltage gain from port <i>i</i> to port <i>j</i> with network terminations in place.			
Nij	Noise correlation matrix parameters	re		

GMAX	Maximum available gain*	db	
NF	Noise figure*	ddb	
NMEAS	Noise measure*	db	
NFT	Effective noise input temperature*	Linear (real)	
GOPT	Optimal gamma for noise*	db	GOPT
YOPT	Optimal admittance for noise*	re	GOPT
ZOPT	Optimal impedance for noise*	re	GOPT
RN	Normalized noise resistance*	Linear (real)	
NFMIN	Minimum noise figure*	db	
ZMi	Simultaneous match impedance at port i*	re	$\mathrm{GM}i$
YMi	Simultaneous match admittance at port i*	re	GM <i>i</i>
GM <i>i</i>	Simultaneous match gamma at port i*	db	GM <i>i</i>
K	Stability factor*	Linear (real)	
B1	Stability measure*	Linear (real)	
SB1	Input plane stability circle*	None (Circle)	SB1 Circles
	Note: Filled areas are unstable regions.		
SB2	Output plane stability circle*	None (Circle)	SB2 Circles
	Note: Filled areas are unstable regions.		
NCI	Constant noise circles* (shown at .25, .5, 1, 1.5, 2, 2.5, 3, and 6 dB less than optimal noise figure)	None (Circle)	NCI Circles
GA	Available gain circles**	None (Circle)	GA Circles
GP	Power gain circles**	None (Circle)	GP Circles
GU1	Unilateral gain circles at port 1**	None (Circle)	GU1 Circles
GU2	Unilateral gain circles at port 2**	None (Circle)	GU2 Circles
1	I .	1	1

^{*}Can only be used on 2-port networks

**Gain circles are only available for 2-port networks. Circles are shown at 0, 1, 2, 3, 4, 5, and 6 dB less than optimal gain. In GA and GP, if K<1, then the 0dB circle is at GMAX, and the inside of this circle is shaded as an unstable region.

Note: For port numbers greater that 9 a comma is used to separate port numbers. For example, on a 12 port device some of the S-Parameters would be specified as follows: S1,11 S12,2 S12,11 S12,2.

Nonlinear Measurements

Tip: All available measurements and their operators for a given circuit or sub-circuit with their appropriate syntax are shown in the measurement wizard. To bring up the measurement wizard select "measurement wizard" from the graph properties dialog box.

Here indep is the number of points in the independent vector. The short form can be used in most cases. GENESYS will automatically create the appropriate formula in the dataset to derive the short-form.

Meas.	Description	Size	Short Form
VPORT	Peak Voltage at all ports	indep x nPorts	Vport (e.g. V1)
PPORT	RMS Power delivered at each port	indep x nPorts	Pport (e.g. P2)
nameIProbe	Peak Current through the probe (name is the current probe designator name)	indep	

Operators

Measurements are often combined with operators to change the data format. Please read the Using Equations chapter in the User's Guide for more complex equations.

The general format for combining operators with measurements is standard function syntax

operator(measurement)

where *operator* is one of the operators listed in the table below (or any other function described in equations) and *measurement* is one of the measurements listed in the table in the previous section.

All measurements have default operators. For instance, on a table, using S21 will display in dB/angle form and Z32 will display in rectangular (real & complex) form. Likewise, on a graph, S21 graphs in dB, while Z32 graphs the real part of Z32.

Note: For a description of mathematical operators such as + and -, see Operators.

Operator	Description	Measurement Should Be	Result Is
mag()	Linear magnitude	Real/Complex	Real

ang()	Angle in range -180 to 180	Complex	Real
ang360()	Angle in range 0 to 360	Complex	Real
re()	Real part of complex measurement	Complex	Real
im()	Imaginary part of complex measurement	Complex	Real
db()	dB Magnitude	Real/Complex**	Real
gd()	Group delay	Complex	Real
ql()	Loaded Q [QL = (2 pi f) GD / 2]	Complex	Real
time()	Converts Frequency domain to Time domain via inverse Fourier Transform. Intended for use with Voltage/Current to get time waveforms.	Complex	Real

Note: All available measurements and their operators for a given circuit or sub-circuit with their appropriate syntax are shown in the measurement wizard. To bring up the measurement wizard select "measurement wizard" from the graph properties dialog box.

Sample Measurements

Measurement	Result in graph, Smith chart	Result on table
S[2,2]	dB Magnitude of S22	dB Magnitude plus angle of S22 (default)
ql(S[2,1])	Loaded Q of S21	Loaded Q of S21
mag(S21)	Linear Magnitude of S21	Linear Magnitude of S21
im(ZIN1)	Input reactance at port 1. On a Smith chart, S11 will be displayed, while IM(Zin1) will be used for the marker readouts.	Input reactance at port 1
S	show all S parameters	Shows dB Magnitude (alterable via complex format)
SB1	On Smith or polar chart, shows input plane stability circles	Displays center, radius, and stability parameter of input plane stability circles
NCI	On Smith or polar chart, shows constant noise circles	Displays center, and radius of all noise circles (27 numbers per frequency)

Using Non-Default Simulation/Data

In all dialog boxes which allow entry of measurements, there is a "Default Dataset" combo box. Any measurement can override this default. The format to override the dataset is:

operator(dataset.measurement)

where *dataset* is the name of the Dataset from the Workspace Window, and *operator(measurement)* are as described in previous sections. An override is most useful for putting parameters from different simulations on the same graph.

Some examples of overrides are:

Meas.	Meaning
db(Linear1.S[2,1])	Show the dB magnitude of S21 from the Linear1 dataset
EM1.S11	Shows S11 from the EM1 dataset
Filter.ql(Filter1.S21)	Shows the loaded Q of the Filter design using the current simulation.
Linear1.db(S21) (wrong)	ILLEGAL. The operator must go around the entire measurement.
X	Shows the global equation variable X, which must contain post-processed results.

Using Equation Results (post-processing)

Note: An advanced post-processing example called *STFT of Oscillator Response.wsx*, which produces a graph of the time-dependent Fourier Transform of an oscillator's transient response, can be found in the *Equations* subdirectory of your *Examples* directory.

Anywhere that a measurement is used, post-processed equation variables can be used. The format is:

variableName

where variableName is a variable from the equations for the workspace.

Inline equations can also be used anywhere a measurement can be used. Start the measurement with = to indicate an inline equation. For example:

$$=$$
mag(V1) - mag(V2)

will use the difference of V1 and V2.

Note: For more information on Equation syntax and available functions, see the *Using Equations* chapter of the *User's Guide*.

Linear

S-Parameters

This S-parameter (or *scattering* parameter) measurements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. The s-parameters assume a 50-ohm reference impedance unless otherwise specified. The s-parameters for an n-port network are of the form:

$$S_{ij}$$
 for i, j equal 1, 2, ... n

Details on the S-parameters and their application are found in Section x.x of this Manual.

Values: Complex matrix versus frequency.

Simulations: Linear, EMPOWER

Default Format: Table: dB, angle Graph: dB Smith Chart: dB, angle

Commonly Used Operators:

Operator	Description	Result Type
ang(S[1,1])	Angle in range -180 to 180 degrees	Real
gd(S[2,2])	Group Delay	Real
ql(S[2,1])	Loaded Q	Real

{ Other Operators: db(), mag(), re(), im() }

Examples:

Measurement	Result in graph, Smith chart, optimization, or yield	Result on table
S[2,2]	dB Magnitude of S22	dB Magnitude plus angle of S22
ql(S[2,1])	Loaded Q of S21	Loaded Q of S21
mag(S[2,1])	Linear Magnitude of S21	Linear Magnitude of S21
S		Shows dB Magnitude plus angle of all S Parameters
gd(S[2,1])	Group delay of S21	Group delay of S21

Note: For port numbers greater than 9 the array must be indexed. For example use S[12,33] for $S_{12,33}$

H-Parameters

This H-parameter (or *hybrid* parameter) measurements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. The H-parameters are only defined for a two port network, and are of the form:

 H_{ij} for i, j equal 1, 2

The equations relating the input voltage (V_1) and current (I_1) to the output voltage (V_2) and current (I_2) are:

$$V_1 = H_{11} I_1 + H_{12} V_2$$

 $I_2 = H_{21} I_1 + H_{22} V_2$

Values: Complex matrix versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: (none)

Commonly Used Operators:

Operator	Description	Result Type
rect(H11)	real/imaginary parts	Real
re(H22)	real part	Real
magang(H21)	Linear magnitude and angle in range of -180 to 180	Real

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
H22	RE[H22)	real part of H22
rect(H)		Shows real/imaginary parts of all H Parameters
mag(H21)	Linear Magnitude of H21	Linear Magnitude of H21
Н		Shows real/imaginary parts of all H Parameters

^{*} Not available on Smith Chart

Y-Parameters

This Y-parameter (or *admittance* parameter) measurements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. The Y-parameters for an n-port network are of the form:

$$YP_{ij}$$
 for i, j equal 1, 2, ...n

For a two port network, the equations relating the input voltage (V_1) and current (I_1) to the output voltage (V_2) and current (I_2) are:

$$I_1 = YP_{11} V_1 + YP_{12} V_2$$

 $I_2 = YP_{21} V_1 + YP_{22} V_2$

Values: Complex matrix versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: (none)

Commonly Used Operators:

Operator	Description	Result Type
re(YP22)	real part	Real
magang(YP21)	Linear magnitude and angle in range of -180 to 180	Real

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
YP22	re(YP22)	real part of YP22
mag(YP21)	Linear Magnitude of YP21	Linear Magnitude of YP21
YP		Shows real/imaginary parts of all Y Parameters

^{*} Not available on Smith Chart

Z-Parameters

This Z-parameter (or *impedance* parameter) measurements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. The Z-parameters for an n-port network are of the form:

For a two port network, the equations relating the input voltage (V_1) and current (I_1) to the output voltage (V_2) and current (I_2) are:

$$V_1 = ZP_{11} I_1 + ZP_{12} I_2$$

 $V_2 = ZP_{21} I_1 + ZP_{22} I_2$

Values: Complex matrix versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: (none)

Commonly Used Operators:

Operator	Description	Result Type
re(ZP22)	real part	Real
magang(ZP21)	Linear magnitude and angle in range of -180 to 180	Real

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
ZP22	re(ZP22)	real part of ZP22
mag(ZP21)	Linear Magnitude of ZP21	Linear Magnitude of ZP21
ZP		Shows real/imaginary parts of all Z Parameters

^{*} Not available on Smith Chart

Voltage Standing Wave Ratio (VSWR)

The VSWR measurement is a real function of frequency. The measurements are made looking into the network from the port with other network terminations in place. The frequency range and intervals are as specified in the Linear Simulation dialog box. A port number "i" is used to identify the port:

VSWRi is the Voltage Standing Wave Ratio looking in from port i.

The VSWR is a measure of the energy reflected back to the port. The VSWR₁ is related to the s-parameter S₁₁ by:

$$VSWR_1 = [1 + |S_{11}|] / [1 - |S_{11}|]$$

Therefore, as the reflected energy goes to zero, $|S_{11}|$, goes to zero and the VSWR approaches unity. As the reflected energy increases, $|S_{11}|$ approaches unity, and VSWR goes to infinity.

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: RE (Real) Graph: RE (Real) Smith Chart: S_{ii} (plots s-

parameters)

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
VSWR1	VSWR1	VSWR
VSWR		Show VSWR for all ports

^{*} Not available on Smith Chart, plots s-parameters

Note: a vswr function is available in Equations.

Input Impedance / Admittance (ZINi, YINi)

The port impedance and admittance measurements are complex functions of frequency. The measurements are made looking into the network from the port with other network terminations in place. The frequency range and intervals are as specified in the Linear Simulation dialog box. A port number "i" is used to identify the port:

ZINi is the input impedance looking in from port i.

YINi is the input admittance looking in from port i.

Values: Complex value versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: S_{ii} (plots s-paramters)

Voltage Gain

This voltage gain measurements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. The voltage gain, E_{ij} , is the ratio of the output voltage (V_i) to the input voltage (V_i) .

$$E_{ij} = V_j / V_i$$

Note that due to reflections, the gain Eii may not be unity.

Values: Complex matrix versus frequency.

Simulations: Linear

Default Format: Table: dB/angle Graph: dB Smith Chart: (none)

Noise Measure (NMEAS)

The "Noise Measure" measurement is a real function of frequency and is available for 2-port networks only.

The noise measure is defined in terms of the noise figure (NF) and maximum available gain (GMAX) as:

$$NMEAS = (NF - 1) / (1 - (1 / GMAX))$$

The noise measure represents the noise figure for an infinite number of networks in cascade.

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: mag() Graph: mag() Smith Chart: (none)

Commonly Used Operators:

Operator Description Result Ty

db(NMEAS)	noise measure in dB	Real
mag(NMEAS)	magnitude of the noise measure	Real

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
NMEAS	mag(NF)	mag(NF)
db(NMEAS)	magnitude of the minimum noise measure	magnitude of the minimum noise measure

^{*} Not available on Smith Chart

Noise Figure (NF) / Minimum Noise Figure (NFMIN)

The "Noise Figure" measurements are real functions of frequency and are available for 2-port networks only.

The noise figure is defined as the ratio of input signal-to-noise power ratio (SNR_{IN}) to the output signal-to-noise ratio (SNR_{OUT}):

$$NF = SNR_{IN} / SNR_{OUT}$$

The noise figure is related to the minimum noise figure (NFMIN) by the expression:

$$NF = NFMIN + \{R_N / G_S\} * | Y_S - Y_{OPT}|^2$$

where

$$Y_s = G_s + j$$
 $B_s = Source$ Admittance
 $R_N = Normalized$ Noise Resistance

The minimum noise figure represents the noise figure with ideal match of source impedance (i.e. $Y_S = Y_{\mathrm{OPT}}$)

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: dB Graph: dB Smith Chart: (none)

Constant Noise Circles (NCI)

A noise circle is a locus of load impedances for a given noise figure as a function of frequency. This locus, which is specified via a marker, is plotted on a Smith chart, with noise figure degradations of 0.25, 0.5, 1.0, 1.5, 2.0, 2.5, 3.0 and 6.0 dB from the optimal noise figure.

Note: See the section on S-Parameters for a detailed discussion of noise circles.

Values: Complex values versus frequency.

Simulations: Linear

Default Format: Table: center (MAG[], ANG[]), radius (Linear) Graph: (none)

Smith Chart: Circles (6)

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
NCI	noise circle	locus of load impedances for optimal noise figure, for each circle: center:MAG[], ANG[] radius: Linear

^{*} Available on Smith Chart and Table only.

Noise Correlation Matrix Parameters

The noise correlation matrix elements are complex functions of frequency. The frequency range and intervals are as specified in the Linear Simulation dialog box. For a "n" noise sources, the elements are of the form:

CS_{ij} for i, j equal 1, 2

Note: See References [5,6] for a complete discussion of noise correlation matrix properties.

Values: Complex matrix versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: (none)

Commonly Used Operators:

Simultaneous Match Gamma at Port i (GMi)

The "Simultaneous Match Gamma" is a complex function of frequency and is available for 2-port networks only. Computes the reflection coefficient that must be seen by the input port *i* to achieve a simultaneous conjugate match at both the input and output.

Values: Complex value versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: GMi

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
-------------	--	-----------------

GM		real / imaginary parts of gamma for all ports
GM1	re(GM1)	real / imaginary parts of GM1

Simultaneous Match Admittance / Impedance at Port i (ZMi, YMi)

The "Simultaneous Match Admittance" is a complex function of frequency and is available for 2-port networks only.

This is the value of admittance which must be seen at port *i* to achieve a simultaneous match at both input and output.

Values: Complex value versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: GMi

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
YM		real / imaginary parts of admittance for all ports
ZM1	re(ZM1)	ZM1

Maximum Available Gain (GMAX)

The "Maximum Available Gain" measurement is a real function of frequency and is available for 2-port networks only.

For conditions where the stability factor (K) is greater than zero, i.e. the system is unconditionally stable, then:

$$GMAX = (|S_{21}| / |S_{12}|) * (K - sqrt(K^2 - 1))$$

If K < 1, then GMAX is set to the maximum stable gain, therefore:

 $GMAX = |S_{21}| / |S_{12}|$

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: dB Graph: dB Smith Chart: (none)

Available Gain & Power Gain Circles (GA, GP)

An available gain input network circle is a locus of source impedances for a given gain below the optimum gain. This locus, which is specified via a marker, is plotted on a Smith chart, and is only available for 2-port networks. The center of the circle is the point of maximum gain. Circles are displayed for gains of 0, 1, 2, 3, 4, 5, and 6 dB less than the

optimal gain. Similarly, the power gain output network circle is a locus of load impedances for a given gain below the optimum gain. If the stability factor K is less than unity, then the 0 dB circle is at GMAX, and the inside of this circle is shaded as an unstable region. The available power gain (G_a) and power gain (G_p) are defined as:

 $G_a = \text{(available from network)} / \text{(power available from source)}$

 G_p = (power deliver to load) / (power input to network)

Note: See the section on S-Parameters for a detailed discussion of Gain Circles.

Values: Complex values versus frequency.

Simulations: Linear

Default Format: Table: center (magnitude/angle), radius (Linear) Graph: None

Smith Chart: Circle

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
GA	available gain circles	center: magnitude/angle radius: Linear
GP	power gain circles	center: magnitude/angle radius: Linear

^{*} Available on Smith Chart and Table only.

Unilateral Gain Circles at Port i (GU1, GU2)

A unilateral gain circle at port 1 is a locus of source impedances for a given transducer power gain below the optimum gain. This locus, which is specified via a marker, is plotted on a Smith chart, and is only available for 2-port networks. The center of the circle is the point of maximum gain. Circles are displayed for gains of 0, 1, 2, 3, 4, 5, and 6 dB less than the optimal gain. Similarly, the unilateral gain circle at port 2 is a locus of load impedances for a given transducer power gain below the optimum gain. The transducer power gain (G_t) is defined as:

 $G_t = (power deliver to load) / (power available from source)$

For the "unilateral" transducer gain, S_{12} is set to zero.

Note: See the section on S-Parameters for a detailed discussion of Gain Circles.

Values: Complex values versus frequency.

Simulations: Linear

Default Format: Table: center (magnitude/angle), radius (Linear) Graph: (none)

Smith Chart: Circles

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
GU1	unilateral gain circle at port 1	center: magnitude/angle radius:Linear
GU2	unilateral gain circle at port 2	center: magnitude/angle radius:Linear

^{*} Available on Smith Chart and Table only.

Stability Factor (K), Stability Measure (B1)

The "Stability Factor and Measure" parameters are real functions of frequency and are available for 2-port networks only. These parameters aid in determining the stability of the 2-port network. If S₁₂ of a device is not zero, a signal path will exist from the output to the input. This feedback path creates an opportunity for oscillation. The stability factor, K, is:

$$K = (1 - |S_{11}|^2 - |S_{22}|^2 + |D|^2) / (2 |S_{12}| |S_{21}|)$$

where $D = S_{11}S_{22} - S_{12}S_{21}$

From a practical standpoint when K>1, S₁₁<1, and S₂₂<1, the two-port is unconditionally stable. These are often stated as sufficient to insure stability. Theoretically, K>1 by itself is insufficient to insure stability, and an additional condition should be satisfied. One such parameter is the stability measure,B1, which should be greater than zero.

B1 = 1 +
$$|S_{11}|^2 - |S_{22}|^2 - |D|^2 > 0$$

Note: See the section on S-Parameters for a detailed discussion of stability analysis.

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: Linear Graph: Linear Smith Chart: (none)

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
K	stability factor	stability factor
B1	stability measure	stability measure

^{*} Not available on Smith Chart

Input / Output Plane Stability Circles (SB1, SB2)

A output stability circle is a locus of load impedances for which the input reflection coefficient (S_{11}) is unity. This locus, which is specified via a marker, is plotted on a Smith chart, and is only available for 2-port networks. This locus is a circle with radius R_{out} about a point C_{out} , where:

$$R_{out} = |S_{12}S_{21} / (|S_{22}|^2 - |D|^2) | C_{out} = (S_{22} - DS_{11}) / (|S_{22}|^2 - |D|^2)$$

The region inside or outside the circle may be the stable region. The filled areas of the graphs are the unstable regions. The input plane stability circle equations are the same as the output plane equations, with 1 and 2 in the subscripts interchanged.

If SB1 and SB2 are placed on a table, you can see the PAR value. If it is zero, then the region is outside the circle is stable. If it is 180, then the region inside the circle is stable.

Note: See the section on S-Parameters for a detailed discussion of stability analysis. See the Stability Example for usage.

Note: To see stability circles on a smith chard a marker must be placed on the SB1 or SB2 traces. The trace is generally located outside the smith chart area.

Values: Complex values versus frequency.

Simulations: Linear

Default Format: Table: center (magnitude/angle), radius (Linear) Graph: (none)

Smith Chart: Circle

Commonly Used Operators: None

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
SB1	input stability circle	center: magnitude/angle radius:Linear "par"**
SB2	output stability circle	center: magnitude/angle radius:Linear "par"**

^{*} Available on Smith Chart and Table only.

Optimal Gamma for Noise (GOPT)

The "Optimal Gamma for Noise" is a real function of frequency and is available for 2-port networks only.

The optimal gamma is defined in terms of the reference admittance (Y_0) and the optimal value of admittance (Y_{OPT}) as:

$$GOPT = [Y_o - Y_{OPT}] / [Y_o + Y_{OPT}]$$

Notice that gamma goes to zero if the reference admittance is optimal.

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: Linear Graph: Linear Smith Chart: GOPT

Commonly Used Operators: none

^{**} Parameter indicating the unstable region.

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
GOPT	gamma coefficient	gamma coefficient

Optimal Admittance / Impedance for Noise (YOPT, ZOPT)

The "Optimal Admittance for Noise" is a complex function of frequency and is available for 2-port networks only.

The optimal admittance is the value of the input admittance which minimized the noise figure of the network. The optimal admittance is defined in terms of the source admittance (Y_S) and the noise resistance (R_N) and the noise figures (NF, NFMIN) as:

$$NF = NFMIN + \{R_N / Re[Y_S]\} | Y_S - Y_{OPT}|$$

The optimal impedance is the inverse of the optimal admittance, i.e. $Z_{OPT} = 1 / Y_{OPT}$

Values: Complex value versus frequency.

Simulations: Linear

Default Format: Table: RECT Graph: RE Smith Chart: GOPT

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
YOPT	real part of optimal admittance	real / imaginary parts of admittance

Effective Noise Input Temperature (NFT)

The "Effective Noise Input Temperature" is a real function of frequency and is available for 2-port networks only.

The effective noise temperature is defined in terms of the noise figure (NF) and a standard temperature (T_0) in degrees Kelvin as:

NFT =
$$T_o * [NF - 1]$$
 where $T_o = 300$ degrees Kelvin

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: Linear Graph: Linear Smith Chart: (none)

Commonly Used Operators: none

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
NFT	noise temperature in degrees Kelvin	noise temperature in degrees Kelvin

^{*} Not available on Smith Chart

Normalized Noise Resistance (RN)

The "Normalized Noise Resistance" measurement is a real function of frequency and is available for 2-port networks only.

The noise resistance is normalized with respect to the input impedance of the network (Zo). See the definition of Nosie Figure (NF) for a discussion of R_N .

Values: Real value versus frequency.

Simulations: Linear

Default Format: Table: Linear Graph: Linear Smith Chart: (none)

Commonly Used Operators: none

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
RN	noise resistance	noise resistance

^{*} Not available on Smith Chart

Reference (Port) Impedance (ZPORTi)

The reference impedance measurements are complex functions of frequency. The measurements are associated with the network terminations. The frequency range and intervals are as specified in the Linear Simulation dialog box. A port number "i" is used to identify the port:

ZPORT[i] is the reference impedance for port i.

Values: Complex value versus frequency.

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
ZPORT[2]	re(ZPORT[2])	real/imaginary of ZPORT[2]
mag(ZPORT[1])	Linear Magnitude of ZPORT[2]	Linear Magnitude of ZPORT[1]
ZPORT	the ZPORT array	Shows real/imaginary parts of all ports

^{*} Not available on Smith Chart

Load Pull

Load Pull Contours

Note: See example named *Load Pull Contours Example.wsx* located in the *Amplifiers* subdirectory of your *Examples* directory.

GENESYS can import Focus and Maury Microwave format load pull data files. Using this data, contours may be generated on a Smith Chart using the *contour* function which utilizes a thin-plate spline of the data.

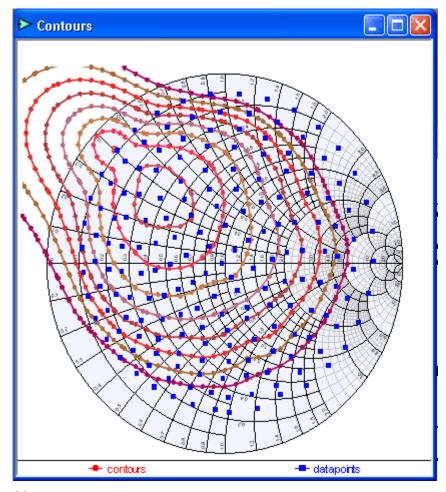
By selecting the *File* menu and choosing the *Import* submenu, followed by *Load Pull Data File*, one may import Focus format data files (by selecting *Focus Format...*) or Maury Microwave format (*Maury Format...*) and selecting the appropriate file from the dialog box. This will produce a data set in the root workspace folder with the name set to the name of the file (without the file extension).

In this data set, three variables will be present: *DATA*, *GAMMA*, and *MeasNames*. *DATA* contains the numeric data of the measurements specified in the load pull data file. *GAMMA* contains the gamma values at which each measurement is taken, and is the independent variable of *DATA*. *MeasNames* is a string array containing the name of the measurement of each column of *DATA*, as specified in the load pull data file.

The Load Pull Contours example (Load Pull Contours Example.wsx located in the Amplifiers subdirectory in Genesys\Examples) loads a Focus Microwave data file. The file contains several columns of amplifier measured data. In the plot, the Gain column from the data file is used to plot load pull contours from the two equation statements shown below:

```
contours = contour("GAIN", 20, 30, 1, 0, -2, 2, -2, 2) datapoints = plotpoints("GAIN")
```

The first function, *contour*, generates the contours based on the parameters passed to the function. See Built In Functions for a description of these functions and their parameters.



To create contours from a load pull data file:

- 1. From *File* menu, select the *Import* submenu, followed by *Load Pull Data File*. From this submenu, select the type of file you are trying to import (Focus or Maury format).
- 2. Select the file you are importing and click OK.
- 3. Add a Smith Chart to the workspace.
- 4. In the Smith Chart measurement properties dialog box, click "measurement wizard".
- 5. Select the load pull data set from the first dialog.
- 6. From the second measurement wizard box, select "Contours" or "Plotpoints" from the first column. Select the data to plot from the second column. Click OK to close the measurement wizard box and click OK to close the Smith Chart properties box.

You should then see contours like the ones in the Load Pull Contours Example, shown above.

Nonlinear

Port Power (PPORT)

This power measurement array is the RMS power delivered at the port. The port number is the column index into the array..

Values: Real value in specified units. Simulations: Nonlinear (dc analysis).

Default Format: <u>Table</u>: DBM <u>Graph</u>: DBM <u>Smith Chart</u>: (none)

Short Form: Pport

Example: P1 is equivalent to PPORT[1]

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
PPORT[1]	dbm(PPORT[1]) = RMS power delivered to port 1	dbm(PPORT[1])

^{*} Not available on Smith Chart

Port Voltage (VPORT)

This voltage measurement array is the RMS Voltage at the ports.

Values: Real value in specified units. Simulations: Nonlinear (dc analysis).

Default Format: <u>Table</u>: MAG <u>Graph</u>: MAG <u>Smith Chart</u>: (none)

Short Form: Vport

Example: V1 is equivalent to VPORT[1]

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
ICP1	magnitude of ICP1 = current through current probe 1	magnitude of ICP1

^{*} Not available on Smith Chart

Node Voltage (Vnode)

This voltage measurement is the peak voltage at the specified node. The node is the name of the node (net) as seen on the schematic or in the part netlist.

Values: Real value in specified units.

Simulations: Nonlinear (dc analysis).

Default Format: Table: MAG Graph: MAG Smith Chart: (none)

Examples:

Measurement	Result in graph, Smith chart*, optimization, or yield	Result on table
VTP2	mag(VTP2) = voltage at test point TP2	mag(VTP2)

^{*} Not available on Smith Chart

Large Signal S-Parameters

The Large Signal S-Parameters (LS - parameters) of an N-port non-linear device can be calculated using 2 different methods:

1. Exciting each of ports of the Device Under Test (DUT) separately.

To calculate the full set of LS- parameters, this method needs to create N designs, differing by the port where the 1-tone exciting signal enters the circuit. The design, with signal port number j, j=1,2,...,n is used to calculate LS[i,j], i=1,2,...,n.

LS- parameters are calculated from set of N HB-analyses, with one created for each of the designs.

2. Exciting all ports of the DUT simultaneously.

The full set of LS- parameters are calculated from one design, where the 1-tone exciting signals are entered at each of ports and and are analyzed by one multitone HB-analysis. Frequencies of the signals slightly differ for each of the ports, to extract spectral components from the analysis solution, corresponding to each of the ports. For example, the frequencies may be defined by formula:

$$F[i] = F0 + i * deltaF, i=1,2,..,n$$

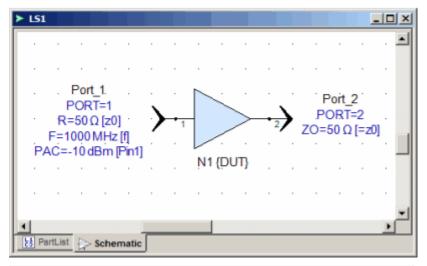
where F0 = frequency of the LS- analysis, deltaF = small frequency offset, deltaF << F0.

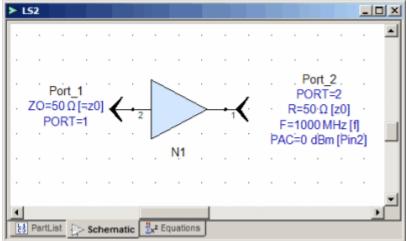
The choice of the method should be made on the actual setup of the physical DUT. If the real circuit is to be excited from one port only, then the first method is preferable; conversely, if the circuit is to be excited from multiple ports, method 2 should be employed. For a linear circuit, both methods calculate identical results, while for a nonlinear DUT, LS- parameters that are calculated by the two methods may be different,

and the difference will increase with rising power of tested signals.

Note: The signal power for each of the signal ports are to be equal to the actual power, dissipated at the port loads in tested operating regime of the circuit.

For example, to calculate LS- parameters of a 2-port DUT, we first create two schematics for each of signal ports:





In order to calculate the LS parameters, we need to create 2 HB analyses HB1 and HB2 (one per each design). To calculate the LS-parameters from the input power, we create 2 Parameter Sweeps: SweepPower1 and SweepPower2 (for each HB analysis).

NEW: In Genesys 2005 to calculate the LS parameters, we need to define new variables LS11, LS21 in HB1, and L12, LS22 in HB2 analysis datasets, which call the Harbec analysis function hb_LargeS().

hb_LargeS(Vin,Vout,sameport)

where:

Vin – voltage amplitude of port source and

Vout – amplitude of 1st harmonic of voltage at node, where the port is connected to the circuit.

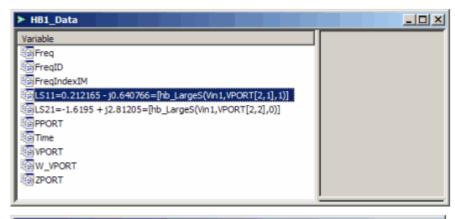
The spectrum of the port voltages are saved in VPORT HB-analysis dataset variable. To get the n-th harmonic of the k-th port voltage spectrum, we can use direct indices: VPORT[n+1,k]. (The + 1 offset is used because 1, the first element, is DC)

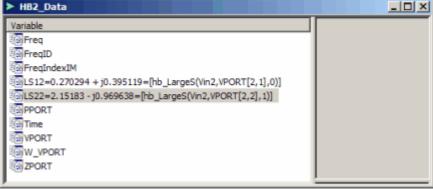
So, the 1st harmonic of voltage at the 1st port is calculated as

Vout1 = VPORT[2,1]

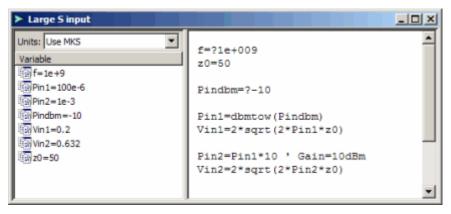
And for the 2nd port it is

Vout2 = VPORT[2,2]





The voltage amplitudes of input signals Vin1 and Vin2, used in the equations, are calculated from the input powers of the signal ports in the global equations block:



Note:

It's strictly not recommended to mix up the pre-processed data (input design or analysis parameters) with post-processed data in the same equations block, because after deleting the post-processed data from the workspace (for example, after recalculating the analysis), its dataset is cleared and post-processed data does not exist anymore. It results in an error parsing the equation block, after which all the input data used by the updated design (or analysis) will be not accessible more. As a result it stops the workspace updating process.

For example, the above global equation block includes only pre-processed data and no post-processed data.

Now add two parameters sweep and check the "propagate all variables" checkbox to make LSij sweep along with the built-in variables.

See the below example where the above steps are done to verify that for an RLC circuit the Large Signal S-Parameters match Sij perfectly:

Large Signal S Parameter Linear Test

The "Large Signal S Parameter Linear Test (2-tones)" shows up using the 2-nd method of the LS - parameters calculation.

Intercept Point Calculation

NEW Genesys 2005 and later now has special functions calculating IP-n for any 2 components of a spectrum for any number of signal tones of Harmonic Balance analysis for input:

$hb_iipn(SpectrPout,FreqIndexIM,IndexS1,IndexS2,\,PindBm)$

or output power:

hb_oipn(SpectrPout,FreqIndexIM,IndexS,IndexIM)

To propagate these in sweeps, the functions need to be called directly in declared variables of the HB-analysis dataset, and the flag "Propagate All Variables When Sweeping" of Parameter Sweep analysis must be set.

For example, the tested circuit has input signal port with 2-tones signal of equal power:

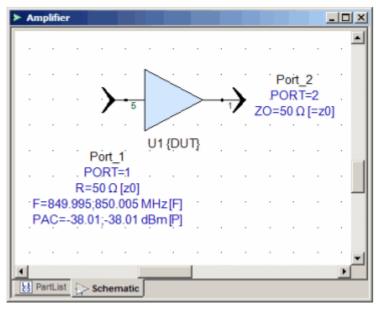
Simulation

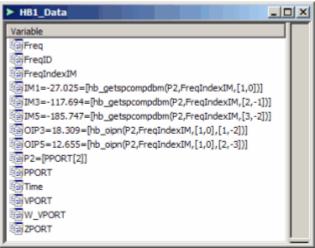
```
F1=F0 + delta\_F / 2

F2=F0 - delta\_F / 2 P0 = -35 dBm,

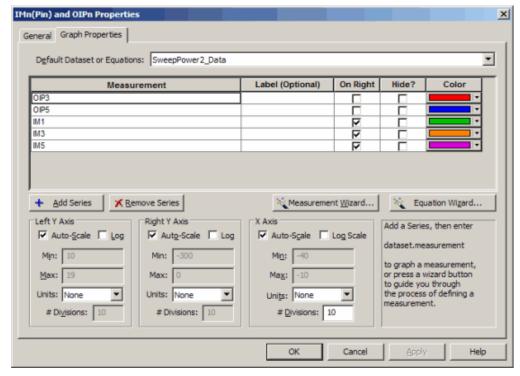
F0 = 850 \text{ MHz}, and delta\_F=10 \text{ kHz}: P1 = P2 = P0 - 3.01 dBm

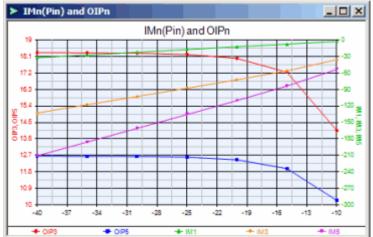
F=[F1;F2] P=[P1;P2]
```





The variables are propagated in the sweep and may be plotted:





For an example of the above in an Amplifier design, see the example **\Examples\Amplifiers\Amplifier IPn Calculation.wsx**

Parameter Sweeps

Parameter Sweep

3D graphs in GENESYS require parameter sweeps to generate a third dimension for plotting. Parameter Sweeps give you this third dimension by adjusting a tuned variable, repeating another simulation for each adjustment. For example, to see how the response of a circuit changes when a capacitor is adjusted, you can add a Parameter sweep which sweeps the linear or electromagnetic simulation while adjusting the capacitor value. You can then view the results on a 3-D graph.

To add a Parameter Sweep Evaluation:

- 1. Create a design with a schematic.
- 2. Define your tunable parameters.
- 3. Click the New Item button () on the Workspace Tree toolbar and choose "Add Sweep" from the Evaluation menu.
- 4. Define the Parameter Sweep Properties and click **OK**. The analysis runs and creates a data set.

For advanced applications, you can nest Parameter sweeps, creating 4-D, 5-D, or higher data. This data can then be viewed on a table.

Performing a Parameter Sweep

A parameter sweep gives you a set of responses for a set of parameter values. You can perform a parameter sweep on any tuned variable.

To create a parameter sweep:

Click the New Item button (on the Workspace Tree toolbar and select Add Sweep from the Evaluations menu.

Parameter Sweep Properties Sweep Name: Sweep1 Calculate Now Eactory Defaults... Analysis to Sweep: Linear1 Parameter to sweep: Designs\Design1\C1.C Output Dataset: Description: Type Of Sweep Parameter Range Start: 100 (pF) O Linear: Number of Points: 10 (pF) O Log: Points/Decade: Stop: 1000 O Linear: Step Size (pF): Unit of Measure: pF OList (pF): Х ✓ Show Long Parameter Names Propagate All Variables When Sweeping (or only analysis variables) OK Cancel Help

2. You will see the sweep properties box, which will be similar to this:

3. By default the sweep settings will be the same as the last time you created a sweep. The default parameter to sweep is just the first in the list. Here the parameter is in the Designs folder, in the design named Design1, in the part named C1, as parameter C.

In the list are all tuned parameters (or equation variables). Use the settings shown above, then click Calculate Now to calculate the sweep.

- 4. Note that a Sweep1_Data dataset is built.
- 5. Double-click the S21 graph and change the "Default Dataset or Equations" to Sweep1_Data so you plot S21 for the swept data. Turn off symbols by clicking the Symbols button (the last button on the Graph toolbar). You get a range of traces that looks like this:

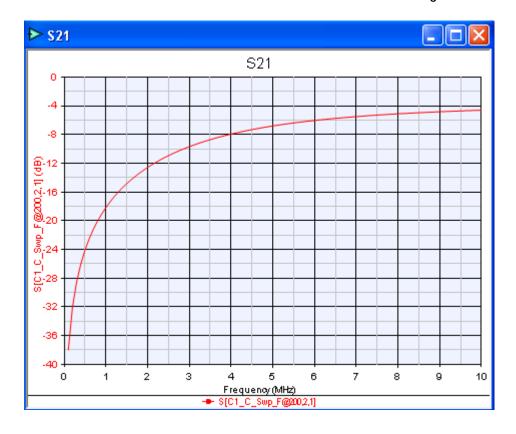


Here the mouse is hovering over a dot on the dark green trace and the popup identifies the trace and value.

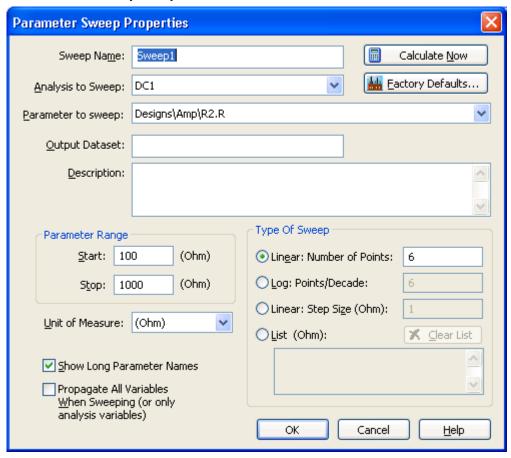
To look at the range at 200 pF enter the following formula into the graph line

- 6. Enter S[C1_C_Swp_F@200,2,1]. Note that the swept C value is in the Sweep1_Data set and named C1_C_Swp_F (C1.C swept on F).
- 7. The graph now is:

Getting Started



Parameter Sweep Properties



Name	Description
Sweep Name	Name of Sweep Evaluation
Analysis to Sweep	Analysis used for the parameter sweep. The selected analysis will be recalculated for each different value of the swept parameter.
Parameter to Sweep	Parameter that gets changed to create the sweep. All parameters defined as tunable are available to be swept.

Output Dataset		Dataset file in which the data is saved. If not specified, the dataset name will be the name of the analysis with "_Data" appended.		
Description		Description of the evaluation being run. For documentation purposes only, not otherwise used by GENESYS.		
Calculate Now		Run the evaluation. Always runs the analysis, regardless of whether or not any changes were made.		
Propagate All Variables When Sweeping		During the sweep process, if the source dataset has user defined variables these will also be swept and aggregated into the sweep dataset.		
Show Long Parameter Name		Display the full parameter name (with path) in case you have multiple parameters with the same short name (such as C1.C).		
Factory Defaults		Reset all values to their default		
Parameter Range	Start	The lower bound (minimum frequency) of the sweep.		
	Stop	The upper bound (maximum frequency) of the sweep.		
	Unit of Measure	Unit of measure used for the evaluation		
Type of Sweep	Linear: Number of Points	Number of points in entire sweep.		
	Log: Points/Decade	Number of points in each decade of the sweep.		
	Linear: Step Size (MHz)	Allows specification of start and stop frequencies, and space between points.		
	List of Frequencies (MHz)	Allows the explicit specification of analysis frequencies. These points are entered into the List of Frequencies box separated by spaces.		

Chapter 2: Advanced Modeling Kit

Advanced Modeling Kit Overview

The GENESYS Advanced Modeling Kit (AMK) consists of three main parts:

- Approximately 12 additional nonlinear models for use in HARBEC and CAYENNE. These models are ready to use and do not require knowledge of the Verilog-A language.
- A built-in Verilog-A compiler for creating your own nonlinear models.
- Verilog-A source code for some of the non-proprietary nonlinear models
 contained in GENESYS. These files allow you to make custom changes to
 existing nonlinear models. For example, you can make a new model identical to a
 built-in transistor but with a change to the nonlinear capacitance equations.

Hardware description languages were developed as a means to provide varying levels of abstraction to designers. Integrated circuits are too complex for an engineer to create by specifying the individual transistors and wires. HDLs allow the performance to be described at a high level and simulation synthesis programs can the take the language and generate the gate level description. As behavior beyond the digital performance was added, a mixed-signal language was created to manage the interaction between digital and analog signals. A subset of this, Verilog-A was defined. Verilog-A describes analog behavior only; however, it has functionality to interface to some digital behavior.

Most other Verilog-A implementations are interpreted languages and are relatively slow. However, the GENESYS AMK includes a Verilog-A compiler that creates C++ code which is compiled, yielding simulation times similar to hand-coded models. Additionally, since the derivatives symbolically calculated by the AMK are often more accurate, convergence of circuits using Verilog-A models is generally better. This often results in a speed-up (not slow-down) when using Verilog-A models.

Using the Additional AMK Models

The GENESYS AMK includes additional nonlinear models. As of the time of this writing, the additional models are:

- Angelov NFET/PFET
- BSIM4 NMOS/PMOS
- EKV NMOS/PMOS
- HiSIM NMOS/PMOS
- Philips JUNCAP

- MEXTRAM NPN/PNP
- Philips MOS9 NMOS/PMOS
- Philips MOS11 NMOS/PMOS
- Parker/Skellern NFET
- TFT NMOS/PMOS
- UCSD HBT NPN

To access these models simply place the appropriate part from the schematic nonlinear toolbar or from the part library.

Creating New Verilog-A Models

The basic steps in creating a new Verilog-A Model are:

- 1. We recommend placing new Verilog-A models into your GENESYS User Model directory. This is generally the "My Models" directory in your "My Documents" folder. Open the Tools/Options Dialog, go to the Directories Tab, and examine or change the User Model location listed here. If you do not place your Verilog-A source files in the directory listed here, you must specify a full directory path when referring to the model. Note: You may add a relative path if you place your Verilog-A files in a subdirectory under your User Model path.
- 2. Create a text file containing the Verilog-A source code in a text editor such as Windows Notepad and save it into the directory chosen in step 1. Be sure to use the extension ".va" on the file. See the Verilog-A Tutorial for information about creating a Verilog-A file.
- 3. To use your model, you must change the model on a part to module@filename. For example, if your module is called "limiter" and it is in the file "MyLimiter.va", you would set the model to "limiter@MyLimiter.va". If you do not put the file in the directory from step 1, then you should specify a full path (drive and directory). Note: GENESYS also searches the directory which you saved the workspace. If your Verilog-A module is only used for a few workspaces, you could simply place the model in the same directory as the workspaces.
- 4. GENESYS will compile your Verilog-A file. If there are errors shown in your Verilog-A code, fix them and repeat step 3.
- 5. When the model successfully compiles, a "Compiled" subdirectory is created in the same directory as the Verilog-A source file. GENESYS creates compiled model library (.cml) file and an XMLmodel (.xml) file for each Verilog-A file.

Customizing Built-In Nonlinear Models

GENESYS supplies Verilog-A source code for most of the built-in nonlinear models. This allows you to create models identical to the GENESYS built-in nonlinear models and then customize these as you see fit.

Note: You cannot change the built-in models. Instead, you must create a new model and must use this new model in your schematic.

The source code is in the Examples\VerilogA directory (normally installed to C:\Program Files\GENESYS 2005.11\Examples\VerilogA). To use these files, you should copy them to a new directory as described in step 1 of "Creating New Verilog-A Models" above.

The example modules have "_va" added to the end of the name to keep them from conflicting with the built-in models.

After you have copied the Verilog-A source file, you should follow the steps in "Creating New Verilog-A Models" above.

Verilog-A Tutorial

Verilog-A is a procedural language, with constructs similar to C and other languages. While the language does allow some knowledge of the simulator, most model descriptions should not need to know anything about the type of analysis being run.

Perhaps the simplest possible Verilog-A file is a resistor (the line numbers are not part of the verilog file):

```
1: `include "disciplines.vams"
 2:
 3: module resistor(p,n);
      inout p,n;
 4:
 5:
      electrical p,n;
      parameter real r=50 from (0:inf) exclude 7;
 6:
 7:
      analog
 8:
         begin
 9:
          V(p,n) <+ r*I(p,n);
10:
        end
11: endmodule
```

You can use this resistor as a starting point for your own Verilog-A files, or you may start with a more complex file such as the built-in nonlinear models.

Line 1: 'include "disciplines.vams"

This line includes the definitions for electrical nodes, among other things, and should be the first line of most Verilog-A files. Note the use of the `symbol. *It is not a normal*

apostrophe ('). On most keyboards it is located on the upper left key, the same key as the tilde (~).

Line 3: module resistor(p,n);

Declares the start of a module named resistor with two external terminals, p and n. These terminals are used in order by GENESYS, so p becomes pin 1 and n becomes pin 2 in the symbol.

Line 4: inout p,n;

Declares that these ports are input/output ports.

Line 5: electrical p,n;

Declares that these nodes are electrical. If internal nodes are needed, they should be added to this line.

Line 6: parameter real r=50 from (0:inf] exclude 7;

Declares model parameter "r" with a default value of 50. This value can range from greater than zero (using opening parenthesis to indicate zero is not allowed) to infinity. Infinity is a legal value since square bracket was used. The value 7 is specifically excluded.

Line 7: analog

Header for the analog equations. Required in all files.

Line 8: begin

Starts the actual analog equations. Often, this is combined with "analog" on one line: "analog begin".

Line 9: V(p,n) <+ r*I(p,n);

Adds a voltage due to the resistor (V=IR). V(p,n) is the voltage from node p to node n. I(p,n) is a branch current flowing from node p to node n. Note: This branch current is automatically added by the compiler as another variable to be solved, and the matrix entries to support this Modified Nodal Analysis relationship are also added automatically.

Line 10: end

Ends the analog equations started at line 8.

Line 11: endmodule

Ends the resistor module started at line 3.

Other commonly used features not shown in this simple example include local variables/equations and if/then statements. See the Verilog-A examples or the Verilog-A reference section of this manual

Verilog-A Reference

Verilog-A Reference Overview

This manual does not give a complete technical reference to Verilog-A. Rather, the objective is to give a model developer enough details to implement complex models without being weighted down with syntax charts and excessive details. To purchase a complete reference to Verilog-A, contact Accellera at www.accellera.org.

Preprocessor

The preprocessor supports certain directives in order to simplify code development. These directives are very similar to their C counterparts.

Include

The `include directive is used to insert the entire contents of a source file during compilation. The `include can be used to simplify code by including global definitions or without repeating code within module boundaries. The compiler directive `include can be specified anywhere within the Verilog-A file. The filename is the name of the file (with either the full or relative path) to be included in the source file.

Only white space or comments can appear on the same line as the 'include directive.

A file included in the source using `include can contain other `include compiler directives; however, infinite nesting is not permitted.

```
`include "filename"
Examples:

`include "/user/include/global_decl.vams"
`include "../myIncludes.txt"
`include "myFunctions.va"
```

Macros

String substitution can be performed with the `define directive both inside and outside module definitions. The macro is used in the source file by insert the `character, followed by the macro name. The preprocessor then substitutes the text of the macro for the string `text_macro_name. All compiler directives are considered predefined macro names and so redefining a compiler directive as a macro name is not allowed.

A text macro can be also be defined with arguments to provide much more flexibility. However, the use of macros can complicate symbolic debugging, so the user should be careful in their use.

Examples:

```
`define EPSSI (1.03594e-10) 
 `define KboQ (`P_K / `P_Q) 
 `define strobe(flag, xName, X) if (_debug >= flag) \ strobe("\n %s = %g", xName, 1.0 *(X))
```

The macros are then accessed in the code as:

```
factor1=sqrt(`EPSSI / `EPSOX * tox);
   `strobe(1, "Vth", Vth);
ifdef, else, endif
```

These are conditional compiler directives for optionally including lines of Verilog-A source file. `ifdef checks for if variable name is defined. If it is defined, the lines following `ifdef are included up to the `endif directive. If the variable name is not defined, but an `else directive exists, this source is compiled. The ifdef, else, and endif directives can appear anywhere in the Verilog-A source file.

Examples:

```
`ifdef Thermal
    module bjt(c,b,e,dt);
`else
    module bjt(c,b,e);
`endif
```

Note: GENESYS does not support predefining a macro (as is often done from a command line build). You must define any necessary switches within the Verilog-A source. A useful method is to create a Verilog-A file that does nothing but `define macros and then `includes the real Verilog-A source. In the example shown above, that file could `define Thermal before including the bjt module.

Data Types and Parameters

Integer

An integer declaration declares one or more variables of type integer holding values ranging from -231 to 231-1. Arrays of integers can be declared using a range which defines the upper and lower indices of the array where the indices are constant expressions and shall evaluate to a positive or negative integer, or zero.

Example:

```
integer flag, MyCount, I[0:63];
```

Real

A real declaration declares one or more variables of type real using IEEE STD-754-1985, (the IEEE standard for double precision floating point numbers). Arrays of reals can be declared using a range which defines the upper and lower indices of the array where the indices are constant expressions and shall evaluate to a positive or negative integer, or zero.

Example:

```
real X[1:10], Tox, Xj, Cgs; net_discipline
```

The net_discipline is used to declare analog nets and for declaring the domains of digital nets and regs. A net is characterized by the discipline that it follows. A net is declared as a type of discipline and so a discipline can be considered as a user-defined type for declaring a net.

A discipline is a set of one or more nature definitions forming the definition of an analog signal whereas a Nature defines the characteristics of the quantities for the simulator. A discipline is characterized by the domain and the attributes defined in the natures for potential and flow.

The discipline can bind:

- One nature with potential
- One nature with potential and a different nature with flow
- Nothing with either potential or flow (an empty discipline)

The disciplines are typically predefined in the disciplines vams file, a portion of which is shown below.

```
// Electrical
// Current in amperes
nature Current
units = "A";
access = I;
idt_nature = Charge;
`ifdef CURRENT_ABSTOL
  abstol = `CURRENT_ABSTOL;
`else
  abstol = 1e-12;
`endif
endnature
// Charge in coulombs
nature Charge
units = "coul";
access = Q;
ddt_nature = Current;
`ifdef CHARGE_ABSTOL
  abstol = `CHARGE_ABSTOL;
`else
  abstol = 1e-14;
`endif
endnature
// Potential in volts
nature Voltage
nature Voltage
units = "V";
access = V;
idt_nature = Flux;
```

```
`ifdef VOLTAGE_ABSTOL
  abstol = `VOLTAGE_ABSTOL;
`else
  abstol = 1e-6;
`endif
endnature
```

genvar

Genvars are integer-valued variables which compose static expressions. They are used for instantiating structure behaviorally e.g., accessing analog signals within behavioral looping constructs.

```
genvar list_of_genvar_identifiers; where list_of_genvar_identifiers is a comma separated list of genvar identifiers.
```

Example:

```
genvar I, j;
```

Parameters

Parameters provide the method to bring information from the circuit to the model.

Parameter assignments are a comma-separated list of assignments. The right hand side of the assignment is a constant expression (including previously defined parameters).

For parameter arrays, the initializer is a list of constant expressions containing only constant numbers and previously defined parameters within { and } bracket delimiters.

Parameters represent constants; their values can not be modified at runtime.

Parameters can be modified from the declaration assignment at compilation time. The purpose is to allow customization of module instances. A parameter, however, can be modified with the defparam statement or the module_instance statement. It is not legal to use hierarchical name referencing from within the analog block to access external analog variable or parameter values. An example is:

```
parameter real TestFlag = 0 from [0:inf) exclude (10:100) exclude (200:400];
The general format is:

parameter {real | integer} list of assignments;

where the list of assignments is a comma separated list of parameter_identifier = constant {value-range}

where value-range is of the form from value_range_specifier | exclude value_range_specifier
```

exclude constant_expression

```
where the value_range_specifier is of the form start_paren expression1 : expression2 end_paren
```

The type (real | integer) is optional. If it is not given, it will be derived from the constant assignment value. A parenthesis indicates the range can go up to, but not include the value, whereas a square bracket indicates the range includes the endpoint.

The value range specification is quite useful for range checking. Some examples of this are:

```
parameter real Temp = 27 from [-273.15:inf);
parameter R = 50 from (0:inf];
and value ranges can have simple exclusions:
parameter R = 50 from (0:inf] exclude (10:20) exclude 100;
```

Analog Block

Expressions and statements

Conditional statement (if-else statement)

The conditional statement is used to determine whether a statement is executed or not. The syntax is

```
if ( expression ) true_statement_or_null;
[ else false_statement_or_null; ]
```

If the expression evaluates to True (non-zero), then the *true_statement* will be executed (or not, if false). If there is an else *false_statement* and the expression evaluates to False, the *false_statement* is executed instead.

Case statement

A case statement is useful for multiple actions to be selected based on an expression.

The format is:

```
{ case | casex | casez } (expression)
```

```
case_item
{ case_item }
endcase

where case_item is
expression { , expression } : statement_or_null
| default [:] statement_or_null
```

The *default-statement* is optional but if used, can only be used once. The *case-expression* and the *case_item* expression can be computed at runtime (neither expression is required to be a constant expression). The *case_item* expressions are evaluated and compared in the exact order in which they are given. If one of the *case_item* expressions matches the case-expression given in parentheses, then the statement associated with that *case_item* is executed. If all comparisons fail then the default item statement is executed (if given). Otherwise none of the *case_item* statements are executed.

Repeat and while looping statements

The repeat() statement executes a statement a fixed number of times. Evaluation of the expression determines how many times the statement is executed.

The while() looping executes a statement until an expression becomes False. If the expression is False when the loop is entered, the statement is not executed at all.

The syntax for the repeat() and while() statements is shown

```
repeat (expression) statement while (expression) statement
```

For() statement

The for() statement controls execution of its associated statement(s) using an index variable. If the associated statement is an analog_statement, then the control mechanism must consist of genvar_assignments and genvar_expressions.operators (no use of procedural assignments and expressions).

```
for (procedural_assignment; expression; procedural_assignment) statement where for analog_for_statement the format is
```

```
\label{lem:continuous} for \ (\ \textit{genvar\_assignment}, \textit{genvar\_expression}, \textit{genvar\_assignment}\ ) \ \textit{analog\_statement} \\ \textbf{Signals}
```

Accessing net and branch signals

Signals on nets and branches are be accessed only by the access functions of the associated discipline. The name of the net or the branch is specified as the argument to the access function.

Examples:

```
Vin = V(in);
CurrentThruBranch = I(myBranch);
```

Events

The analog behavior of a component can be controlled using events, which have the characteristics:

- Events have no time duration
- Events can be triggered and detected in different parts of the behavioral model
- Events do not block the execution of an analog block
- Events can be detected using the @ operator
- Events do not hold any data
- There can be both digital and analog events

There are two types of analog events: global events and monitored events. Null arguments are not allowed in analog events.

cross function

The cross() function is used for generating a monitored analog event. It is used to detect threshold crossings in analog signals when the expression crosses zero in the direction specified. cross() can control the timestep to accurately resolve the crossing. The format is

```
cross( expr [ , dir [ , time_tol [ , expr_tol ] ] ] );
```

where *expr* is required, and *dir*, *time_tol*, and *expr_tol* are optional arguments. The *dir* argument is an integer expression; the other arguments are real. If the tolerances are not defined, they are set by the simulator. If either or both tolerances are defined, then the direction of the crossing must also be defined. The direction can only evaluate to +1, -1, or 0. If it is set to 0 or is not specified, the event and timestep control will occur on both positive and negative signal crossings. If dir is +1 or -1, then the event and timestep control occur on rising edge (falling edge) transitions of the signal only. For other transitions of the signal, the cross() function will not generate an event. *expr_tol* and *time_tol* represent the maximum allowable error between the estimated crossing point and the actual crossing point.

Examples:

The following description of a sample-and-hold illustrates how the cross() function can be used.

```
module sample_and_hold (in, out, sample);
output out;
input in, sample;
electrical in, out, sample;
real state;
analog begin
    @(cross(V(sample) -2.0, +1.0))
state = V(in);
V(out) <+ transition(state, 0, 10n);
end
endmodule
```

The cross() function maintains its internal state. It has the same restrictions as other analog operators in that it can not be used inside an if(), case(), casex(), or casez() statement unless the conditional expression is a genvar expression. Also, cross() is not allowed in the repeat() and while() iteration statements but is allowed in the analog_for statements.

timer function

The timer() function is used to generate analog events. It is used to detect specific points in time. The general form is

```
timer (start_time [, period [, time_tol]]);
```

where start_time is a required argument but period and time_tol are optional. The timer() function schedules an event to occur at an absolute time (start_time). The analog simulator then inserts a time point within timetol of an event. At that time point, the event evaluates to True. If time_tol is not specified, the default time point is at (or just beyond) the time of the event. If the period is specified as greater than zero, the timer function schedules subsequent events at multiples of period.

Examples:

A pseudo-random bit stream generator is an example how the timer function can be used.

```
module bitStreamGen (out);
output out;
electrical out;
parameter period = 1.0;
integer x;
analog begin
@(timer(0, period))
x = $random + 0.5;
V(out) <+ transition(x, 0.0, period/100.0);
end
endmodule
```

Operators

Analog operators operate on an expression and return a value. Furthermore, they can operate on more than just the current value of their arguments as they maintain their internal state and so their output is a function of both the input and the internal state.

Because they maintain their internal state, analog operators are subject to several important restrictions. These are:

- Analog operators can not be used inside conditional (if and case) or looping (for) statements unless the conditional expression is a genvar expression (which can not change their value during the course of an analysis).
- Analog operators are not allowed in repeat and while looping statements.
- Analog operators can only be used inside an analog block; they can not be used inside an initial or always block, or inside a user-defined analog function.

Under most cases, you can not specify a null argument in the argument list of an analog operator.

Operator	Function
Time derivative	The ddt operator computes the time derivative of its argument. The form is ddt(<i>expr</i>)
Time integral	The idt operator computes the time-integral of its argument. The general form is idt(expr)
Linear time delay	absdelay() implements the absolute transport delay for continuous waveforms The general form is absdelay(input, td [, maxdelay])
Discrete	transition(expr[, td[, rise_time[, fall_time[, time_tol]]]])
waveform filters (transition, slew)	The slew analog operator bounds the rate of change (slope) of the waveform. The general form is slew(expr [, max_pos_slew_rate [, max_neg_slew_rate]]). The last_crossing() function returns a real value representing the simulation time when a signal expression last crossed zero. The format is last_crossing(expr, direction)
Laplace transform	laplace_zp() implements the zero-pole form of the Laplace transform filter. The general form for each is laplace_zp(expr, z, r [,e])
filters	laplace_zd() implements the zero-denominator form of the Laplace transform filter. The laplace_np() implements the numerator-pole form of the Laplace transform filter. laplace_nd() implements the numerator-denominator form of the Laplace transform filter.
Z-transform filters	The Z-transform filters implement linear discrete-time filters. Each filter uses a parameter T which specifies the filter's sampling period. The zeros argument may be represented as a null argument. The null argument is produced by two adjacent commas (,,) in the argument list.
	All Z-transform filters share three common arguments: T, t, and t0. T specifies the period of the filter, is mandatory, and must be positive. t specifies the transition time, is optional, and must be nonnegative.
	zi_zp() implements the zero-pole form of the Z-transform filter. The general form is zi_zp($expr$, z , r , T [, t [, $t\theta$]])
	zi_zd() implements the zero-denominator form of the Z-transform filter. zi_np() implements the numerator-pole form of the Z-transform filter. zi_nd() implements the numerator-denominator form of the Z-transform filter.

Contribution assignment statements

Sequential block

A sequential block is a grouping of two or more statements into one single statement. The format is:

```
begin [: block_identifier { block_item_declaration } ]
    { statement }
end

where block_item_declaration is
    parameter_declaration
    integer_declaration | real_declaration
```

Indirect branch assignment

An indirect branch assignment is useful when it is difficult to solve an equation. It has this format:

```
V(n) : V(p) == 0;
```

Which can be read as "find V(n) such that V(p) is equal to zero." This example says that node n should be driven with a voltage source and the voltage should be such that the given equation is satisfied. V(p) is probed and not driven.

Indirect branch assignments are allowed only within the analog block.

Branch contribution statement

A branch contribution statement typically consists of a left-hand side and a right-hand side, separated by a branch contribution operator. The right-hand side can be any expression which evaluates to (or can be promoted to) a real value. The left-hand side specifies the source branch signal to assign the RHS. It consists of a signal access function applied to a branch. The form is:

```
V(n1, n2) < + expression;
```

Branch contribution statements will implicitly define source branch relations. The branch is goes from the first net of the access function to the second net. If the second net is not specified in the call, the global reference node (ground) is used as the reference net.

Ports

Ports provide a way to connect modules to other modules and devices. A port has a direction: input, output, or inout, which must be declared. The ports are listed after the module declaration. The port type and port direction must then be declared in the body of the module.

Examples:

```
module resistor(p,n);
inout p,n;
electrical p,n;
...
module modName(outPort, inPort);
output outPort;
input inPort;
electrical out, in;
...
```

Ports can support vectors (buses) as well.

Analog Functions

Analog functions provide a modular way for a user-defined function to accept parameters and return a value. The functions are defined as analog or digital and must be defined within modules.

The analog function is of the form:

```
analog function {real|integer} function_name;
input_declaration;
statement_block;
endfunction
```

The *input_declaration* describes the input parameters to the function as well as any variables used in the statement block:

```
input passed_parameters;
real parameter_list;
```

The statement_block and analog function:

- Can use any statements available for conditional execution
- Can not use access functions
- Can not use contribution statements or event control statements
- Must have at least one input declared; the block item declaration declares the type
 of the inputs as well as local variables used
- Can not use named blocks
- Can only reference locally-defined variables or passed variable arguments

The analog function implicitly declares a variable of the same name as the function, *function_name*. This variable must be assigned in the statement block; its last assigned value is passed back.

Example:

```
analog function real B_of_T;
input B, T, T_NOM, XTB;
real B, T, T_NOM, XTB;
begin
B_of_T = B * pow(T / T_NOM, XTB);
end
endfunction
The function is called by the line:
BF_T = B_of_T(BF, T, T_NOM, XTB);
```

System tasks and functions

System functions provided access to system level tasks as well as access to simulator information.

Environment parameter functions

These functions return simulator environment information.

Function	Return Value	
\$temperature	Circuit ambient temperature in Kelvin	
\$abstime	Absolute time in seconds	
\$realtime[(scale)]	\$realtime can have an optional argument which scales the time. If no argument is given, \$realtime's return value is scaled to the `time_unit of the module which invoked it. If an argument is given, \$realtime shall divide the absolute time by the value of the argument (i.e., scale to the value specified in the argument). The argument for \$realtime follows the semantics of the `time_unit, that is it shall consist of an integer followed by a scale factor. Valid integers are: 1, 10, and 100; valid scale factors are: s (seconds), ms (milliseconds), us (microseconds), ns (nanoseconds), ps (picoseconds), and fs (femtoseconds)	
\$vt[(Temperature)]	\$vt can optionally have <i>Temperature</i> (in Kelvin units) as an input argument and returns the thermal voltage (kT/q) at the given temperature. \$vt without the optional input temperature argument returns the thermal voltage using \$temperature.	

Input/output operations

These functions provide access to display and file operations.

Function	Return Value
\$fopen(file_name)	\$fopen opens the file specified as an argument and returns a 32-bit multichannel descriptor which is uniquely associated with the file. It returns 0 if the file could not be opened for writing.
\$fclose(file_id)	\$fclose closes the channels specified in the multichannel descriptor and does not allow any further output to the closed channels. \$fopen reuses channels which have been closed.
\$strobe(args)	\$strobe provides the ability to display simulation data when the simulator has converged on a solution for all nodes using a printf() style format.
\$monitor(args)	\$monitor provides same capabilities as \$strobe but outputs only when a parameter changes.

Eagleware Verilog-A Extensions

Eagleware has created several extensions to Verilog-A. These extensions are not required in any Verilog-A files, but they allow more complete information to be given to GENESYS about the model, making it easier to pass Verilog-A files between users. In GENESYS, a Verilog-A file gives a complete description of the model, and no other files are generally necessary to share between users.

Parameter Descriptions

First, parameter descriptions and units can be included in comments:

```
parameter real Vtr = 20.0; // Soft breakdown model parameter [V] parameter real P3 = 0.0; // Polynomial coeff P3 for channel current [1/V^3] parameter real Fnc = 0.0 from [0:inf); // Noise corner freq [Hz] parameter real Cds = 0 from [0:inf]; // Zero-bias D-S junction capacitance [F]
```

Any comments on the same line as the parameter are assumed to be a description of the parameter. Additionally, units can be given inside square brackets. Currently supported units include: Hz, Ohm, mho, H, F, V, A, s, C, deg, m, W, and DB. If you use any of these units, then other related units (such as pF or dBm) can be specified when the parts are used. Unrecognized units (such as " $1/V^3$ " above) are simply put into the description so that the user knows what units must be entered for the part.

Additionally, if the comment starts with "Unused" or "Alias", then the parameter is not shown to the user in GENESYS and the default value is used. If the comment starts with "Required", then GENESYS will give an error if the parameter is not specified. If the value `NOT_GIVEN is used as the default, then GENESYS will not show a default, but will just show "optional" for the default value.

Eagleware extension keywords

All Eagleware extension keywords are placed inside comments in the Verilog-A and are always placed between two pairs of percent signs, like:

```
// %%KEYWORD%%
// %%KEYWORD=value%%
```

Since these keywords are placed in comments, they will be ignored by other simulators. The keywords *must* be placed inside the module that they are to affect (after the module statement). Keywords only affect one module. If you have multiple modules in your VA file, you will need to duplicate any keywords which are to affect multiple modules.

DEVICE_CLASS keyword

The DEVICE_CLASS keyword tells GENESYS what type of device the module represent. This allows GENESYS to:

- Select a appropriate symbols
- Create multiple models for N or P class devices (such as NFET or PFET) from one Verilog-A source.
- Automatically reverse pins 1 and 2 for transistor class devices. This reversal is necessary since in SPICE (and in most Verilog-A source) the input is pin 2 and

the output is pin 1. In GENESYS and most RF/Microwave simulation, the convention is for the input to be pin 1 and the output to be pin 2.

Some examples of device class statements are:

```
// %%DEVICE_CLASS=DIODE%%
// %%DEVICE_CLASS=FET(NFET,PFET)%%
// %%DEVICE_CLASS=MOS(NMOS:type=1,PMOS:type=-1)%%
The general format of the keyword is:
```

// %%DEVICE_CLASS=type(option1:var1=value1,option2:var2=value2...)%% type is required and should be one of:

```
DIODE, BJT, BJT4, BJT5, FET, JFET, MOS, RESISTOR, CAPACITOR, CCCS, CCVS, VCCS, VCVS
```

BJT4 adds a substrate node, and BJT5 adds substrate and temperature nodes. MOS supports both three and four pin devices.

option1, option2, ..., are not required. If they are given, GENESYS will create one model for each option. Additionally, if var is not given for an option, the value of the option will be set to 1. For the FET example above, GENESYS will make two models, with "_NFET" and "_PFET" added to the base model name. For the NFET model, the value "NFET" will be set to one. Additionally, NFET and PFET will not be shown as parameters in GENESYS. GENESYS will also use appropriate symbols for any recognized option. The following options are recognized by GENESYS:

```
BJT, BJT4, BJT5: NPN and PNP
FET and JFET: NFET, NJF, PFET, and PJF
MOS: NMOS and PMOS
```

If *var1,var2,...*, are specified, they are set to the specified value (instead of the option being set to a value). Additionally, the parameters referenced are not shown as parameters in GENESYS. Otherwise, they behave identically to the case above.

EAGLEWARE_LAYOUT keyword

Advanced keyword which allows overriding of footprints or association entries.

EAGLEWARE_OPTIONS keyword

Advanced keyword which allows specification of additional model options.

EAGLEWARE_NAME keyword

Normally, the GENESYS model name is the same as the Verilog-A model (with any device class options added to this base name). The base name can be overridden by:

```
// %%EAGLEWARE_NAME=modelname%%
```

EAGLEWARE_SWAP12 keyword

Advanced keyword which reverses pins 1 and 2 in GENESYS. Can override DEVICE_CLASS swapping if placed later in the file.

EAGLEWARE_NOSWAP12 keyword

Advanced keyword which prevents pins 1 and 2 from being swapped in GENESYS. Can override DEVICE_CLASS swapping if placed later in the file.

EAGLEWARE_IGNORE keyword

Tells GENESYS to ignore a parameter. For example,

// %%EAGLEWARE_IGNORE=x%%

will cause the parameter x to not be displayed in GENESYS, and the default value will be used in Verilog-A.

Chapter 3: CAYENNE (Transient Analysis)

CAYENNE Overview

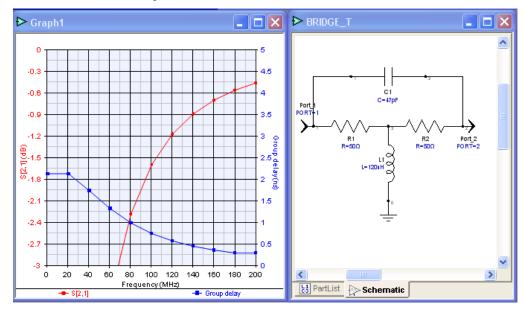
CAYENNE, like SPICE, simulates the time response of a circuit to an arbitrary input waveform. In order to accomplish this, a time-stepped DC analysis is performed to compute samples of the output waveform. All elements, whether energy-storing, linear, or non-linear, are broken down into a form that allows Nodal Analysis to be performed. Nodal analysis, based on Kirchoff's laws, describes the currents in a circuit as an equation involving the conductances and voltages in the circuit. The number of nodes in a circuit determines the number of variables and equations to be solved simultaneously.

CAYENNE Walkthrough

In this example, we will modify a simple circuit to include a transient analysis. First, please load the example circuit Bridge-T:

- 1. Select New from the File menu. (If you have disabled the "Start Page", you will need to select "Show Start Page" from the Help menu instead.)
- 2. Press the Open Example button and select the Bridge-T.wsx file from the root of the examples folder.

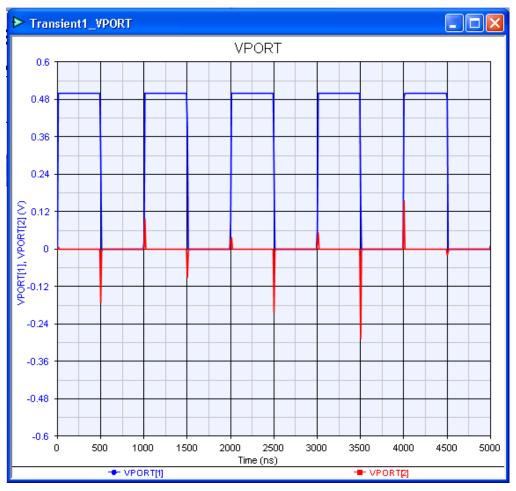
The response should look like the figure below. Note that this circuit has a substantial amount of loss at low frequencies.



Simulation

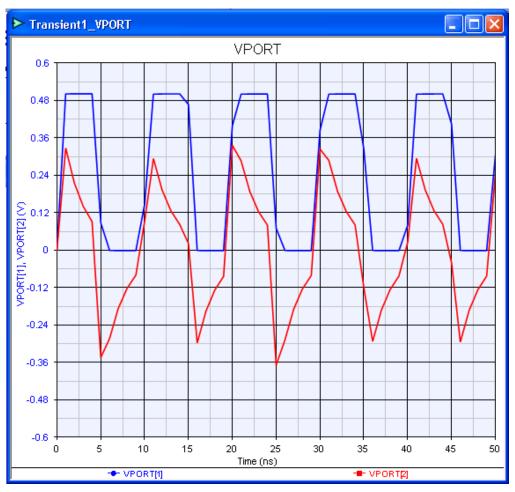
All transient analyses must have a source. The source may simply be DC, allowing you to view startup and self-oscillation. Or, the sources may be waveforms, allowing the display of a transient response to a stimulus. In our existing schematic, there are no sources, so any transient analysis would be all zero. To perform a meaningful transient analysis on this example, we will replace the input with a periodic pulsed waveform. To do this and also add a transient analysis and display results:

- 1. Delete the input port of the schematic.
- 2. From the part selector, Filter by Pulse.
- 3. Find the "Input(Pulsed Volt): model and place it on the schematic where the old input used to be. Note: These sources are also found in the Input button on the schematic "Basic" toolbar.
- 4. Double-click the input and set the pulse width to 500 ns. This will give a 50% duty cycle pulse at the default Frequency for the part of 1 MHz.
- 5. We are now ready to add the transient analysis. Click the New Item button on the Workspace Tree and select Analyses/Add Transient Analysis.
- 6. Click the Factory Defaults button to be sure we are starting with good settings. This is also a good practice is an analysis begins to have unexpected behavior.
- 7. The only parameters we need to modify are Stop Time and Maximum Step Size. Set the Stop Time to 5000 ns and the maximum step size to 10 ns. This will show us 5 cycles at 100 MHz with 100 time points in each cycle. Note that the simulator will simulate at more points as necessary to maintain accuracy.
- 8. Click the Calculate Now button. This will close the dialog box and run the transient analysis.
- 9. Double-click the newly created Transient1_Data dataset in the workspace tree.
- 10. Right-click on the VPORT variable and select Graph/Rectangular Graph. You should now see a graph similar to the one below.



Note that the output has only small spikes at each transition. This is consistent with our circuit which has a highpass response. Next, we will examine the response of this circuit to a higher frequency pulse:

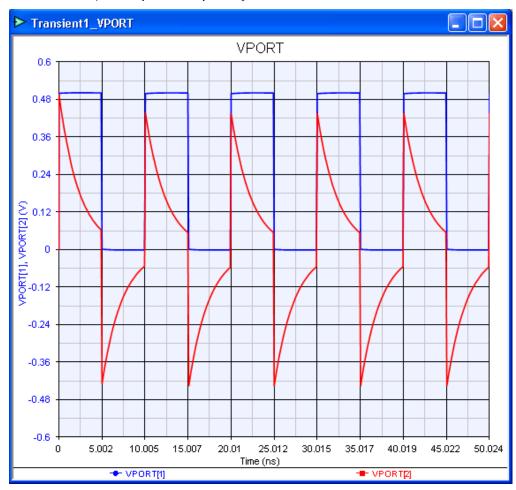
- 1. Change the parameters of the input pulse model on the schematic. Set the pulse width to 5 ns and the Frequency to 100 MHz. Be sure "Use Default" is not checked for the Frequency variable.
- 2. Double-click the Transient1 analysis on the workspace tree.
- 3. Change the Stop Time to 50 ns and the Maximum step size to 1 ns. Note that we are only using 10 points per cycle.
- 4. Click Calculate Now. The VPORT graph has changed to the following:



Note the ragged edges on the square wave. On first glance, it appears that the simulation might not be very accurate. However, these problems are actually caused by the data reduction in the transient simulator. We can actually look at the exact points being simulated instead of simply interpolated results. To do this:

- 1. Double-click the Transient1 analysis on the workspace tree.
- 2. Click on the "Output/Miscellaneous" Tab. Note that "Output Step Size" is set to "Use Maximum Step Size". This means, that, no matter how many points are simulated, we will get evenly spaced points every nanosecond. While this is extremely convenient for many operations (including FFTs), it can sometimes cause one to draw incorrect accuracy conclusions.
- 3. Click and select "Output All Simulated Points". This will not modify the simulation, but it will cause the simulator to output all analyzed time points.

4. Click Calculate Now on the General Tab. You should see the graph below. You can turn on the marker symbols (Click the "Toggle Symbols" button on the graph toolbar) to easily see exactly what points were simulated.



Simulation Time Steps

CAYENNE is a time-stepped transient simulator. The basic flow of the simulator is:

- 1. Solve the circuit at time=0. If Skip Bias is selected, the initial solution at all nodes is zero volts. Othewise, the initial solution is the DC solution.
- 2. Advance the time by an amount determined by the simulator. Note that the entire circuit always uses the same time value.
- 3. Solve the circuit at the new time step, replacing charge-based elements (like capacitors) with equivalent current sources and resistances. If the circuit cannot

- be solved (or the error appears to be too large), then return to the last good time point and go back to step two, taking a different step size.
- If we have reached the next time point needed for output, then save data to the dataset
- 5. Repeat steps two, three, and four until the stop time has passed.

The most important concept is that the time points output in the dataset are NOT the same time points calculated by the simulation. To ensure that the data at the output time points is accurate, CAYENNE simulates at many, many more time points that are not saved. CAYENNE uses the following basic rules to set the internal simulation time steps:

- 1. The first time step is set to the Minimum Time Step. Also, time steps are always at least as large as the Minimum Time Step. This value is specified on the Integration/Time Step tab and defaults to 1% of the Maximum Time Step. Note: The only exception is when the circuit cannot converge due to nonlinearities. In that case, smaller time steps may be used if absolutely necessary.
- 2. The simulation time step will never, under any circumstance, be larger than the Maximum Time Step value as specified on the General tab.
- 3. After a successful initial step, CAYENNE will change the time step as follows:
 - a. If the simulator is using fixed time steps, the step will be doubled until the Maximum Time Step is reached. The Maximum Time Step will then be used for the remainder of the simulation.
 - b. If the simulator is using robust truncation error controlled time steps, then each point will be checked for accuracy BEFORE it is accepted. The accuracy will be checked by comparing the actual answer at every node to the predicted values. If the values are not close enough, then the time point is not accepted, and the time step is repeated with a smaller value. However, if the values do agree (within tolerance), then the time step will be doubled for the next step, up to the Maximum Time Step.
 - c. If the simulator is using approximate truncation error controlled time steps, then simulated points are always accepted (if converged). An accuracy check is then done (using the Truncation Factor and a SPICElike algorithm) which controls the step for the NEXT time point. The further away the solution was from the predicted value, the smaller the next step will be. Again, the step is limited by the minimum and maximum step sizes.
- 4. If numerical precision has caused non-convegence (see the explanation below), then the step size is doubled and the step is repeated. If the step size had already been decreased, then simulation is halted with an error.

Note that all of these rules apply only to simulated time points, not output time points. The output time points (the ones saved into the dataset) are determined from the entries

on the Output/Miscellaneous tab. Using the default settings, data points will be output starting at time=0 and at points separated by the maximum step. To change these defaults, use the following entries:

- Output Step Size is the smallest step output to the dataset. This allows you to output fewer (or more) points than are calculated by the simulator.
- Output Start Time controls when data collection begins. If it is not zero, then no data is saved until that time point is reached. Note that simulation always starts at time zero, no matter what the output start time is set to.
- When Force Output at Exact Step is checked, Cayenne will use the predictor
 (generally third order gear) to interpolate the simulated points to ensure that the
 output waveform is sampled uniformly at exactly the time points requested
 (needed for performing FFT analysis on the output waveform). If this is not
 checked, then Cayenne will output exact values at time points simulated but
 which will vary in spacing.
- Output All Simulated Points outputs every point that the simulator calculated, which can often output ten times more data. This option can be useful when debugging your circuit to determine where the simulator is actually calculating values. Hint: To see these points, graph a response, turn on symbols on the traces, then zoom in to see exactly which points the simulator chose.

Numerical Precision

Cayenne is different from traditional SPICE simulation in one significant way: Cayenne tracks and controls the error in current at each node. Traditional SPICE tracks charge, which is not normally observed by the user. This difference is important when a circuit has a capacitance that is large relative to the time step. To understand the problem, you must first understand how a transient simulator analyzes a circuit with a capacitor. Note: The equations in this section are simple first-order approximations sufficient to allow easy understanding of the issues. In Cayenne, more sophisticated and higher order methods are generally used.

The current through a linear capacitor is governed by the following equation:

$$I = C dV/dt$$

For a simulator using finite steps, this equation can be replaced by a first order approximation:

$$I = C * (V1 - V0) / (T1 - T0)$$

where the time step being used is (T1 - T0), the voltage across a capacitor at time T0 is V0 (known), and the voltage being solved is V1, the voltage across the capacitor at time T1. For this example, use the following values:

V0 = 2 volts

V1 = ?

T0 = 0.1 picosecond (10⁻¹³ seconds)

```
T1 = 0.2 picoseconds
C = 10 microfarad (10^{-5} Farads)
```

The problem is that there are no values between 2 and 2.0000000000000001 that can be stored in a double precision number. Anything closer to 2 will simply round off to exactly 2. As a result, given the time-step of 0.1ps, all solutions will cause the current will be some multiple of 10-8 Amps. If the exact answer (given infinite precision) should be 6*10-9 Amps, then we will never be able to get closer than (10-8 - 6*10-9), or 4*10-9 Amps. If the default precision of 10-12 Amps is used, then convergence will never be obtained. In reality, convergence problems actually will begin occurring if convergence tighter than about 100 times this minimum, or around 10-6 Amps in this example.

Cayenne detects this condition and increases the time step, but sometimes that large time step will cause accuracy errors and Cayenne will throw an error. You have a few choices in this case:

- 1. Increase the current tolerance. Increasing it to a large value will prevent the error and force Cayenne to give an answer similar to traditional SPICE.
- 2. Increase the minimum and maximum time step values. Notice from the equation above that any increase in the time step value causes an corresponding increase in the precision of the current.
- 3. Change the time-step method to fixed (which will always use the max step). If you are forcing very small time steps for output, it may be inappropriate to cause the simulator to take even smaller steps. In the example above, we may have requested output every 10ps, a 100 GHz sampling rate. Using the defaults, the simulator would then take steps as small as every 0.1ps, a 10 THz sampling rate, which is probably excessive.
- 4. Reduce the value of the capacitors or inductors. In the example above, we are sampling at high GHz to THz rates. Decreasing a 10 microfarad capacitor to 10 nanofarads is unlikely to have a significant effect.

Note that SPICE does not directly track current error and will not warn the user if the current is not within a reaonable tolerance. For more details on this subject, see Ken Kundert's book (by Kluwer Academic Publishers), "The Designer's Guide to SPICE and Spectre."

Frequency-dependent Models

Frequency dependent models can cause difficulties for all time domain simulators. Traditional SPICE simulation does not allow any use of frequency dependencies. In later versions and derivations of SPICE, the capability to simulate s-domain devices defined by rational polynomials was added. While these models are good for simple structures like

filters or first-order frequency roll-off effects, they are of little use for much more complicated models typically found in RF and Microwave simulation, such as dispersive and coupled transmission lines, measured s-parameter data, and ideal elements with frequency dependent losses and skin effects.

Even though CAYENNE is a time domain simulator, it has several different strategies for simulating frequency dependent models. The two basic methods are approximate models and convolution. The process CAYENNE uses to setup each element is as follows:

- 1. Determine whether the model is nonlinear, frequency dependent, and/or time dependent.
 - a. Frequency dependent models include:
 - i. Models which use the FREQ variable in equations which define their parameters.
 - ii. Internal models which use frequency in their definitions, such as transmission lines and INDQ/CAPQ (inductor and capacitor with frequency dependent Q.
 - iii. Aggregate models or user models which include either of the above.
 - iv. Frequency domain sources, such as IAC and PAC, are not considered frequency dependent models. These sources all have direct, straightforward time domain equivalents, like v=sin(wt).
 - Charge-dependent elements, such as ideal inductors and capacitors, are not considered frequency dependent.
 CAYENNE can directly simulate models with an impedance or admittance of the form (R + jwX), where R and X are constant an w is the frequency.
 - b. Time dependent models include:
 - i. Models which use the TIME variable in equations which define their parameters.
 - ii. Internal models which use time (or delay) in their definitions. Currently, the only models in this category are nonlinear transistor or Verilog-A models which contain delay.
 - iii. Aggregate models or user models which include either of the above.
 - iv. Time domain sources, such as IPWL and VPULSE, are not considered time dependent models. These sources all have direct, straightforward frequency domain equivalents using Fourier transforms...
 - c. Nonlinear models include elements like diodes and nonlinear transistors (gummel-poon, BSIM, etc.).

- 2. If a model is frequency dependent, but is also either nonlinear or time dependent, CAYENNE gives a warning and ignores the frequency dependency.
- 3. Otherwise, If a model is frequency dependent, CAYENNE checks the response as set in the Convolution tab in the Accuracy Testing section. By default, this does two things:
 - a. If the only frequency dependency is due to loss, and the "Always Use Constant Loss" box is checked, then CAYENNE uses the impedance or admittance at the "Most Accurate Frequency" (specified on the general tab) to calculate equivalents of the form (R+jwX) for all matrix entries for that element. This allows elements like INDQ and CAPQ (plus all elements like WIRE which are based on RLOSS or GLOSS models) to avoid convolution.
 - b. Otherwise, the response for the element is calculated over a range of frequencies as specified the Accuracy Testing section (11 points from DC to twice the "Most Accurate Frequency" by default). If the R and X values for the impedance or admittance in the equivalent of the form (R+jwX) for any matrix entry varies by more than the tolerance (0.01 [1%] by default), then convolution is used. Otherwise, the approimxation accuracy is acceptable, and the (R+jwX) equivalent at the Most Accurate Frequency is used. Note that this approximation can even be used for measured s-parameter data if there is not much variation with frequency. Also note that transmission line responses are never in this form (they are periodic) and must always use convolution.
- 4. If an element needs to use convolution, then the settings in the "Impulse Response" section of the convolution tab are used.
 - a. Independent impulse responses are created for each matrix entry for the element. For a two node element, that will generally be four entries
 - b. For each entry, the minimum number of points is attempted first (128 by default).
 - c. The frequency domain response is calculated from DC to the maximum Frequency.
 - d. An inverse FFT of the data is taken to get the impulse response.
 - e. If any entries in the last half of the impulse response are larger than the Convolution Absolute Truncation or are larger than the Convolution Relative Truncation times the maximum entry in the convolution response, then the accuracy is considered insufficient, the number of points is doubled (up to the maximum), and we go back to step C.
 - f. The convolution response is truncated according to the same criteria from step E. For a simple transmission line, this often results in a single point convolution entry with a delay.

g. If "Save Impulse Responses" is checked, then the impulse responses are saved to the dataset with the name h_modelname_row_column_numpoints.

The Accuracy Testing and Most Accurate Frequency settings are very important and unique features of CAYENNE. These features allow the user to make tradeoffs between accuracy and simulation time, while the default settings give generally acceptable accuracy while avoiding most of the difficulties associated with convolution based simulators. Generally, you should do the following:

- Set the Most Accurate Frequency to the frequency of greatest interest in your circuit, such as an expected oscillation frequency. Remember, the modeling error will be limited to 1% (by default) at other frequencies.
- Turn on "Always use Constant Loss (Not Frequency Dependent Losses)." This setting will use approximate models for INDQ and CAPQ which are otherwise very problematic elements for a convolution simulator since they are non-causal. For these elements, the loss resistance (or admittance) as calculated at the Most Accurate Frequency will be used for the time domain simulation. For example, if you are designing a filter, you should set the Most Accurate Frequency to the center frequency (for bandpass) or cutoff frequency (for lowpass or highpass). The response will be almost unchanged due to the approximation.
- Set the Maximum Frequency for convolution carefully. It must be low enough to capture the delay of your longest transmission line and must be high enough to avoid time step errors:
 - 1/Delay < MaxFreq < MinNumOfPoints/Delay.
 - If the response has unexpected oscillations or noise, set MaxFreq > 0.1/MaxTimeStep.
 - For example, if you have a transmission line with a 0.5 ns delay, plus you need 10 ps resolution (time step), you should set max frequency within: 1/0.5ns < MaxFreq < 128/0.1ns (between 2 GHz and 256 GHz), and greater than 0.1/10ps (greater than 10GHz. The following rule of thumb generally works well: use 10/Delay, which is 20GHz in this example.
 - The convolution Maximum Frequency is generally not very sensitive. The most important thing is to be sure, for example, that it is not set to 100GHz if your circuit is operating in the 10 or 20 MHz range.

Convergence Criteria

CAYENNE has three convergence criteria, all on the General tab: voltage, current, and relative. (We will refer to this as VoltTol, CurrentTol, and RelTol. CurrentTol is sometimes called AbsTol since it is also used for voltage errors.) At each time point, the following steps are used to determine whether or not convergence has been reached:

- 1. Find the maximum contribution for each node type. At standard nodes, this is the largest current from a single element going into the node. In branch currents, this is the maximum voltage. At temerature nodes (as in an LDMOS model), this is the maximum power.
- 2. Next, the error at each node type is calculated. According to Kirchoff's laws, this should be zero. This error must be less than:
 - a. For current error in voltage nodes: CurrentTol + RelTol * MaxCurrent
 - b. For voltage error in branch currents: CurrentTol + RelTol * MaxVoltage
 - c. For power error in temperature nodes: 1e-5 + RelTol * MaxPower
 - d. For other node types defined in Verilog-A: Within tolerances specified in the Verilog-A source.

If these tolerances are not met at all nodes, then the circuit is not converged and iterations continue. Additionally, even if the criteria are met, if the value of the solution at any node changed by more than (VoltTol + RelTol * Value), then iterations continue since significant improvements are still being made.

After convergence has been achieved, the solution is tested for accuracy using criteria defined above in Simulation Time Steps.

Integrator and Predictor

The Integration/Time Step tab controls the operation of the integrator, time step control, and predictor. The integrator is used for all charge-based elements which are not using convolution. By default, the settings are "trapezoidal" for the integrator and third order "Gear" for the predictor.

In general, RF & microwave circuits will simulate with no problems using the default settings. If you have problems with your simulation, the integrator should be the last thing you change after you adjust the time step and convolution settings. If you do change the integrator, you should ensure that the predictor is set to at least one order higher than the integrator. If you set the predictor to "Auto", it will automatically be set to Gear and one order higher than the integrator.

Generally, using a higher order integrator will allow CAYENNE to take larger timesteps and will speed simulation. However, higher order integrators are not as stable and can cause false oscillations, generally growing exponentially with time. If you are going to make a very long simulation, you might want to increase the order of the integrator after first trying a small run to be sure that the simulation is not unstable.

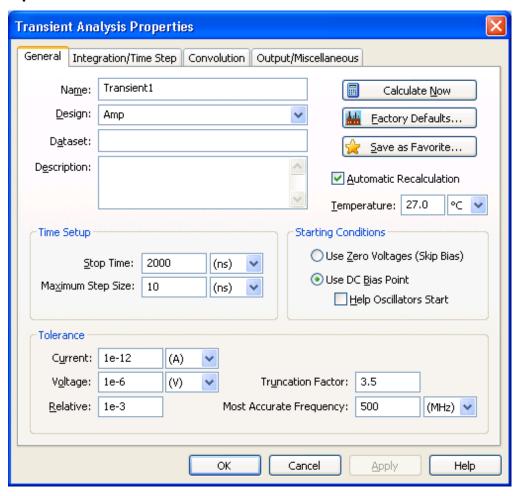
When solving for each time step, CAYENNE must use an initial guess for the solution for that time step. If the predictor is off, then the initial guess is simply the solution at the previous time step. If the predictor is on, then an Nth order polynomial approximation is fit to the previous points (generally using a Gear integrator) and the predicted values at the new time point is used as the initial solution. Generally, using the predictor results in

faster simulation. However, in some highly nonlinear circuits, the predictor can actually hinder convergence. CAYENNE may automatically turn off the predictor if it detects this situation.

In summary:

- Only change integrator settings as a last resort in an attempt to fix simulation problems. One of the problems sometimes fixed by switching to second order gear integration is high frequency ringing.
- If you have a very long simulation to run, try running a piece of it with higher order integration (up to sixth order gear), with the predictor set to Auto, and with the predictor both on and off. Then use the best settings to speed simulation while maintaining accuracy.

Cayenne Options



Time Setup

Simulation always starts at 0 seconds. The stop time tells the much time to simulate. The maximum step size tells the simulator the minimum sampling rate at which to compute the output waveform. The simulator may calculate samples at a higher sampling rate, depending upon the settings in the Integration/Time Step tab.

Starting Conditions

Use Zero Voltages (Skip Bias) assumes an initial condition of zero volts at every node in the circuit, which can be useful to simulate turn-on. Use DC Bias Point runs a DC analysis at time 0 to determine the initial voltages for the circuit. The option to help oscillators start slightly randomizes the initial voltages and is often necessary when analyzing an oscillator, since oscillators rely on start-up transients to oscillate.

Tolerance

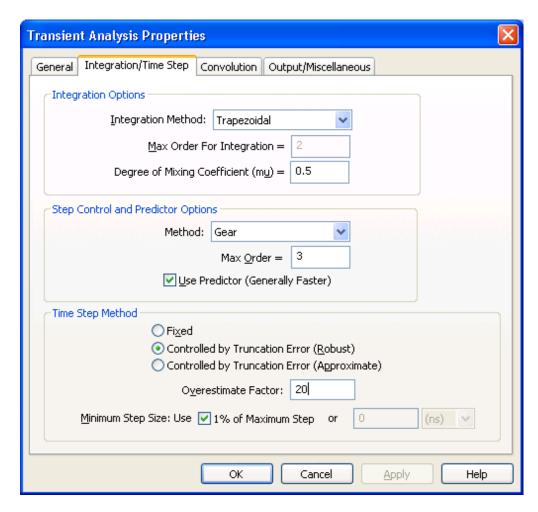
The Current and Voltage tolerance tell the simulator at what precision the iterative algorithms used to solve the circuit equations can terminate.

Most Accurate Frequency

If CAYENNE determines that the accuracy of a frequency-independent model is acceptable, then all models will be exact at this frequency and approximate at all others. The Accuracy Testing section on the Convolution tab sets the accuracy requirements.

Calculate Now

Click this to force CAYENNE to recalculate (and decache models).



Integration Options

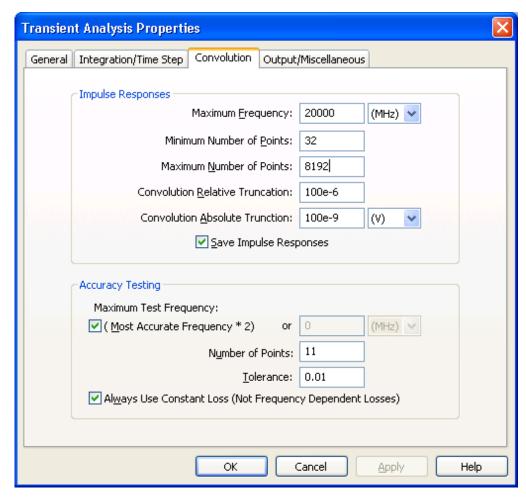
Integration method tells the simulator what method to use for numerical integration. The options available are Trapezoidal and Gear.

Max Order for Integration tells the simulator what order to use for numerical integration for Gear integration. Orders two through six are supported.

Step Control is used to calculate predicted values to determine whether the time step needs to be decreased. If Use Predictor is selected, then these predicted values are also used as the initial guess for the next simulation time point. If Use Predictor is not selected, then values from the previous time step are used as the initial guess.

Time Step Methods: Fixed step mode forces the simulator to always use the maximum step size. **Robust** mode uses a sophisticated test of predicted vs. actual values to determine if the time step needs to be decreased. The Truncation Factor and Relative Tolerance values (on the General tab) are multiplied together to determine acceptable

error. If the error is too large, the solution point is discarded, and a smaller step from the previous solution is used. In **Approximate** mode, if accuracy is not acceptable, then the *next* time step is decreased (no solution is ever discarded).



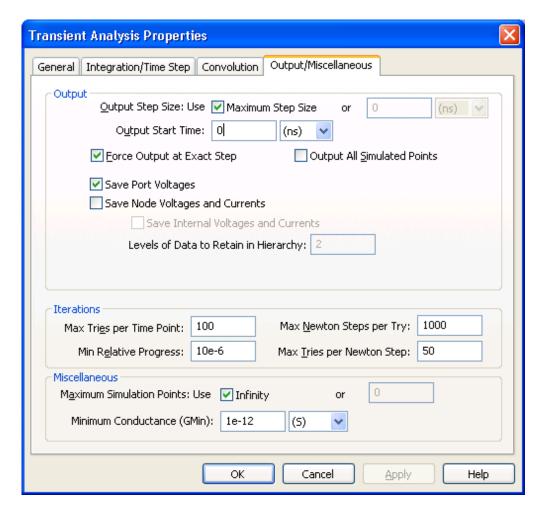
Impulse Responses are used to calculate results when only frequency domain models are available. The maximum frequency should correspond be at frequency where every device needing convolution (like transmission lines) is at least two wavelengths long. An FFT is performed using uniform steps from DC to the maximum frequency. Initially, the minimum number of points is used. If the solution quality is not good enough, the number of points is doubled, up to the maximum specified. The truncation values are used to determine if the solution is acceptable. If, in the second half of the fft impulse waveform the voltage level is above the absolute truncation value, or is (compared to the maximum at any time) relatively larger than the relative truncation, then the solution is not acceptable.

CAYENNE (Transient Analysis)

If Save Impulse Responses is checked, then impulse responses for all convolution-based elements will be saved into the dataset, beginning with the letter H.

Accuracy Testing is used to determine if convolution is necessary. All linear elements are sampled across the specified band using the specified number of points. If the resistance and capacitance (or inductance) for an element do not vary across the band by more than the tolerance amount, then the value at the Most Accurate Frequency (from the General tab) is used for all frequencies. If the variance is greater than the tolerance (typically 1% as shown above), then full convolution is used for that element.

This accuracy test does not generally work as expected for loss resistances, since they are often zero at DC, which would be a 100% error when compared to higher frequencies. The RLOSS and GLOSS models instead switch to a constant resistance/admittance mode if this box is checked. A constant resistance/admittance (as computed at the Most Accurate Frequency) is used instead. Most GENESYS built-in models with loss (such as microstrip viaholes and inductors/capacitors with Q) use the RLOSS models interanally and take advantage of this feature.



Output

Output Step Size is the smallest step output to the dataset. If Output Start Time is not zero, then no data is saved until that time point. (Simulation always starts at time zero). Force Output at Exact Step will use the predictor (generally third order gear) to interpolate the simulated points to ensure that the output waveform is sampled uniformly in time (needed for performing FFT analysis on the output waveform). Output all simulated points outputs every point that the simulator calculated, which can often output ten times more data. See the Simulation Time Steps section above for more details.

If Save Port Voltages is selected, then a VPORT array is created with voltages for each port. This feature works with standard and differential ports.

If Save Node Voltages and Currents is selected, then all node voltages and currents are saved, subject to these limitations: If Save Internal Voltages and Currents is not selected, then internal nodes (for example, inside a transistor) are not saved. Levels of Data specifies how far down in the hierarchy (counting the master level) to save values.

CAYENNE (Transient Analysis)

Iterations sets up details characteristics of the solver and should generally not be modified.

Miscellaneous

Maximum Simulation Points is useful during automated runs or optimizations to ensure that bad value does not cause the simulator to shrink the step size too far and take too long to run. Notice that this is a limitation on simulation points, not output points.

The Mimimum Conductance is added from every node to ground to help convergence and matrix stability within the simulator. In the example above, a 1 teraohm resistor is added from each node to ground.

Chapter 4: DC Analysis

DC Analysis Overview

DC simulation analyzes the static operating points (DC voltages and currents) at each nonlinear node and port in the circuit. When designing circuits using non-linear models, you should always check the DC operating point before doing linear or harmonic balance simulations. DC analysis is very fast and will help to make sure that you have entered a workable design.

Note: DC Simulation is not generally the same as the DC (zero frequency) level from a harmonic balance simulation. In DC simulation, all AC sources are turned off.

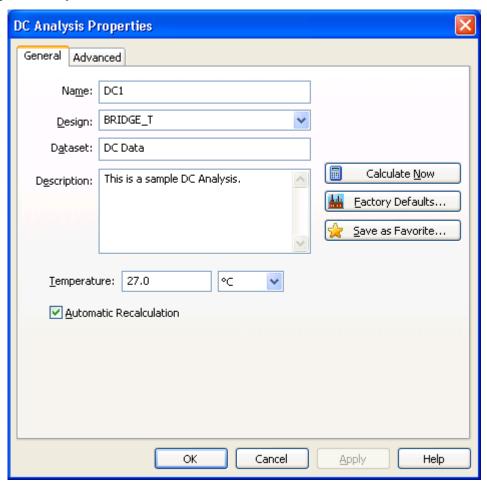
Nonlinear device models have many parameters that can be entered in error. To make sure that the model is correct, it is a good idea to look at the DC characteristic curves of the device before entering a complete circuit. Workspace templates are available (Select New from the File Menu, then use the BJT Test.wsp template) that make it easy to create these curves.

In addition to analysis, DC results can be optimized. For example, you can optimize bias resistor values to achieve a desired collector current and voltage for a bipolar transistor. See the walkthrough DC Analysis - Verifying Transistor Parameters for an example. It is located in one of the following sections.

To add a DC analysis:

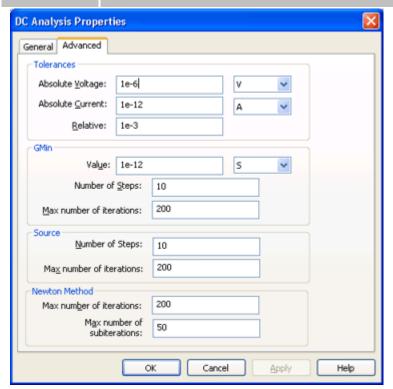
- Create a design with a schematic. Include DC sources and use nonlinear device models. Linear or S-parameter models will generally not produce accurate results at DC.
- 2. Click the New Item button () on the Workspace Tree toolbar and choose "Add DC Analysis" from the Analyses menu.
- 3. Define the Analysis Properties and click **Calculate Now**.
- 4. The original schematic may now show DC voltage levels and a dataset is created that includes DC operating point values.

DC Analysis Properties



Name	Description
Name	Name of Analysis
Design	Design on which the DC Analysis is run

Dataset	Dataset file in which the data is saved. If not specified, the dataset name will be the name of the analysis with "_Data" appended.
Description	Description of the analysis being run. For documentation purposes only, not otherwise used by GENESYS.
Temperature	Ambient temperature at which the DC analysis is performed, specified in the unit of measure chosen from the drop-down menu.
Calculate Now	Runs the analysis, regardless of whether or not any changes were made.
Factory Defaults	Reset all values to their default
Save As Favorite	Close the dialog and establish this set of options as default for the "new" operation. When you add a new DC Analysis it will look just like this one.



The following table shows optional simulation parameters that can be set on the Advanced Tab.

*note - more than one simulation can be added by placing a semicolon between each parameter.

(Ex. gmin=1e-6; reltol=1e-4)

Name		Description
Tolerances. Convergence is achieved if at least one criteria is met at every node.	Absolute Voltage	The absolute accuracy to which the sum of node voltages must sum to zero to achieve DC convergence. The simulator is converged if the magnitude of the vector sum of the voltages entering a given node at a given frequency is less than the specified absolute tolerance. Default value is 1e-6, specified in the unit of measure chosen from the drop-down menu.
	Absolute Current	The absolute accuracy to which the sum of node currents must sum to zero to achieve DC convergence. The simulator is converged if the magnitude of the vector sum of the currents entering a given node at a given frequency is less than the specified absolute tolerance. Default value is 1e-12, specified in the unit of measure chosen from the drop-down menu.
	Relative	The relative accuracy to which the sum of node currents must sum to zero to achieve DC convergence. The simulator is converged if the ratio of the vector sum of the currents into a given node currents to the sum of magnitudes of the current entering that node is less than the specified relative tolerance. Default value is 1e-3.
Gmin	Value	The value of conductances added to each nonlinear node in the circuit. The default is a 1 pico-siemens conductance (1 teraohm resistor) between each node in the circuit and ground to assist with convergence. Specified in the unit of measure chosen from the drop-down menu.
	Number of Steps	The maximum number of Gmin steps used during DC analysis. These steps are used if there are convergence difficulties using the nominal value. Default value is 10.

	Max Number of Iterations	The maximum number of iterations performed. The analysis will iterate until it converges, an error occurs, or this limit is reached.
Source	Number of Steps	The maximum number of amplitude steps used in DC analyses. When having difficulty finding DC convergence, the amplitude of independent sources in the circuit will be raised slowly from zero. Default value is 10.
	Max Number of Iterations	The maximum number of iterations performed. The analysis will iterate until it converges, an error occurs, or this limit is reached.
Newton Method	Max Number of Iterations	The maximum number of iterations of the Newton method process that terminates when the sum of the currents into each node equals zero at each node, and the node voltages converge. Default value is 200.
	Max Number of Subiterations	The maximum number of subiterations within each iteration of the Newton method process that terminates when the sum of the currents into each node equals zero at each node, and the node voltages converge. Default value is 50.

DC Analysis Output

DC simulation produces the following variables:

Variable	Description
Vnet	DC voltage at net
RHSerror	Final error of simulation. Generally only used for advanced troubleshooting.
Tnet	Temperature at net. Only available for certain transistors (such as LDMOS) which include a temperature output.
Ibranch	Current through an internal branch, such as in an inductor
IpartIProbe	Where part is a current probe, contains the current through the probe. If the part is in a subnetwork, it will contain

the name of the network container part.

Chapter 5: EMPOWER: Planar 3D EM Analysis

EMPOWER: Basics

Overview

A major part of any electromagnetic simulation is to break the problem down into manageable size pieces that allow an approximation of Maxwell's equations to be solved. Electromagnetic simulators traditionally fall into three major categories: 2-D, 3-D, and 2-1/2-D.

2-D SIMULATORS

2-D simulators can only analyze problems that are infinitely continuous in one direction. Ideal transmission lines and some waveguide problems are practical problems which fall into this category. A 2-D simulator will analyze a slice of the line(s) and determine propagation, impedance, and coupling values. 2-D simulators are the fastest but most limited type of simulator available.

3-D SIMULATORS

3-D simulators can analyze virtually any type of problem and are ideal for use with non-planar geometries such as a coaxial T-junction, radar target reflections, or other truly three dimensional problems. 3-D simulators have the advantage that they can analyze almost any problem, but they have the disadvantage that they are extremely slow.

21/2-D SIMULATORS

2 1/2-D Simulators are simulators designed for mainly planar (microstrip, stripline, etc.) circuits. While they have less flexibility than true 3-D simulators, they are much faster and are ideally suited for microstrip, stripline, and other similar geometries. EMPOWER is an advanced 2 1/2-D simulator. It can solve planar problems as well as problems with via holes and other z-directed currents, putting it in a class above true 2 1/2-D simulators which do not allow z-directed currents. In fact, most people would consider EMPOWER to be a 3-D simulator because it can handle z-directed currents.

Features

EMPOWER incorporates many features still not present in competitive, late generation, EM simulators. Principle features include:

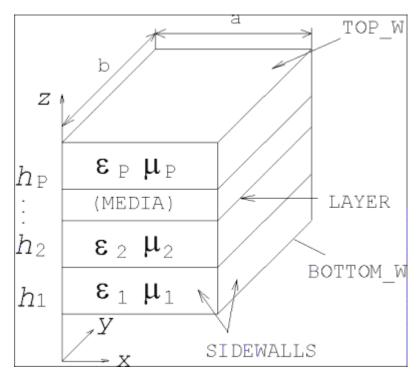
- Benchmarked accuracy
- Easy to use graphical circuit layout editor
- Complete integration with the GENESYS circuit simulation, synthesis and layout tools

Simulation

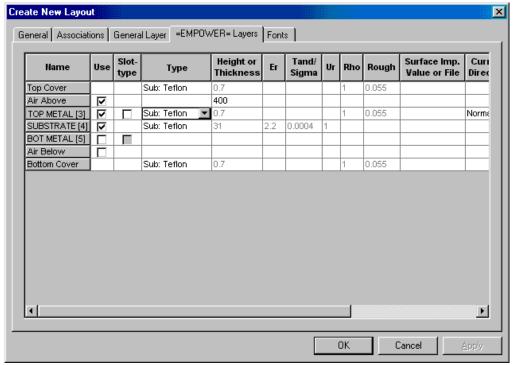
- Multilayer simulations (with EMPOWER ML)
- Automatic incorporation of lumped elements
- Automatic detection and solution with symmetry
- Generalized S-parameter support
- Multi-mode support for ports and lines
- Tuning of EM objects in GENESYS using decomposition
- Deembedded or non-deembedded ports
- Viaholes including generated fields
- Any number of dielectric layers
- Dielectric and metal loss
- Includes box modes and package effects
- Slot-mode for slot and coplanar circuits
- Thick metal simulation (with EMPOWER ML)
- 32-bit code for Windows 95/98/NT/XP

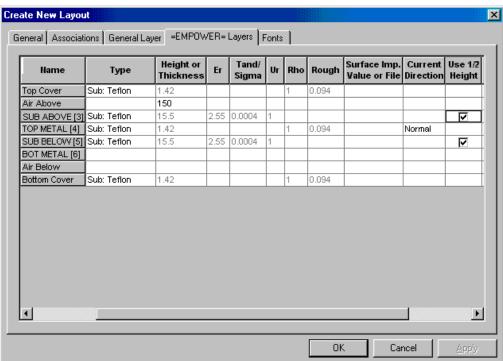
Basic Geometry

All circuits in EMPOWER exist in a rectangular box as shown below. The Media (substrate) layers each have specific dielectric and permittivity constants and loss tangents. There must be at least two media layers: One above the metalization layer and one below. For standard microstrip, there is a substrate below and air above. For suspended microstrip, there are three media layers (two air and one substrate). For buried microstrip, there are also three media layers (two substrate and one air).



The dialogs below show two typical EMPOWER Layer Tab setups: one for microstrip and one for stripline (triplate). The EMPOWER Layer Tab must be carefully checked when a new problem is created, as it is probably the most likely source of errors when setting up an EMPOWER run.





The EMPOWER Layer Tab consists of the following main entries:

Top Cover and **Bottom Cover** - Describes the top and bottom covers (ground planes) of the circuit:

- Lossless: The cover is ideal metal.
- Physical Desc: The cover is lossy. These losses are described by Rho (resistivity relative to copper), Thickness, and Surface Roughness.
- Electrical Desc: The cover is lossy and is described by an impedance or file. See the description below under metal for more information.
- Semi-Infinite Waveguide: There is no cover, and the circuit is simulated as if the box walls and uppermost substrate/air layer extend up or down forever (an infinite tube).
- Magnetic Wall: The cover is an ideal magnetic wall. This setting is only used in advanced applications.
- Substrates: Choosing a substrate causes the cover to get the rho, thickness, and roughness parameters from that substrate definition. We recommend using this setting whenever possible so that parameters do not need to be duplicated.

Air Above and **Air Below** - The presence of air at the top of the box (as in microstrip) or the bottom of the box (as in suspended microstrip) is so common that special entries have been provided for these cases. Checking the box to turn these layers on is the equivalent of adding a substrate layer with Er=1, Ur=1, and Height (in units specified in the Dimensions tab) as specified.

Caution: When setting up a new circuit, be sure to check the height of the air above, as it is often the only parameter on this tab which must be changed, and is therefore easily forgotten.

Metal Layers - In LAYOUT, multiple METAL layers (e.g., copper and resistive film) are automatically converted to one EMPOWER signal layer if no media layer is in between the metal layers.

All metal layers from the General Layer Tab are also shown in the EMPOWER Layer tab. These layers are used for metal and other conductive material such as resistive film. The following types are available:

- **Lossless**: The layer is ideal metal.
- Physical Desc: The layer is lossy. These losses are described by Rho (resistivity relative to copper), Thickness, and Surface Roughness.
- **Electrical Desc**: The layer is lossy and is described by an impedance or file. This type is commonly used for resistive films and superconductors. If the entry in this box is a number, it specifies the impedance of the material in ohms per square. If the entry in this box is a filename, it specifies the name of a one-port data file which contains impedance data versus frequency. This data file will be

- interpolated/extrapolated as necessary. See the Reference manual for a description of one-port data files.
- **Substrates**: Choosing a substrate causes the layer to get the rho, thickness, and roughness parameters from that substrate definition. We recommend using this setting whenever possible so that parameters do not need to be duplicated.

Caution: Thickness is only used for calculation of losses. It is not otherwise used, and all strips are calculated as if they are infinitely thin.

Metal layers have three additional settings available:

Slot Type - Check this box to simulate the non-lossless-metal areas (as opposed to the metal areas) in EMPOWER. Use this for ground-planes and other layers which are primarily metal. Do not use this for lossy layers. See your EMPOWER manual for details.

Current Direction - Specifies which direction the current flows in this layer. The default is along X and Y. "X Only" and "Y Only" can be used to save times on long stretches of uniform lines. "Z Up", "Z Down", "XYZ Up", and "XYZ Down" allow the creation of thick metal going up/down to the next level or cover.

Thick Metal - Checking this box forces EMPOWER to model the metal including thickness. EMPOWER does this by putting two metal layers close together, duplicating the traces on each, and connecting them with z-directed currents. If thick metal is used, then Current Direction is ignored.

Element Z-Ports - This setting specifies the default direction for automatically created element ports, either to the level above or to the level below. Generally, you should choose the electrically shortest path for this direction.

Substrate/Media Layers - All substrate layers from the General Layer Tab are also shown in the EMPOWER Layer tab. These layers are used for substrate and other continuous materials such as absorbers inside the top cover. An unlimited number of substrate/media layers can be used. The following types are available:

- Physical Desc: The layer is lossy. These losses are described by Height (in units specified in the Dimensions tab), Er (relative dielectric constant), Ur (relative permittivity constant, normally 1), and Tand (Loss Tangent).
- Substrates: Choosing a substrate causes the cover to get the height, Er, Ur, and Tand parameters from that substrate definition. We recommend using this setting whenever possible so that parameters do not need to be duplicated.

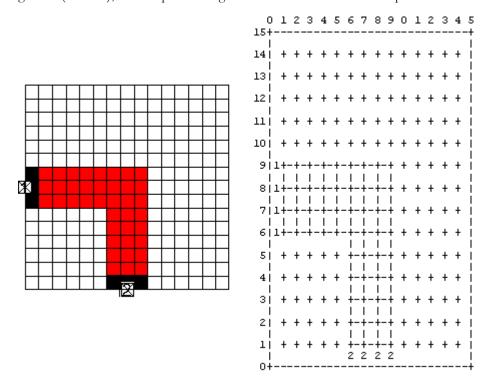
Caution: For true stripline (triplate), be sure to check the "Use 1/2 Height" checkbox if you are using a substrate. This forces EMPOWER to use 1/2 of the substrate height for each substrate (above and below) so that the total height for both media layers is correct.

In addition to the metalization and substrate layers, viaholes and other z-directed currents can be used. These currents can go from the metalization layer through one media/air layer to either the top or bottom walls.

Besides conductive materials, ports are placed on the metal layers and in z-directed positions.

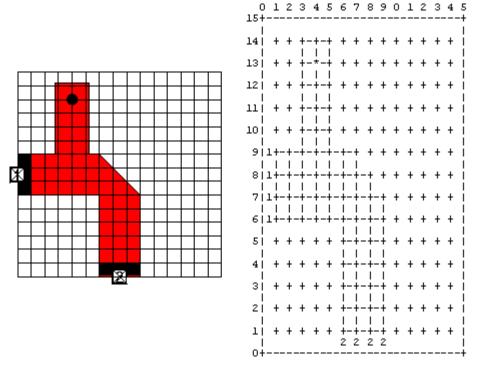
The Grid

All conductive surfaces and ports must be on a grid. This grid is composed of regular rectangular cells. An example of mapping a microstrip bend to the grid is shown below. The left half of the figure shows the circuit as it appears in LAYOUT. The right half of the circuit shows a part of the EMPOWER listing file. Each of the plus signs ("+") in the listing file represents an intersection of two grid lines as shown on the layout. Lines connecting plus signs represent metal. Numbers represent port locations. Notice that the ports map onto the grid in place of metal, so the ports go between the end of the line and ground (the wall), so each port has a ground reference as would be expected.

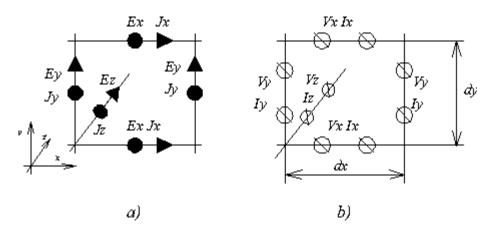


EMPOWER will move all surfaces to the nearest grid cell before analyzing a circuit. EMPOWER maps the structure onto the borders of the cell, not onto the space inside the cell. A slightly more complex example which does not exactly fit the grid is shown below. There are three important things to notice in this figure: 1) The stub line going up is about 2 1/2 cells wide, but is approximated by EMPOWER as being 2 cells wide. 2) The

chamfered corner is approximated by a "stairstep." 3) The viahole near the end of the stub is represented by an asterisk in the listing.

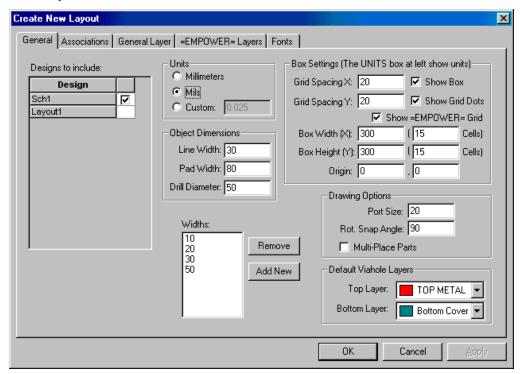


A close-up is shown below where you can see how metal and ports are mapped onto the borders of the cells. The presence of metal or conductors along the grid causes EMPOWER to close the connections along the grid. The presence of an EMPort causes the line to be opened, creating an open circuit which turns into a port in the final data file.



Note: It is possible to make a line so narrow that it maps to one border between cells (zero cells wide). This is legal, but is not normally recommended and should be used only for very high impedance lines where accuracy is not important, such as DC power lines.

The grid and the box are controlled with parameters in the Preferences box from the LAYOUT File menu. The Dimensions Tab shown below is as it was setup for the microstrip bend above.



The following entries are especially relevant to EMPOWER:

Show EMPOWER Grid - Turning on this checkbox forces LAYOUT to display the rectangular EMPOWER grid. It also allows different grid spacings in the X and Y dimensions. It is strongly recommended to turn this checkbox on whenever you are creating a layout for EMPOWER.

Grid Spacing X and Grid Spacing Y - These control the cell size for the EMPOWER run as well as the grid snap feature in LAYOUT. When using the "EMPOWER Grid Style," there will be LAYOUT snap points between each grid line which allow lines to be centered between two grid points if necessary. They are often referred to as *dx* and *dy* and should be small with respect to a wavelength at the maximum frequency to be analyzed, preferably less than wavelength/20 and always less than wavelength/10.

<u>Box Width</u> and <u>Box Height</u> - These are the box size for EMPOWER simulation. They correspond directly to the SIZE statement in the TPL file. The number of cells across the

box (equal to Width or Height divided by Grid Spacing X or Y) is displayed for your convenience and can be changed to adjust the page width. Note: Any metal put down completely outside the box will be ignored by EMPOWER. This can be used to your advantage to temporarily or permanently remove metal or components from the EMPOWER simulation.

<u>Default Viahole Layers</u> - The Start Layer and End Layer combo boxes control the default layers for the viaholes. These can be overridden individually for each viahole.

Viaholes and Z-Directed Ports

The grid in EMPOWER is a truly three dimensional grid (rectangular lattice). Z-Directed currents and ports are mapped from the intersection points to the top or bottom cover. There are two caveats: metal and ports in the z-direction are modeled as one continuous current, so the viaholes should be small in comparison with a wavelength. Also, you cannot have both a port and metal along the same grid line, so you should be extremely careful when placing a viahole directly underneath an internal port. You should check the listing file (select "Show Listing File" from the EMPOWER simulation right-click menu) carefully to see that both the port and the viahole are represented on the grid.

The physical length of a viahole in a substrate should be kept shorter than about 1/10 to 1/20 wavelength within the analysis range. Longer lengths can suffer calculation inaccuracies in EMPOWER. For example, suppose a microstrip circuit with a 10 mil substrate and a dielectric constant of 2.4 is to be used. What is the highest accurate frequency for this setup?

Note: If the substrate layer is broken down into two substrate layers (by adding an additional layer), each 1/2 the height of the original, then the viaholes will be accurate at twice the original frequency. This procedure can be repeated as necessary.

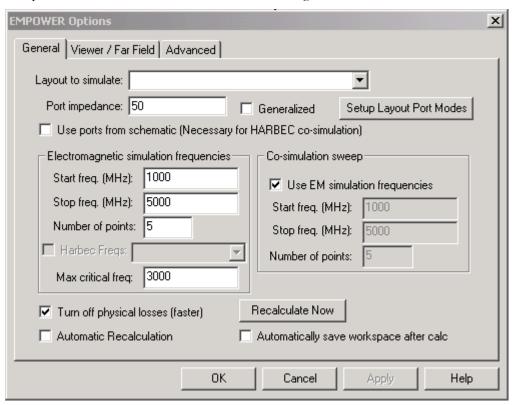
$$\begin{split} & \epsilon_0 = 8.8542 \times 10^{-12} \quad \text{F/m} \\ & \mu_0 = 1.2566 \times 10^{-6} \quad \text{H/m} \\ & c = \frac{1}{\sqrt{\epsilon_r \epsilon_0 \mu_0}} = \frac{1}{\sqrt{2.4 \epsilon_0 \mu_0}} = 1.935 \times 10^8 \quad \text{M/s} \\ & \frac{\lambda}{15} = 10 \text{ mils} = 2.54 \times 10^{-4} \quad m \Rightarrow \lambda = 3.81 \times 10^{-3} \quad m \\ & f_{\text{max}} = \frac{c}{\lambda} = \frac{1.935 \times 10^8 \quad \text{M/s}}{3.81 \times 10^{-3} \quad m} \approx 50 \quad \text{GHz} \end{split}$$

EM Ports

All circuits must contain at least one EMPort to allow data to be taken from the EMPOWER simulation. The number of ports is equal to the number of ports in the EMPOWER network to be analyzed. They are placed in the layout using the EMPort button and can be Normal deembedded external ports (gray), external ports with No Deembedding (white), or internal ports (white). External Ports and Lumped Elements and Internal Ports are discussed in their respective sections.

EMPOWER Options

To open: double-click or create a Planar 3D Electromagnetic Simuation.



General Tab

Layout to Simulate - Allows you to select which layout in the current workspace to simulate. Since workspaces can have multiple layouts and multiple EMPOWER simulations, you can simulate many different layouts within the same workspace.

Port Impedance - When EMPOWER S-Parameter data is plotted on a graph, it will be normalized to this impedance. Different impedances can be used for each port by separating impedances with commas. A 1-Port Device Data File can be used in place of any impedance file to specify frequency dependent or complex port impedances.

Generalized - When this box is checked, the impedance for each line as calculated by EMPOWER are used for their terminating impedance. See your EMPOWER manual for details on Generalized S-Parameters.

Use ports from schematic - Check this box when co-simulating with HARBEC harmonic balance nonlinear simulation. This forces all sources and impedances to be considered in the simulation.

Note: Be sure to check "Use ports from schematic" if you will be using this simulation as the basis for a HARBEC Simulation, otherwise there will be no nonlinear sources available.

Electromagnetic Simulation Frequencies - Specifies the frequencies at which to run EMPOWER. If you have lumped elements in your simulation, you can often turn down the number of frequencies here and increase the number of frequencies in the Cosimulation sweep specified below.

Start Freq (MHz) - Specifies the minimum frequency to analyze.

Stop Freq (MHz) - Specifies the maximum frequency to analyze.

Number of Points - Specifies the number of frequency points to analyze. Points are distributed linearly between the low and high freq specified above.

HARBEC Freqs - Select this box to cause EMPOWER to simulate the layout at each frequency calculated by the harmonic balance simulator. Checking this box makes sure that EM results are available at all frequencies so that the data will not need to be interpolated or extrapolated for harmonic balance analysis.

Max Critical Freq (MHz) - Specifies the highest important frequency that will be analyzed on any run of this circuit. MAXFRQ is specified in the units defined in the DIM block. (The default units are MHz.) Parameters of the solution quality, thinning out thresholds, and lengths of lines for de-embedding are based on the maximum critical frequency value. In other words, this value influences both accuracy of simulation and calculation time. Decreasing the value accelerates simulation but may increase model error, especially at frequencies above the value, On the other hand, an unnecessarily high value may slow down the solution without visible improvements in accuracy.

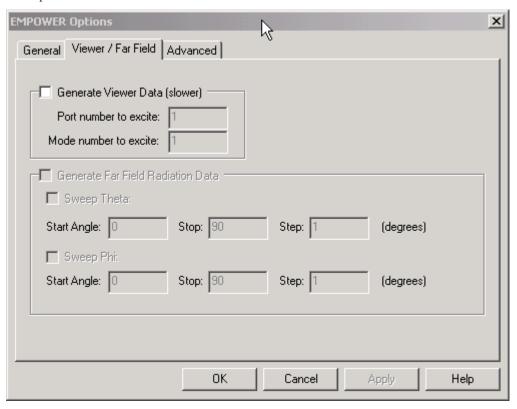
Note: An important reason to specify MAXFRQ: By default this value is set equal to the highest sweep frequency specified in EMFRQ. Even a small change of its value may cause the grid to change, forcing recalculation of de-embedding parameters and unnecessarily increasing simulation time as a consequence, This change will also change the answer slightly, with disastrous results if you are merging data. This will not happen if you use MAXFRQ. It is also important to remember to update it if you change the frequency range substantially.

Co-Simulation Sweep - Specifies the frequencies at which to run simulate the lumped elements + EMPOWER data combination. If you have no lumped elements in your simulation, you should normally check the "Use EM Simulation Frequencies" box. For circuits with lumped elements, you can often save much time by using fewer points in the

electromagnetic simulation frequencies above, allowing the co-simulation to interpolate the EMPOWER data *before* the lumped elements are added.

Turn off physical losses (Faster) - If checked, EMPOWER will ignore any losses specified in the EMPOWER Layer tab. This option is very useful to speed up any preliminary runs.

Automatically save workspace after calc - This checkbox is handy for overnight runs to help protect against a power outage. Note that checking this box will force the *entire* workspace to be saved after each run.



Viewer / Far Field Tab

Generate Viewer Data (Slower) - Checking this box causes EMPOWER to generate a *.EMV file that can be loaded in the EMPOWER current/voltage viewer program. Selecting this box will increase the amount of time required to solve the problem. This box must also be checked in order to generate far field radiation data. See the Viewer section for more information.

Port number to excite - This option is available if "Generate viewer data" above is checked. It specifies which EMport to excite for viewer data. By default, mode one is excited, but if the input is multi-mode, then you can add the option -Imj to excite mode j instead.

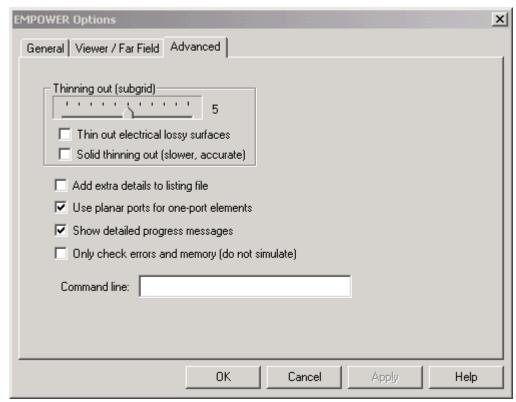
Simulation

Mode number to excite - This option is available if "Generate viewer data" above is checked. It specifies which mode to excite for viewer data. Generally, mode one is excited, but if the input is multi-mode, then you can add excite any mode number up to the number of modes at that input.

Generate Far Field Radiation Data - Checking this box causes EMPOWER to generate data for the radiated electric fields of a structure in the far field region. The data generated is specified by the sweeping theta and phi coordinates of the spherical coordinate system.

Sweep Theta - This option is available if "Generate Far Field Data" above is checked. It generates data for varying theta in the spherical coordinate system. Theta is the angle formed from the z-axis to a point in 3-space. If "Sweep Theta" is unchecked, a fixed-angle will be specified, and far-field data will be produced only at this theta angle.

Sweep Phi - This option is available if "Generate Far Field Data" above is checked. It generates data for varying phi in the spherical coordinate system. Phi is the angle formed from the positive x-axis to a point projected on the xy plane in 3-space. If "Sweep Phi" is unchecked, a fixed-angle will be specified, and far-field data will be produced only at this phi angle.



Advanced Tab

Only check errors, topology, and memory (do not simulate) - Useful to make sure you have the simulation and layout setup properly before a long EMPOWER run. This option provides a very important means both for checking the grid mapping and required memory. EMPOWER just maps the problem onto the grid and calculates the required number of the grid variables for each frequency. Check the "map of terminals" in the listing file to see the grid model of the problem and check the MEMORY lines in the listing file to get some idea about problem complexity and probable simulation time.

Setup Layout Port Modes - Brings up the multi-mode setup dialog box as described in the Decomposition section of your EMPOWER manual. If this button has exclamation points on it, then multi-mode lines are active.

Thinning out (slider) - Control the amount of thinning. The default thinning out amount is 5. Setting the slider to zero turns off thinning. See your EMPOWER manual for details on thinning.

Thin out electrical lossy surfaces - If checked, lossy metal described using electrical parameters will also be thinned. Since the thinning out model assumes that most current flows on the edges of the lines, this option will be somewhat less accurate for resistive films (where current flows more evenly throughout the material). In these cases, you should probably also check the Solid thinning option shown below.

Solid Thinning out (slower) - If checked, slower solid thinning out model is used. This model restores capacitance lost due to thinning out and can be most useful for when large sections of metal have been thinned out.

Use planar ports for one-port elements - This box should almost always be checked. When not checked, EMPOWER uses z-directed ports at each terminal for all devices. When it is checked, EMPOWER uses in-line ports for elements like resistors and capacitors (two-terminal, one-port devices). The only time this can cause a problem is when you have a line running "under" an element (for example, running a line between the two terminals on a resistor, in the same metal layer as the resistor pads).

Note: EMPOWER planar ports cannot be used for ground referenced elements, such as transmission lines, even though the element might only have terminals.

Add extra details to listing file - If checked, extra information which can be used to double-check your setup is inserted into the listing file.

Show detailed progress messages - Turning this option off suppresses almost all output in the EMPOWER log. (The listing file is not affected.) Turning it off can dramatically speed up very small runs.

Command Line - Some options are available which are not shown on this dialog box. One common example is the -On option which controls the size of the box for line analysis.

<u>-NC</u> - If this option is used, EMPOWER will allow de-embedded ports to be away from the wall. This option is especially useful for finline and slotline configurations.

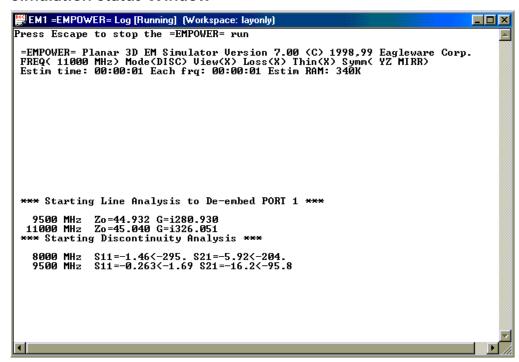
<u>-VM</u> - Allow virtual memory usage. To solve a complex problem, EMPOWER always limits usage of computer virtual memory (hard disk space) in a rational way. It will not use it for some numerically intensive parts of the simulation. The option VM tells EMPOWER to use virtual memory more freely. But even with this option, the program stops calculations if substantial hard disk space is involved in some parts of the simulation. Check the MEMORY lines in the listing file to have an idea how much memory your computer lacks or how to reduce the problem.

<u>-Sg</u> - Use an alternate method of thinning out, "Global" thinning. Can reduce memory requirements under some circumstances.

<u>-On</u> - Use a smaller line segment (*n* times smaller) for de-embedding calculations. Can speed up line analysis.

<u>-IT</u> - Output viewer data file in text format (.PLX).

Simulation Status Window



The window above is shown when EMPOWER is running.

The objects on the second line are:

FREQ - The current calculation frequency.

Mode - DISC (discontinuity), LINE (line analysis), or LN+D (both).

View - Checked if viewer data is to be generated.

Loss - Checked if physical loss is being modeled.

Thin - Checked if thinning is enabled.

Symm - Displays the type of symmetry possessed by the circuit being analyzed. This option can be XZ, YZ, Mirror, 2-way mirror, or 1800 rotational.

The objects on the third line are:

Estim Time - The estimated total time to complete the current calculation mode.

Each frq - The estimated calculation time per frequency in the current mode.

Estim RAM - The estimated total memory required for the current simulation.

The fourth line displays the simulation time of the current frequency and symmetry, plus the symmetry stage.

The fifth line displays the calculation stage.

The lines below the fifth line describe the calculated data for each frequency. During line analysis, the impedance (Z) and propagation constant (G) are displayed for each frequency. In the discontinuity calculation mode, the first row of the s-matrix is displayed at each frequency.

Batch Runs

Multiple workspaces can be loaded simultaneously and all EMPOWER simulations can be updated sequentially. Simply open as many Workspace files as you need (Select Options from the Tools menu and check "Allow Multiple Open Workspaces"). Click the red Calculator button on the toolbar to run all of the analyses.

Note: You should check "Automatically save workspace after calc" if you are running long or overnight batches, so that if there is a power outage, you will not lose your results.

EMPOWER: Operation

Overview

An EMPOWER simulation requires a board layout description. The easiest (and recommended) method is to use LAYOUT to create a graphical representation of the desired layout pattern. The board can then be simulated by creating an EMPOWER Simulation.

This chapter describes how to use LAYOUT to construct a board layout and obtain an EMPOWER simulation. GENESYS is then used to display and compare the linear simulation with the EMPOWER data.

Examples

The examples are completely contained in the EXAMPLES manual. Examples which illustrate EMPOWER include:

- Microstrip Line.WSP
- Stripline Standard.WSP
- Spiral Inductor 2.WSP
- Box Modes.WSP
- Film Atten.WSP
- Edge Coupler.WSP
- Dual Mode.WSP
- 8 Way.WSP
- Edge Coupled.WSP
- Coupled Stepped Z.WSP
- Tuned Bandpass.WSP
- Patch Antenna Impedance.WSP

The required RAM specified in the Examples manual is the value estimated by EMPOWER. They are approximate and are determined by algorithm rather than a test of memory used. The execution times are for a 266 MHz Pentium II with 256Mbytes of RAM operating under Windows 98. In most cases execution time is for the discontinuity mode.

Creating a Layout Without a Schematic

The completed file for this walkthrough is the GENESYS Examples folder: EMPOWER\Layout Only.wsx.

This example demonstrates the following topics:

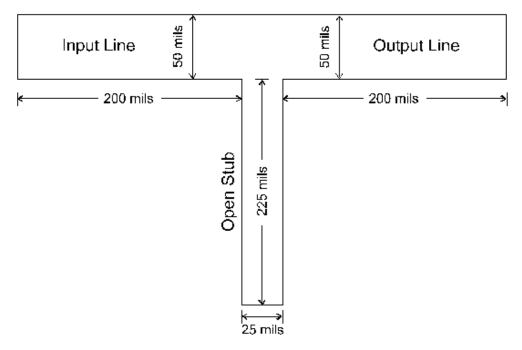
- Creating a layout without a schematic
- Choosing grid spacings
- Choosing the box size

A microstrip stub notch filter with a transmission zero at 9.5 GHz is to be simulated. The filter has the following specifications:

- 15 mil RT/Duroid substrate (er=2.2, tan d=0.0009)
- Copper metalization
- 50 Ohm terminations

• The stub line should be 70 W and 90° at 9.5 GHz

The series lines and the stub dimensions were calculated using T/LINE, and were rounded to the nearest 5 mil increment. The final line dimensions are shown below.



Note: Before beginning this example, you should be sure your Workspace Window is visible. Select Docking Windows\Workspace Window from the View menu if necessary.

To begin, select New from the GENESYS File menu. Since we do not need a schematic for this circuit, we will delete the schematic: In the workspace window, Right-click on "Sch1 (Schematic)" and select Delete. Next, we will create a layout. Click on the New Item button in the workspace window and select Designs/Add Design with a Layout. Enter "Stub" for the design name.

Note: For all dialog boxes, be sure that your entries are exactly like the ones shown in the figures.

Creating a Layout

A board layout can be created one of two ways:

- By starting without a schematic
- By starting from an existing schematic

Simulation

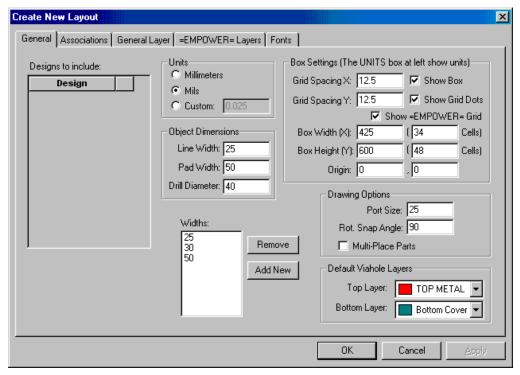
The first method starts in the GENESYS Environment by creating a layout without an associated schematic. The layout is created by drawing lines and placing footprints in the LAYOUT editor.

The second method begins in with a schematic and creates a board layout based on the schematic objects. This method is normally used when a linear simulation (using GENESYS) has been performed on a schematic and an EMPOWER simulation is desired, or when any lumped elements are needed in the EMPOWER Simulation. In addition to the schematic objects, any desired LAYOUT objects can be added to the board before simulation. For example, linear simulation would normally not include ground pours, power supply rails, and lumped element pads. However, these are included in the EMPOWER run, allowing inspection of their effects.

Box Dimensions

Note: In EMPOWER, the layout's box dimensions are used to define the bounding box.

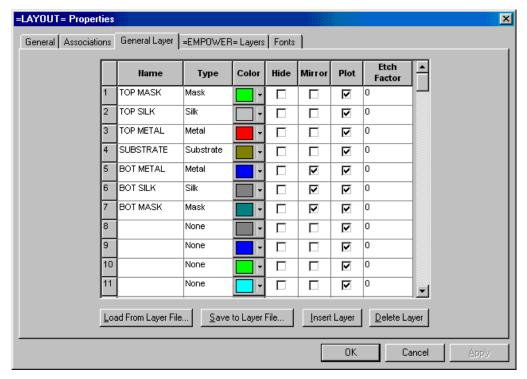
Double-click on the layout to open the "LAYOUT Properties" dialog box. The box dimensions are shown below. Box Width was chosen as 425, the width of the filter since there are two 200 mil lines and a stub width of 25 mils. The filter height is 275 mils, including the stub length and series line width. The box height was chosen as 600 mils to give plenty of spacing on either side of the filter. This minimizes wall interference in the filter's frequency response.



The EMPOWER grid settings for this example are shown in the upper right above. EMPOWER simulation time is greatly reduced if dimensions are chosen so that metal lies exactly on as large a grid size as possible. The grid width and height settings for this filter were chosen as 12.5, since the filter dimensions (425x275) are exactly divisible by this value.

General Layers

The general layer settings for this example are shown below. Click on the General Layer tab in the LAYOUT Properties dialog box.



Only three layers had to be defined for this filter:

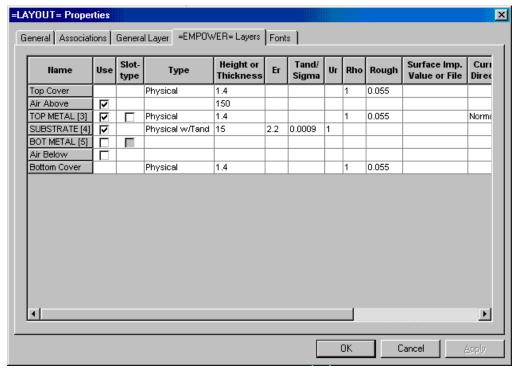
- Top Metal
- Substrate
- Bottom Metal

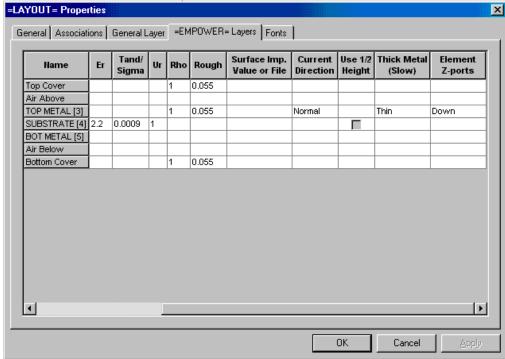
These are the only layers that are needed to simulate the microstrip filter. For a general layout, more layers are often included for purposes only. For example, defining a silk screen or mask layer would not affect simulation since none of the filter metal is placed on those layers.

Note: Since the bottom of the box will be used as a ground plane, the bottom metal layer defined above is not technically necessary. However, since it is often necessary for manufacturing reasons, it is normally defined here.

EMPOWER Layers

Next, click on the EMPOWER Layers tab. The EMPOWER layers are automatically selected from the available general layers (see the previous section). They are chosen from the available metal and substrate layers, and can be enabled or disabled for EMPOWER simulation.





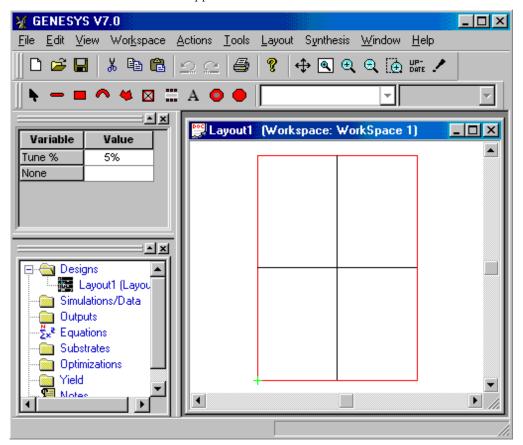
Simulation

Since Air layers above and below a substrate are so common, a special option has been given here to add them. For more information on the individual layer options, see the EMPOWER Basics section.

Notice that BOT METAL and Air Below are not enabled. This places the box bottom at the lower substrate boundary so that it acts as a ground plane.

Note: In almost all cases where a completely solid ground plane is used, you should use the top or bottom cover to simulate it. This is much more efficient than using an extra metal layer.

Click OK. The LAYOUT editor appears. The screen should look like similar to:



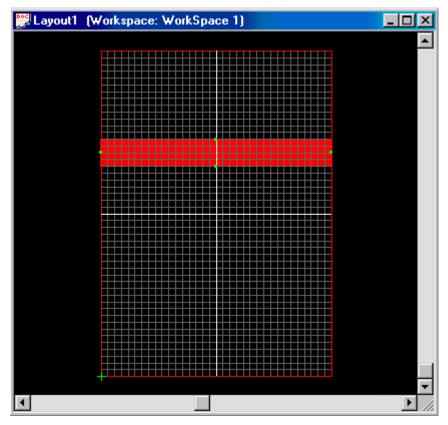
Drawing the Layout

To draw the series line:

1. Select the Rectangle button from the LAYOUT toolbar (the sixth button on the toolbar).

- 2. Click on the left edge of the page border, and drag toward the right and down until the status bar (bottom of the screen) shows DX=425 and DY=50.
- 3. Release the mouse button.

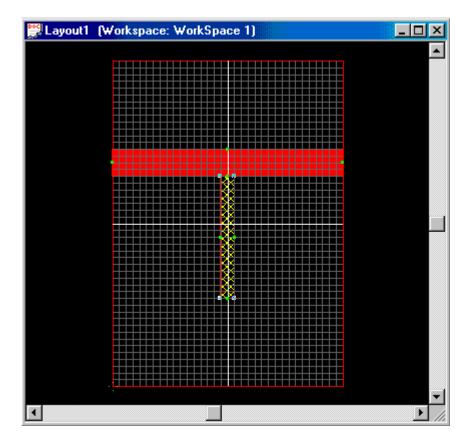
This is the series transmission line. The screen should now look as below. Don't worry if the line isn't at the exact same position on the page - the layout will be centered later.



To draw the open stub:

- 1. Select the Rectangle button from the toolbar.
- 2. Click at the bottom edge of the line just drawn, one grid cell left of the series line's center.
- 3. Drag to the right and down until the status bar shows DX=25 and DY=225.
- 4. Release the mouse button.

The screen should now look like the following. If the stub line isn't centered horizontally on the screen, select the stub by clicking on it, and drag it to the proper position.



Centering the Layout

As a general rule, EMPOWER simulation time is greatly reduced if the circuit to be simulated exhibits symmetry in any of several planes. Many circuits will exhibit some form of symmetry if they are centered in the page area.

To center the example filter:

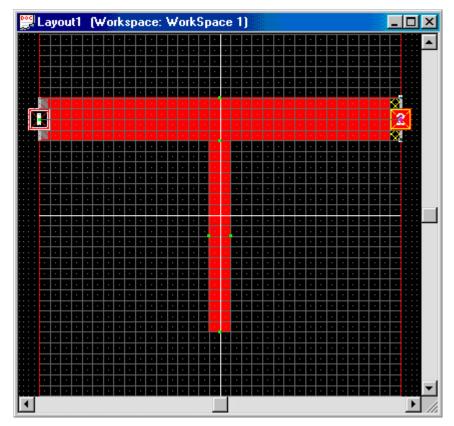
- 1. Choose Select/All from the Edit menu.
- 2. Choose Center Selected On Page from the Layout menu.

Placing EMPOWER Ports

Before running EMPOWER, the filter's ports must be designated. Select the EMPort button (on the LAYOUT toolbar, and click on the center left end of the series line. The EM Port Properties dialog appears. Set the "Draw Size" to 25. This controls how large the port numbers will be drawn on the LAYOUT screen (but has no effect on simulation). Note that the default port number is 1. Select the OK button.

Next, select the EMPort button on the toolbar again. Click on the center right end of the series line. The EM Port Properties dialog appears. Again, type 25 into the Draw Size box. Note that the default port number is 2. Select the OK button.

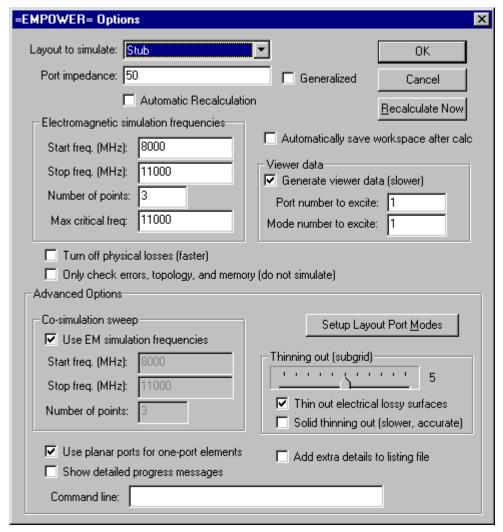
The screen should now look like:



For simulation, EMPOWER will take S-Parameters from these ports.

Simulating the Layout

To run EMPOWER, you must create a simulation. Click on the Add Item button in the Workspace Window and choose Analyses/Add Empower Analysis. This displays the EMPOWER Options dialog. This dialog is shown below. For a description of the dialog options, see the section on External Ports. For now, *just set the prompts as shown below.*



We are starting with 3 sample points in the range 8-11 GHz. This will place 1 point at 8, 9.5 (the supposed resonance), and 11 GHz.

Click the Recalculate Now button. This launches EMPOWER to simulate the layout.

Note: While EMPOWER is calculating any simulation which takes more than two seconds, a window similar to the one in below will be shown. This window shows the current status throughout the calculation mode. For more details on the contents window, see the Basics Console section.

```
### Starting Line Analysis to De-embed PORT 1 ***

9500 MHz Zo=44.932 G=i280.930
11000 MHz Zo=45.049 G=i326.051
*** Starting Discontinuity Analysis ***

8000 MHz Si1=-1.46<-295. S21=-5.92<-204.
9500 MHz Si1=-0.263<-1.69 S21=-16.2<-95.8
```

Viewing Results

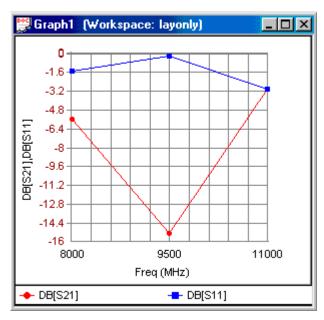
After EMPOWER simulation of the layout, the data must be displayed in GENESYS. This can be done first by examining the DataSet and then by creating a Data Output such as a Rectangular Graph.

To create a rectangular graph in this workspace (using InstaGraph):

- 1. Double-click EM1_Data in the workspace tree to open the EMPOWER results.
- 2. Right-click on S and select Graph/Rectangular Graph

This instructs GENESYS to create a graph containing EMPOWER S parameter data. Data will be displayed at 8000, 9500, and 11000 MHz. (For a complete description of rectangular graphs, see the GENESYS User's Guide.)

The GENESYS display below shows the EMPOWER run with 3 sample points.



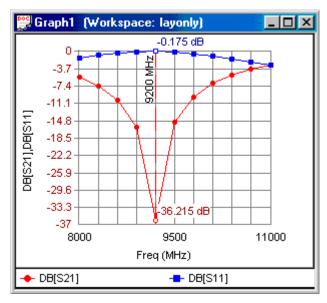
In this response, the notch frequency appears to occur exactly at 9.5 GHz, but we don't have enough points to tell for sure. To add more frequency points to the EMPOWER simulation.

To re-simulate, adding more points:

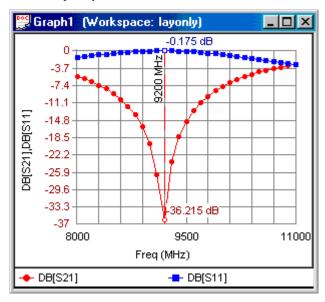
- 1. Double-click "EM1" under Simulations/Data in the Workspace Window.
- 2. Change the "Number of Points" in the "Electromagnetic Simulation Frequencies" to 11.
- 3. Click the Recalculate Now button.

This will add to the previous EMPOWER simulation so that we have 11 instead of 3 data points. EMPOWER will intelligently recalculate only the additional points.

The figure below shows the simulation with 11 EMPOWER data points. The notch frequency now appears to be at 9.2 GHz! Let's add increase the simulation 31 points to ensure that we get the actual notch frequency. Repeat the previous steps to change the number of EMPOWER points to 31 and recalculate.

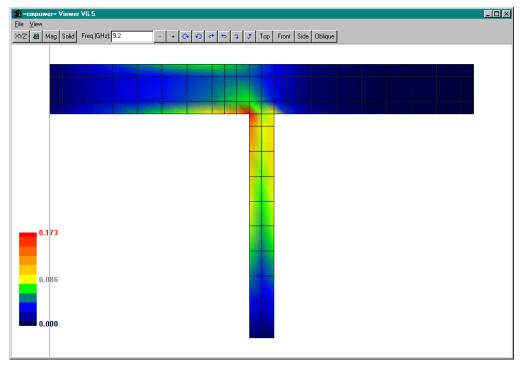


The display below is after the EMPOWER run with 31 points. The response has not changed noticeably since the 11 point simulation, so we must have found the correct notch frequency.



Using the Viewer

Once the EMPOWER run is completed, the viewer can be loaded if Generate Viewer Data was selected in the EMPOWER options dialog. Generating this data slows the EMPOWER simulation, so it's usually only checked during last-run simulations.



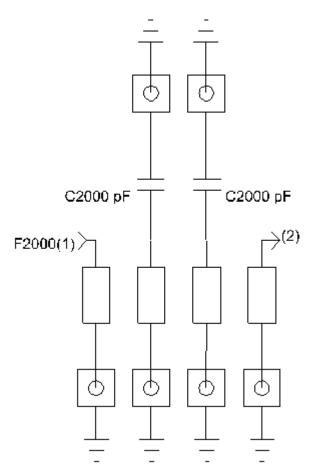
Right-Click the EMPOWER simulation (EM1) in the Workspace Window and select "Run EMPOWER Viewer". A top-down view has been selected, and the notch frequency has been specified. Port #1 is at the left of the image, and port #2 is at the right. The plot is color-coded to the scale given in the lower left of the figure. Notice that port #2 is nearly black. This indicates that very little energy is being delivered to that port at 9.2 GHz, as we'd expect.

Creating a Layout From an Existing Schematic

The file used in this example is Filters\Tuned Bandpass.wsp. This example demonstrates the following topics:

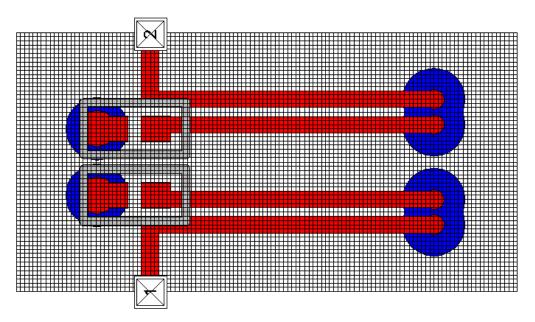
- Creating a layout from an existing schematic
- "Tuning" with EMPOWER data
- Using lumped elements with EMPOWER

In GENESYS, open the example Filters\Tuned Bandpass.wsx. Double-Click the F2000 design in the Workspace Window to display the schematic for this filter (shown below).



This is the schematic of a 2nd order microstrip combline bandpass filter with 50 Ohm terminations and transformer coupling on the input and output. The lumped capacitors are gang-tuned to adjust the resonant frequency of the two center lines. Tuning in this manner affects only the center frequency, and keeps the passband bandwidth constant.

Double-Click Layout1 under Designs in the Workspace Window to display the layout for this schematic (shown below).



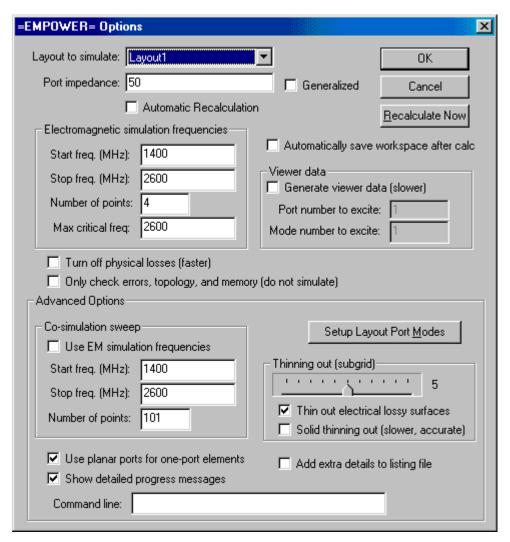
A 0402 Chip Capacitor footprint has been used for each of the lumped capacitors. Whenever a lumped element is used for an EMPOWER run, GENESYS creates an internal ports for the element. These ports are placed:

- If "Use Planar Ports for two-port elements" is checked in the EMPOWER properties box, one port is created for 2-terminal elements (like resistors or capacitors) which are aligned horizontally or vertically.
- In all other cases, an internal port is used for each terminal of the element. This
 port is placed at the center of the pad footprint, and EMPOWER writes data for
 each port created, whether internal or external.
- The "1" and "2" ports pictured in the figure above are examples of external ports.

Ports are described in the External Ports and the Internal Ports sections. Automatic port placement is a powerful technique, and real time tuning can be employed in GENESYS once the EMPOWER data for has been calculated.

Simulating the Layout

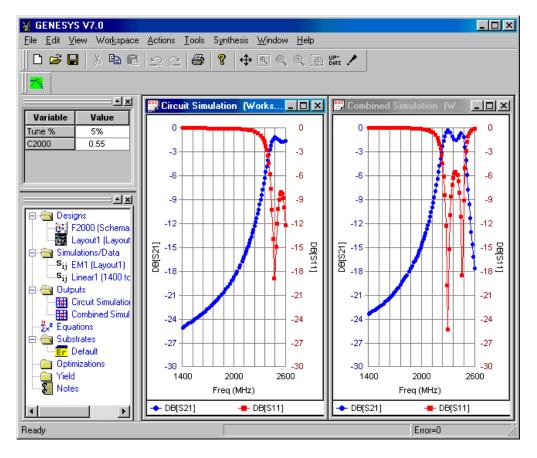
Double-click EM1 in the Workspace Window. This displays the EMPOWER Options dialog shown below.



Click the Recalculate Now button. If anything has been modified since the last EMPOWER run, this launches EMPOWER to simulate the layout.

Note: EMPOWER has been given a lot of intelligence to determine when it needs to calculate. Clicking Recalculate Now will not do anything if EMPOWER believes it is up to date. To force EMPOWER to recalculate from scratch, right-click on the electromagnetic simulation in the workspace window and select "Force Complete Analysis Now".

Once EMPOWER calculation is completed, GENESYS displays the calculated data. The graphs below show GENESYS after EMPOWER simulation. (Double-click the graph items in the workspace window to open them and select Tile Vertical from the Window menu to organize them as shown below.)



Lumped Elements

The first example in this section required several data points to find the exact notch frequency. This second example only used 4 data points, and produces data very close to the GENESYS simulation. This is because the capacitors which load the coupled lines (causing resonances at the center frequency) were removed during the EMPOWER simulation. This effectively removes the resonances from the simulation range, producing a flat response from the open coupled lines. Since a flat response is well suited for linear interpolation, few data points are required in the EMPOWER simulation. In the EMPOWER options dialog, the Co-Simulation Sweep box is used to set up a simulation with more points after lumped elements are added.

When GENESYS uses the EMPOWER results, it replaces the lumped capacitances, resulting in the bandpass response shown in the previous section.

This technique is similar to using approximations for inductors and capacitors when creating a lumped filter. Even though the response of each element is simple and can be interpolated from just a few widely spaced points, the complete filter response can be quite complex and require many more points to characterize.

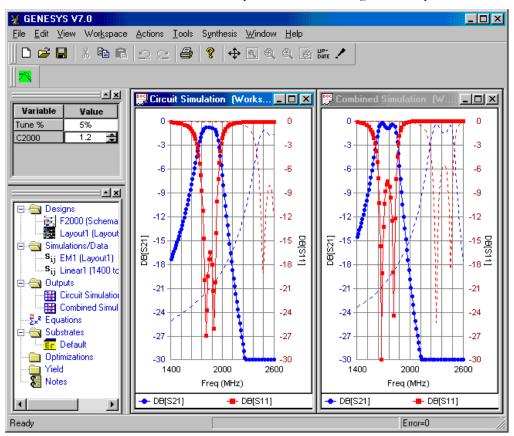
Real-Time Tuning

As stated before, GENESYS creates ports internal to a layout structure containing lumped elements before invoking EMPOWER. During calculation, EMPOWER creates Sparameter data with port data for all ports, whether internal or external. This allows GENESYS to tune the lumped elements while still using the original EMPOWER data.

To see an example of tuning:

- 1. Click inside the Equation.C2000 prompt in the Tune Window.
- 2. Type a new value for the capacitor, or tune using Page Up/Page Down keys or the spin buttons.

The GENESYS screen below is shown after tuning the capacitors from 0.55 pF to 1.2 pF. The response shown on the left in this figure is the linear simulation response. The EMPOWER data is combined with the lumped elements in the rightmost response.



EMPOWER: Tips

Overview

Often, electromagnetic simulation involves tradeoffs and compromises to keep simulation times and memory requirements as small as possible while making accuracy as high as possible. This section looks at several choices and clarifies the tradeoffs. Table 3-1 lists various features and gives their impact on simulation times, accuracy, and memory requirements. Each of these choices are looked at in detail below. The values are approximate and may vary.

Choice	Memory	Accuracy	Time
Reducing Cell Size by 2	x16	x2	x64
Raising Max Critical Freq	x1.5	x1.5	x2
Fixing Symmetry	x1/4 to x1/16	0	x1/4 to x1/16
Turning Off Thinning Out	x16	x1.2	x64
Increasing Wall & Cover Spacing	x1.1	x1.5	x1.1
Choosing Correct Cover	0	x4	0
Including Loss	x2	Lossy	x4
Generating Viewer Data	x1.2	0	x2-x10
Corecting Slot- Type Structure	x1/64	0	x1/256
Using Preferred Box Cell Count	0	0	
Using Thick Metal	x6	;	x16

Cell Size

Cells should be small enough so that the result is accurate, at least 10 cells per wavelength at the maximum critical frequency (see below). Additionally, the cells should be small enough that there is at least one, and preferably more, cell across every line and gap. Decreasing the cell size makes all stages of the solution take longer, so decreasing cell size can be an expensive way to get more accuracy. Conversely, increasing cell size is a great

way to do an initial run of your problem to make sure that the result is close before you start a simulation that will take hours.

See the EMPOWER Basics section for more information on cells and the problem geometry.

Maximum Critical Frequency

This parameter is set in the EMPOWER dialog box when starting a simulation. Changing this parameter has three (and only three) effects:

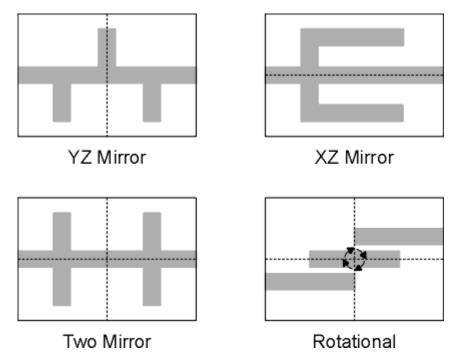
- 1. The maximum amount of thinning out is affected. EMPOWER will thin out until an area is 1/20th of a wavelength at this frequency in the default thinning mode.
- 2. The length of line analyzed for deembedding is 1/2 wavelength at this frequency in automatic mode.
- 3. Many parameters in the listing file are based on this frequency.

The most important thing to know about maximum critical frequency is to keep it the same between runs of the same problem, even if you are changing the frequency range which you are analyzing. If it is changed, then the thinning out is changed, and the entire problem geometry is slightly different. As an example, if you are analyzing a filter with a passband from 5.1 to 5.5 GHz with a reentrance mode (additional passband) around 15 GHz, you should probably set the maximum critical frequency to 5.5 GHz. This is because the exact characteristic of the reentrance mode probably is not important ("critical"); you just want to know approximately where the filter re-enters. On the other hand, you want to know *precisely* where the passband is, so you set the maximum critical frequency above it.

The effect of maximum critical frequency is generally secondary. Most of the other choices in the table above have a bigger effect on accuracy.

Symmetry

Making a problem exactly symmetrical is an easy way to make a problem require less memory and time without sacrificing any accuracy. There are four types of symmetry recognized by EMPOWER: YZ mirror symmetry, XZ mirror symmetry, two mirror symmetry, and 180° rotational symmetry. These types are illustrated below.



When EMPOWER is running, you should look at the information area at the top of the screen to see if symmetry is active. If it is not, recheck your problem to see if it is exactly centered on the box, and to see if it is in fact symmetrical. Two tools can help with this:

- Using "Center Selected on Page" from the Edit menu in LAYOUT. This
 command makes it easy to make sure that your circuit is exactly centered on the
 page
- Showing the listing file by selecting "Show Listing File" from the EMPOWER right-click menu. This file shows exactly how the problem was put on the grid, and lack of symmetry is often obvious.

Making an unsymmetrical problem symmetrical will make it run 4 times faster in most cases, and will make it 16 times faster if your problem can use two-mirror symmetry.

See EMPOWER Basics section for more information on cells and the problem geometry. See the Files section for more information on the listing file.

Thinning Out

For most examples, the default thinning out should be used. As a general rule, you will get better accuracy for a given amount of time and memory when you use thinning. Thinning out helps by removing currents which have little or no effect. This reduces the number of variables in the problem considerably with little effect on the accuracy of the solution. There are a few cases where thinning out should not be used, and they generally involve very large sections of metal which are affected too much by thinning out. The Dual-Mode Power Divider example is one of these cases.

Wall & Cover Spacing

Generally, the wall and cover spacing should match the problem which you are trying to model. This will give an accurate assessment not only of circuit performance but also of box resonances. However, this will not be possible in a few situations:

- 1. The structure will not be in a box.
- 2. You are analyzing part of a larger circuit, and the box walls would be prohibitively large to model.
- 3. You are designing a component (such as a spiral inductor) which will be reused in many different circuits, so the cover height is not known.

In these cases, you must use an approximation. Set the box size so that the walls are separated from the circuit by at least 3 times the substrate thickness, preferably 6 times. For microstrip, set the cover spacing (air above) to 5 to 10 times the substrate height.

See for more info, see Box Modes. See Microstrip Line for an example of the effect of wall spacing on line impedance.

Cover Type

Choosing the correct cover type is absolutely critical to getting an analysis which matches measured results. The choice is usually between whether to use an open cover or a closed cover. Choosing the correct cover type usually has no effect on analysis time, so there is no reason not to set this to the proper type. With an open cover, there will be radiation, and this can have a huge impact on circuit performance. You can choose the correct cover types in the Layers Tab when starting an electromagnetic simulation.

See the EMPOWER Basics and Box Modes sections for more information on covers. See the Edge-Coupled Filter example for an example of the impact that removing a cover has on circuit performance.

Lossy Analysis

If you do not need information about circuit loss, you can check the box labeled "Don't use physical loss (Faster)" when starting an EMPOWER run. Turning off losses will generally make a problem require 1/2 the memory and 1/4 the time as a lossy problem.

We recommend that you define all layers with their proper characteristics, including losses. You can then quickly change between lossy and lossless modes as described above. A common technique is to analyze a circuit first without losses, then turn on losses and run an analysis with a few points in it. This allows you to determine the amount of loss and confirm that it has no other major effect on performance while not having to wait the additional time while doing most of your analyses.

There is an additional caveat regarding loss described in the section on Slot-type structure.

See the Narrowband Interdgital example for an example of the effect of loss on an interdigital filter.

Viewer Data

Looking at currents in the viewer is a great way to get insights into circuit performance. However, generating this viewer data requires additional time, increasing the length of a run by a factor from two to ten, and sometimes requiring additional memory also. Generating viewer data has no effect whatsoever on the solution given, so you should not have this option turned on unless you actually intend to run the viewer. You can turn this option on and off by using the checkbox labeled "Generate Viewer Data (Slower)" when starting an EMPOWER run.

You will not normally need viewer data, and when it is needed, you will not normally need viewer data at every frequency. Our recommendation:

- 1. Run all problems the first time without generating viewer data. If the answer is completely unexpected, check for errors in your description of the file. This can save a lot of time in the experimenting stage.
- If you decide you want viewer data, open the EMPOWER Options dialog box. Reduce the number of frequency points to be analyzed and turn on "Generate Viewer Data (Slower)." Recalculate the EMPOWER simulation, and you will now have viewer data at some points.
- 3. If your problem is very large, you may want to increase the cell size or make other tradeoffs to reduce the time required for calculation. If you use this technique, save the file with a new name before you generate viewer data so that you do not corrupt your existing S-Parameter data!

See the EMPOWER Viewer section for more information.

Slot-Type Structure

In the normal mode EMPOWER solves for the currents in the metal. There is an additional mode where EMPOWER solves for the voltages in the gaps and in lossy metals. This mode must be turned on manually by checking "Slot-type structure" when starting an EMPOWER run from GENESYS, or by using the VOLTAGE keyword when describing a LAYER in a TPL file.

In general, you should check "Slot-type structure" whenever the metalization layer has more lossless metal than open space. This is often the case in a slot-type structure such as coplanar waveguide. The answer will always be identical, but you will save orders of magnitude of memory and simulation time by ensuring that this checkbox is set to the right value. Note: This setting has no effect on z-directed metal (viaholes, etc.) which is always calculated as currents.

There is a caveat when describing lossy problems with this option: All non-ideal metal must be analyzed, so if the metal in your problem is lossy, turning on "Slot-type structure" will result in both the air and the metal being analyzed, which will have a disastrous effect on memory and time requirements. Be sure that your metal layers are set to lossless if you check the slot-type structure box.

Preferred Cell Count

The first part of an EMPOWER run involves taking Fourier Transforms of the grid. These transforms will run much faster if the number of cells along the each side of the box is of the form 2a3b5c7d11c13f where e and f are either zero or one, and a,b,c, and d are arbitrary integers. In other words, a circuit with a box 512 cells by 512 cells (28 by 28) will analyze much faster than a circuit with a box 509 cells by 509 cells (509 is prime). Making one side a preferred number will help, so a box 509 x 512 cells is better than one 509 x 509 cells. Note that only the time while EMPOWER is working on the Fourier Transform is affected, and this is normally only substantial with boxes 100x100 or larger. If you see a status with "FFT" in the message for a long time, check to see that the box width and height are a preferred number of cells across. Preferred numbers (which fit the form given above) 10000 and below are:

9100 9152 9216 9240 9261 9360 9375 9408 9450 9477 9504 9555 9600 9604 9625 9702 9720 9750 9800 9828 9856 9900 9984 10000

Thick Metal

Using "Thick Up" or "Thick Down" metal will greatly increase the complexity of an EMPOWER run, as all metal layers must be duplicated (for the top and bottom of the thick metal) and z-directed currents must be added along the sides of all metal.

The detailed of defining metal layers is found in the EMPOWER layers dialog box, as follows:

Metal Layers - All metal layers from the General Layer Tab are also shown in the EMPOWER Layer tab. These layers are used for metal and other conductive material such as resistive film. The following types are available:

- Lossless: The layer is ideal metal.
- Physical Desc: The layer is lossy. These losses are described by Rho (resistivity relative to copper), Thickness, and Surface Roughness.
- Electrical Desc: The layer is lossy and is described by an impedance or file. This type is commonly used for resistive films and superconductors. If the entry in this box is a number, it specifies the impedance of the material in ohms per square. If the entry in this box is a filename, it specifies the name of a one-port data file which contains impedance data versus frequency. This data file will be interpolated/extrapolated as necessary. See the Device Data section for a description of one-port data files.
- Substrates: Choosing a substrate causes the layer to get the rho, thickness, and
 roughness parameters from that substrate definition. We recommend using this
 setting whenever possible so that parameters do not need to be duplicated
 between substrates and layouts.

Caution: Unless thick metal is selected, thickness is only used for calculation of losses. It is not otherwise used, and all strips are calculated as if they are infinitely thin.

Metal layers have three additional settings available:

Slot Type - Check this box to simulate the non-lossless-metal areas (as opposed to the metal areas) in EMPOWER. Use this for ground-planes and other layers which are primarily metal. Do not use this for lossy layers. See your EMPOWER manual for details.

Current Direction - Specifies which direction the current flows in this layer. The default is along X and Y. "X Only" and "Y Only" can be used to save times on long stretches of uniform lines. "Z Up", "Z Down", "XYZ Up", and "XYZ Down" allow the creation of thick metal going up/down to the next level or cover.

Thick Metal - Checking this box forces EMPOWER to model the metal including thickness. EMPOWER does this by putting two metal layers close together, duplicating the traces on each, and connecting them with z-directed currents. If thick metal is used, then Current Direction is ignored.

Element Z-Ports - This setting specifies the default direction for automatically created element ports, either to the level above or to the level below. Generally, you should choose the electrically shortest path for this direction.

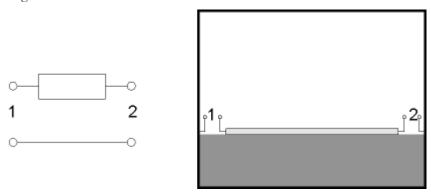
EMPOWER: External Ports

Overview

Every EMPOWER circuit must contain at least one port. These ports are divided into two major categories: external ports which are at a sidewall, and internal ports which are inside the box. This section will cover only external ports; internal ports are discussed in a later section of this manual.

Placing External Ports

By now you should be familiar with the placement of external ports (EMPorts). If not, you should follow the first example To briefly review: An external port is placed in LAYOUT by selecting EMPort from the toolbar. These ports are generally placed on the edge of the box at the end of a line.

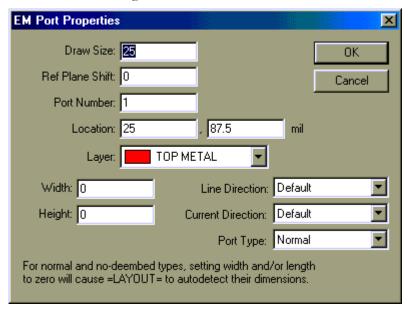


This figure shows a comparison between a port in circuit theory and a port in EMPOWER. In the circuit theory schematic on the left, there are two ports. Each port has two terminals, with the bottom terminal generally being ground.

In the EMPOWER illustration shown on the right the figure, the section of line stops before the edge of the box (generally one cell-width away) and a port begins in its place. (See the Grid discussion in the Basics section to see how this is mapped onto the grid.) As in the circuit theory schematic, there are two ports, and each port has two terminals. However, in EMPOWER, instead of the ground plane being modeled as a simple short circuit, the effect of currents traveling through the box is taken into account.

EMPort Options

When you first create a port, it is automatically configured to be an external port with the proper characteristics to be placed on the end of a transmission line. For many applications, you will want to modify these characteristics when you place the port. These characteristics are shown in the EM Port Properties dialog box which comes up automatically when the port is placed and which can be accessed later by either double-clicking on the port or by selecting the port and choosing Details from the Edit menu. A typical EM Port Properties dialog box is shown below. The following sections describe the entries in this dialog box.



<u>Draw Size</u> - This has no effect on the simulation. It controls the size that the port number appears on screen and on printouts.

Ref Plane Shift - This parameter is only available if "Port Type" is set to "Normal" (see below). On most complete circuits, this value can be left at zero. A positive Reference Plane shift causes the deembedding to add extra line length to the circuit; A negative value is more common and causes the reference planes to move inside the box. (See the Patch Antenna Impedance example for an example of a patch antenna simulation and the Edge-Coupled Filter example which uses a reference plane shift.) The reference plane is shown as an arrow on the layout. Additionally, when the EMPort is selected, Handles appear on the reference plane, allowing it to be moved with the mouse.

<u>Port Number</u> - When EMPOWER is run, the port numbers specified here correspond to the port numbers in the resulting data. These port numbers must be sequential (numbers cannot be skipped), and Normal ports must always have lower numbers than non-deembedded and internal ports. LAYOUT assigns a new port number automatically when an EMPort is placed, and the port number is displayed on the layout at the port.

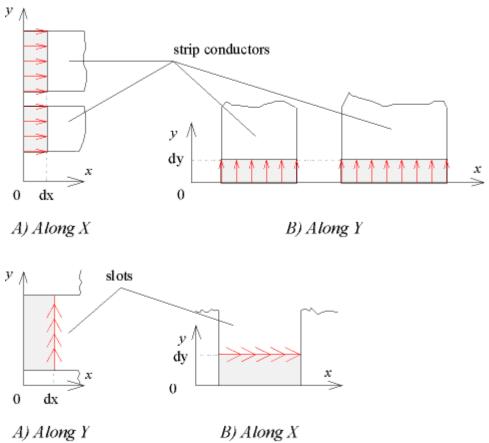
<u>Width & Length</u> - When placing an external port on the end of a strip-type transmission line, you should normally leave these at zero so that LAYOUT sizes the port automatically. If you want to override the size, or for slot-type or internal ports, you can specify width and length here. Note: Width and length are measured relative to the line direction, so these parameters can appear to be reversed. Length is the length in the direction of propagation (along the line), and width is the width of the strip.

<u>Layer</u> - Specifies the metal layer on which the port is placed.

<u>Location</u> - specifies the edge of the port for external ports and the center of the port for internal ports.

<u>Line Direction</u> - Gives the direction of the line at the port. In the default mode, the nearest wall determines the direction of the line. This value rarely needs to be overridden.

<u>Current Dir</u> - Specifies the direction of current flow within the port. The first figure below shows the default current direction for external ports on strip-type structures such as microstrip and stripline. The second figure shows the default current direction for external ports on slot-type structures such as coplanar waveguide. For internal ports, the default current direction is "Along Z." This value also rarely needs to overridden.



Port Type - Specifies the basic type of port: Normal, No Deembed, and Internal.

- Normal ports are external ports which are deembedded and may be multi-mode. They are shown in gray on the layout.
- No Deembed ports are external ports which are not deembedded and cannot be multi-mode. They are shown in white on the layout.
- Internal ports are also not deembedded and cannot be multi-mode. They are shown in white on the layout.

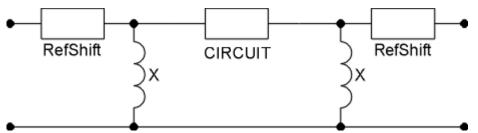
For more information on dembedding and multi-mode lines, see below.

Deembedding

If you are actually building your circuit in the same style as an EMPort, that is, if your ports consist of a line which stops just short of the end wall, as is often the case with a coax-microstrip junction, then you may not need to use deembedding, because EMPOWER is simulating the circuit as you are actually going to build it.

However, you may not have this kind of construction or you may be simulating a small segment of a larger circuit. In an external port, there is capacitance at the port due to coupling from the open end of the line to the wall. Deembedding removes this extra reactance, perfectly matching the transmission line, modeling it as though the line and box extend out to infinity.

Deembedding also allows you to define a reference plane shift. By default, the reference plane shift is zero, which means that the resulting data is measured at exactly the side wall. If the reference plane shift is negative, then the data is measured from inside the box, effectively subtracting length from the circuit. If the reference plane shift is positive, then the data is measured from outside the box, effectively adding length to the circuit.



This is the equivalent network used when deembedding is active. The center of the figure, labeled CIRCUIT contains the raw results from the EMPOWER simulation. Reactance X (shown as inductors above) cancels the capacitance caused by the end wall as well as correcting other reactances. (The value of X may be negative, and it is frequency dependent.) The RefShift lines at the outside move the reference planes to the correct location. Since the RefShift lines also help to correct for the discontinuity at the box wall, their lengths are normally not zero, even if the reference shift specified for the port is zero. The impedance of the RefShift lines is equal to the port line impedance, so only the

phase is shifted by the addition of these lines. The magnitude of the reflection coefficients is not affected.

The parameters for deembedding are calculated prior to the analysis of the circuit. EMPOWER does this automatically by analyzing two different length lines at each frequency for each port used, solving for the reactance and the base RefShift value.

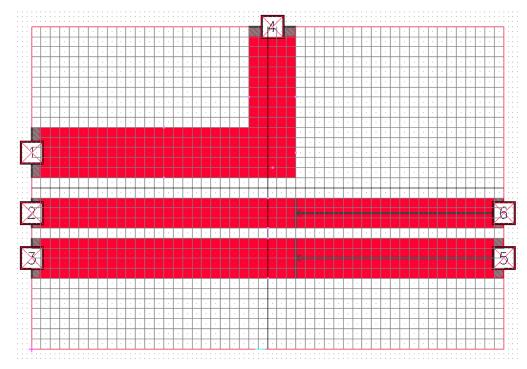
Note: Deembedding requires an additional line analysis mode at the start of the run, so runs using deembedding can take substantially longer.

This is especially true if the lines at the ports are wide, since a wide line is simulated across the entire length of the box. However, line analysis is always symmetrical, and may be symmetrical in two planes if the port lines are placed exactly in the middle of the box. EMPOWER also caches the line analysis results, so if the box and port lines are not changed between runs, previous data will be used. The data for these lines are stored internally in the Workspace (WSP) file using internal files namedEMPOWER.R1, EMPOWER.R2, etc. EMPOWER also has the intelligence to detect when two or more ports have the same configuration (width, position, etc.), and will only run the line analysis once.

See Microstrip Line for a complete example which examines deembedding.

MultiMode Ports

Until now, all ports which we have looked at have been single mode ports. Single mode ports act just like regular nodes in GENESYS, and external components can be added directly to these ports. EMPOWER also supports external multimode ports where two EMPorts are close enough together that they are coupled. This circuit uses multimode ports, with ports 1, 2, and 3 being a 3-mode port, 4 being a normal single-mode port, and ports 5 and 6 being a 2-mode port:



Multimode ports have the following features:

- They much more accurately characterize the performance of a network with two or more lines close together on one wall.
- They cannot be used like normal GENESYS nodes; They can only be connected to other multimode ports, including multi-mode lines and multimode EMPOWER data. Further, any multi-mode elements connected together must have the same number of modes for each port.

Caution: Do not connect standard lumped elements to a multimode port! The results will not be correct. If you will be connecting directly to components, you should use single-mode ports. Use multi-mode ports only for connection only with other multimode ports and multi-mode lines.

 They can be used with decomposition to accurately analyze much larger structures than would be possible in a single EMPOWER circuit. See the Decomposition section for more details.

To create a multi-mode port, click on the "Mode Setup" Button from the EMPOWER setup dialog box when you start an EMPOWER run. You will see a box similar to the one at the end of this section. To make ports multi-mode, check the boxes between them. EMPorts 1,2, and 3 form one multi-mode port, and EMPorts 5 and 6 form another multi-mode port. EMPort 4 is a single mode port. To make a multi-mode port, you must follow these rules:

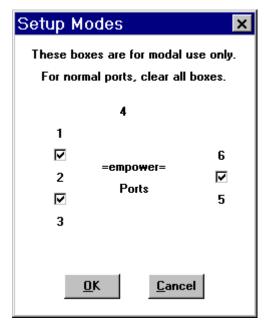
- All EMPorts for a multi-mode port must be on the same wall.
- All EMPorts must have the same length, line direction, current direction, and reference plane shift. The EMPorts may (and often do) have different widths, as above..
- All EMPorts must be "Normal" (not "No Deembed" or "Internal").
- Port numbers must be sequential and in order. For example, if you swapped ports 1 and 2 above, you could not use a 3-mode port, because the ports would be in the order 2-1-3 along the sidewall.

Running the circuit above in EMPOWER will give 6-port data, as would be expected by glancing at the picture. However, the fourth port is the only normal, single-mode port. In the data file, the first three ports of data are in mode-space, and the last two ports of data are in mode-space. For example, in the data file:

- S41 represents the transmission of energy from mode 1 of multi-mode port (1,2,3) to port 4.
- S25 represents the transmission of energy from mode 1 of multi-mode port (5,6) to mode 2 of multi-mode port (1,2,3).
- S66 represents the reflection of energy in mode 2 of multi-mode port (5,6).

Multimode data should be carefully connected. Multimode ports should be connected only to other identical multi-mode port or line configuration (same box, line widths, spacings, etc.). Otherwise, the connection is non-physical and the results are meaningless.

See the Spiral Inductor example in the Decomposition section for more information on the use of Multimode lines.



Generalized S-Parameters

When normal circuit-theory analysis is performed, the ports are often terminated with a standard impedance such as 50 or 75 ohms. However, EMPOWER will give much more accurate results if you use generalized S-Parameters. With generalized S-Parameters, instead of the ports being terminated with 50 or 75 ohms, the ports are terminated with the characteristic impedance of the line as calculated by EMPOWER. This is a more internally consistent representation, and the results are often far more accurate. You should use generalized S-Parameters if the following three conditions hold:

- 1. You are using normal, deembedded ports. Ports marked "No Deembed" or "Internal" are not appropriate for reporting generalized S-Parameters, so they are normalized to 50 ohms if generalized parameters are requested.
- 2. You have calculated the impedance of the lines at the ports (using T/LINE, for instance), and they are 50 (or 75) ohms.
- 3. You have run EMPOWER, but it calculated the port impedances to be a little different (for example, 47 instead of 50 ohms). This error is generally a result of the grid size. (A finer grid would result in less error in the impedance).

In this case, you know that your port lines should be 50 ohms, but EMPOWER reported 47 ohms. If you then request Generalized S-Parameters, GENESYS will also use 47 ohms for the terminating impedance, and a large part of the analysis error due to the grid will be cancelled. The results will be close to the results obtained if you measured the circuit in a 50 ohm network analyzer.

To get generalized S-Parameters from GENESYS, Check the "Generalized" box in the EMPOWER properties dialog box.

When EMPOWER is run, it outputs a file (in the structured storage when run from GENESYS) for each port with impedance data with extensions R1, R2, R3, etc., so, for a 2-port network in file EMPOWER analysis EM1, using "Generalized" impedance is equivalent to using an impedance of "WSP:Simulations\EM1\EMPOWER.R1, WSP:Simulations\EM1\EMPOWER.R2".

See the examples manual an example of the use of generalized S-Parameters.

EMPOWER: Decomposition

Overview

NOTE: The Single and Multi-Mode transmission lines required to use decomposition are not available in GENESYS.

In EMPOWER, it is possible to break down large circuits into smaller segments which are connected by transmission line sections. Decomposition can be tedious to implement, but its reward is that simulations can be performed accurately in much less time and with fewer frequency points. The principal benefits of decomposition are:

- Ability to tune single or coupled transmission line sections inside a circuit which
 was simulated by EMPOWER. For example, you can change the size of a
 meander line or adjust the tap point on an interdigital filter without rerunning the
 EMPOWER simulation.
- Most circuits require far fewer frequency points for accurate analysis. This is due to the fact that quarter-wave resonant lines are broken down into much smaller lines that do not resonate, and interpolation is possible. For example, a 7th order interdigital filter can often be simulated with just 5 frequency points in the EMPOWER run while 100 points are displayed in the output sweep!
- Ability to simulate problems too large to otherwise run.

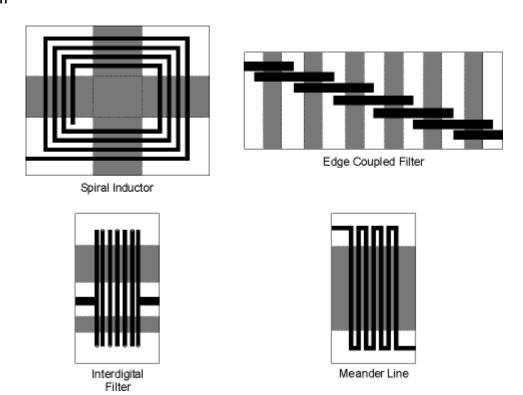
The main disadvantages of decomposition are:

- Tedious to setup circuit. The simulation requires multiple EMPOWER runs combined with a schematic.
- Box modes and other phenomena related to the entire problem are not modelled. However, since EMPOWER uses mode space to model coupled line connections, this is less of a problem that it would be with other simulators.
- Losses in the connecting lines are not modelled.

Basics

NOTE: The Single and Multi-Mode transmission lines required to use decomposition are not available in GENESYS.

Decomposition can be applied to circuits with parts which are connected via single or multiple transmission lines. Some typical circuits which can be broken apart are shown below. In each of the circuits, the unshaded areas are simulated individually. The pieces are then combined using multi-mode transmission lines to connect the pieces, representing the lines in the shaded area.



For decomposition to be possible, you must be able to break the circuit down into rectangular areas which are interconnected with transmission lines. For example, the spiral inductor above is broken down into four rectangular areas, one for each corner. These sections are then connected with multi-mode transmission lines.

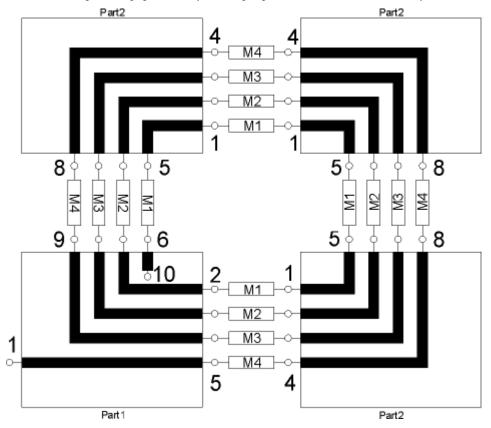
In each of the circuits above, the three main advantages of decomposition can be seen:

- The lengths of the connecting transmission lines can be varied. In the spiral inductor, this allows the size of the spiral (and the inductance) to be tuned or optimized in GENESYS.
- Far fewer points need to be analyzed. This is because each of the pieces is simpler and interpolation works well. For example, in the edge coupled filter, each of the pieces contain only open ends and small sections of lines which do not resonate. As a result, this filter only needed 5 frequency points for a good analysis.
- With any of these circuits, The grey areas can easily get so large that the problem requires hundreds of megabytes to analyze. In the meander line, if the lengths of the coupled lines (grey areas) gets very long, the EMPOWER simulation could take a long time. When the circuit is decomposed, simply changing one length value in GENESYS gives a virtually instant analysis, no matter how long the coupled sections are.

Spiral Inductor Example

NOTE: The Single and Multi-Mode transmission lines required to use decomposition are not available in GENESYS.

As a first decomposition example, we will analyze a spiral inductor. The first step is to come up with a plan for decomposition as shown here. We strongly recommend that you write a similar plan on paper when you setup a problem for multi-mode analysis.



The first step is to create workspace with a layout for each unique piece. In this example, there are two unique pieces: The lower left corner is the first, and each of the other three corners which are identical. There are two basic methods for creating these pieces:

 Create the pieces individually, drawing only the part that will be simulated in each piece. In this case, each individual layout will look like the parts shown above.

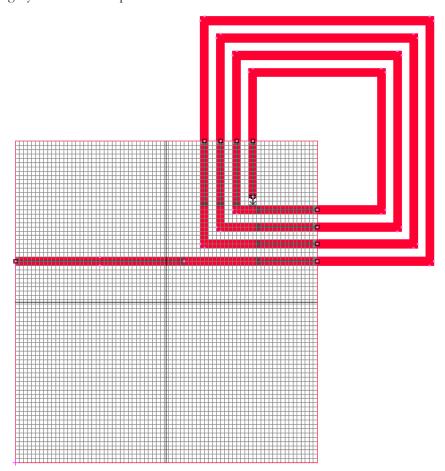
Or,

 Create a complete layout of the entire problem first. Then, make the box smaller so that only the desired piece is simulated. This is the method we will use for the spiral.

Simulation

We have created a layout of the entire spiral inductor as a starting point (\EAGLE\EXAMPLES\DECOMP\FULL.WSP). This file was created by starting with an MRIND element so that the layout was created mostly automatically. The only addition was the extra length leading to port 1 and the EMPorts. Notice that the reference plane for port 1 is shifted to the actual start point of the spiral model. Port 2 is an internal port. This circuit can be analyzed directly, but it requires minutes per frequency point and 37 megabytes of RAM.

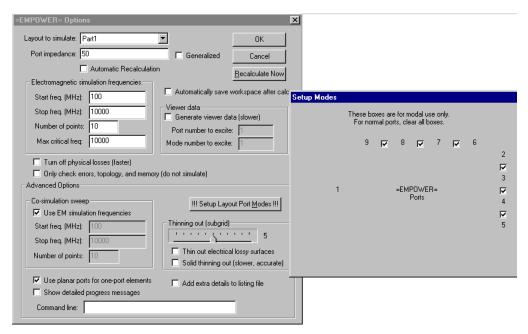
This file was then saved as COMBINE.WSP. The box was shrunk and the circuit was moved so that only the bottom left quarter of the circuit is in the box. The number on the internal port on the end of the spiral was changed to 10. Ports 2-5 on the right and 6-9 were added. Since these ports are in the middle of a line instead of on the end, their width must be set manually. Also, the reference planes on the ports were shifted in. The resulting layout for the first piece is shown below.



EMPOWER was run for Part1. The settings are as shown below. Note that only 5 points are needed since the individual parts are not resonant. The "Setup Layout Port Modes" button was

clicked, and the checkboxes in the Setup Modes dialog box were set to indicate that those inputs are modally related.

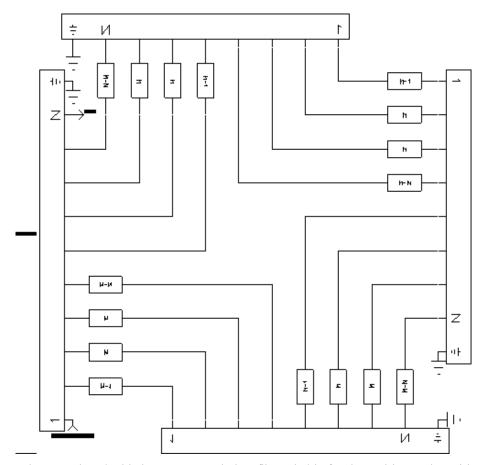
Caution: Do not forget to setup the modes when you are analyzing by decomposition. The Mode Setup box turns red if any inputs are modally related. Improper mode setup is one of the most common errors in decomposition.



A similar set of steps was followed for Part2.

The final step in decompositional analysis is to combine the pieces. The Schematic (COMBINE) which does this is shown here. The pieces used are NPO10 and NPO8 blocks (under "DEVICE" in schematic) for the data in PART1 and PART2 plus MMTLP8 models (multi-mode physical transmission lines, found under "T-LINE") for the interconnecting lines. The data for the NPO10 is in WSP:Simulations\EMPart1\EMPOWER.SS, and the data for the NPO8 is in WSP:Simulations\EMPart2\EMPOWER.SS.

Note: Some users may find it easier to write a text Netlist to combine the pieces. At Eagleware, we find it easier to use a schematic for this purpose, but you may use whichever you feel most comfortable with.

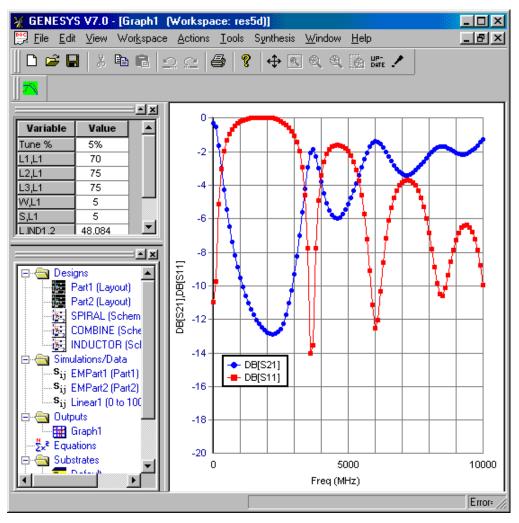


Whenever deembedded ports are used, data files suitable for the SMTLP and MMTLP models are automatically created during the LINE portion of the EMPOWER run. For the MMTLP8 lines, the file WSP:Simulations\EMPart1\EMPOWER.L2 was used. This corresponds to the second set of inputs for PART1. You should view the listing file (Right-click on EMPart1) and look at the port numbers to determine which EMPOWER.L* file contains the line data you need.

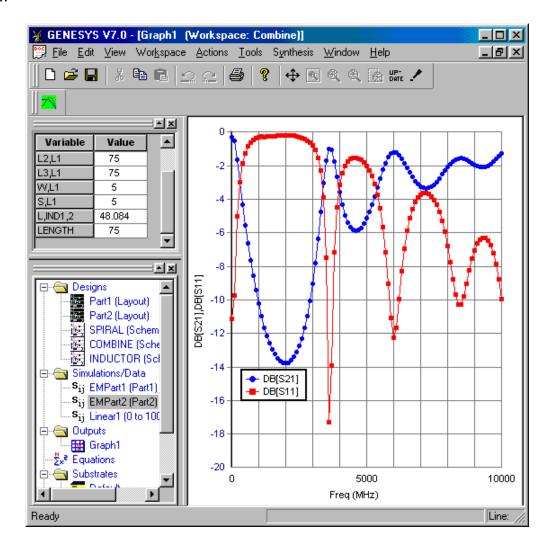
Note: Files with names like WSP:Simulations\EMPart1\EMPOWER.L2 are taken from within the current workspace. For a complete explanation of how these files are names, see the File Formats section in this manual.

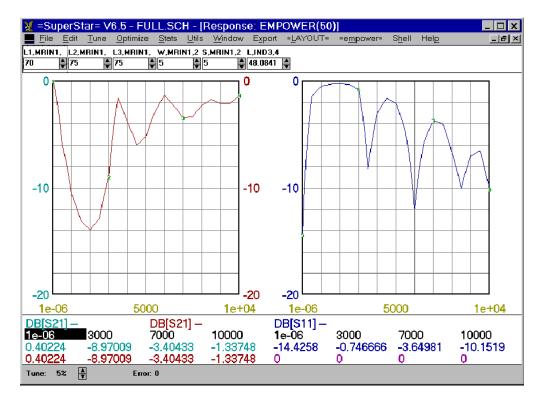
The substrate must also be specified, but only the UNITS parameter is used by the MMTLP8 model.

A variable was setup (LENGTH) so that the lengths of line can be tuned in GENESYS simultaneously, changing the size of the spiral and thus the inductance very quickly.



The results from this are shown above. Notice that even with only 5 analysis points across the band, the interpolation is very good. To illustrate this, the spiral inductor was recalculated with 10 points below. You can see quite good agreement between the two. To test the validity of the decompositional analysis, the entire spiral was analyzed, and the results are given in the second figure below. This full analysis took hours on a 266MHz Pentium II, and if the lengths of the lines in the spiral are changed, it must be rerun.





Losses

NOTE: The Single and Multi-Mode transmission lines required to use decomposition are not available in GENESYS.

A current limitation of decomposition is that losses are not taken into account in multimode transmission line sections or in reference-plane shifts. For the spiral inductor, this means that the losses as calculated are accurate for the nominal dimensions, but any modification to the lengths using the multimode lines will not affect the calculated loss.

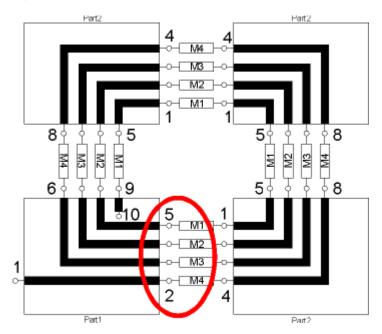
In general, if the decomposed pieces cover the circuit completely (as is the case in the spiral inductor), then the losses will be accurate. If the pieces do not completely cover the circuit (if sections of line are left out of the EMPOWER analysis and are added with MMTLP sections, then the losses will not include these sections. This is true regardless of the reference plane shifts used, since these shifts do not affect the loss.

Port Numbering

NOTE: The Single and Multi-Mode transmission lines required to use decomposition are not available in GENESYS.

You must be very careful when setting up and numbering ports for decompositional analysis. The following rules must be followed:

- Never connect anything other than MMTLP lines or other identical modal inputs to inputs which are modally related. Connecting lumped elements to modal inputs is incorrect and will give bad results.
- Ports which will be modally related must have sequential numbers. They must also all have the same reference shift.
- Ports for mode-space inputs must be marked type "Normal," not "No deembed" or "Internal." Correspondingly, their numbers must be lower than any "Nodeembed" or "Internal" ports.
- The order of ports used must correspond between the pieces and the MMTLP lines used. The lowest port number in a modally related set of inputs should connect to Mode 1 in the MMTLP line, and the highest port number in the set should connect to Mode N on the MMTLP line. Also, port ordering should be exactly the same on both pieces connected through the MMTLP. *The figure below shows an incorrect numbering of the spiral inductor.* In this example, PART1 and PART2 are inconsistently numbered, since on PART1 the outermost inputs (numbers 2 and 6) are the lowest number while in PART2 the innermost inputs (numbers 1 and 5) are the lowest number.



 Pieces can be connected directly together without using MMTLP. In this case, the lowest ports in each modally related set of inputs are connected to each other.

EMPOWER: Lumped Elements and Internal Ports

Overview

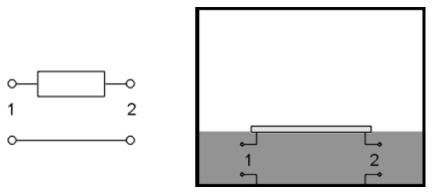
As described in the External Ports section, every EMPOWER circuit must contain at least one port. This section will cover lumped elements and internal ports (ports inside the box). External ports (along a sidewall) were also covered in that section.

Placing Internal Ports

The process of placing an internal port is similar to the process of placing an external port. To summarize: An internal port is placed in LAYOUT by selecting EMPort from the toolbar. Internal ports can be placed anywhere in the box. When the EMPort Properties dialog box appears, first select "Internal" in the Port Type combo box. Next, fill in the width and length of the pad. Press OK to complete the placement.

Note: The rest of the options in the EMPort Properties dialog box were covered in the section entitled "Port Options." You may want to review these options now.

The figure below shows a comparison between ports in circuit theory and internal ports in EMPOWER. In the circuit theory schematic on the left, there are two ports. Each port has two terminals, with the bottom terminal generally being ground.



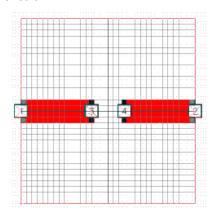
In the EMPOWER illustration there are two z-directed ports, one at each end of the line. These z-directed ports are mapped onto the grid along Z, much in the same way as a viahole would be mapped. (See the Basics section for more information on mapping to the grid.) As in the circuit theory schematic, there are two ports, and each port has two terminals. The bottom terminals, which are true ground in the circuit schematic, are connected to the bottom wall (ground plane), a physical representation of ground.

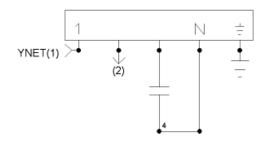
Z-directed internal ports can be used in GENESYS to connect elements, just like a node in a schematic. In other words, components like resistors and transistors can be connected directly to these ports. You simply place a z-directed port in the center of the pad for the component in these cases. Note: GENESYS does this automatically as described later in this section.

Manually Adding Lumped Elements

Note: GENESYS will automatically add lumped elements to your simulation if components are on your layout. This section is for background information and advanced applications

The circuit shown below contains an EMPOWER circuit which was drawn completely in LAYOUT. (The schematic for this network was blank.) It has 4-ports; ports 1 and 2 are external, and ports 3 and 4 are internal. EMPOWER will create a 4-port data file for this circuit.





Note: Internal ports and "no-deembed" ports must always have higher numbers than normal, external, deembedded ports. In the figure above, the internal ports are numbered 3 and 4, while the external ports are numbered 1 and 2.

The data file created by EMPOWER can then be used in GENESYS. The circuit on the right above uses the resulting data in a complete network. First, a FOU (four port data) device was placed on the blank schematic. The name assigned to this FOU block was the name of the internal file from the EMPOWER run ("WSP:Simulations\EM1\EMPOWER.SS").

An input and output were added on nodes one and two of the FOU block, the ground was added to the ground node, and a capacitor was connected across ports 3 and 4. This has the effect of putting the capacitor "into" the EMPOWER simulation. This capacitor can then be tuned and optimized, just like any other element in GENESYS.

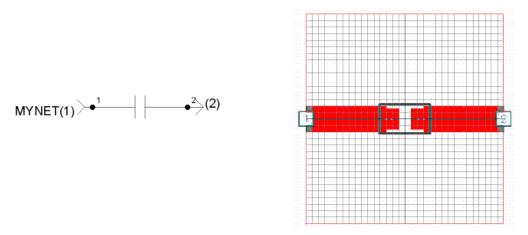
When the S-Parameters of MYNET are displayed, you see the resulting S-Parameters of the entire circuit.

Automatic Port Placement

One advantage of EMPOWER is its true integration. In most electromagnetic simulators, you would have no choice but to go through the complicated steps above. (Imagine how tedious this would be if you had 10 lumped elements, 2 transistors, and an op-amp chip in

the box!) Fortunately, the internal ports and lumped elements can be generated and added automatically.

The circuit below uses automatic port placement. Initially, the circuit on the left is drawn. The layout on the right of the figure was then created: The footprint for the chip capacitor was automatically placed. The lines and EMPorts were then manually added. When EMPOWER is invoked, internal ports are automatically added, so the circuit simulated is virtually identical to the one on the left below, and the result is a 4-port data file.



EMPOWER then automatically creates a network which is identical to the network shown in the previous section. This result is fundamentally the same as the result from MYNET below. When the capacitor below is tuned or optimized, the networks MYNET and EMPOWER are both updated simultaneously.

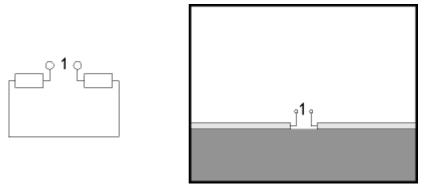
Even if you create a file with a layout only (no schematic), you can still use automatic port placement. Simply put the parts down onto a blank schematic, connecting them into a dummy network. The parts will now show up in the layout and can be moved as needed, ignoring any rubber bands. (The rubber bands come from the meaningless connections in the dummy network.) When you display the EMPOWER simulation results, it will include the components. You do not need to display the results from the schematic.

Planar (X- and Y-Directed) Ports

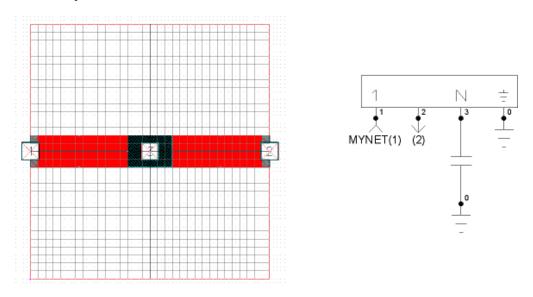
Note: EMPOWER will create planar ports for lumped elements if the "Use Planar Ports for one-port elements" box is checked in the EMPOWER options dialog. See your reference manual for details.

In some situations, you may want to place internal ports with X- or Y-directed currents. These ports are much trickier to use manually, since they are not referenced to ground. For components in your layout, EMPOWER will automatically place planar port and lumped elements, so this section is for background or advanced applications.

This figure shows the configuration of these ports. These ports can be more accurate for manually connecting lumped elements to EMPOWER data since the ports are a more accurately represent the physical connection of lumped elements.



The circuit shown in below contains an EMPOWER circuit which was drawn completely in LAYOUT. (The schematic for this network was blank.) It has 3-ports; ports 1 and 2 are external, and port 3 is internal with current direction "Along X." EMPOWER will create a 3-port data file for this circuit, however, you must be aware that port 3 will be a series connected port and *cannot be used in the normal manner.*



The data file created by EMPOWER can then be used in GENESYS as described in the previous section using "WSP:Simulations\EM1\EMPOWER.SS". The circuit on the right uses the resulting data in a complete network. First, a THR (three-port data) device was placed on the blank schematic, using the EMPOWER.SS file from the EMPOWER run. An input and output were added on nodes one and two of the THR block, the ground was added to the ground node, and a capacitor was connected from port 3 to ground.

This has the effect of putting the capacitor across port 3 in the EMPOWER simulation. The rules to follow for "Along X" and "Along Y" internal ports are simple:

- Do not attempt to use them for transistors or other 3-terminal (or more) devices.
- Set the Current Direction of the EMPort to "Along X" (along the x-axis) if the current along the component flows from left to right, as on the layout on the left above. Set the Current Direction of the EMPort to "Along Y" (along the y-axis) if the current along the component flows from top to bottom, as if the capacitor were turned 90 degrees from the one on the layout above.
- Connecting a lumped element from the port to ground when you use the resulting data is equivalent to connecting the lumped element accross the length of the port in the layout. *This does not mean that the component is grounded. It simply means that the component is connected across the port.* This concept is key to understanding X- and Y- directed ports.

When the S-Parameters of MYNET are displayed in a graph, you see the resulting S-Parameters of the entire circuit..

Resonance

Often, when a circuit contains lumped elements, you can use very few frequency points for the EMPOWER runs. Since the lumped elements are not included in the EMPOWER data, there are generally many fewer resonances, and the data interpolates much more accurately. In this case, you may want to only use 2 or 3 points in the electromagnetic analysis while showing the results of the entire network with 100 points or more (specified in the Co-Simulation Sweep in the EMPOWER Options Dialog box).

For a complete example which takes advantage of this property, see the Narrowband Interdigital example.

EMPOWER: Box Modes

Overview

A fully enclosed rectangular box acts as a cavity resonator. At frequencies near each resonance mode significant coupling exists between the desired signal metalization and the cavity. Because this coupling is reciprocal coupling occurs between segments of the signal metalization. This is nearly certain to perturb the circuit responses as the operating frequency approaches or exceeds the first resonant frequency of the cavity. While EMPOWER inherently predicts these effects, they may have a significant destructive effect on the performance of your designs. Box modes are clearly illustrated in this example.

Homogeneous Rectangular Cavity

In the formulation which follows we use definitions from the section on Geometry. The height of the box in the z direction is h, the length of the box in the x direction is a and the width of the box in the y direction is b.

The resonant wave number for a rectangular cavity is

$$k_{mnp} = \left[\left(\frac{m\pi}{a} \right)^2 + \left(\frac{n\pi}{h} \right)^2 + \left(\frac{p\pi}{b} \right)^2 \right]^{\frac{1}{2}}$$

(MKS units) and the resonant frequency when homogeneously filled with material with a relative dielectric constant of e_r is

$$f_{mmp} = \frac{k_{mmp}c}{2\pi \sqrt{\varepsilon_r}}$$

where c is the velocity of light in a vacuum, $2.997925 \times 10^8 \text{m/sec}$. The frequency of the dominant mode is f_{101} (lowest resonant frequency) and in a vacuum we have

$$f_{101} = \frac{c}{2} \sqrt{\frac{1}{a^2} + \frac{1}{b^2}}$$

In air, with linear dimensions in inches and the frequency in megahertz

$$f_{101} = 5900 \, MHz \bullet inches \sqrt{\frac{1}{a^2} + \frac{1}{b^2}}$$

With linear dimensions in millimeters and the frequency in gigahertz

$$f_{101} = 149.8GHz \bullet mm \sqrt{\frac{1}{a^2} + \frac{1}{b^2}}$$

For example, in air (er=1.0006) with a 2'4 inch, 0.5 inch high box, b=101.6mm, a=50.8mm and h=12.7mm. Then k_{101} =69.14 and f_{101} =3297 MHz.

Higher Order Box Modes

It is interesting to note that if b < a and b < b then the frequency of the dominant mode is not a function of the cavity height. This is not the case for certain higher order modes. The mode which is next higher in frequency than the dominant mode is a function of the relative values of b, a and b.

Consider for example the previous 2x4x0.5 inch box (or, any size box with the size ratios b=2a and b=I/4). Therefore the wave numbers are

$$k_{mnp} = \frac{\pi}{a} \sqrt{\left(m^2 + 16n^2 + \frac{p^2}{4}\right)}$$

The wave numbers for the lowest frequency modes for this shape box and the resonant frequencies with a=2 inches are listed here:

Mode	Wave #	Freq (MHz) @ a=2 inches
101	1.118pi/a	3299
102	1.414pi/a	4173
103	1.803pi/a	5319
201	2.062pi/a	6083
104	2.236pi/a	6598
105	2.693pi/a	7945
301	3.041pi/a	8974
106	3.162pi/a	9331

Notice that higher order modes occur frequently after dominant mode resonance. It is possible to minimize perturbations in narrowband applications by operating between resonant frequencies. However, the above analysis assumes a pure homogeneous rectangular cavity and dielectric. Partial dielectric loading and signal metal within the cavity will influence the frequency. A more conservative and safer approach is to enclose the circuit in a box with the dominant resonant mode higher than the highest frequency of interest.

Partial Dielectric Loading

If the cavity is not homogeneous, but instead is partially filled with a dielectric and the remainder of the cavity is filled with air then the dominant mode resonant frequency is reduced and may be approximated using a filling factor [Johnson, 1987]. Assuming the substrate is mounted on the floor of the cavity, the resonant frequency of a partially filled rectangular cavity, *fpartial*, is

$$t_{partial} = t_{101} \sqrt{1 - \frac{\varepsilon_r - 1}{\varepsilon_r} \left(\frac{t}{h}\right)}$$

where t is the thickness of the substrate and h is the height of the cavity without a substrate. For example, f_{101} for the 2x4 inch box is reduced from 3299MHz to 3133MHz with t=62mils and e_r =4.8.

This expression is approximate because the electric field lines are not parallel to the z axis and a component of these lines terminate on the side walls. This mode is referred to as a quasi- TEM_{101} mode.

Signal Metal Effects

Relatively sparse signal metal has little effect on the resonant frequency. Larger metal segments, particularly when grounded, significantly reduce the resonant frequency. To obtain a feel for the significance of signal metal you may add extraneous metal to the substrate in Example 10, Box Modes, and observe the shift in the transmission peaks.

Top Cover

Transmission line discontinuities disturb current flow and energy is lost from the transmission structure. While this lost energy is typically small, the Q of the resonant cavity is high and coupling at these frequencies is significant. Removing the cover of the enclosure causes energy to be lost to free space and resonance effects are reduced. This greatly reduces coupling between metal segments of the circuit and it is evident in the responses given in the Box Mode example cited earlier with the cover removed. Effects of removing a top cover are illustrated in the Examples Filters\EdgeCoupledOpen.WSP" and "Components\Box Modes.WSP". See your Examples manual for details.

Cavity Absorber

A similar benefit may be derived by placing absorber material on the cover or in the cavity. While the poor ultimate rejection in the stopbands of filters is not recovered, heavy coupling between segments is avoided. This is sometimes necessary to eliminate oscillations of high gain amplifiers in oversize enclosures.

By far the most elegant and safest approach to minimizing box mode problems is placing circuits in small enclosures.

EMPOWER: Viewer and Antenna Patterns

Overview

This section describes how to launch the EMPOWER viewer program and how to use it to visualize and interpret currents (or voltages) generated by EMPOWER. It also describes the viewer interface.

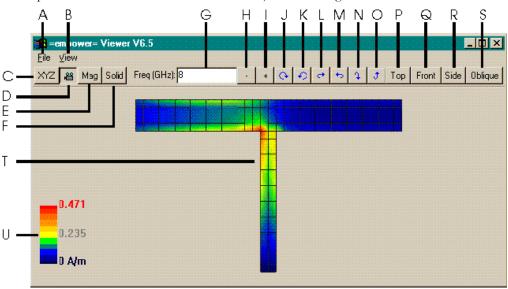
The EMPOWER viewer helps you visualize current distribution and densities in a board layout. It processes current density magnitude and angle and plots them as two or three dimensional static or dynamic graphs. These plots provide insight into circuit behavior and often suggest modifications which improve the performance. Most electromagnetic simulators include visualization tools. The EMPOWER viewer has distinct advantages such as three dimensional graphs, true animation capabilities, and precise information about current phase. The full potential of the EMPOWER viewer is realized with practice so we encourage you to investigate your circuits with the viewer and reflect on the results you observe.

The viewer is started by selecting Run Viewer from the right-click menu of an EMPOWER simulation (Workspace Window in GENESYS)

Interface

This section describes the viewer menu items and buttons. It can be used to become acquainted with the interface in general as well as as a reference section.

A sample viewer screen is shown below. The objects in this figure are described below.



A - File Menu

Open - Opens a new viewer data file.

Exit - Exits the viewer.

<u>Toggle Background Color</u> - Toggles the background from black to white, or white to black. A white background is normally selected before a screen or window print.

<u>Print Screen</u> - Sends a copy of the entire screen to a bitmap file or to a printer.

<u>Print Window</u> - Sends a copy of the viewer window to a bitmap file or to a printer.

B - View Menu

The objects in this menu affect how the current image is displayed.

<u>Top (Home)</u> - Shows a top-down view of the current image. This option can also be selected by pressing Home.

Front (Ctrl+Home) - Shows a "front" view of the current image. This view is from the y-axis, at z=0. This option can also be selected by pressing Ctrl+Home.

Side (Ctrl+End) - Shows a "side" view of the current image. This view is from the x-axis, at z=0. This option can also be selected by pressing Ctrl+End.

Oblique (End) - Shows an oblique view of the current image. This view is top-down on the x-y plane with a slight offset. This option can also be selected by pressing End.

Rotate - The objects in this sub-menu rotate the current image.

<u>Rotate - Left (Left Arrow)</u> - Rotates the current image clockwise in a horizontal plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

<u>Rotate - Right (Right Arrow)</u> - Rotates the current image counter-clockwise in a horizontal plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

<u>Rotate - Up (Up Arrow)</u> - Rotates the current image forward in a vertical plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

<u>Rotate - Down (Down Arrow)</u> - Rotates the current image backward in a vertical plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

<u>Rotate - Clockwise (PgDn)</u> - Rotates the current image clockwise in the plane of the screen. The center of the viewer image window is always the center of rotation. This option can also be selected by pressing Page Down.

<u>Rotate - Counter-Clockwise (PgUp)</u> - Rotates the current image counter-clockwise in the plane of the screen. The center of the viewer image window is always the center of rotation. This option can also be selected by pressing Page Down.

Pan - The objects in this sub-menu shift the apparent location of the viewer window relative to the current image.

<u>Pan - Left (Ctrl+Left)</u> - Moves the viewer location to the left (relative to the current image). This moves the image to the right in the viewer window.

<u>Pan - Right (Ctrl+Right)</u> - Moves the viewer location to the right (relative to the current image). This moves the image to the left in the viewer window.

<u>Pan - Up (Ctrl+Up)</u> - Moves the viewer location up (relative to the current image). This moves the image down in the viewer window.

<u>Pan - Down (Ctrl+Down)</u> - Moves the viewer location down (relative to the current image). This moves the image up in the viewer window.

<u>Pan - Zoom In (Ctrl+PgUp)</u> - Moves the viewer location closer to the current image. This increases the size of the image in the viewer window.

<u>Pan - Zoom Out (Ctrl+PgDn)</u> - Moves the viewer location away from the current image. This decreases the size of the image in the viewer window.

Toggle - The objects in this sub-menu toggle the available options listed below.

<u>Toggle - Absolute Value Display</u> - When selected, the viewer displays absolute values only. If not selected, an actual value with information about flowing direction is displayed. The difference is that absolute value is always positive, whereas the actual current values can be positive for forward directed currents and negative for backward directed currents. Negative amplitudes are drawn below the x-y plane. This option has a checkmark beside it when selected.

<u>Toggle - Animation</u> - When selected, the viewer "animates" the image in real or angle mode. This is accomplished by multiplying the individual currents by exp(jw), where w cycles from 0 to 2pi and showing a sequence of snapshot images for increasing w. This option has a checkmark beside it when selected.

<u>Toggle - Scale</u> - When selected, the viewer displays the scale in the lower-left of the viewer window. This option has a checkmark beside it when selected.

<u>Toggle - Value Mode (Real,Mag,Ang)</u> - This option selects the current display option. The options include the Real current value for current distribution snapshots and animation, Magnitude for time averaged current values, and Angle for the current phase delay distribution snapshots.

<u>Toggle - Wireframe</u> - When selected, the viewer displays a wireframe version of the current plots. A wireframe is created by drawing the outlines of the EMPOWER grid currents without filling the resulting polygons. When this option is not selected, the viewer fills the polygons, resulting in a solid surface plot of the current patterns. This option has a checkmark beside it when selected.

<u>Load - From User View #(1-10)</u> - Loads the previously saved viewer settings for the selected view #. Saved settings can also be restored by pressing the number key corresponding to the desired setting #.

<u>Save - To User View #(1-10)</u> - Saves the current viewer settings into the selected view #. The settings can be restored later by selecting the desired # from the load sub-menu described above. The options in this menu can also be selected by pressing Shift + the number key corresponding to the desired save #.

Tip: The save and load functions are extremely useful. If you rotate and pan to a view that you like, press Shift plus a number (not an arrow) to save that view. Simply press the number by itself to return to that view. These views are remembered even if you exit the viewer, so you can easily store your favorite views.

C-X/Y/Z/XY Button

Pressing this button toggles between the four possible modes:

- X Displays the x-directed current density distribution.
- \underline{Y} Displays the y-directed currents density distribution.
- Z Displays the z-directed currents.
- XY Displays additive surface current density distribution function.

D - Animate Button

This button toggles viewer "animation" on the current image. When this option is selected, the button appears pressed. The viewer animation is accomplished by multiplying the individual currents by exp(jw), where w cycles from 0 to 2pi and plotting snapshot graphs for sequential time moments. What is animated is controlled by the Display Option Button (see E below).

E - Display Option Button

This button selects the current display option.

- <u>Real</u> Displays the real portion of the current values.
- Mag Displays the magnitude or time averaged values of the currents.
- Ang Displays the phase delay of the current values.

F - Solid/Wire Button

This button toggles the type of surface plot to display.

<u>Wire</u> - Displays a wireframe version of the current patterns. A wireframe is created by drawing the outlines of the EMPOWER grid currents without filling the resulting polygons.

<u>Solid</u> - Displays a solid surface plot of the current patterns. This is created by filling the wireframe polygons.

G - Freq (GHz)

This box shows the simulation frequency (in GHz) for which the current image data is being displayed. This box is restricted to frequencies that EMPOWER has created data for. The value can be increased by clicking the "+" button (see I below), and decreased by clicking the "-" button (see H below).

H - Decrease Frequency Button

Decreases the current frequency (see G above). If you are already at the lowest calculated frequency then this button has no effect.

I - Increase Frequency Button

Increases the current frequency (see G above). If you are already at the highest calculated frequency then this button has no effect.

J - Clockwise Button

Rotates the current image clockwise in the plane of the screen. The center of the viewer image window is always the center of rotation. This option can also be selected by pressing Page Down.

K - Counter-Clockwise Button

Rotates the current image counter-clockwise in the plane of the screen. The center of the viewer image window is always the center of rotation. This option can also be selected by pressing Page Down.

L - Rotate Right Button

Rotates the current image counter-clockwise in a horizontal plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

M - Rotate Left Button

Rotates the current image clockwise in a horizontal plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

N - Rotate Down Button

Rotates the current image backward in a vertical plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

O - Rotate Up Button

Rotates the current image forward in a vertical plane perpendicular to the screen. The center of the viewer image window is always the center of rotation.

P - Top Button

Shows a top-down view of the current image. This option can also be selected by pressing the Home key.

Q - Front Button

Shows a "front" view of the current image. This view is from the y-axis, at z=0. This option can also be selected by pressing Ctrl+Home.

R - Side Button

Shows a "side" view of the current image. This view is from the x-axis, at z=0. This option can also be selected by pressing Ctrl+End.

S - Oblique Button

Shows an oblique view of the current image. This view is top-down on the x-y plane with a slight offset. This option can also be selected by pressing End.

T - Current Plot

Shows the color-coded current patterns for the loaded EMPOWER generated viewer data file. The menus and toolbar buttons control how this image is displayed.

U - Color Scale For Current Plot

This scale shows the relative current and current density magnitudes based on the color used to draw the plot patterns.

Far-Field Radiation Pattern Viewer

The EMPOWER far-field radiation data describes the electric field patterns in the far-zone region radiated from a structure. The far-zone is defined as the region where $2\pi R/\lambda$ >> 1, where R is the distance from the structure and lambda is the wavelength of the signal exciting the structure. Far-field radiation patterns are described in the spherical coordinate system, where phi is the angle on the xy plane from the positive x-axis, and theta is the angle from the positive z-axis. The distance is not specified since it is assumed to be in the far-zone.

Assumptions Made when Generating Far-Field Radiation Data

Data for radiation in the far-field is generated using equations that make simplifying assumptions about the layout of the structure. It is, therefore, necessary to take these assumptions into account and follow them to get accurate solutions:

- The walls of the box are assumed to be infinitely far away from the structure.
- If a substrate is used, it is also assumed to extend infinitely in the lateral dimensions.
- Fields generated from z-directed currents are not taken into account, therefore it is not recommended that you include vias in the layout.

Setting Up the EMPOWER Box

To get good results for the far-field radiation patterns, the following rules must be observed:

- The structure should be centered in the box.
- The walls of the box should be far away from the structure.
- Only one layer of metal must be used.
- Exactly one substrate or an Air-Below layer must be under the metal layer, not both.

There are 3 different antenna types for which far-field radiation patterns can be generated:

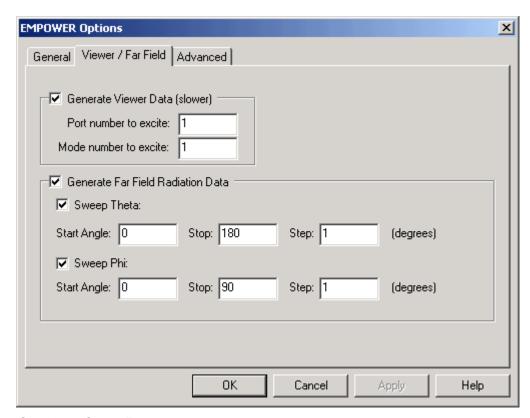
Antenna in free-space

- Antenna above a ground plane
- Microstrip antenna above a substrate and ground plane

To simulate an antenna in free space, no substrate should be used and the only layer below the metal layer should be Air-Below. The height of the Air-Below layer in this case is irrelevant. Both the Top Cover and Bottom Cover should be set to Electrical type, with surface impedance set to 377 ohms. (377 ohms is the intrinsic impedance of free-space).

To simulate an antenna above a ground plane with no substrate, the Air-Below layer should be set to the height the antenna is to be above the ground plane. The Bottom Cover should be set to Lossless type, and the Top Cover should be set to Electrical type, with surface impedance set to 377 ohms.

To simulate a microstrip antenna, the Air-Below layer should not be used. The substrate layer, instead, should be used. The Bottom Cover should be set to Lossless type, and the Top Cover should be set to Electrical type, with surface impedance set to 377 ohms.



Specifying Sweep Parameters

In order to generate far field radiation data, Generate Viewer Data (slower) and Generate Far Field Radiation Data must be checked. You may then select either Theta, Phi, or both, to

Simulation

be swept. Data is generated for all points between Start Angle and Stop Angle for both Theta and Phi, with a step size specified in the Step field. All angles are in degrees.

In the above figure, data is being generated sweeping both Theta and Phi. Theta is being swept from 0 to 180 degrees in 1 degree increments, while Phi is being swept from 0 to 90 degrees, also in 1 degree increments.

Measurements and Plotting

Once far-field radiation data is generated, the following measurements can be plotted:

ETHETA(*phis, thetas, freqs*) - the theta component of the total electric field. *Phis, Thetas*, and *freqs* can either be single values or ranges of values.

EPHI(*phis, thetas, freqs*) - the phi component of the total electric field. *Phis, Thetas*, and *freqs* can either be single values or ranges of values.

ETOTAL(*phis, thetas, freqs*) - the magnitude of the total electric field. *Phis, Thetas*, and *freqs* can either be single values or ranges of values.

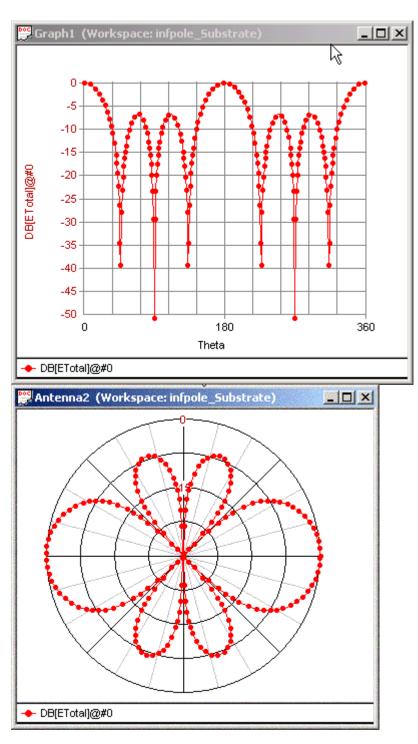
ELHCP - E-field Left Hand Circular Polarization

ERHCP - E-field Right Hand Circular Polarization

EAR - E-field Axial Ratio

The measurement wizard can be used to to select these measurements, and the proper syntax is automatically generated.

Rectangular, Antenna (Polar), and 3D charts may be generated to display the antenna data. Only one variable out of Phi, Theta, and Frequency may be swept when displayed on the two-dimensional charts, and two variables may be swept when displayed on the 3D chart. Below is both a rectangular and Antenna plot (polar) of the ETOTAL measurement, where Theta is being swept from 0 to 360 degrees, Phi is held constant at 0, and the frequency is held constant. This particular antenna is a very small dipole located one wavelength above a ground plane, on top of a substrate.

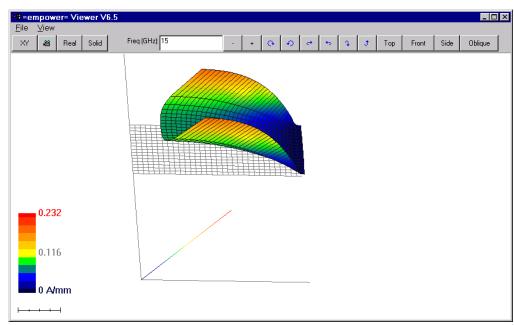


Examples

This section illustrates the use of the EMPOWER viewer using a number of examples. The WSP files for the examples are located in the VIEWER subdirectory in the GENESYS examples. You should load them as you follow along.

The viewer displays current distributions as two or three dimensional graphs. The viewer has several modes that are used to view various components of the currents from different view perspectives. The best view of most problems is often found by minor adjustments of the view orientation. The following examples include a few examples of such adjustments. The examples are simple problems selected because the results are predictable. Nevertheless, they are interesting and illustrate concepts which may be applied to more complex problems.

Consider the possible graphs for a simple line segment analysis. The schematic file for this example is METR16.WSX. It contains description of a segment of the 50-Ohm standard stripline [Rautio, 1994] that is also discussed in the Examples Chapter. The segment is 1.4423896 mm wide by 4.996540 mm long and the box size along the z-axis is 1 mm. The segment length is 90 degrees at 15 GHz and 180 degrees at 30 GHz. Load METR16.WSP in GENESYS. Run the viewer by selecting "Run EMPOWER Viewer" from the right-click menu of Simulation "EM1". The default plot seen in the main window is an animated surface electric current density distribution function reflecting the surface currents in the strip plane. At the initial time t=0 it will look similar to the graph shown below.



To get this snapshot we stopped animation by clicking the Animation camera icon, adjusted the view slightly, and toggled the background color to white. To obtain this view,

simply press the Oblique button on the toolbar after starting the viewer. All other settings are the default:

- Show XY current density distribution (XY/X/Y/Z button).
- Show Real part of the current density distribution (View Menu/Switches/Value Mode or Value Mode button).
- Show Absolute values of the current density quantities (View Menu/Switches/Absolute Value Display).
- Animation is off and time is set to initial (View Menu/Switches/Animation or Animation Camera button).
- Scale is on (View Menu/Switches/Scale)
- Solid polygons view (View Menu/Switches/Wireframe or Solid/Wire button)

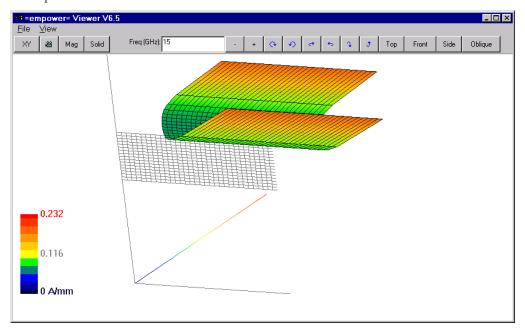
Note: For printing, Toggle Background Color from the File menu was also used to change the background to white. To reset the time to zero, the animation was turned off, and the Real/Mag/Angle button was clicked three times, returning the mode to real but resetting the time.

The resulting picture in the main viewer window is a 3D plot of the surface current density shown with the grid generated to solve the problem. The axes in the metal plane (grid plane) correspond to the X and Y axes in the box. The origin of the coordinates X and Y correspond to the geometrical origin of the box, (0,0) in LAYOUT. The z-axis perpendicular to the metal plane corresponds to the plotted current/voltage values. The red color on the axis is for high values and dark blue is for zero. The color coded scale makes it possible to evaluate actual values of current density. The plotted values are an additive function of interpolated X- and Y-components of the current density. The current components are calculated along the cell sides, not at the corners of the cells. The X and Y current components are interpolated to the grid corners and are then added.

The X-Y current display provides general insight into circuit behavior. Again consider the view given above. The dominant eigenwave of the stripline is excited at the left input of the structure. Observe the typical current distribution in the cross section X=0 (click the side view button for a better look at this). At this time the current declines to almost zero at the right output (click the Front view button). This confirms a line length of 90-degrees. Next, animate the response by clicking on the Animate button again. Notice how the dominant stripline wave propagates in the structure. The animation is a simple set of snapshots for the subsequent time moments. The time will vary between zero and the period of the incident wave (1/f seconds).

The previous example illustrates the propagation of the wave. For simple evaluation of the high and low current density region the time average values of the current density is more practical. To obtain this plot switch to Magnitude mode by clicking on the Real button. The viewer in this mode is shown below. The results are as expected for a transmission line segment. The current density is highest at the edges and lowest in the middle. Note that the absolute values of the current density at the edges are greatly affected by the grid

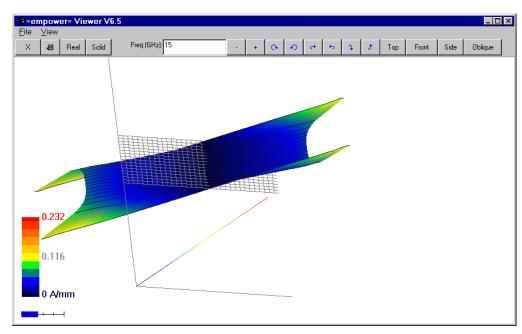
cell size used. A smaller grid cell size increases the edge current density. However, integrated values of current density are nearly invariable, as they should be [Mexiner, 1972]. If the exact current density values are required we recommend choosing a grid cell size equal to the metalization thickness.



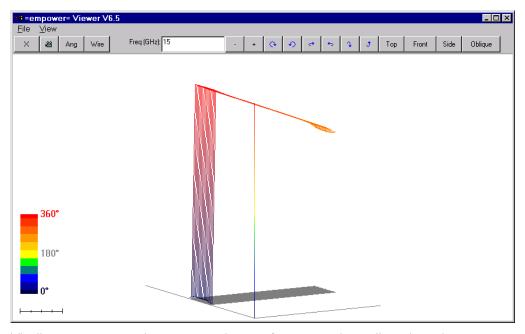
To investigate the various current components you may switch from the XY mode to the X mode (XY/X/Y/Z button). You see only a small change in the graph because the current flows primarily along the line segment as expected. Note however, the component visualization modes (X, Y or Z) are more accurate because the values displayed correspond directly to the values calculated by EMPOWER; no interpolation is necessary for these modes.

The absolute value of the current density is currently displayed. Switch to the Real mode using the menu: **View Menu/Switches/Absolute Value Display** and select **Real** mode. Animation should be turned on also (Animation camera button). A snapshot of the plot is shown below. The Real mode displays both current density values and direction. Current flows in the positive X direction if the displayed values are above the metal layer (the color coded axis direction). The current flows in the opposite direction if the displayed values are below the metal plane.

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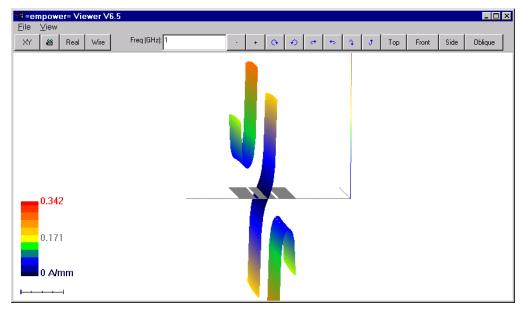
To obtain even additional insight the phase of the signal along the line may be displayed. Stay in X component mode, turn off animation, and switch to the Angle mode by clicking the Display Option button until it reads Ang. You may view the wireframe mode by clicking the Wire/Solid button until it reads Wire. At the initial time t=0 and with a matching rotation you will a display similar to the one below. It displays delay of the current densities along the structure in terms of a complex vector rotation angle. 360 degrees of phase corresponds to a one wavelength delay period. The difference of the current phases at the input and output again confirms a 90 degrees line segment.



The line segment example was prepared at two frequency points. All graphs and explanations given here used the first frequency point 15 GHz. The second point is 30 GHz and the corresponding segment length is a half of the wavelength. You may display results at 30 GHz by clicking the + button and then choosing the views of your choice.

MultiMode Viewer Data

This example illustrates the eigenwave multi-mode excitation capabilities of EMPOWER. A three conductor coupled microstrip line segment from [Farr, Chan, Mittra, 1986] is described in the schematic file LNMIT3.WSP. Three microstrips are 1 mm wide and 0.2 mm apart. They are on a 1 mm substrate with relative permitivity of 10. The segment is 8 mm long. The structure has three modally coupled inputs at opposite segment sides. We expect at least three propagating modes. Load the example in GENESYS. The listing file (Right-Click on the EMPOWER simulation in the Workspace Window and select "Show Listing File") gives information about the propagating waves. The first eigenmode is an even mode with integral current distribution pattern +++, the second eigenmode is odd (pattern +0-), and the third one is again even (pattern +-+). To excite the odd mode as an example, select Generate viewer data and enter 2 in the "Mode Number to Excite" box of the EMPOWER properties dialog. Run the viewer. A snapshot of the calculated current density function is shown here. You must turn "Absolute Value Display" off (View Menu/Switches). All settings except two are the same as in the previous example. The initial view was set to the side view (View Menu/Side or Side button), and the polygon view was set to wireframe (View Menu/Switches/Wireframe or Solid/Wire button).



The plot confirms that this is an odd mode and shows the typical current density distribution. If currents on the left strip flows in the forward direction, the currents on the right strip flow in the backward direction and the center strip currents flow in opposite directions at the opposite strip sides. For a dynamic view, turn on the animation and rotate the plot for a better view of the propagating wave.

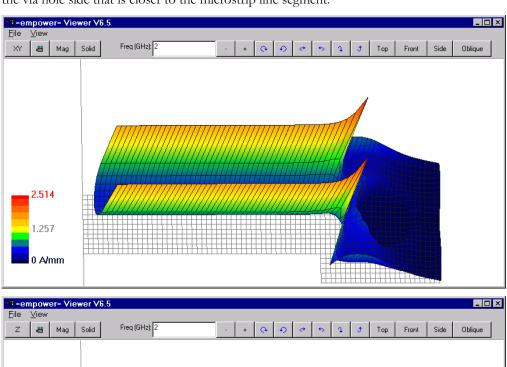
To calculate the viewer data for the other eigenwaves run EMPOWER and the viewer twice more with "Mode Number to excite set to 1 and 3. Note that newly calculated data will overwrite the previous ones. To avoid this and to keep viewer data for all excitation experiments you need to save a copy of the existing workspace (LNMIT3.WSP in this case) before the next run.

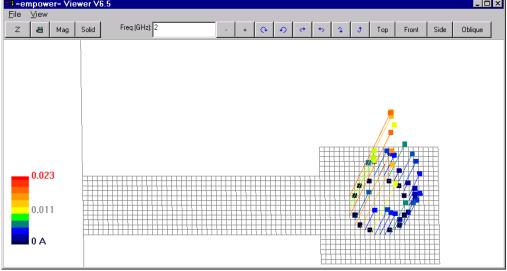
Via Hole Viewer Example

The last visualization example shows a structure with non-zero X, Y, and Z current components. A segment of microstrip line terminated by a via hole from [Swanson, 1992] is described in the file VIA.WSP. The line is 12 mil wide and is terminated by a metal square 24 by 24 mil with a 13 mil diameter circular via hole in the center. The substrate height is 15 mil and the relative permitivity is 9.8. The box size is 120 by 120 mil. Load this example in GENESYS and run the EMPOWER viewer. The first figure below shows the time averaged plot (View Menu/Switches/Value Mode or Value Mode button) for additive (XY) current density distribution. The view point is the oblique view with a few minor adjustments. The plot shows how the dominant microstrip line mode currents spread across the square metal pad. You can see the typical peaks in the current density function in the vicinity of the metal internal corners where the surface current changes flowing directions. Toggling to the X and Y components of the current (XY/X/Y/Z button), you can investigate how the surface currents change direction in different parts of the structure. Switching to the Z-current visualization mode will show a plot like the

Simulation

second figure below. Note that the scale for the Z-directed currents is in Amperes and not current density. Each current represents a volume current density integrated across the grid cell. They are shown as lines connecting the corresponding geometrical point in the grid plane and the point corresponding to the actual current values. If a via hole surface shape is known, using the current in Amperes it is possible to estimate a current density on the via hole surface. It is obvious from the picture that the current density is higher on the via hole side that is closer to the microstrip line segment.





Viewer Theory

The EMPOWER viewer is a program designed to read, to process and to visualize the current distribution data created by EMPOWER. To obtain a current distribution inside a structure the excitation condition must be defined. This mirrors a real measurement where there are incident and reflected waves. The viewer depicts the case with one incident wave at one input. The excitation conditions are passed to EMPOWER in the command line when running EMPOWER text files. When EMPOWER is launched from GENESYS the excitation conditions are automatically defined from the EMPOWER Setup dialog box when the Generate Viewer Data check box is active. If Generate Viewer Data is selected, the default incident wave is the first eigenwave of the first input. The input number can be changed in the Port number to excite box of the EMPOWER Setup dialog, and the input mode number can be changed in the Port mode to excite box. The control information about what input and what mode are actually excited in the structure is printed out in the listing file (see "PPLT: Input ___ mode ____ will be incident." in the listing file).

An output binary file with the extension .EMV is created by EMPOWER to pass data to the viewer program. (In a GENESYS Workspace, the internal name of this file is EMPOWER.EMV) An optional self-documented ASCII data file with extension .PLX can also be written for import into other programs.

To understand the viewer, a review of EMPOWER input and mode representations is helpful. A circuit can have external and/or internal inputs. External inputs are transformed to eigenmode space, de-embedded, and normalized to characteristic impedances of eigenmodes. They could be one-mode or multimode (modally coupled) and the incident wave for these inputs can be one of the input eigenmodes. The incident wave is a harmonic function of time. Its magnitude is unity, and it corresponds both to one Watt instantaneous power and 1/2 Watt time averaged power. The initial phase of the incident wave is zero. Other eigenmodes of the structure are terminated by their characteristic impedances and are perfectly matched. It numerically represents a row of the generalized scattering matrix.

The internal ports are often locations where lumped elements will be included by GENESYS.Parameters of the lumped elements are not required for the EMPOWER simulation. Thus internal ports default to 1 ohm normalization. In this case, the viewer data may not be as useful, since the lumped elements are not taken into account by the viewer.

It is also possible to use an internal port as a source of energy to excite a structure. The termination impedance can be specified using the option -NI<n>. In this case, the internal inputs are terminated by virtual transmission lines with the specified characteristic impedance. The unit incident wave is excited at the specified input. Note that if option - NI<n> is used then the external inputs are also terminated by transmission lines (or loads) with this impedance after de-embedding and transformation into the mode space if necessary.

If the excitation conditions are defined, EMPOWER calculates the scattering matrix S with default or defined normalization first. Then it creates an excitation vector A=[0...,1,...,0] that contains only one unit element corresponding to the specified input.

The other elements of the vector are zeros. Reflected waves vector B are calculated from the equation:

$$B = S * A$$

Then the simulator defines normalized voltages and currents in mode space, denormalizes them, and restores the grid currents and voltages inside regions corresponding to all input surface current regions. Finally, using the input region variables, the program calculates non-zero grid currents Ig for strip-like structures or voltages Vg for slot-like structures. The grid currents and voltages are locally defined model currents and voltages (see the Theory section), and their units are Amperes and Volts accordingly. The grid currents and voltages together with their coordinates on the grid are stored in the .EMV file. (The same data can be written in the self-documented text file with the extension .PLX) The viewer reads the .EMV file and to displays data.

Note that the initial current (voltage) distribution is a model representation and is treated using complex number conventions. The currents (voltages) are complex quantities and harmonic functions of time. So, their magnitudes are maximal values for the excited wave period. The real component corresponds to instantaneous values of currents, and their phases reflect the phase delays of currents at the initial time t=0. Using these initial data the current distribution is calculated versus time. If f is the incident wave frequency, the current distribution Ig(t) at time t is given by expression:

$$Ig(t) = Ig(0) \exp(j*2*pi*f*t)$$

The same formula is valid for the voltage distributions. Advancing time displays snapshots of the current or voltage distribution thus animating the display.

As we mentioned above, the viewer reads the grid currents (or voltages) with their coordinates and prepares them for plotting. The preparation stage includes a transformation of the grid variables to more general current density functions (surface electric current density function for strip-like problems or surface magnetic current density function for slot-like problems). The units for the electric current density magnitudes are Amperes per millimeter (A/mm). The units for the magnetic current densities are Volts per millimeters (V/mm). We choose millimeters to scale graphs to more readable values. The current density functions are created only for the currents in the signal or metal layer. Viaholes and z-directed ports are always represented as z-directed currents in Amperes.

Summary

To summarize viewer behavior:

- If **Generate Viewer Data** is selected, the default incident wave is the first eigenwave of the first input.
- Define the input number and mode number in the EMPOWER properties dialog
- An incident wave is a time harmonic function with unit magnitude and zero initial phase.

- The external ports are terminated by corresponding mode characteristic impedances while the internal ports are terminated by 1 Ohm if another termination is not defined by the option -NI<n>.
- The instantaneous power of the incident wave is 1 Watt and time average power is 1/2 Watt.
- Surface current density functions are used for the signal or metal layer and integral currents are used for viaholes and z-directed inputs.

EMPOWER: File Descriptions

Overview

In performing its tasks, EMPOWER creates many different types of files. An understanding these different files is very helpful in understanding the operation of EMPOWER. These files contain the topology of the circuit, external port line data, generalized S-Parameter normalizing impedances, output information, S-Parameter data, batch commands, Y-Parameter data, viewer data, and backup data.

Where are these files?

Starting with Version 2005, GENESYS uses XML storage for its workspace files. The files described in this section are normally stored internally in the workspace. If you need to access these internal files, right-click on the EMPOWER simulation on the tree and select "Write Internal Files". This automatically creates a directory with the same name as the simulation and places copies of the files there.

Note: Previous versions of GENESYS used actual disk files for all internal EMPOWER files, and separate subdirectories were recommended for each circuit. This is no longer necessary for typical usage.

Text Files vs. Binary Files

There are two basic types of data files: text (sometimes called ASCII) and binary. Text files are human readable files. They are universal and can be edited with many different programs such as NOTEPAD. Among the text files used by EMPOWER are batch, topology, listing, and S-Parameter files.

Note: Word processors can also edit text files, however, they will store binary formatting information in the file unless explicitly told not to ("Save as...Text"), so we do not recommend their use for editing text files.

In contrast, binary files are not human readable. They contain information encoded into the numbers which make up the file which are ultimately turned into ones and zeros, thus the name "binary." Unlike text files, binary files are not universal and should only be edited by a program designed for the particular type of binary file you are using. Editing a binary file in a regular word processor or text editor will undoubtedly destroy it! Some

binary files used by EMPOWER and GENESYS are workspace, line, and Y-Parameter files

File Extensions

You can normally tell the kind of file you have by looking at its extension (the part of the name after the last period). Some commonly used extensions include EXE (executable), TXT (text), and HLP (help). Each kind of file used by EMPOWER has its own unique extension. These extensions are shown here. Each of these types will be discussed individually in the following sections.

Note: Unfortunately, Windows can be setup to hide files extensions, as well as actual files, from the user. We would recommend that you turn off this "feature": Double click on "My Computer," Select Options from the View menu, Click the Viewer tab, Click "Show all files," Deselect "Hide MS-DOS file extensions for file types that are registered", and click OK. Different versions of Windows may have slightly different procedures.

Extension	Туре	Purpose
EMV	Binary	Viewer data
L1, L2, etc.	Binary	Port deembedding and line data for port 1, 2, etc.
LST	Text	Listing file summarizing all EMPOWER data
PLX	Text	Text listing of viewer currents.
R1, R2, etc.	Text	Port normalizing impedances
RGF	Binary	Port deembedding and line data for a port with a user-specified deembedding file name.
RX	Text	Frequency vs. impedance data
WSP	Binary	GENESYS Workspace File
SS	Text	S-Parameter results
TPL	Text	"Netlist" for EMPOWER
Y	Binary	Y-Parameter results
~SS, ~RG, etc.	Backup	All files with either a name or an extension starting with tilde (~) are backup files and can be safely deleted.

.EMV (EMPOWER Viewer) Files

Written by: EMPOWER

Type: Binary

Can be safely edited: No

Average size: 10 to 100Kbytes, but may be larger **Use:** Data for viewing currents or voltages

EMV files (EMPOWER Viewer) files are completely self-contained files containing all information needed by the viewer to display currents and voltages for a circuit. These files contain information about the box and the grid mapping of the circuit as well as actual complex current or voltage values at each frequency. EMPOWER creates an .EMV file whenever "Generate Viewer Data" is checked or the -In option is specified.

.EMV files can only be read by the EMPOWER viewer. If you want to generate viewer data for import into other programs, you should generate a .PLX text file. For more information on viewer files, the Viewer section.

.L1, .L2,Ln (Line Data) Files

Written by: EMPOWER

Type: Binary

Can be safely edited: No

Average size: 1 to 5Kbytes, but may be larger

Use: Internal file for EMPOWER but can also be used in the SMTLP and MMTLP

models in GENESYS

EMPOWER must perform a separate line analysis for all external ports. If no filename is specified by the user, then the results from the line analysis are stored in .Ln files. These files also store all information about the box and port and are intelligent: They are only recalculated if necessary, and even then only at frequencies necessary. Even if the circuit changes they are only recalculated if the change affects the line analysis. Notes: When these files are numbered, modally related groups of ports are counted as one. Also, if two ports are identical, then only the first one will create a .Ln file.

.LST (Listing) Files

Written by: EMPOWER

Type: Text

Can be safely edited: Yes*

Average size: 50K to 200K, but may be larger

Use: Gives all calculated data and grid mapping from EMPOWER in human readable

form

This file is overwritten whenever EMPOWER is run. It should be carefully checked whenever a new circuit is analyzed, especially if that circuit was described manually from a text TPL file. The following sections describe the contents of a listing file. Note: Some of the information described below is only output if "Output additional info in listing file" is checked or -La is specified.

QCHK SECTION

This section allows you check the quality of the solution. Entries include:

Min. media wavelength to mesh size ratios - should be at least 20.

<u>Thinning out thresholds</u> - Specifies the maximum number of lines in a row which can be thinned out.

<u>Max box size to media wavelength ratios</u> - If the box is too large, you will have box resonances. If this line ends with an exclamation mark (!), it may be too large. See the Box Modes section for more details.

PACKAGE STRUCTURE

This section is only present when the "Extra Details in Listing File" option is used. It gives a summary of the substrate and metal layers used as well as cell sizes.

MEMORY SECTIONS

Several memory sections throughout the listing file give memory requirements for different parts of the simulation.

MAP OF TERMINALS

This section shows the grid representation of the problem.

SDTC SECTION

Symmetry detection sections specify whether the structure is symmetrical. The symmetry processing additionally shows where any differences occurred and can be very useful in finding out where the structure is not symmetrical. The coordinates specified refer to the terminal map shown above.

LINE ANALYSIS MODE RESULTS

This area of the listing contains sections identical to those described above which pertain to the line analysis. Below these sections you will find a table of line parameters for each frequency. The entries are:

Nm - port number

<u>Type</u> - impedance type, real (re) or imaginary (im). Normal lines should have a real impedance.

Zo (ohm) - Line impedance

<u>Gw(rad/m)</u> - propagation constant

<u>Gw/Go</u> - propagation constant relative to free space

<u>Comp Phase, Compensation Admittance</u> - value of phase and impedance compensation for deembedding.

S-MATRIX TABLES

Each table gives the circuit's s-parameters at one frequency. For normal, non-multimode inputs, as an example, S21 is found in the row with input numbers 2 and 1 (in that order).

.PLX (Current/Viewer Data) Files

Written by: EMPOWER

Type: Text

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Can be safely edited: Yes*

Average size: 200 Kbytes to 2Mbytes, but may vary

Use: Importing current data from EMPOWER into another application, such as Matlab or Excel.

This file contains two tables per frequency, one each for x- and y-directed currents. Each table contains 4 columns containing the x and y coordinates followed by the real and imaginary part for each current. These tables could be edited, but it would be best to leave them alone since they would be very tedious and error-prone to edit them by hand. These files should be very useful in other applications, as the engineers at Eagleware used third party applications to graph currents before our EMPOWER viewer was completed.

.R1, .R2, ... Rn (Port Impedance) Files

Written by: EMPOWER

Type: Text

Can be safely edited: Yes* Average size: 1Kbyte

Use: Read by GENESYS when Generalized S-Parameters are requested

These files contain each port's impedance versus frequency. These ports are read by GENESYS if the keyword GEN is used in place of a termination impedance. The files are formatted just like RX files in GENESYS. GENESYS always requests these files when EMPOWER is run from GENESYS.

Notes: These files are numbered differently than Ln files. When these files are numbered, each port in a related group of ports is counted individually.

.RGF (Line Data) Files

Written by: EMPOWER

Type: Binary

Can be safely edited: No

Average size: 1 to 5Kbytes, but may be larger

Use: Internal file for EMPOWER but can also be used in the SMTLP and MMTLP

models in GENESYS

These files are used in place of .Ln files if a filename was given on the PORT line in the TPL file. When run from GENESYS, this file type is not available; use the .Ln files instead. Otherwise, they are completely identical to the .Ln files described earlier.

.RX (Frequency vs. Impedance) Files

Written by: User **Type:** Text

Can be safely edited: Yes Average size: 1Kbyte

Use: Specifying electrical losses

These files are used to specify the impedance of conductors in ohms per square. These files are used in the EMPOWER layers setup dialog box or in the TPL file. The files are formatted just like RX files in GENESYS.

.SS (S Parameter) Files

Written by: EMPOWER

Type: Text

Can be safely edited: Yes*

Average size: 5 to 50 Kbytes, but may be larger

Use: Contains S-Parameter data calculated by EMPOWER

This file contains the S-Parameter data written by EMPOWER. It is in the industry standard S2P format and can be loaded into most RF and Microwave simulators. Even though these files can be edited, they will be overwritten whenever EMPOWER is rerun.

.TPL (Topology) Files

Written by: User or GENESYS

Type: Text

Can be safely edited: Yes* Average size: 1 to 5Kbytes

Use: Describing circuit to EMPOWER

This file contains a complete description of the circuit to be analyzed by EMPOWER. GENESYS will create this file automatically whenever EMPOWER is run from the EMPOWER menu in GENESYS. Even though this files can be edited, it will be overwritten if EMPOWER is rerun from within GENESYS.

.WSX (Workspace) Files

Written by: GENESYS

Type: Binary

Can be safely edited: Yes, but only using GENESYS

Average size: 10 to 2,000 Kbytes

Use: Contains complete simulation, graph, schematic, and layout information from

GENESYS

Contains a complete GENESYS workspace.

.Y (Y-Parameter) Files

Written by: GENESYS

Type: Binary

Can be safely edited: No

Average size: 2 to 25Kbytes, but may be larger **Use:** Internal data file for EMPOWER

This file contains the calculated Y-parameters before deembedding. If merge (-ME) is specified, the previous data stored in this file is combined with the newly calculated data, and the .SS (S-Parameter) file is rewritten.

~SS, ~RG, etc. (Backup) Files

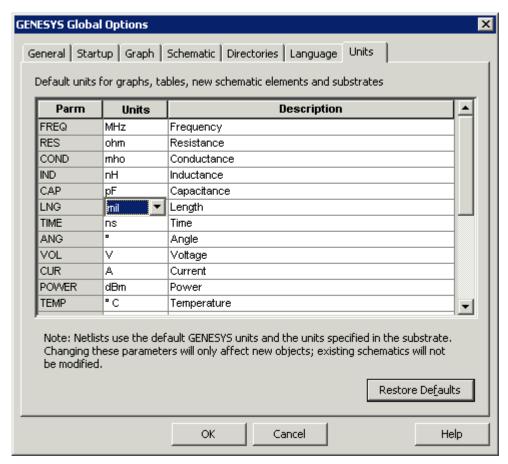
All files with a name or an extension starting with tilde (~) are backup files and can be safely deleted. Examples of these files are ~OMBINE.TPL and COMBINE.~RG.

EMPOWER: Advanced M/FILTER Example

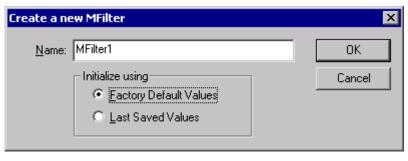
EMPOWER Advanced Example: Filter Synthesis

This advanced example shows how to combine M/FILTER, circuit simulation, and electromagnetic simulation. We will design a bandpass filter with a lower cutoff frequency of 2100 MHz and an upper cutoff frequency of 2300 MHz. We will use the M/FILTER module to design the filter, then we will perform a linear and EM simulation of the filter.

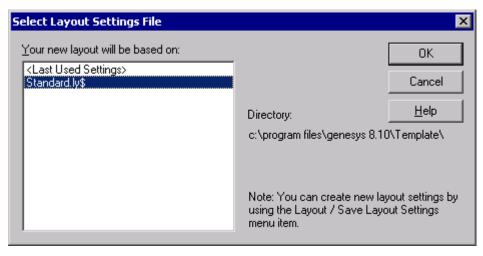
1. First, all units in this example use mils. In order to get the results in this example the default units should be changed to mils. This can be done by selecting 'Tools' and then 'Options' from the main menu then selecting the *Units* tab. Make sure the 'Length' parameter says 'mils' as shown below.



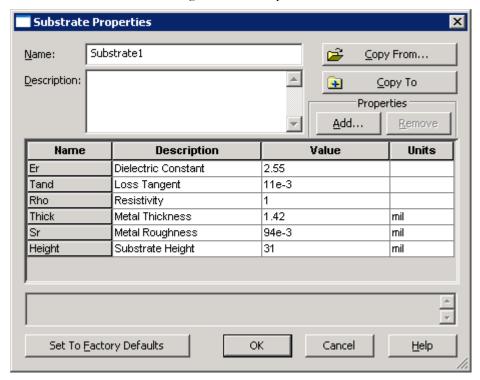
2. Next lets open the Microwave Filter module from the GENESYS tree to start the design process by selecting the New Item button and picking Synthesis / Add Microwave Filter. In the 'Create a new Microwave Filter' dialog box change the 'Initialize using' to 'Factory Default Values' then select OK.



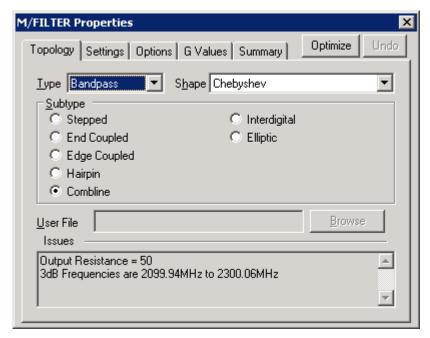
3. Now the user will be prompted for the printed wiring board layer settings in the 'Select Layout Setting File' dialog box. Select 'Standard.ly\$' and then OK.



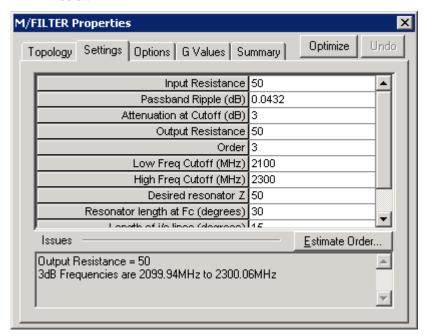
4. It will ask you to specify a substrate. For this example, just choose all default values, set Er=2.55, Height=31mil, and press OK.



5. We want to choose 'Bandpass' as the type and 'Combline' as the Subtype. For this walkthrough we want to use the 'Chebyshev' filter shape. Your topology tab should look like what we have below. NOTE: Ignore locals errors created during this process since the design has not been completed.



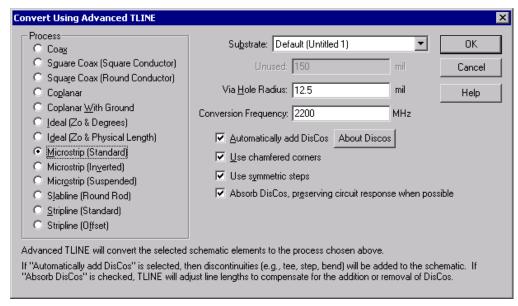
6. The next step is to specify all the filter parameters in the *Settings* tab as we have below.



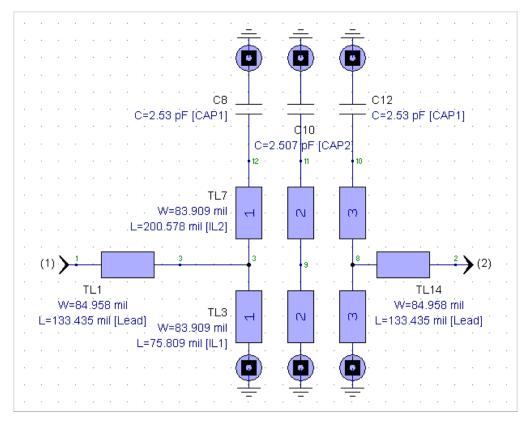
7. Under the *Options* tab we should select the manufacturing process. For this example we will use microstrip (standard) as the Process. The conversion

EMPOWER: Planar 3D EM Analysis

process should look similar to what we have below. Press OK and you should have an schematic that looks like ours (below).



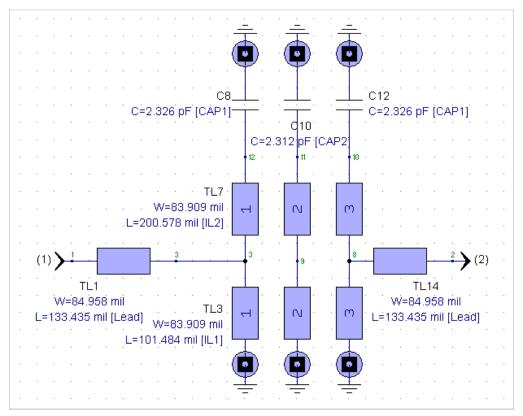
Schematic of the synthesized unoptimized filter:



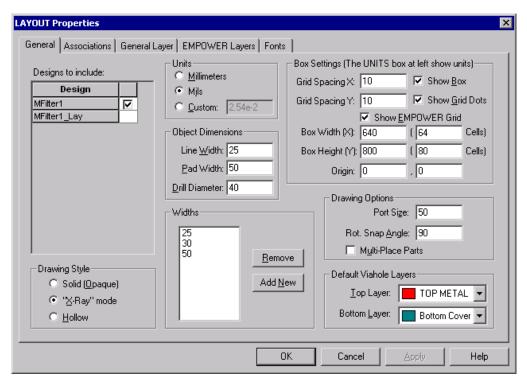
Notice how M/FILTER automatically inserts the discontinuities to model their effect.

8. The next we must optimize this filter by pressing the 'Optimize' button at the top of the MFilter dialog box. This is very important in order to obtain the expected filter performance in this example. After the optimization the schematic should now look as shown below.

Note: You should stop the optimizer by hitting the 'Esc' key once the error value is not improving much.

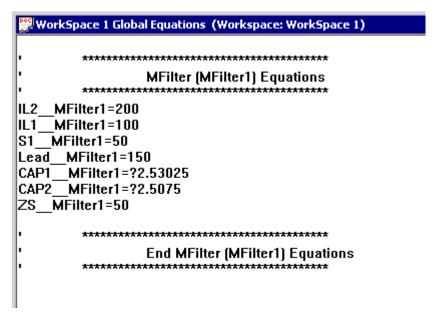


9. Now we need to set the board dimensions and the EMPOWER grid spacing. For this walkthrough we set the Grid Spacing X: 10 and the Grid Spacing Y: 10 and the Box Width (X) to 640 and the Box Width (Y) to 800. The other properties should be set as follows. We have chosen the grid spacing to be 10 because the widths and lengths of the synthesized filter are very close to multiples of 10 mils.

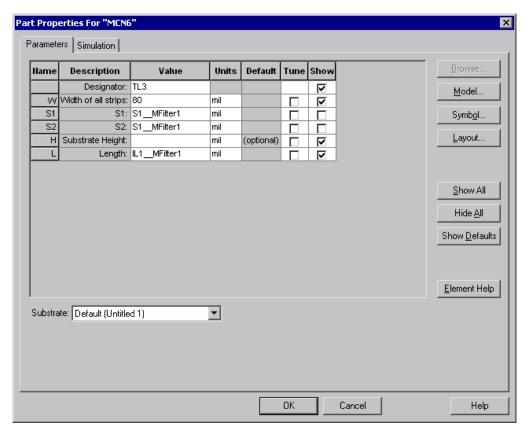


10. Now we need to slightly edit our layout. The ultimate goal is for the resonators dimensions to be an exact multiple of the grid dimensions. In this case the spacing between resonators is very important, therefore we will not change them to much. First we need to change some of the dimensions in the equations block. Change the 'Lead_MFilter1', 'IL2_MFilter1', 'IL1_MFilter1', and 'S1_MFilter1' to the values as show below. Also be sure to remove the question mark since we will not reoptimize the layout dimensions.

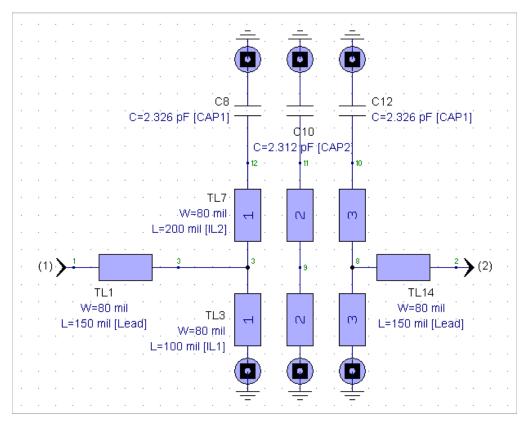
Note: The equation order may appear differently in your example.



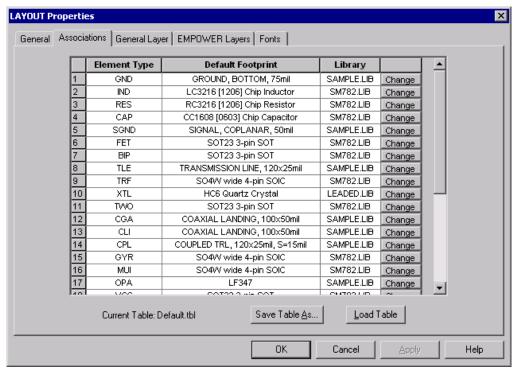
11. Next we need to change the resonator widths for all four transmission lines (TL1, etc.) by double-clicking on each of these schematic elements and changing the "Width" or "Width of all strips" to 80 mils.



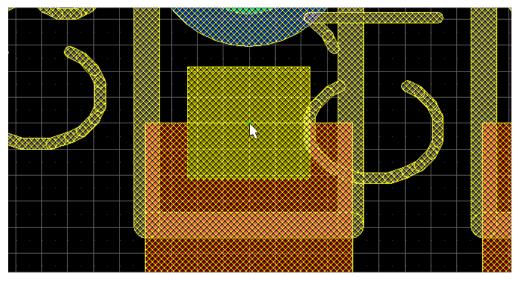
12. The optimized readjusted filter schematic should now appear as follows.



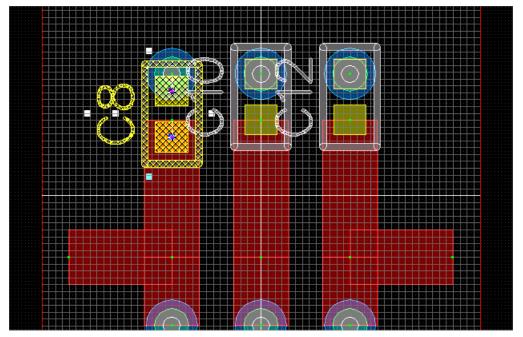
13. You also may need to change the capacitor footprints to 0603, (depending on your default footprints). This can be done by bringing up the 'Layout Properties' by double-clicking the layout background and then selecting the 'Associations' tab. Then proceed to click on the 'Change' button and choose 'CC1608 [0603] Chip Capacitor' from the 'SM782.LIB'.



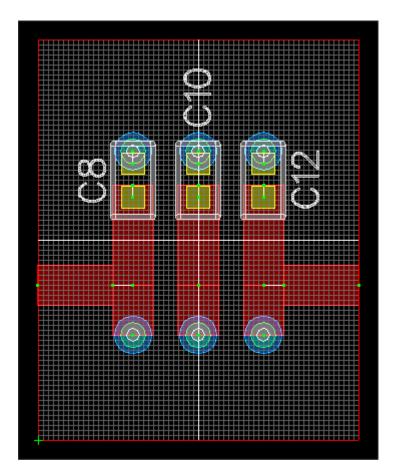
14. The next step is center the components on the PWB. This is done by selecting the 'MFilter1_Lay' Layout window and from the 'Edit' menu select 'Select All'. Then from the 'Layout' menu select 'Connect Selected Parts' and then 'Center Selected on Page'. Then click the zoom maximize button (crossed arrows). The layout should now be centered on the PWB. However, the transmissions lines might not be lined up exactly on grid. These can be placed on grid by placing the mouse over the center of one of the bottom capacitor pads and dragging the entire filter structure up to the nearest grid line (all parts must be selected in order to drag the entire filter).



15. We need to move the capacitor footprints so that the capacitor pads do not extend beyond the length of the resonators. Furthermore, the ground vias should be moved up so the drill hole is at the top of the upper capacitor pad, as shown on the left resonator.



16. Next, we need to change the placement of the input and output lines. We want to pull them away from the center of the resonators to the edge to match the synthesized schematic by using the arrow keys. Your layout should look like what we have below.

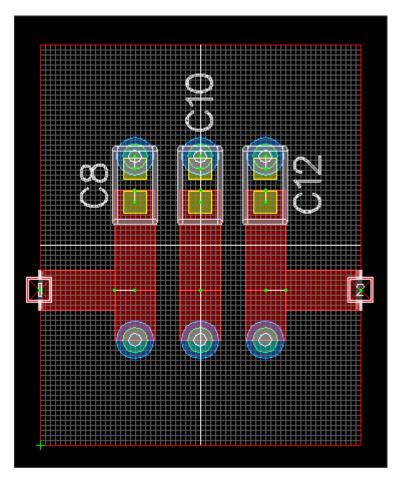


Tip: You can move the designator text, if desired, by grabbing the handle in the middle of the text block.

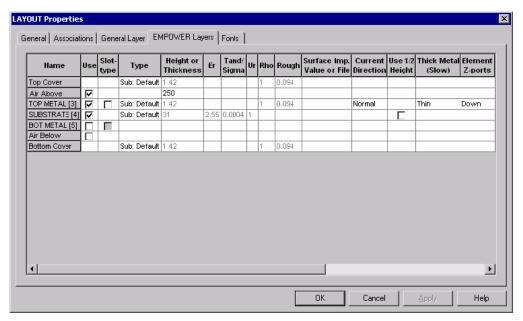
17. Now it is time to add an input and output port. EM ports are found in the GENESYS toolbar (below). The EM ports should line up exactly on the pwb edge and the gray shaded bar underneath the EM port will appear showing that they have been snapped correctly to the top metal layer.



Filter Layout of the schematic:

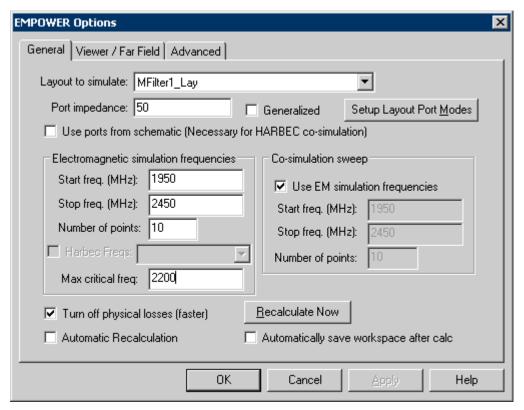


18. Next we need to set the EM layout properties as shown below. This can be done by bringing up the 'Layout Properties' by double-clicking the layout background and then selecting the 'EMPOWER Layers' tab.

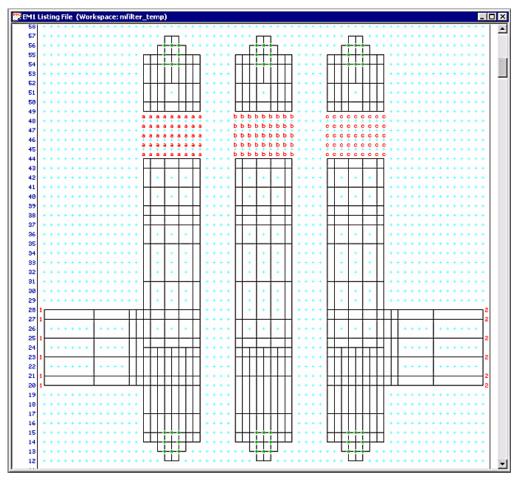


19. The next step is create an EM simulation of the layout. We do this by right-clicking on 'Simulations/Data' folder and selecting "Add Planar 3D EM Analysis". Then you should set up your simulation by changing the number of points. Your EMPOWER options should be setup just like ours below. Pressing "Recalculate Now" will start the EM simulator. This simulation takes a couple minutes on a Pentium III 500MHz CPU with 192MB of RAM.

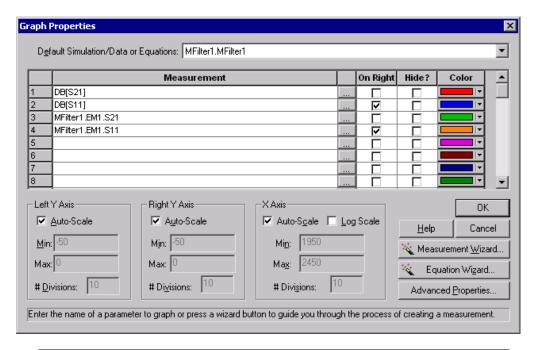
Note: We specified a wider simulation frequencies to get a bigger picture of the response.



20. After the simulation is done, you should first take a look at the Empower Listing file. Right click the Empower simulation titled EM1 (in the workspace tree) and select "Show Listing File". Inspect this file to verify the simulation geometry. As you can see, this listing matches the desired layout:

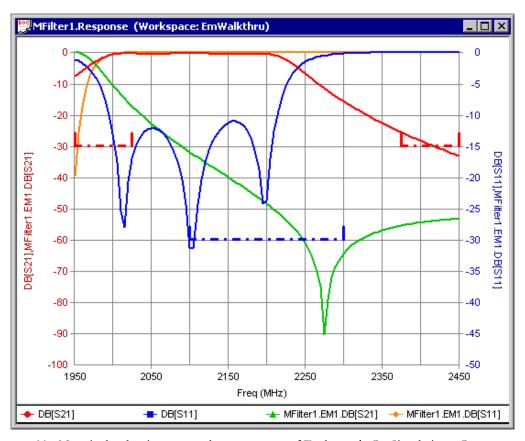


21. Now we would like to see the EM response on the same graph as the linear response to compare the two. We can do this by opening the linear graph's properties (MFilter1.Response) and typing in "MFilter1.EM1.DB[S21]" and "MFilter1.EM1.DB[S11]" on line three and four of the measurements just like it's illustrated below.



Note: You can also use the "Measurement Wizard" instead of manually typing in the measurement.

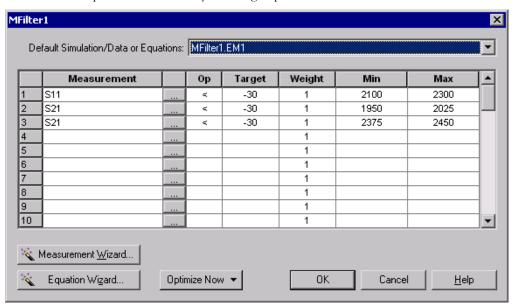
22. Now it's time to analyze what each simulation is showing us. Below is the graph which shows us both linear and EM simulations. Notice how the EM response is slightly down in frequency. The linear simulator does not take parasitic losses and box effects into account like the EM simulator does. The main reason why the EM response is shifted down in frequency is because the footprint pads (for the capacitors) actually add more capacitance to the filter. The filter responses are shown below. The red and blue response is S21 and S11 of the linear simulation, and the orange response is S21 and the green response is S11 of the EM simulation.



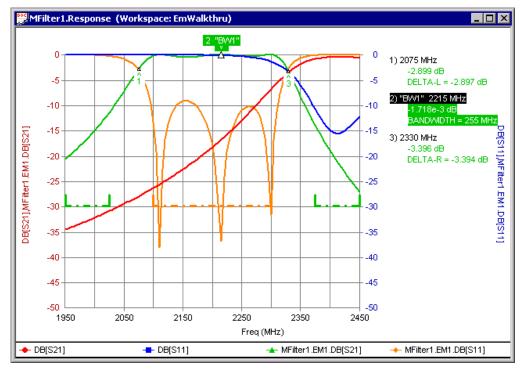
23. Now is the the time to see the true power of Eagleware's Co-Simulation. Co-Simulation allows your to tune your filter in real time without having to re-run the EM simulation. In other words, you are able to tune your capacitor values without re-running EMPOWER! Since the response has shifted down in frequency we will need to decrease the amount of capacitance in all caps. We can manually change the capacitor values by tuning them in the tune window.



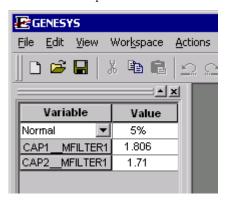
24. However, we can use the optimizer to tune the filter for us. We need to open up the optimization targets titled 'MFilter1' located under the 'Optimizations' folder and change the 'Default Simulation / Data or Equations' to 'MFilter1.EM1'. Then optimize the circuit by selecting 'Optimize Now' and 'Automatic'.



25. The final response of the optimized filter is as shown below. The last step is to press F5 on your keyboard to update the new traces. If you want you can add a bandwidth marker to display the final result.



And the final capacitor values are:



Note that the original linear response is much higher in frequency than the electromagnetic simulation.

EMPOWER: Theory

Overview

This section gives a technical description of the basic EMPOWER algorithms. Unlike most similar tools on the market, EMPOWER is based on the method of lines (MoL) and comprises a set of numerical techniques designed to speed up calculations while increasing

accuracy of computations. Incorporation of geometrical symmetries (including rotational), reduction of problem complexity using thinning out and linear re-expansion procedures, and multimode deembedding by the simultaneous diagonalization method are outlined here. This theory section is for EMPOWER users familiar with numerical electromagnetics foundations. We have added this material because MoL is less well known than the method of moments or the finite difference method.

MoL can be represented as a simple combination of both method of moments and finite difference method. Thus we have skipped common parts and given our attention to the original parts of the algorithm. More details on particular algorithm parts, accuracy and convergence investigation results can be found in publications listed in the References section in the EMPOWER Engine Theory and Algorithms section.

Basically, the theory behind the simulator can be reduced to the following: An initial 3D problem in a layered medium is reduced to a 2D problem through a partial discretisation of the Maxwell's equations and its solution for a homogeneous layer in a grid spectral domain. The resultant matrix relating local grid currents and voltages is reduced to an immitance matrix relating integral currents and voltages in ports. To extract a generalized scattering matrix of the problem from the immitance matrix, the method of simultaneous diagonalizations is used.

After this introduction we are ready to formulate the reasons for using MoL as a basis for an electromagnetic simulator. The 3D problem is discretized only in two directions and reduced to a 2D one that corresponds naturally to the planar MIC structures. In contrast with the method of moments, the MoL gives a self-regularized solution with only one variable (grid cell size) defining all parameters of the numerical model. That eventually leads to monotonic convergence of calculated data and predictable errors of calculations. The high grade of internal symmetries of the MoL based algorithms makes it possible to substantially reduce the numerical complexity of the main matrix computation stage. The main restriction of using a regular grid related with its potentially excessive number of variables has been overcome by introducing thinning out and re-expansion procedures. Basically, the discrete analogue of a problem is processed in a way similar to the method of moments but in discrete space like the finite difference approach which facilitates different aspects of the solution and programming.

Thus, the main advantages of the MoL are reliable solution with the predictable calculation error, relatively straightforward algorithms that facilitate development of general purpose programs, and a lot of possibilities to speed up calculations and to increase accuracy of solutions. For these reasons and others, we decided to use it for the electromagnetic simulator. This section summarizes the theoretical backgrounds with emphasis on the problem formulation and acceleration techniques.

Historical Background

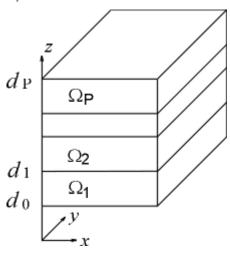
Most commercial electromagnetic (EM) simulators designed for MIC and MMIC work are based on integral equations and the method of moments (MoM). EMPOWER is based on the method of lines (MoL). This technique has excellent error convergence properties and submits well to code optimization to minimize numeric complexity.

The root of EMPOWER is work which began in 1987 at the Novosibirsk Electrical Engineering Institute. This lead to the commercial development of TAMIC in 1991 in Moscow. TAMIC saw commercial use in the Soviet Union and elsewhere. In late 1996, Eagleware acquired TAMIC and the principle contributor joined Eagleware to begin significant improvements. The code was integrated into the GENESYS environment at release Version 6.5 in 1998.

Problem Formulation

This section describes a general mathematical formulation of the boundary value problem to be solved. It defines all restrictions in the problem domain. You can use this section to decide whether your particular problem fits the formulation or not.

For analysis, a passive MIC structure is confined inside a three dimensional rectangular volume bounded by electric or magnetic walls. The volume is filled by a layered medium that may consist of an arbitrary number of isotropic homogeneous dielectric or magnetic layers as shown below.



The electric (**E**) and magnetic (**H**) field vectors are related by Maxwell's system of equations:

$$\begin{array}{l} \operatorname{rot} \mathbf{H} = i \omega \varepsilon_{p} \mathbf{E} + \mathbf{J} \mathbf{z} \\ \operatorname{rot} \mathbf{E} = -i \omega \mu_{p} \mathbf{H} \\ \operatorname{div} \mathbf{E} = 0 \\ \operatorname{div} \mathbf{H} = 0 \end{array} \right\} (x, y, z) \in \Omega_{p}$$

Here Jz is the volume density vector of z-directed currents inside a media layer. e_p and mu_p are permittivity and permeability of the media layer. e_p is a complex value for a lossy media. The z-directed currents are constant values inside a layer, but they can change from layer to layer, which gives a possibility to discretize the problem along the z-axis. Thus we have all six components of the electric and magnetic fields inside a layer with constant current across it. X and y current components can exist only in a signal layer $z=d_j$, parallel to medium layer interfaces. Generalized boundary conditions for the signal layer are:

$$1_z * \{ H(+dj) - H(-dj) \} = \eta$$
$$1_z * \{ E(+dj) - E(-dj) \} = 0$$
(A-2)

The signal layer plane can contain arbitrarily shaped regions of perfect metalization, regions with complex surface impedances (lossy metal), resistive films, and regions modeling lumped element connections. All regions have zero thickness. The top and bottom walls of the box can be ideal electric & magnetic walls or walls with surface impedance. The structure can also be terminated by semi-infinite rectangular waveguides in the planes of the box top and bottom walls. A clarification of the boundary conditions for the media layer interfaces (A-2) are given in the following table.

1.	Region without metalization	$\eta = 0$
2.	Lossless metalization	$1_z * E(d_j) = 0$
3.	Surface Impedance	$\eta = \sigma E$
4.	Port Region along X-Axis or Internal Port (Lumped Element Region) along X-Axis (the same for y-axis). C is region cross- section, l is region length.	$\int_{C} \eta dy = Y_i \int_{I} E_x dx$
5.	Internal Port along Z-axis	$\iint_{C} \mathbf{j}_{z} dx dy = Y_{l} \int_{l} \mathbf{E}_{z} dz$

Input ports in the structure are modeled by line segments approaching the outer boundaries (line conductors) and surface current sources in the regions where line conductors approach the walls of the volume. It is assumed that the currents inside the input and the lumped element regions are constant in the direction of current flow and the

corresponding electric field component along the region is constant across it. Thus, the integral of current across the region gives an integral current, and integral of the electric field along the region gives an integral voltage for the region.

The desired solution of the electromagnetic problem is an immitance matrix relating the integral voltages and currents in the port and lumped element regions. This is actually a kind of Green's function contraction on the port and lumped element regions. After connection of the lumped elements the immitance matrix can be transformed into a generalized Y- or S-matrix using the simultaneous diagonalization method (see the deembedding section).

Thus, we have a problem formulation that is appropriate for a wide range of microwave and mm-wave devices such as planar filters, dividers/combiners, matching circuits, phase-shifters, attenuators, diplexers, amplifiers as well as their components.

Method of Lines

The method of partial discretization (later called the method of lines [MoL]) is as old as partial differential equations and the finite difference approach to their solution. Traces of it can be found in the 18th century works of J.-L. Lagrange. Its first conscious usage for the numerical solution of elliptical problems could be attributed to M.G. Slobodianskii [1939]. An almost complete reference on the MoL development and applications in the period from the beginning up to sixties are given in Liskovets' paper [1965].

The network analogue method of B.L. Lennartson [1972] is probably the first technical application of the MoL to the static numerical analysis of planar multiconductor lines. It was not quite straightforward when it was published, and the actual exploration of the method for microwave integrated circuit structures began in the early eighties in works of German scientists H. Diestel, R. Pregla, U. Schulz, S.B. Worm and others [Pregla, Pascher, 1989].

The EMPOWER algorithms can be also classified as MoL because of its semi discrete nature. Originally the network impedance analogue method [Kron, 1944/ Sestroretzkiy, 1977] and a grid spectral representation inside homogeneous layers were used to analyze the layered three dimensional structures [Sestrorezkiy, Kustov, Shlepnev, 1988] that correspond to a combination of the 3D finite difference approach and the spectral domain technique. Later, only the discretisation in the metal plane was left, but the method still retains some advantages of the network impedance analogue method. That is why we sometimes refer to the EMPOWER numerical techniques as the impedance interpreted method of lines.

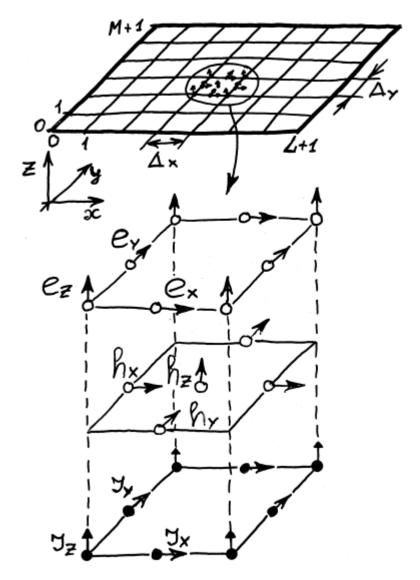
Here are the main solution stages of the impedance interpreted MoL:

- Partial discretisation of the Maxwell's equations, only in the plane of metalization (x-y plane).
- Grid spectral representation of the EM fields in the homogeneous layers.
- Building Grid Green's Function (GGF) matrix in spectral domain using impedance form of the solution in a layer.

- Representation of each GGF matrix element as a sum of four elements of an auxiliary array obtained using DFFT technique.
- Equidistant grid transformation to a non-equidistant grid using thinning out and linear re-expansion procedures.
- Automatic detection of symmetry for symmetrical and nearly symmetrical problems (reflection and 180° rotational).
- Solution of the main system of linear algebraic equations using partial inversion.
- Resolution to Y- or Z-matrix relating integral grid currents and voltages in the input and lumped element regions.

Mapping on the Grid

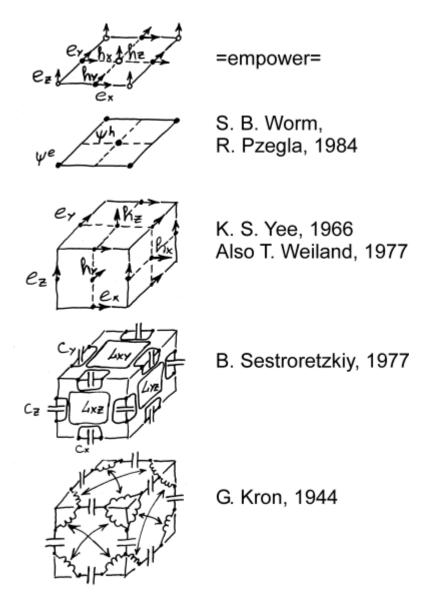
To map a boundary value problem for a partial differential equation on the grid basically means to substitute the problem with solution defined in a space of continuous functions by a problem with a solution defined in a discrete space. The model solution must be as close to the continuous one as possible. To solve the problem we approximated the partial derivatives in the signal plane by finite differences applied to grid analogues of the field components. The corresponding grid is shown here.



There are L+1 equidistant cells along the x-axis and M+1 cells along the y-axis. The grid equivalents of the electric (e) and magnetic (h) fields are defined as corresponding continuous function values in offset grid points as is shown for a grid cell above. The grid functions are continuous along the z-axis. Grid x- and y-directed current variables (Jx,Jy) are defined as integrals of the surface current in the metal plane across the grid cell. Grid z-directed currents (Jz) are defined as surface integrals of the volume current density jz across the grid cell.

The first offset model of Maxwell's equations was apparently proposed by G. Kron [1944]. The cells below show a summary of the similar models implemented by different authors. The resultant system of differential-difference equations approximates the initial

system with the second order locally inside a layer. The initial boundary value problem can contain infinitesimally thin metal regions with consequent singularities of the field and conductivity currents at the metal edges [Meixner, 1972]. That is why a global approximation order of the problem is usually lower and the largest calculation error part for integral parameters of a structure (Y, S-matrix elements, characteristic impedance) decreases usually proportionally to the grid cell size. That is, the monotonic convergence was observed for almost all problems solved on the initial equidistant grid. This makes it possible to use such powerful convergence acceleration techniques as Richardson's extrapolation [Richardson, 1927; Marchuk, Shaidurov, 1979]. Note that this is an observation and it cannot be proven to work for all problems. The technique used here for the descriptor matrix evaluation using current sources in the metal plane is empirical. The evaluation accuracy depends on parasitic high order modes that could be excited by current sources and if they are close to their cutoffs or even are propagating, the estimated descriptor matrix could be far away from the correct one. This can be expected, however, since real circuits which have unexpected high order modes near the cutoff usually do not work properly either.



Grid Green's Function

The Grid Green's Function (GGF) has been mentioned quite a few times. The GGF is a solution of the differential-difference analogue of Maxwell's equations (A-1) excited by a unit grid current (Jx,Jy or Jz). The solution or response function is a discrete function in the xy plane and continuous inside layer along the z-axis. Actually to solve the formulated problem we need just a contraction of the GGF to the signal plane and to the regions with non-zero z-directed currents. This contraction is a matrix due to the discretization.

To find the GGF matrix we used a spectral approach similar to one used in the spectral domain technique or in the method of moments [Nikol'skii, 1982; Vesnin, 1985; Jansen,1985; Rautio, Harrington,1987; Dunleavy, Katehi,1988]. Instead of continuous TE and TM rectangular waveguide eigenwaves [Samarskii, Tikhonov, 1948], their grid analogues are used as a basis to expand the electromagnetic field inside a layer. The number of the grid TE and TM waves is finite and their system is complete. This means that instead of a summation of series as in the spectral domain approach we have finite sums. Moreover each basis grid eigenwave has a grid correction that provides convergence of sums to the series obtained by the continuous spectral domain approach. Note that a backward process is impossible and a simple truncation of the series does not give the same answer as the grid technique. The finite sums and the grid corrections are the most important things for monotonic convergence of the algorithm.

To construct the GGF matrix in the grid spectral domain, the impedance form of the solution for a layer was used. The base of the solution is a layer admittance matrix in the grid spectral domain. This matrix relates the grid analogues of the tangential electric and magnetic field components at opposite surfaces of the layer, z-directed currents and integrals of z-directed grid electric field along the z-directed current inside the layer. All of these are in the basis of the grid eigenwaves, thus we have a set of independent matrices for each pair of grid eigenwaves. Uniting those matrices for all layers in a structure gives a grid spectral GGF representation. The construction procedure is completely automated for arbitrarily layered configurations. This technique is similar to the impedance approach in the spectral domain [Uwano, Itoh, 1989]. The grid spectral GGF representation was also called a GGF eigenvalue vector, but that term is not quite correct. The dimension of the vector is about 3*L*M if there is only one signal layer.

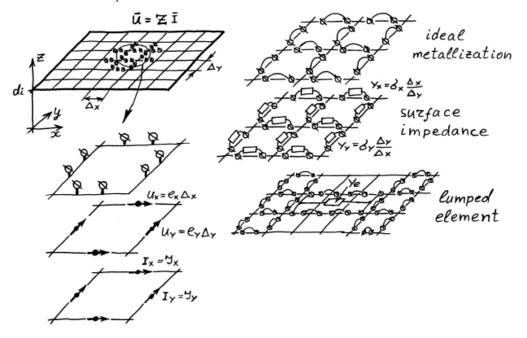
All we need now to get the GGF matrix in the initial space is to perform a backward transformation of the GGF eigenvalue vector from the grid spectral domain to the spatial domain. To do it an auxiliary array called general sums array is introduced. The dimension of the general sums array is also about 3*L*M. Each element of the GGF matrix can be obtained as a sum of four elements of the general sums array. The general sums array depends only on the box and media structure and the grid cell size. Its elements are calculated via the discrete Fourier transforms of the GGF eigenvalue vector using the Prime Factor algorithm. This stage is based on the maximal utilization of internal symmetries of the bounded equidistant grid and usually takes negligibly small CPU time. Moreover it can be done only once for all structures with the same box, media and grid. The described technique is quite similar to the main matrix filling procedure designed for the spectral domain technique [Hill, Tripathi, 1991], except that it has been done here in finite space and we calculate the GGF matrix elements without additional truncation (or series summation) errors. It can also be reformulated in matrix form in accordance with [Pregla, Pascher, 1989]. The GGF matrix can be represented by a sum of Toeplitz and Hankel matrices and their rows can be obtained directly from the general sums arrays.

Informational Multiport

The informational multiport term was introduced by B.V. Sestroretzkiy [1987] and in a nutshell means a model multiport that reflects electromagnetic properties of an object before superimposing an additional boundary condition. It comprises information about

all possible structures that could be formed by different combinations of the additional conditions. The boundary condition superimposing can be represented as a set of simple manipulations with the informational multiport terminals. We have added this section to clarify connections of the numerical electromagnetic solution with the circuit theory. This technique is also known as the impedance interpretation of boundary condition superimposition.

The GGF matrix obtained in the previous section can be represented as an impedance matrix Z of a multiport shown on the left below.



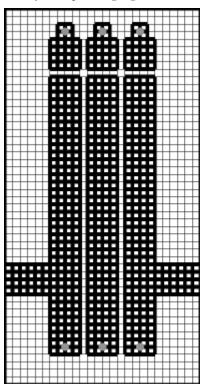
The multiport terminals are conceptual and their positions are just a schematic representation. Four conceptual ports or pairs of terminals correspond to a grid cell as shown in the figure. The total number of ports oriented along the x-axis is M*(L+1). The total number of ports oriented along the y-axis is L*(M+1). The multiport can also have a set of z-directed ports corresponding to via-holes or z-directed internal inputs. Note that we do not need to calculate all elements of the multiport impedance matrix and its order can be reduced taking into account that some ports are no-loaded or short circuited. The no-loaded terminals correspond to regions of the signal layer without any conductivity currents. The right half of the figure illustrates the correlation of other types of the boundary conditions to operations with the informational multiport terminals. Operations with the z-directed terminals are similar.

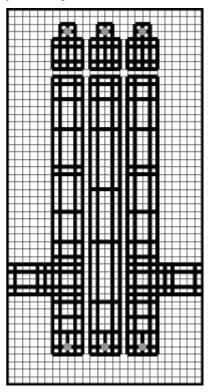
The operations in a discrete space of the informational multiport terminals are completely in accordance with the usual electromagnetic theory. To connect a lumped element for example, we performed both serial connections of terminals along the element that corresponds to the electric field integration along the element and parallel connections that corresponds to the surface current integration across the element (see the Table

above). The analogies described are meant to facilitate understanding of numerical electromagnetics. Note that the examples given are not the only possible manipulations with the terminals with physical electromagnetic equivalents.

Numerical Acceleration Procedures

Before filling the reduced GGF matrix we can additionally decrease the GGF matrix order and required storage space by means of thinning out with linear re-expansion procedures and by incorporating a geometrical symmetry into the problem.





Thinning out is a simple elimination of the grid currents in metalized regions that can be represented by a smaller number of currents without loosing accuracy. As an illustrative example, the left half above shows a three resonator filter mapped on the grid. The grid cells with possible non-zero conductivity currents (metalization regions) are depicted by the thick lines. The thinning out procedure decreased the number of the currents in the problem and leaves the currents that are shown by the thick lines in the right half above. This looks like a pseudo-non-equidistant grid over the regular grid that is finer near edges, corners and via-holes and coarser inside the solid metal regions. The enlarged secondary grid cells after the thinning out consist of non-divergent current borders along each side that can be substituted by two variables on the grid using linear re-expansion. Combination of these two procedures makes it possible to overcome restrictions of the MoL with a regular grid while keeping the main advantages of the equidistant grid.

The described procedure with total elimination of some currents inside the solid metal regions is called the wire model. It basically substitutes a problem with another one with removed small metalization pieces. It certainly gives an additional error, but fortunately this error is opposite to the regular grid model error. In other words, the wire thinning out model actually increases the solution accuracy if the structure is thinned out properly. However, if too much metal is removed, the thinning out error dominates. Thus, a solid thinning out model procedure was introduced to avoid it. The solid model can be represented as a simple modification of the wire model. To explain it we start from the pseudo-non-equidistant grid of currents formed for the filter and shown above. Instead of complete elimination of the currents inside the enlarged grid cells we leave some of them to keep metal surface solid. Those currents left are also replaced with just two variables by means of linear re-expansion. The solid model is more correct but gives a larger number of variables for similarly thinned out problems in comparison with the wire model. (The solid model is actually a way to form a non-equidistant grid with the grid function re-expansion in a discrete space.)

The GGF matrix of a symmetrical problem could be reduced to a centrosymmetrical matrix (with centrosymmetrical blocks in the case of two-plane symmetry) and it is treated in the way similar to described in [Weeks, 1979]. This reduces required CPU memory from 4 to 16 times (serial allocation of partial matrices) and speeds up calculations from 4 to 16 times. One plane, two plane, and 180° rotational symmetries are included in the program.

Thereafter, the classic Gauss' inversion algorithm is used with a few changes. The result of this stage of solution is a matrix (Y- or Z-matrix) relating the grid currents and voltages in the input source regions, and thus we need to get only a small part of the inverted matrix corresponding to these variables. A partial inversion procedure performs it and gives an additional acceleration.

De-Embedding Algorithm

The method of simultaneous diagonalization (MoSD) [Shlepney, 1990, 1998] is used to extract a multimode or generalized S-matrix. The MoSD is based on the electromagnetic analysis of two line segments corresponding to an MIC structure port to be de-embedded. The segments have different lengths and the same surface current source regions as in the initial structure. The result of the EM analysis is two Y-matrices relating integral grid currents and voltages in the source regions. These matrices, transformed from the space of the grid functions to a space of the line eigenmodes, are set equal to Y-matrices describing independent modes propagated in continuous part of the line segments. It gives the basic non-linear system of equations relating eigenwave propagation constants and characteristic impedances, a matrix of transformation from the grid functions space to the mode's space (transformation matrix) and an auxiliary matrix that helps to match propagated modes perfectly (compensation matrix). Solution of the system is based on simultaneous diagonalization of Y-matrix blocks. Each port of the MIC structure or discontinuity can be de-embedded using the pre-calculated line parameters and the transformation and compensation matrices. The main advantages of this approach are the possibility of multimode deembedding without direct spectral analysis of the line crosssection and ideal matching of line eigenmodes in the analysis of the line segment that increases the accuracy of discontinuity analysis.

Note that despite the theoretical ability to excite and to match any propagating line eigenwave using the surface current sources in the metal plane, it does not always work in the discrete models. Using a limited number of variables in the source regions it is sometimes impossible to separate different modes completely. Moreover, the success of the MoSD application depends on the high order modes that could substantially influence the result. This is the main drawback of the described MoSD application to planar structures.

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Chapter 6: HARBEC (Harmonic Balance Analysis)

HB (Harmonic Balance) Analysis

Harmonic Balance Overview

The HARBEC harmonic balance simulator simulates the steady-state performance of nonlinear circuits. Circuits can be stimulated with a variety of periodic signals (voltage, current, and power) such as single CW tones, pulsed waves, or dual tones. Complex waveforms can be constructed by combining various periodic signals; HARBEC makes this through the custom voltage and current sources. The two assumptions that harmonic balance uses are 1) the signals in the circuit can be accurately modeled using a finite number of spectral tones and 2) the circuit has a steady-state solution.

HARBEC works by solving Kirchoff's current law in the frequency domain. It applies the stimulus sources to the designed network. It then searches for a set of spectral voltages that will result in currents that sum to zero at each node and each frequency in the circuit. It adjusts the voltage levels (a spectrum of voltages at each node) through a variety of methods until the sum of the currents is less than a user-specified level (see "Absolute Error" and "Relative Error" on the Harmonic Balance dialog box in the Reference Manual). This process of searching is known as "convergence." The length of time it takes to take a search step is roughly equal to the cube of the product of the number of frequencies and the number of nonlinear nodes. Thus, if you double the number of frequencies in the circuit, you can expect the solution to take roughly 8 times longer. However, this is only a rough estimate. The convergence process is complex and difficult to predict.

At a fundamental level, harmonic balance solves a simultaneous set of nonlinear differential equations. No mathematical approach is guaranteed to find a solution to the problem. Years of work have gone into HARBEC to develop the most robust strategies available.

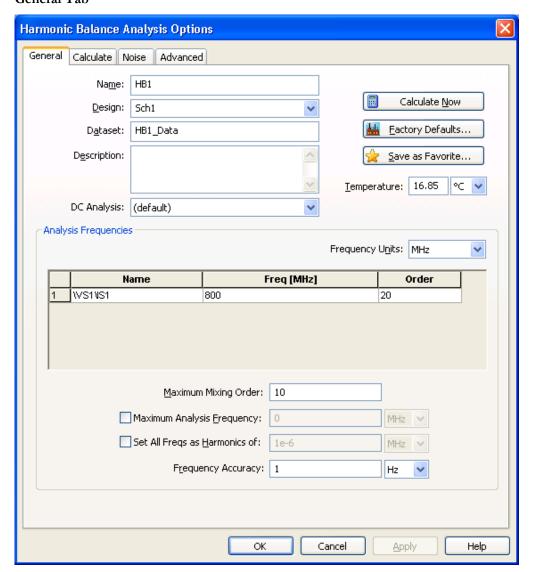
To add a harmonic balance simulation:

- 1. In the Workspace Window, click the New Item button and select "Add Harmonic Balance Analysis" from the Analysis submenu.
- Complete the HARBEC Options dialog box. For details, see the Reference manual.

HARBEC Options

To edit a Harmonic Balance properties, double-click the Harmonic Balance Analysis or click the analysis and click the Properties button on the Workspace Window.

General Tab



Design - Defines the schematic or EMPOWER electromagnetic simulation that will be analyzed. If an EMPOWER simulation is selected, electromagnetic results will be co-simulated with the circuit elements associated with the layout.

Note: If an EM simulation is selected, it is very important that the "Use Ports from Schematic" option be properly checked on the EMPOWER Properties dialog.

Frequency Table and Order Control

HARBEC (Harmonic Balance Analysis)

Name - The schematic designator of the source. GENESYS searches the specified design for all sources and places them in the table.

Freq - The frequency specified on the source. GENESYS fills in this value by reading the frequency from the schematic.

Order - The number of harmonics to be analyzed. The larger the number of harmonics, the more accurately waveforms will be represented. However, the length of time to find a solution increases as roughly the cube of the number of frequencies. Order must always be set large enough to model the majority of the energy in each branch current. Typical numbers for mildly nonlinear circuits are 4-5. For circuits deep in compression (square waves present), the order may need to be 8-16 to achieve the desired accuracy.

Maximum Mixing Order - Specifies the maximum combined order of signals to be simulated. In the example shown, all 4th order products will be calculates. For example, the 1900*2 -1905*1-1800*1 (95MHz)-the mixer third order intermodulation term-is a 4th order term (2+1+1) and will be calculated. This term only affects the mixing terms and will not override the order of individual sources specified in the frequency table.

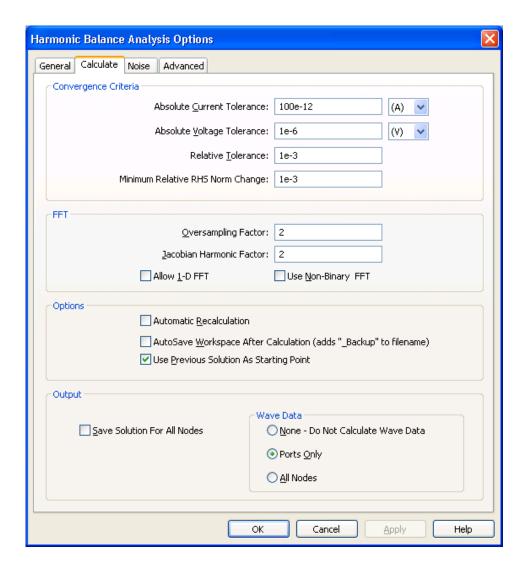
Temperature - The temperature, in degrees Celsius, at which to perform nonlinear analysis.

Maximum Analysis Frequency - Frequency above which no nonlinear analysis is performed. If not checked, all frequency points in the analysis (input frequencies, their specified number of harmonics, and intermods) will be used.

Frequency accuracy - The minimum difference in frequencies before the simulator will merge frequency terms. If the difference between two calculated frequencies (usually mixed frequency terms) is less than the frequency resolution, they will be considered a single frequency term for simulation.

Calculation

- defines basic convergence criteria and contents of output data.



Absolute Current Tolerance - The absolute accuracy to which the sum of node currents must sum to zero to achieve harmonic balance convergence. The simulator is converged if the magnitude of the vector sum of the currents entering all node at all frequencies is less than the specified absolute tolerance.

Absolute Voltage Tolerance

- absolute tolerance of solution changes between 2 consequent Newton iterations;

Relative Tolerance

- The relative accuracy to which the sum of node currents must sum to zero to achieve harmonic balance convergence. The simulator is converged if, for all

frequencies and all nodes, the ratio of (the vector sum of the currents into a given node currents) to (the sum of magnitudes of the current entering that node) is less than the specified relative tolerance.

Min Rel RHS Norm Change

- minimal change of residual norm for a Newton iteration, when current solution method is accepted as successful. In case, when the relative error change is less then the value, Harbec will switch the current solution method to another one. Default: 0 (any decreasing of the residual norm is accepted, as successful)

Oversampling Factor - Sets a factor for additional time points to be calculated during nonlinear device simulation, which can improve convergence but will take additional time. The factor should be set >= 1. Default value is 2.

Allow 1-D FFT - The simulator will normally convert frequency spectrums to time waveforms (and back) using multidimensional FFTs. If the frequencies are evenly spaced (have a large common factor), it may be faster to use a one-dimensional FFT. On some occasions, convergence can also be affected.

Automatic Recalculation - Checking this box will cause the harmonic balance simulation to be run any time there is a change in the design. If the box is not checked, the simulation must be run manually either by right clicking on the simulation icon and selecting "Recalculate Now" or by clicking the recalculation (calculator) button on the main tool bar.

Auto-save Workspace After Calculation - Checking this box will cause GENESYS to save the current workspace after the simulation is complete. This is particularly useful with long simulations or simulations that run overnight. If this box is checked when optimizing, the file will be saved after each optimization step.

Use Previous Solution As Starting Point - Usually checked, this option will start the convergence process using the previous set of node voltages. If the parameters changed (or swept) are relatively small, starting with the previous solution can dramatically speed convergence. If the parameters changed are large is sometimes better to start from scratch. Certain circuits will always converge faster from scratch than previous solutions.

Calculate wave data - The simulation calculate time domain waveforms for all circuit nodes and branches (if checkbox "Save solution for all nodes" is checked on).

Calculate port wave data - The simulation will calculate time domain waveforms for all circuit ports, voltage test points and current probes.

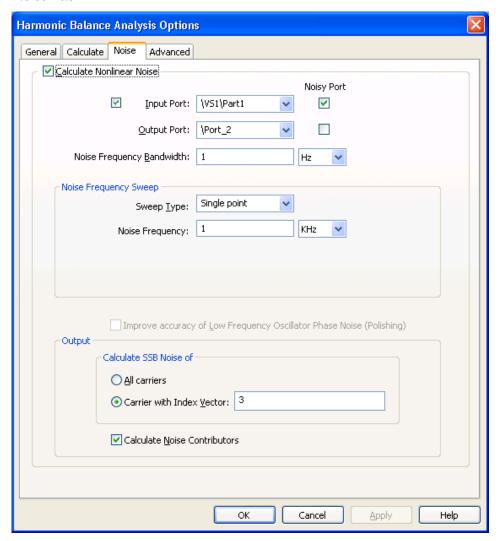
Save solution for all nodes - Checking this box will cause the harmonic balance simulation save in output dataset solution for all circuit nodes and branches.

Calculate Now - Dismisses the dialog box and starts the simulator. Any model caches are removed.

OK - Dismisses the dialog box. If automatic recalculation is on and a simulation is needed, the simulator will run after the box is dismissed

Cancel - Dismiss the dialog box, canceling any changes made.

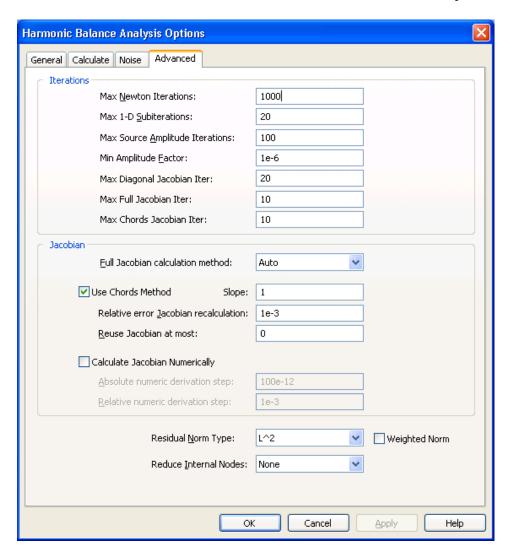
Noise Tab



See Nonlinear Noise Overview...

Advanced Tab

- defines advanced parameters that control Harbec convergence methods



Refer to "Optimizing Simulation Performance" in the User Manual for details on the convergence process and the use of the parameters described below.

Max Newton Iterations - maximuml number of Newton solver iterations to achieve convergence.

Max 1-D Subiterations - maximum number of 1-dimensional improving solution sub-iterations at each Newton iteration.

Max Source amplitude Iterations - maximum number iterations of source amplitude factor (continuation iterations).

Min amplitude factor - minimum value of source amplitude factor.

Max Diagonal Jacobian Iter - maximum number of newton iterations with diagonal Jacobian method before changing it to Full Jacobian Method.

Max Full Jacobian Iter - maximum number of newton iterations with Full Jacobian method before changing it to Diagonal Jacobian Method.

Max Chords Jacobian Iter - maximum number of newton iterations with chords method without updating Jacobian.

Full Jacobian Method -

Auto - defines automatic switching between "Full Jacobian" / "Diagonal Jacobian" methods;

Never - never use "Full Jacobian Method". Less robust, but may be very efficient for too large circuit, or too complicated solution spectrums, when it converged;

Always - always use "Full Jacobian Method". May be more robust, but may be very time-expensive for a very large circuit or complicated solution spectrums.

Use Chords Method - if checked, then "Diagonal Jacobian" method will reuse inverted jacobian for few subsequent iterations without updating it. Parameter **"Slope"** of the method defines chord slope factor (default:1).

Relative Error Jacobian recalculation - force update Jacobian, if the relative norm of residual at the Newton iteration improved less then the value.

Reuse Jacobian At Most - The largest number of times that a Jacobian matrix will be used before updated.

Calculate Jacobian Numerically - if checked, nonlinear part of Full Jacobian will be calculated using numerical algorithm (default: unchecked).

Absolute Numeric Derivation Step - absolute step for numeric derivation (used for 0-valued solution components only);

Relative Numeric Derivation Step - relative step for numeric derivation (used for all nonzero solution components);

Residual Norm Type - formulation of residual norm function

L^2 - quadratic norm;

L^Inf - infinite norm;

Weighted Norm - if it checked on, than components of residual vector will be scaled by factor 1/(Total_Harm_Order), where Total_Harm_Order - is the total harmonic order of the component of residual vector. It increases weights of the higher order spectral components of solution spectrum, and improves their accuracy. Sometimes it helps also to improve convergence.

Reduce internal nodes - controls internal nodes & branches reduction algorithm. Default: None. Reduction of internal nodes & branches deceases size of solution vector, and significantly speeds up convergence. Sometimes the reduction may significantly increase truncation error of Jacobian calculation, which may result to convergence failure or dropping accuracy of the solution. Always compare results calculated with and without nodes (branches) reduction, to be sure that it's acceptable for the analyzed circuit.

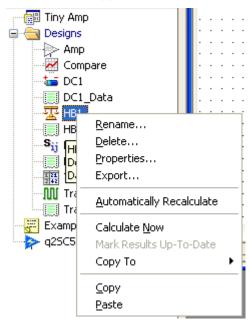
None - none reduction of internal nodes or branches;

Nodes Only - reduce internal nodes only;

Nodes & Branches - reduce all internal nodes or branches;

HARBEC Popup Menu

By right-clicking on the HARBEC simulation icon on the workspace window, the following menu appears.



Rename - Allows the name of the icon to be changed

Delete - Removes the icon and all of its associated data from the system.

Properties - Opens the HARBEC Options dialog box

Calculate Now - Starts a simulation.

Automatically Recalculate - Toggles on or off the state that starts a simulation any time a change is made to the design.

Mark results up-to-date - Changes the status of a simulation to current. Use this feature when a change has been made to the design that does not affect the simulation results (such as changing a value and then changing it back).

Solving Convergence Issues

The simulator searches for a solution until the user-specified accuracy is reached, or until a specified number of searching steps. Sometimes you might run into convergence issues. Below are a few steps that you can use to improve convergence results. Each of the parameters below is changed on the Harmonic Balance (HARBEC) Options dialog box:

- 1. Increase the number of frequencies (the order) used in analysis. If not enough frequencies are used, the data is being undersampled and cannot accurately represent the solution. For example, modeling a square wave with three harmonics will ignore a lot of energy in the circuit, often leading to convergence issues. Increasing the number of frequencies analyzed will more accurately model the signals (at the expense of more time).
- 2. Try "Always" and "Never" options for calculating the Jacobian. If a Jacobian is calculated, the simulator will search in a different direction from the Fast Newton method. Sometimes the Jacobian will be a better direction, sometimes it will be worse. Try both approaches.
- 3. If the convergence issue occurs during a parameter sweep, sweep more points so that that each simulation is closer to the previous one, often requiring less total time. Or, if this is not practical or desired, turn off "Use Previous Solution As Starting Point." This will cause the simulator to start fresh with each new parameter value.
- 4. Increase the value of Absolute Tolerance and Relative Tolerance. This should speed up the solution but will be less accurate, particularly for low signal levels.

Optimizing Simulation Performance

A variety of methods and parameters are available to control the approach that HARBEC uses to find convergence. The speed of performance can be improved by adapting these parameters to the specific circuit being analyzed. To understand how these parameters work, it is useful to understand a little about how the simulator searches.

To find a solution, the simulator uses a Newton-Raphson search to find the solution. It starts with an initial guess and calculates an error function. The derivative of the error function is used to extrapolate the next point. In harmonic balance, partial derivatives exist for every node and every frequency. The full matrix of partial derivatives is known as a Jacobian.

Jacobian Calculation

The full Jacobian is usually the most accurate way to determine the next point. However, the matrix can be very large, requiring a lot of time to calculate and invert. To make the simulator faster, HARBEC generally tries Fast Newton steps first. A Fast Newton step calculates only a portion of the Jacobian and uses it to calculate the next point. For many circuits, the entire solution can be found quickly using only Fast Newton steps.

The default setting for HARBEC is to automatically switch between using Fast Newton and full Jacobian steps. Artificial intelligence techniques are used to determine which technique to use, and when. Usually, the automatic switching will find the solution quickly. However, for certain circuits, it will be better to always use the Jacobian or never use the Jacobian. On the HARBEC Options dialog box, you can specify either "Automatic," "Always," or "Never" use of the Full Jacobian. Experimenting with different values may improve convergence speed.

Order vs. Accuracy and Time

The easiest way to affect simulation performance is to change the order of the frequencies used in simulation. Harmonic balance models signals in the circuit by using a finite number of harmonics of the fundamental signals and a finite number of mixing terms. The larger the number of harmonics and mixing terms, the better the approximation of the actual signals. However, the larger the number of frequencies the longer the simulator takes to work. The length of time to take a search step is roughly proportional to the cube of the number of frequencies. So, doubling the number of frequencies will take about 8 times longer to simulate.

However, if not enough frequencies are present to adequately model the signals, then the results will not be accurate. Moreover, the simulator may have difficultly converging if not enough of the energy in the circuit is modeled.

The best practice in selecting order is to start with a reasonable number of harmonics of each signal (typically 5 is a good point), then increase the number until the results stop changing. "Order" and "Maximum Mixing Order" on the HARBEC Options dialog box control the number of terms. In this way, you can make tradeoffs of speed versus accuracy.

Amplitude Stepping

To start the search for convergence, HARBEC analyzes the circuit at DC, this is, with all independent AC signal turned off. Using DC as a first guess, it turns on the signals to "Maximum Amplitude Step" percentage of full signal. If convergence is reached at this step, it takes another equal step. If convergence is not reached, it decreases the step size and tries at the lower signal level. Some circuits will converge in a single 100% step. Others will require a smaller step to find the solution. If a smaller step is required, it will be faster to start with that step. If the step size is too small, the simulator may waste time calculating intermediate steps to find the final solution. Convergence speed can be improved by setting "Maximum Amplitude Step" to the ideal step.

Krylov Subspace Iterations

When the Jacobian matrix gets very large, it can become very slow to calculate and use. Krylov subspace iterations can dramatically reduce the size of the matrix and thus speed

Simulation

up calculations of very large circuits. In general, however, Krylov will have more convergence issues than full Jacobian steps. Also, for smaller circuits, Krylov may be slower than full Jacobian steps. For very large problems, try selecting Krylov to reduce memory requirements and speed convergence.

Genesys 2006 HARBEC Dataset Variables

Freq: An array [nFout] of the HB solution frequencies;

FreqID: A string array [nFout] of ID's of the HB solution frequencies;

FreqIndexIM: An array [nFout] of index vectors [nFin] defining the harmonic order of each of the signal source frequencies in creating of the HB solution frequency.

For example, for a 1-tone HB-analysis, nFin=1, and the elements of the array are scalars equal to the harmonic number of the HB frequency:

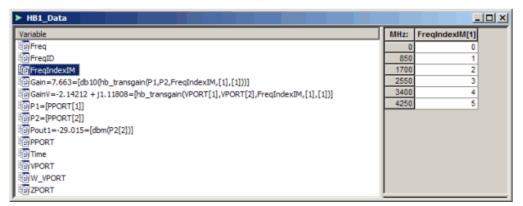


Figure 1

For a 2-tone HB analysis the FreqIndexIM is an array of vectors of size=nFin=2:

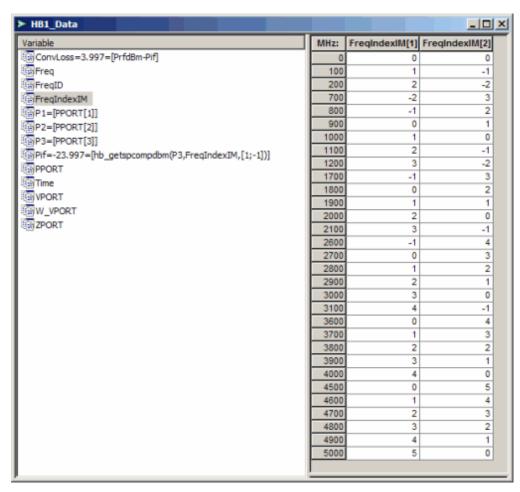


Figure 2

PPORT: array [nPorts] of spectrums of the port impedance dissipated powers (Units: dBm);

VPORT: array [nPorts] of spectrums of port voltages (Units: V);

ZPORT: array [nFout] of port complex impedances at HB solution frequencies (Units: Ohm);

The next variables are created in the dataset only after setting one of the checkboxes defining calculation waveforms of the HB solution (see "Calculate" tab of HB-analysis properties window)

Time: independent variable: array [nTimePoints] of time points for creating waveforms for the HB solution (Units: s);

W_VPORT: port voltage waves (solutions, transformed to the time domain) (Units: V);

The Next variables are created in the dataset only after setting the checkbox "Save solution for all nodes" (in the "Calculate" tab of the HB-analysis properties window)

V< node_name>: voltage spectrum at the node (Units: V);

W_I< branch_name>: current spectrum at the branch (Units: A);

W_V< node_name>: voltage wave at the node (created, when the checkbox "Calculate Wave Data" is set) (Units: V);

W_I< branch_name>: current wave at the branch (created, when the checkbox "Calculate Wave Data" is set) (Units: A).

Harmonic Balance Analysis Functions

Note: To use analysis functions in sweeps of analyses, they must be defined directly in the analysis dataset, and the checkbox "Propagate All Variables When Sweeping" of the Parameter Sweep Properties dialog window must be set.

1. Get spectral component from the spectrum

hb_getspcomp(Spectr, FreqIndexIM, IndexS) see more..

- returns the complex amplitude of the spectral component with IM-index IndexS from spectrum Spectr.

The HB-analysis dataset variable FreqIndexIM is the table of intermodulation (IM) indexes;

hb_getspcompdbm(Spectr, FreqIndexIM, IndexS) = dbm(hb_getspcomp(Spectr, FreqIndexIM, IndexS)) see more...

2. Intercept Points

hb_ipn(SpectrPout, FreqIndexIM, IndexS1, IndexS2) see more..

- calculates the relative part of intercept point equation (Pim1-Pim2)/(Nim1-Nim2) for 2 components with IM-indexes IndexSk of the power spectrum SpectrPout, where:

Pimk – the power in dBm of the k-th spectral component with the IM-index IndexSk.

Nimk – the harmonic orders of the k-th spectral component (equal to the absolute sum of the IndexIMk components), k=1,2;

hb_iipn(SpectrPout, FreqIndexIM, IndexS1, IndexS2, PindBm) = hb_ipn(SpectrPout, FreqIndexIM, IndexS1, IndexS2) + PindBm see more...

- calculates the input intercept point of the 2 component of the power spectrum SpectrPout;

PindBm – input signal power in dBm;

hb_oipn(SpectrPout, FreqIndexIM, IndexS1, IndexS2) = hb_ipn(SpectrPout, FreqIndexIM, IndexS1, IndexS2) + PoutdBm see more..

- calculates the output intercept point of 2 component of the power spectrum SpectrPout, where:

PoutdBm = hb_getspcompdbm(SpectrPout, FreqIndexIM, IndexS1) see more...

- the output signal spectral component power in dBm;

3. Transducer Gain

hb_transgain(SpectrIn, SpectrOut, FreqIndexIM, IndexIn, IndexOut) see more...

- calculates the transducer gain from input spectrum SpectrIn component with IM-index IndexIn to the output spectrum SpectrOut component with IM-index IndexOut;
- hb_transgaindb(SpectrPin, SpectrPout, FreqIndexIM, IndexIn,IndexOut) = db10(hb_transgain(SpectrIn, SpectrOut, FreqIndexIM, IndexIn, IndexOut)) see more..

hb_gain(In, SpectrOut, FreqIndexIM, IndexS) = hb_getspcomp(SpectrOut, FreqIndexIM, IndexS)/In see more..

- calculates the complex gain, where In – voltage (or power) amplitude of the input signal;

SpectrOut: voltage (or power) output spectrum;

IndexS: IM-index of the output spectral component;

4. Large Signal S-parameters

hb_LargeS(Vin, Vout, sameport) see more..

- calculates the Large Signal S-parameter (LS-parameter);

Vin – the signal port voltage source amplitude;

Vout – the complex amplitude of the output spectral component;

Vout = hb_getspcomp(SpectrVout,FreqIndexIM,IndexOut)

sameport = 1, if input and output ports are the same, and = 0, otherwise;

hb_LargeSmix(Vin,SpectrVout,sameport,FreqIndexIM,IndexOut) = hb_LargeS(Vin,Vout,sameport) see more..

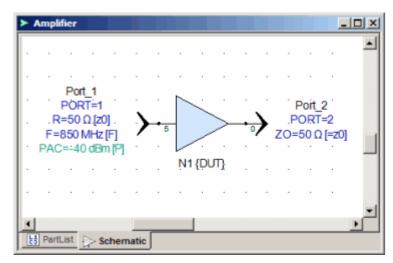
- calculates the LS-parameters, used with multi-tone HB-analysis, or for frequency conversion

Measuring Gain in HARBEC

HB analysis 1-Tone, Gain and compression

Example.

The tested Circuit "Amplifier" has 2 ports input=1 and output=2. The 1st port is 1-tone signal source with frequency =850 MHz. To analyze the circuit, create HB-analysis "HB1".



The compression of gain is defined as Compression(Pin) = Gain(Pin) – GainSS where Gain = dbmPout–dbmPin

and **GainSS** – the small signal gain, which is calculated in the HB-analysis as Gain at very small input power, when it is independent of its value.

To calculate the function, create a Parameter Sweep for HB1 analysis "PowerSweep1", whose parameter is the input power P, from –30 to +10 dBm with step=5dBm.

For the tested circuit the gain is almost constant for input power < -20 dBm. Using it, define GainSS as gain at lowest power of the sweep:

GainSS = Gain(-30 dBm)

In Genesys 2005 and later the analyses functions have been changed;

To use analysis functions in a sweep:

- The variable defined by a function must be defined in the analysis dataset (right click in the dataset and choose "add new variable")
- The checkbox "Propagate All Variables When Sweeping" of the sweep properties dialog window must be set

There are two methods to calculate the gain compression in G5:

- 1. By defining Gain in the swept analysis dataset (directly or using HB functions), and propagating it to the sweep dataset;
- 2. Directly by calculating it from parameter sweep data.

The 1st technique.

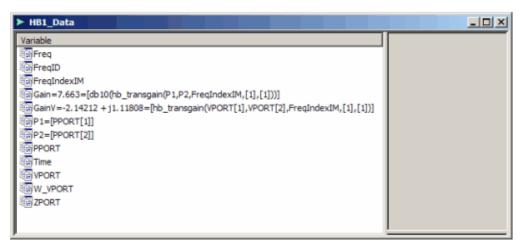
Add a new variable Gain to the HB1 analysis dataset (HB1_Data):

Gain = db10(hb_transgain(P1,P2,FreqIndexIM,[1],[1]))

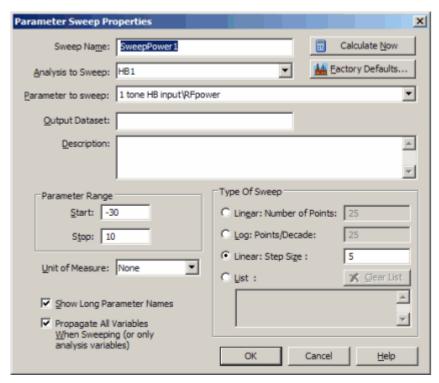
Note. Also, we can add the complex voltage gain variable, if we need to know it (to know information about phase)

GainV = hb_transgain(VPORT[1],VPORT[2],FreqIndexIM,[1],[1])

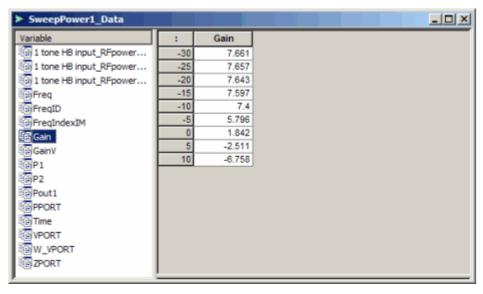
Note the added variables in the data set below:



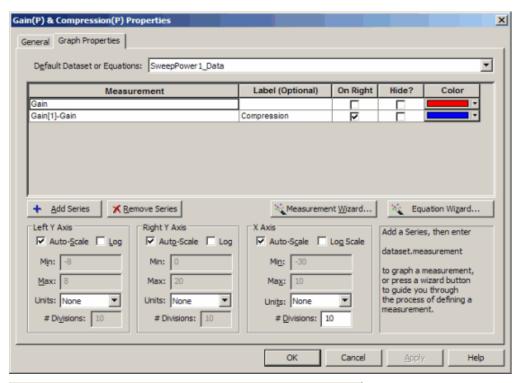
Now check the box to propagate all variables in the sweep:

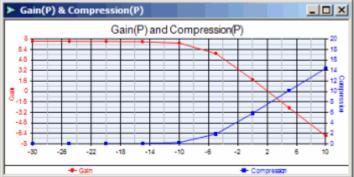


Notice that after running the sweep, the variables have been propagated into the sweep data:



These variables can now be plotted vs. the swept variable:





The 2nd technique.

The sweep of gain may be calculated directly from the spectral data of PowerSweep1_Data.

The frequency index of n-th harmonic in the 1-tone HB-analysis dataset is always equal to the harmonic number+1.

Gain = db10(P2[2]/P1[2])

or, using operator "<array>@<value>", which returns the index of first element of array <array>, which has value =<value>:

Gain = db10(P2[Freq@850]/P1[Freq@850])

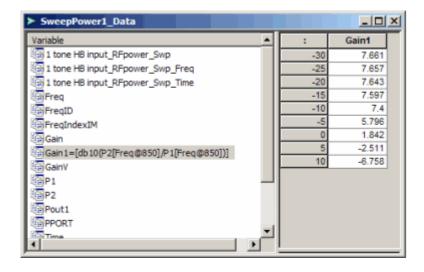


Table 1. Basic HB analysis Measurements

	Measurement	Genesys 2004 and earlier	GENESYS 2005.11 and later
1	Voltage Spectrum at the node <node name=""></node>	V <node name=""></node>	V <node name=""></node>
2	Voltage Spectrum at the port <port number=""></port>	V <port number=""></port>	VPORT[<port number="">]</port>
3	Current Spectrum through branch obranch name>	I <voltage name="" source=""> I<branch name=""></branch></voltage>	I branch name>
4	Voltage Waveform at the node <node name=""></node>	TIME[V <node name="">]</node>	W_V <node name=""> 3) or time(V<node name="">,Freq,Time) 5)</node></node>
5	Current	TIME[I branch name>]	W_I branch name> 3)

	Spectrum through the branch <branch name></branch 	TIME[I <voltage name="" source="">]</voltage>	or time(I <branch name>,Freq,Time) 5)</branch
6	Voltage Waveform at the port <port number=""></port>		W_VPORT[<port number>] 4) or time(VPORT[<port number>],Freq,Time) 5)</port </port
7	Power dissipated at the port <port number=""> resistance</port>	P <port number=""></port>	PPORT[<port number="">] P<port number=""></port></port>
8	Complex amplitude of the Spectral component, which frequency is equal to <freq mhz="" value=""></freq>	<measurement>@<freq value<br="">MHz> Examples: HB1.Sch1.rect[V1@100.1] V1@100.1 P1@100.1</freq></measurement>	<pre><variable>[Freq@<freq value="">]</freq></variable></pre>
8	Complex amplitude of the Spectral component, which order index is equal to <index></index>	<measurement>@#<index> Examples: DC: HB1.Sch1.rect[V1@#0] Amplitude of 1st harmonic 1): V1@#1 P1@#1</index></measurement>	<pre><variable>[<index>+1] Examples:</index></variable></pre>
1 0	Complex amplitude of the Spectral component, which multidimensional intermodulati on index is equal to <im-< th=""><th>Not implemented</th><th>hb_getspcomp(<variable>, FreqIndexIM,<im-index>) hb_getspcompdbm(<variab le="">,FreqIndexIM,<im- index="">) Examples: 3rd harmonic of power at port 2¹⁾:</im-></variab></im-index></variable></th></im-<>	Not implemented	hb_getspcomp(<variable>, FreqIndexIM,<im-index>) hb_getspcompdbm(<variab le="">,FreqIndexIM,<im- index="">) Examples: 3rd harmonic of power at port 2¹⁾:</im-></variab></im-index></variable>

	index>		hb_getspcompdbm(P2,Fr eqIndexIM,[3]) Power of IM which frequency Fim=1*F1- 1*F2 at port 2 ²⁾ :
			hb_getspcompdbm(P2,Fr eqIndexIM,[1,-1])
			Amplitude of 1 st harmonic of frequency F1 of voltage at node Net_20 ²⁾ :
			hb_getspcomp(Vnet_20,F reqIndexIM,[1,0])
1 1	Order index of the spectral component with <im- index></im- 	Not implemented	findrow(FreqIndexIM, <im -index="">) The negative value means negative frequency of the spectral component, 0 – if the spectrum does not have the spectral component having the <im-index>.</im-index></im>
			Example:
			P2[abs(findrow(FreqInde xIM,[-1,1]))]
		LargeSContext(OutPort,InPort, MeasContext,OutFreq,InFreq)	a) LS parameters for the base tone frequency
1 2	Large signal S-parameters	And based on it functions: MixerS(OutPort,InPort, OutFreq,InFreq) MixerSang(OutPort,InPort,OutFreq, InFreq) LargeS(OutPort,InPort)	hb_LargeS(Vin,Vout,same port)
		LargeSdb(OutPort,InPort) LargeSang(OutPort,InPort)	a) LS parameters for frequency conversion
		Examples:	

Using PowerSweep1.Sch1 LS21=LargeS(1,1) or LS21=LargeSContext(2,1, "",1,1) or LS21=LargeSContext(2,1, "PowerSweep1.Sch1",1,1)	hb_LargeSmix(Vin,Spectr Out, sameport, FreqIndexIM,IndexOut) Example: a) LS parameters for base tone: LS11=hb_LargeS(Vin1, VPORT[2,1],1) LS21=hb_LargeS(Vin1, VPORT[2,2],0) LS22=hb_LargeS(Vin2, VPORT[2,2],1) LS12=hb_LargeS(Vin2, VPORT[2,1],0) b) LS parameters for frequency multiplier by 3 1): LS21mix=hb_LargeSmix (Vin1,VPORT[2],0,
	FreqIndexIM,[3]) where Vin1, Vin2 are the amplitudes of signal port voltage sources.
	hb_transgain(SpectrIn,SpectrOut,
Not implemented (as a function) It's calculated using equations:	FreqIndexIM,IndexIn,Index Out) hb_transgaindb(SpectrPin, SpectrPout,
Example: Transducer Gain from port 1 to port 2 from frequency of the 1 st harmonic to 3 rd harmonic ¹⁾ : GainP=.dbm(P2@#3)dbm(P1@#1)	FreqIndexIM,IndexIn,Inde xOut) hb_gain(In,SpectrOut,Freq IndexIM,IndexS)
	LS21=LargeS(1,1) or LS21=LargeSContext(2,1, "",1,1) or LS21=LargeSContext(2,1, "PowerSweep1.Sch1",1,1) Not implemented (as a function) It's calculated using equations: Example: Transducer Gain from port 1 to port 2 from frequency of the 1st harmonic to 3rd harmonic 1st harmonic to 3rd harmonic 1st GainP=.dbm(P2@#3) -

			hb_transgaindb(P1,P2,F1 eqIndexIM,[1],[3])
			b) Conversion gain from
			input port voltage (base
			tone frequency) to output
			port voltage IF frequency (Fif=1*F1-1*F2):
			ConvGainV=hb_transga n(VPORT[1],
			VPORT[2], FreqIndexIM,[1,0],[1,-1]
			c) Conversion gain from input port voltage (base
			tone frequency) to
			current of current probe
			CP1 for IF frequency
			(Fif=1*F1-1*F2): ConvGainV=hb_transga
			n
			(VPORT[1],ICP1_Iprol
			e,
			FreqIndexIM,[1,0],[1,-1]
			c) Conversion gain from available input port power Pin (in Watts) to 3 rd harmonic of output port power ¹⁾ : ConvGain3av = hb_gain(Pin,P2,FreqIndo
			xIM,[3])
		Not implemented (as a function)	The Intercept Point for input power scale:
	Intercept	It's calculated using equations: Example:	hb_iipn(SpectrPout,FreqIndexIM,
	point of 2	Output IP3 (TOI) for 2-tones	T 1 01 T 1 02 P' 17
14	spectral components	signal(F1=1959.5MHz, F2=1960.5MHz) HB-analysis	IndexS1,IndexS2, PindBm
	(IPn)	between spectral components of	The Intercept Point for
	(11)	base frequency (F1) and 3 rd	output power scale:
		order IM component with	hb_oipn(SpectrPout,FreqIr
		frequency Fim3=2*F1-	dexIM,

F2=1958.5MHz:

using HB2.Amp NL Pfundd=.dbm(P2@1959.5) Pintermod=.dbm(P2@1958.5) Pdiff=Pfund-Pintermod TOI=Pin+Pdiff/2

IndexS,IndexIM)

Example: IP3 (TOI) for 2-tones signal between spectral components of base frequency (F1) and 3rd order IM component with frequency Fim3=2*F1-1*F2 OIP3=hb_oipn(P2,FreqI ndexIM,[1,0],[2,-1]) For mixer with 2-tone RF signal (2 RF and 1 LO frequencies (signal frequencies vector: F=[Frf1; Frf2; Flo]) **Output IP3:**

OIP3=hb_oipn(P2,FreqIn dexIM,[1,0,1],[1,-2,1]) The Input IP (relative to power (in dBm) of 1 of RF tones Prf_dBm) IIP3 =hb_iipn(P2,FreqIndexIM,

[1,0,1],[1,-2,1],Prf dBm)

HB Oscillator Analysis

Oscillator Design Overview

Oscillator design begins with three basic elements. Amplification, a frequency determining circuit or device, and feedback to overcome network losses and provide power to the load.

^{1) 1-}tone HB oscillator analysis;

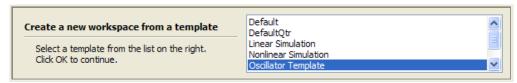
²⁾ Multi-tones HB oscillator analysis (oscillator with external signals: synchronized oscillator, self-oscillating mixer);

³⁾ the HB analysis properties window flag "Calculate Wave Data" must be set;
4) the HB analysis properties window flag "Calculate Port Wave Data" must be set;
5) any of 3) or 4) flags must be set in order that the dataset has created the independent variable Time.

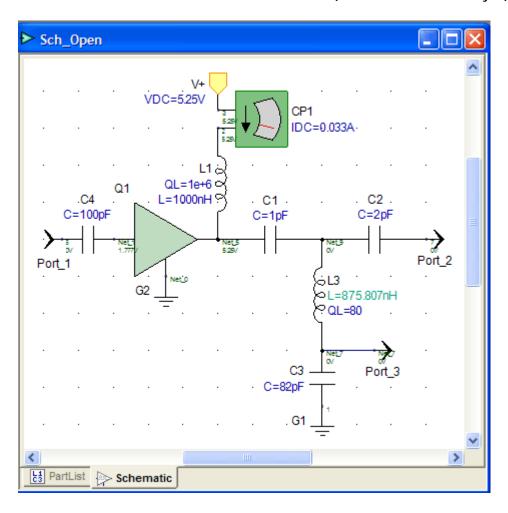
Simulation

We start by selecting an amplifying device and topology that will provide gain at the desired frequency (band of frequencies for tunable oscillators). Next some form of a frequency selective network is added (e.g. crystal, L-C circuit, cavity, or dielectric resonator). And finally a feedback path that provides power flow from the amplifiers output back to the frequency selective network. There are generally many topologies available to provide positive feedback however, the path should be chosen such that opening the path would result in termination of oscillation. A path that provides positive power flow from input to output (S21>1) in a broken feedback loop is an excellent starting point.

The easiest way to begin an oscillator analysis in GENESYS is to create a new workspace from the built-in Oscillator Template in the Getting Started with GENESYS screen (the first thing that comes up when you choose File -> New).



The template's schematic is shown below:

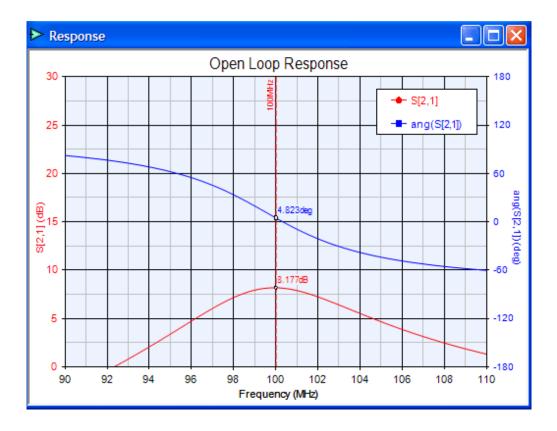


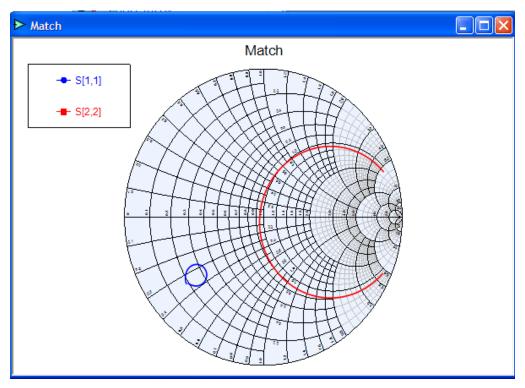
Having established a topology with a broken feedback loop we perform a two-port linear analysis on the oscillator to determine if oscillation is possible given the circuit and active device gain. In analyzing our circuit at the desired output frequency two conditions must be met that are required but not necessarily sufficient to ensure oscillation. At the desired output frequency the open circuit gain must be greater or equal to one(1) and the phase shift is a multiple of 2π n (n*360 degrees) where n is an integer including zero.

Using the tuning option in GENESYS allows for the exact selection of circuit elements to ensure a gain margin of >1 and phase shift of zero degrees at the desired frequency output. Considering the fact that our closed loop requires the connection of both ports it is helpful to view the return loss at the ports of our network to determine if additional matching structures would be necessary to aide in the maximum transfer of power. This data is already available as a result of our linear two port simulation. Ideally, S11=S22*. In

Simulation

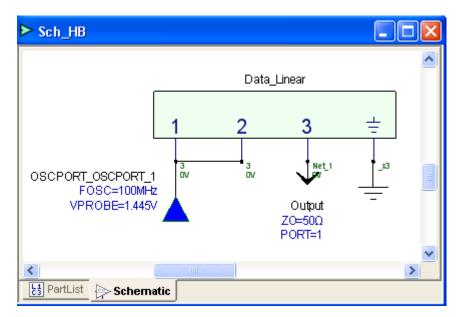
the case that the port impedances are divergent, closing the loop might prevent sustained oscillation.





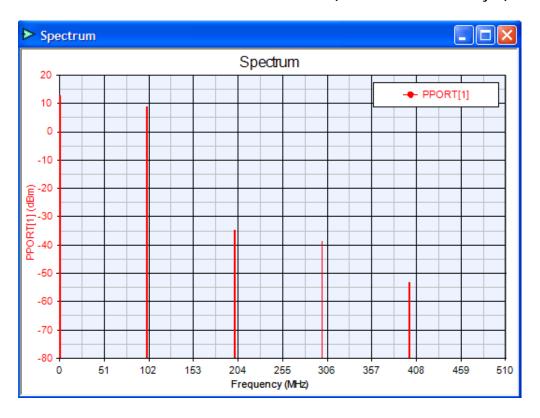
Having met the conditions for gain, phase, and match the next step is to verify oscillator performance and accurately determine the frequency of operation, power delivered to a load and the harmonic content. To accomplish this we use the OSCPORT element along with HARBEC Oscillator analysis.

We begin by connecting the two ports together to close the loop. To initiate or provide start-up impetus to our circuit we will insert an OSCPORT component into the circuit. The placement is not critical, any node is useable, however best results are obtained if we do not place it on the output port or node. We access the OSCPORT element from the source selection icon on the GENESYS toolbar.



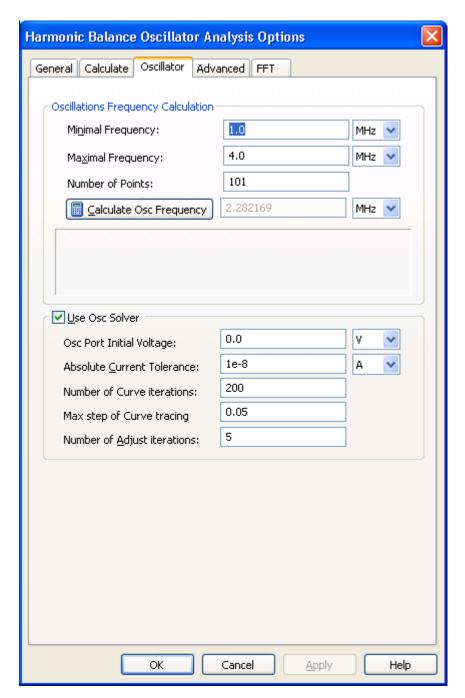
From the Simulations/Data folder in the GENESYS Workspace window add a DC Analysis simulation to determine the operating point of our device. This is recommended prior to any Harmonic Balance simulation.

From the Simulations/Data folder in the GENESYS Workspace Window add a Harmonic Balance Oscillator analysis. Accept the default name or choose another. Note that the default analysis is for the current schematic. The oscillator frequency and note voltage will be filled in by the simulator after a successful run. The Harmonic balance dialog establishes a default value for the number of harmonics. Increased harmonic order results in higher accuracy of the solution at the expense of slower simulation. Having established a working oscillator this value may be changed to improve accuracy. Generally the default values will yield sufficient accuracy.



Selecting the Oscillator tab allows to enter the search range for analysis.

This gives the simulator a range of frequencies to search over to find the exact oscillation frequency. For resonator elements such as crystals, addition points may be required to find the exact frequency considering the higher Q.



Having set the range for search we are ready to perform an analysis.

Select the Update Icon from the GENESYS toolbar to perform the Harmonic Balance simulation. To view the results of our simulation add a rectangular graph from the

Outputs file in the GENESYS Workspace Window. By double clicking on the graph or selecting 'properties' from a right mouse click select the 'Measurement Wizard' to help place the spectrum data on the graph. Alternatively, double click the data generated by the analysis to view the measurements.

For Harmonic Balance simulations we are able to select from a range of node voltages, branch currents and ports.

Node or port waveforms are also available via the Measurement Wizard and data set. This may aide in viewing the distortion and voltage levels at various nodes in the circuit.

There are several examples of Oscillators analyzed with Linear, Harmonic Balance, and Transient simulation in the C:\Program Files\Genesys200X.YY\Examples\Oscillators directory.

Usage and Theory of HB Oscillator Analysis (Genesys 2006.04 and later)

All measurements from the basic HB analysis may be used in the HB Oscillator analysis. Genesys 2004 and Genesys 2006 have a different implementation of the oscillator analysis. In Genesys 2004 the analysis is implemented as an additional feature of HB analysis, while Genesys 2006 has a fully independent oscillator analysis. Genesys 2004 used a double nested Newton algorithm, an internal part of which is a basic HB-analysis, which calculates complex amplitude of current through the oscillator port, which externally controls the amplitude of the port voltage and its frequency.

The Genesys 2006 oscillator analysis algorithm is based on the "tracing" function, whose parameter is the voltage amplitude of the oscillator port Vprobe, when the oscillation frequency is the new additional variable of the HB Newton equations system satisfying the tracing equation:

Im(Iprobe1) = 0

The tracing algorithm starts from very small amplitude of the Vprobe, and increases it while:

Re(Iprobe1) < 0

After the condition fails, the algorithm finds the exact oscillator solution, which is located in the limited band between the previous and the last value of Vprobe of the tracing iterations, satisfying the condition:

Re(Iprobe1) = 0

where 1 means the 1st harmonic of the oscillation frequency.

The Genesys 2006 oscillator analysis method is much more robust and efficient, than the one implemented in G4. It allows the Genesys 2006 user to solve many of the oscillator analysis tasks which couldn't be solved in Genesys 2004.

The circuit used for the oscillator analysis must have one OSCPORT circuit element, which must be connected to a node, where the small signal oscillation conditions may be satisfied at a frequency Fosc:

$$Re(Zin(Fosc)) < 0$$

 $Im(Zin(Fosc)) = 0$

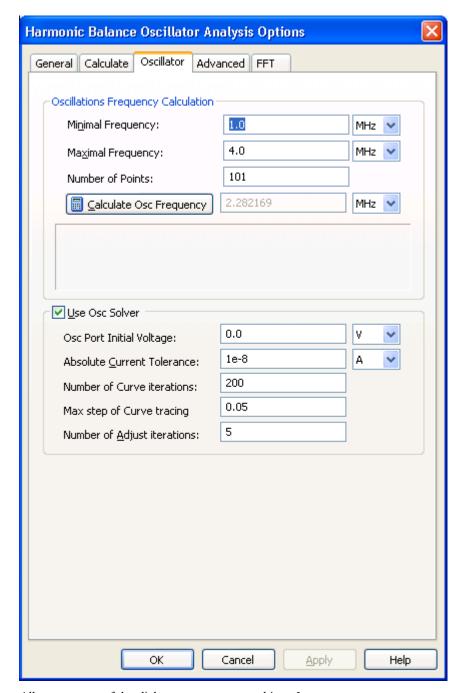
where Zin is the complex impedance of the circuit node, connected to the oscillator port.

Typically, when a tested circuit could oscillate, the conditions are satisfied at a node, where a resonator is connected to the input or output node of the active device, or at the output port of the circuit.

The following steps must be performed to successfully start the oscillator analysis for a new circuit, to be sure that it can oscillate:

- 1. Create "closed loop" oscillator circuit, with OSCPORT Probe properly located on oscillator at a node where small signal oscillator condition may be satisfied;
- 2. Create "Harmonic balance oscillator analysis" HBOSC for the circuit;
- 3. Before using the HBOSC analysis, in the Oscillator Tab, run "Calculate Osc Frequency" (and be sure to put in an appropriate range for the frequency search).
- 4. Once "Calculate Osc Frequency" has been run, the OSCPORT probe on the circuit is automatically calculated with Insertion Voltage and Oscillation frequency.
- 5. Now you can run the full blown oscillator analysis.

The oscillator analysis dialog includes all pages of regular HB analysis, and additional tab "Oscillator", defining specific settings for the analysis. In Genesys 2006 the tab includes the same parameters, as in Genesys 2004, and few new ones.



All parameters of the dialog page are grouped into 3 groups:

1. • Small signal oscillator frequency calculation

• "Minimal Frequency", "Maximal Frequency"

- low and upper frequencies of band, where the small the signal oscillation criteria and oscillation frequency are calculated;
- "Number of Points"
 - number of points in the frequency band;

2. • Nonlinear oscillator solver

- "Use Osc Solver"
 - checkbox enabling using nonlinear HB oscillator solver. If it's disabled, then the analysis calculates the only small signal oscillation frequency (may be useful for fast VCO developing, when nonlinear solver uses too much time to converge);
- "Osc Port Initial Voltage"
 - an initial amplitude of OSCPORT voltage probe. If it set 0, then the solver uses internal default initial guess;
- "Absolute Current Tolerance"
 - minimal absolute value of amplitude of OSCPORT current (convergence criteria). The criteria is checked the only after the solver has found the OSCPORT probe voltage amplitude band, where the real value of the current changes sign from negative to positive;
- "Number of Curve iteration"
 - maximal number of the "tracing" OSCPORT voltage probe amplitude (Vprobe) iterations;
- "Max step of Curve tracing"
 - maximal curve tracing step of voltage probe amplitude (Vprobe);
- "Number of Adjust iterations"
 - maximal number of final iterations searching the minimal absolute value of real part of the OSCPORT current Iprobe(Vprobe) in band Vprobe in [Vproben-1, Vproben], where the function Re(Iprobe(Vprobe)) changes sign (from negative to positive),

Vproben-1 \leq Vproben, n – number of tracing iterations used to find the band.

Results of the oscillator analysis are saved in the dataset:

It includes all variables of a regular HB-analysis plus variables specific for the oscillator analysis, which are:

1. The Small Signal oscillator analysis variables

- "Zosc"
 - the complex array of frequency sweep values of circuit node impedance Zosc(F), connected to OSCPORT;
- "SweepFreq"
 - the double array of the frequencies, at which the Zosc(f) is calculated;
- "Osc_Freqs"
 - the small signal oscillation frequency Foscss (1);
- "Osc_dPhaseZdF"
 - the derivative (1) d(arg(Zosc(F)))/dF at frequency F = Foscss;
- "Osc_ReZ"
 - Re(Zosc(Foscss)) real value of the Zosc(F) at F = Foscss (1);

2. The Large Signal (nonlinear) oscillator analysis variables (2)

- "TraceFprobe"
- "TraceIprobe"
- "TraceVprobe"
 - arrays of dependences Fosc(Vprobe), Iprobe(Vprobe) for tracing values Vprobe **(3)**;
- 1) If the circuit has more then one oscillation frequency, the variable is array (has the value per each oscillation frequency);
- 2) Specific for oscillator analysis only variables;
- 3) The last point of the arrays saves values of Fosc, Iprobe and V probe corresponding to the steady state oscillator solution;

The table summarizes the difference in syntax for HB oscillator measurements in Genesys 2004 vs. Genesys 2006 (and later).

Table 2. Basic HB oscillator analysis Measurements

	Measurement	GENESYS 2004, and earlier	GENESYS 2005.11, and later
1 1	HB solution Frequencies	FHB	Freq
2	Steady State Oscillation	FHB@#1	Freq[2] 1)

	Frequency	FOSHB(MeasContext)	hb_getspcomp(Freq, FreqIndexIM,[1,0,,0]
	Small Signal Oscillation Frequency	FOSC@#0	Osc_Freqs[1]
3	Oscillator port current	loscport(MeasContext)	Not supported 3)
4	Oscillator port voltage	Voscport(MeasContext)	Not supported 3)
5	Frequency sweep of the complex impedance at the oscillator port node	ZOSC	Zosc
6	Trace of oscillation frequency 4)	Not supported	TraceFprobe
7	Trace of oscillator port current 4)	Not supported	Tracelprobe
8	Trace of oscillator port voltage (Vprobe) 5)	Not supported	TraceVprobe

¹⁾¹⁻tone HB oscillator analysis

Harmonic Balance Oscillator Options

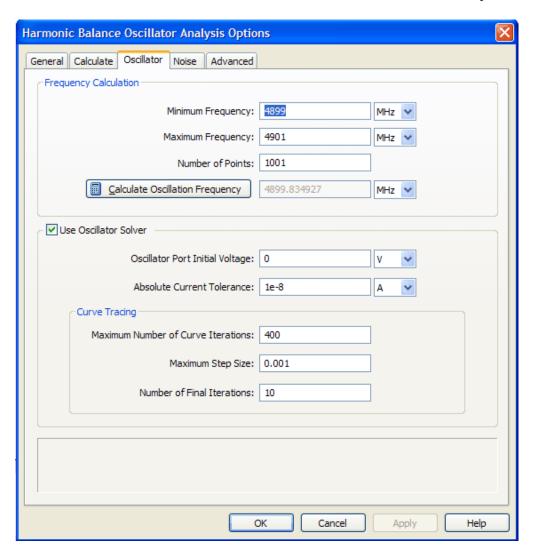
²⁾Multi-tones HB oscillator analysis (oscillator with external signals: synchronized oscillator, self-oscillating mixer)

³⁾Created as a basic HB dataset variable, if the "Save Solution For All Nodes" flag is set

⁴⁾Tracing vs. Vprobe. Tracing conditions:

Im(Iprobe(Vprobe)) =0; Tracing while Re(Iprobe(Vprobe)) < 0.</pre>

⁵⁾Independent variable (Vprobe) for tracing the oscillator measurements.



Minimum Frequency - The smallest frequency to search for the frequency of oscillation.

Maximum Frequency - The largest frequency to search for the frequency of oscillation.

Number of Points - the number of frequencies in the above range, linearly spaced, to search for the frequency of oscillation.

Calculate Osc Frequency - Calculates small signal frequency of oscillation (for linearized circuit at DC operating point)

Harmonic Balance Calculation Options

Use Oscillator Solver - If checked, than performs nonlinear steady state Harmonic Balance Oscillator Analysis.

Oscillator Port Initial Voltage - initial amplitude of 1st harmonic of voltage at OSCPORT node (Vprobe). Default: 0.

Absolute Current Tolerance - maximal absolute value of OSCPORT current (Iprobe), accepted as steady-state solution. Oscillator solver convergence criteria. Default: 1e-8 A;

Number of Curve Iterations - maximal number of curve-tracing iterations, finding Vprobe,

when $Re(Iprobe(Vprobe)) \le 0$ and $Re(Iprobe(Vprobe + Vstep)) \ge 0$;

Default: 200.

Max Step of Curve - maximal voltage amplitude Vprobe step of curve-tracing iterations; Default: 0.05 V.

Number of Final Iterations - maximal number of adjusting voltage amplitude Vprobe terations, finding Vprobe,

when $|Re(Iprobe(Vprobe))| \le AbsCurTol$.

Default: 5

Note. The adjusting Iterations are performed after the tracing algorithm found Vprobe amplitude at which the Re(Iprobe(Vprobe)) function changes its sign at the next curve tracing iteration step.

Next: See HB Oscillator Usage and Theory...

Harbec Nonlinear Noise

Nonlinear Noise Overview

The nonlinear noise options in the Harmonic Balance simulator (Harbec) enable you to calculate:

- Nonlinear spot noise
- Swept noise

If you are not familiar with the harmonic balance simulator, refer to Harmonic Balance Basics, before continuing with this chapter.

Refer to the following topics for details on harmonic balance for nonlinear noise simulation:

- Performing a Nonlinear Noise Simulation describes the minimum setup for calculating noise.
- Basic Concepts is an overview on how nonlinear noise is calculated in a simulation.
- Oscillator Noise Simulation focuses on setting up noise simulations for oscillators.
- Mixer Noise Simulation focuses on noise simulations for mixers.

Performing a Nonlinear Noise Simulation

Use this type of nonlinear noise simulation for spectral noise simulations of circuits.

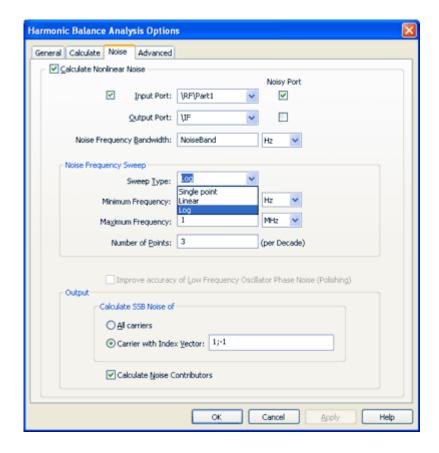
For a successful analysis, observe the following:

1. Nonlinear noise analysis may be performed for one output voltage between 2 circuit nodes or for one output circuit port. If you need to calculate noise figure, you must define a 2nd port (input port) because the noise parameter is meaningful only with respect to two ports.

If the circuit has external injected noise sources, place them where noise is to be injected and edit the component as required. Noise sources are found under the Basic/Sources palette.

Note: When simulating noise figure, noise sources should be added at the input and the input port must be "Noisy", which is set via the checkbox "Noisy Port" for the input port (Harbec Noise properties page). All other circuit ports that are not defined as input and output ports of Harbec noise analysis will contribute thermal noise to the output noise.

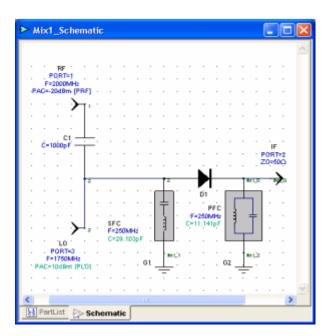
- 2. Open the Harbec Analysis (or Harbec Oscillator Analysis) Noise properties dialog page.
- 3. Select the "Calculate Nonlinear Noise" checkbox and define noise analysis parameters:
- 4. To specify the nodes at which noise will be computed, choose the element "Ouput port" from the pull down list of circuit element names. Nodes of the circuit element define output for noise analysis. The list includes port loads, and 2-terminal elements from the upper level hierarchy of the circuit, excluding elements with branch equations: voltage sources and inductances.
- 5. If output is a port, it activates the "Noisy" checkbox for the output port. Set the checkbox to include noise from the port into output noise.
- 6. To calculate noise propagation parameters (as Noise Figure), specify the input port the same way as output from the pull down list, including only the names of port load elements. The checkbox must be set to activate the "Input port" dialog.
- 7. Set the checkbox "Noisy Port" for the port to include its thermal noise into output noise.



- 8. Define Sweep Type ("Single point", "Linear" or "Log"). Default sweep type is "Log" (Logarithmic). It's recommended to use for sideband noise analysis (SSB, DSB). The "Single point" sweep type is efficient for noise figure calculation at frequency offsets not close to carrier, where the parameter is independent on noise frequency offset from a carrier.
- 9. Define noise sideband frequencies for the noise analysis in the "Noise Frequency Sweep" group. For a swept noise analysis, set the "Minimum Frequency", "Maximum Frequency", and "Number of Points" (per decade for "Log" sweep type) parameters.
- 11. Define output data of the noise analysis. Set the radio button "Calculate SSB Noise of"
 - to "All Carriers" to calculate SSB noise for all noise carriers (all spectral components of Harmonic Balance solution);
 - to "Carrier with Index Vector" to define only one spectral component (carrier) at which SSB noise will be calculated. Set integer index vector of the carrier in the format "k1; k2; ...; kn", where ki is the harmonic index of i-th input signal frequency (from Harbec General page). For example, the

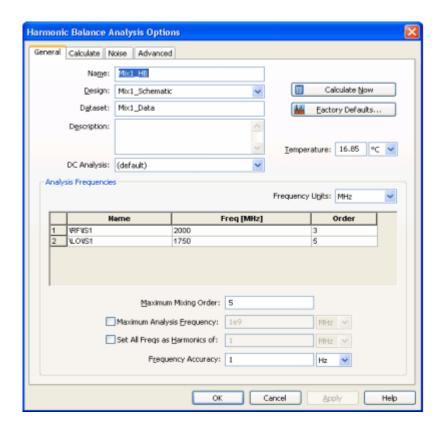
HARBEC (Harmonic Balance Analysis)

lower sideband mixing term in a mixer would be entered as 1 and -1. The indices are listed in sequential order by carrier.



For example, observe the simple mixer circuit above. It has 2 input ports LO (Flo = 1750MHz), and RF (Frf=2000 MHz):

The Frequencies table created for this circuit has n=2 signal sources; the 1st is RF and the 2nd is LO source frequency.



We calculate SSB noise only for the output IF spectral component, whose frequency is defined as:

$$Fif = 1*Frf - 1*Flo,$$

then the index vector of the carrier is:

1;-1

(or -1; 1; the sign of the vector does not matter).

In the general case, to calculate noise of an intermodulation carrier:

$$Fp,q = p*Frf + q*Flo$$

the index vector of the carrier will be:

p;q

(or -p;-q), where |p|=0,1,...,Nrf, |q|=0,1,...,Nlo, where Nrf and Nlo are harmonic orders of the RF and LO frequencies taken into account in the HB analysis (set in the Frequencies table: General page of Harbec properties).

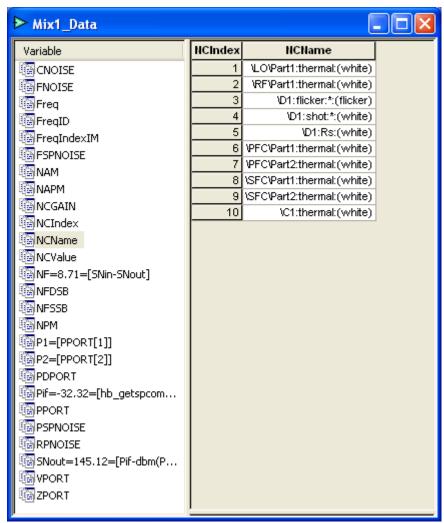
12. To perform noise contributors analysis, set the checkbox "Calculate Noise contributors". This creates noise contributors data in HB analysis output dataset:

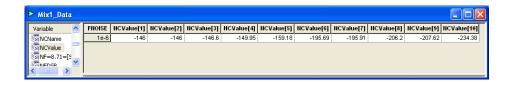
"NCValue" - Relative power of Noise contributors, dBc

"NCName" - Noise contributors names

"NCIndex" - Noise contributors indexes

Note: The noise contributors analysis is activated only for the one carrier noise analysis mode. (*Noise tab/Output/Calculate SSB noise of Carrier with Index vector*). The noise contributors in the tables NCName, NCValue, NCIndex are sorted by weight (NCValue) of noise contributor in output SSB noise of the carrier (from most significant to less significant contributors). The table always consists of the same noise contributors, but their order in the table depends on the noise carrier (defined by its index vector).





- 13. The Checkbox "Improve accuracy of Low Frequency Oscillator Phase Noise (Polishing)" is active only in the Harbec Oscillator controller. Checking it improves the low frequency phase noise solution where the phase noise would otherwise undergo flattening.
- 14. Specify the Noise Frequency Bandwidth parameter value. The output noise voltages scale with the square root of the noise parameter Bandwidth. The default bandwidth is 1 Hz, so that the results have units of .

Notes:

- Bandwidth is for spectral noise simulation. 1 Hz is the recommended bandwidth for measurements of spectral noise power. The noise contributor data do not scale with noise bandwidth.
- To Calculate Noise Figure, set Simulation Temperature (on General page of Harbec options) 16.85 C (or 290 Kelvin). It is the standard temperature for noise figure measurement as defined by the IEEE definition for noise figuration.
- The option Include port noise (setting checkboxes "Noisy" for noise simulation ports) tells the simulator to include the contributions of port noise in the analysis of noise voltages and currents.
- Once you have entered these settings, you can switch the noise simulation off to speed up intermediate simulations by disabling Nonlinear noise at the bottom of the dialog. Your settings will remain in the Noise tabs and become active when Nonlinear noise is enabled again.

Basic Concepts

The results of the harmonic balance simulation (HB solution and Jacobian matrix) are used to determine the periodic operating point for the nonlinear noise simulation. The periodic operating point is the set of steady-state voltages and currents within the circuit at the fundamental, harmonic, and all mixing frequencies. Every upper and lower noise sideband is modeled for each large-signal spectral component; consequently, the number of noise frequencies simulated is double the harmonic frequencies. The result is that a nonlinear noise simulation requires four times the memory of a normal harmonic balance simulation. Use low values for the parameter *Maximum Order* (under the General tab) to limit the demands on computer memory.

If computer memory is insufficient for a noise simulation, reduce the number of tones in the harmonic balance simulation component by 1. The results of the noise figure simulation should not change significantly.

If the noise figure is needed, add an input port to the circuit. In addition, because the single-sideband definition of noise figure is used, the correct input sideband frequency must be specified. The frequency is associated with input port name. To provide the noise figure measurements, the input port must be a one tone signal port.

Oscillator Noise Simulation

This section focuses on setting up noise simulations for oscillators. It describes how to calculate:

- Phase noise around fundamentals and harmonics
- Absolute noise voltage spectrum around a harmonic
- Relative noise voltage spectrum around a fundamental

If you are not familiar with the general procedures for simulating oscillators, refer to Harmonic Balance for Oscillator Simulation before continuing with this chapter.

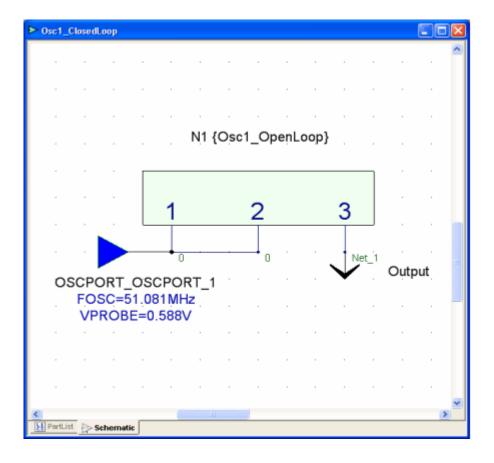
Simulating Phase Noise

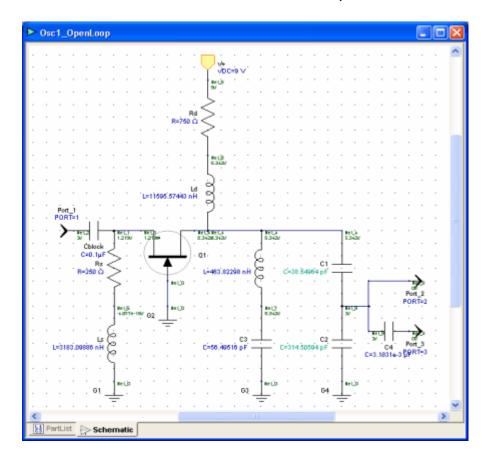
To determine oscillator phase noise:

- 1. Open the Harmonic Balance Oscillator Analysis Options dialog box, Noise tab and enable Nonlinear noise.
- 2. To calculate oscillator phase noise, specify an output port (or output voltage) where the noise will be calculated. Set the checkbox "Noisy" to include noise of the port in phase noise contributors. The phase noise does not need specification of an input port; it may be disabled.
- 3. Set parameters of the frequencies sweep, for example:

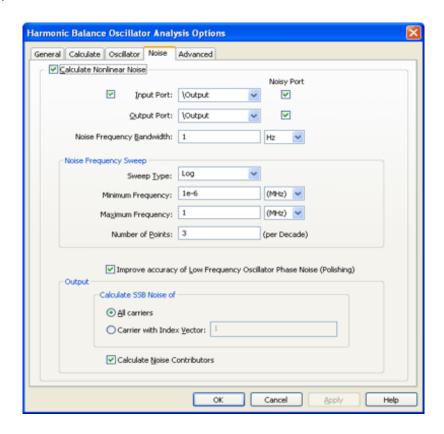
```
Minimum Frequency = 1Hz
Maximum Frequency = 1MHz
Number of Points per decade = 3
```

- 4. Set the checkbox "Improve accuracy of Low Frequency Oscillator Phase Noise (Polishing)" to improve phase noise accuracy at low frequencies, where the characteristic becomes flattened.
- 5. Set the index vector of output carrier. For an oscillator it is typically its index of 1st harmonic "1"; for some applications it may be any harmonic of the oscillator spectrum.
- 6. Set the checkbox "Calculate noise contributors" to perform the noise contributors analysis.





The oscillator simulation noise page is shown below. Parameters for oscillator noise analysis are specified here.



After the oscillator simulation, Harbec creates a set of dataset variables for the oscillator noise analysis:

Name	Descriptio n	Dependence	Data Size	Units	Data Type
FSPNOISE	Frequencies of Noise spectrum	<indep></indep>	2*Ncarriers*Npoints	Freq (MHz)	real
PSPNOISE	Noise sidebands power spectrum	FSPNOISE	2*Ncarriers*Npoints	dBm	real
FNOISE	Noise frequencies	<indep></indep>	Npoints	Freq (Hz)	real
CNOISE	Noise sidebands	FNOISE	Npoints*4*Ncarriers	Volts^2/Hz	complex

HARBEC (Harmonic Balance Analysis)

	correlation matrix				
RPNOISE	Relative power of SSB noise	FNOISE	Npoints	dBc	real
NAM	Relative power of AM SSB noise	FNOISE	Npoints	dBc	real
NPM	Relative power of PM SSB noise	FNOISE	Npoints	dBc	real
NAPM	Relative power of AM-PM SSB noise correlation	FNOISE	Npoints	dBc	complex
NCValue	Relative power of Noise contributors	FNOISE	Npoints * Ncontrib	dBc	real
NCName	Noise contributors names	NCIndex	Ncontrib	<none></none>	String
NCIndex	Noise contributors indexes	<indep></indep>	Ncontrib	<none></none>	Integer

Nearriers:

The number of noise carriers. A carrier is a spectral component of HB analysis solution. Nearriers = 1 if noise calculated for one carrier and

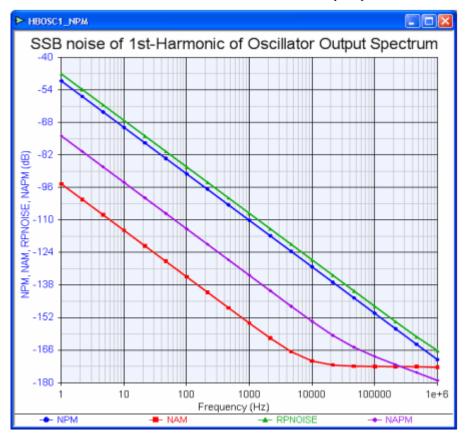
Ncarriers = nHBFreqs if noise calculated for all carriers, where nHBFreqs is the number of frequencies of the HB solution, including DC component.

Npoints: number of noise frequency points, used to calculate noise of SSB.

Ncontrib: number of noise contributors into output noise (all nonzero valued primary noise sources of all circuit elements).

Some examples of the plotted dataset variables are shown below.

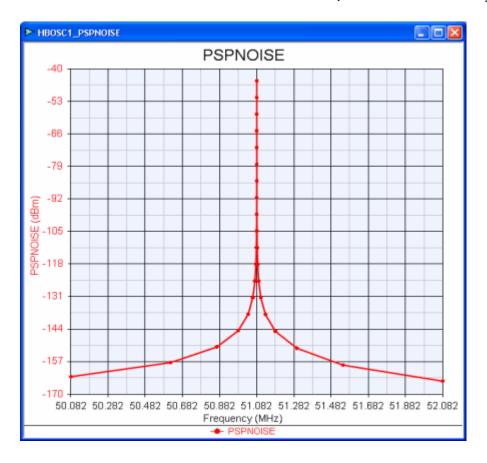
Oscillator SSB noise measurements for 1st harmonic of output spectrum, dBc:



Notice that the noise is at least 45 dB below the fundamental (resonant) frequency.

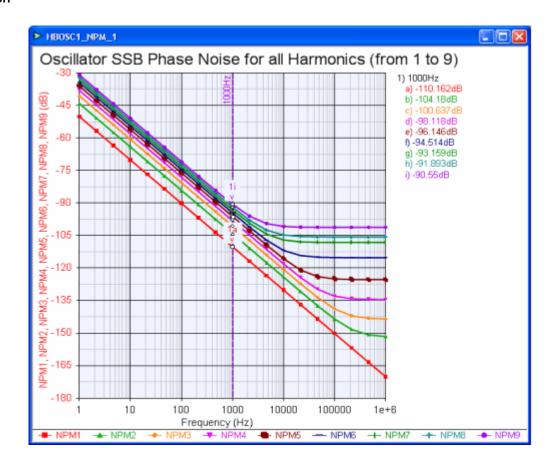
The simulated noise sidebands of 1st harmonic of the oscillator are shown next. The spectrum extends from (Fc-1 MHz) to (Fc + 1 MHz), and is assumed to be centered relative to the carrier frequency, where Fc is the carrier frequency. In this case Fc=Fosc, Fosc is the steady state oscillations frequency.

Oscillator noise spectrum around 1st harmonic:



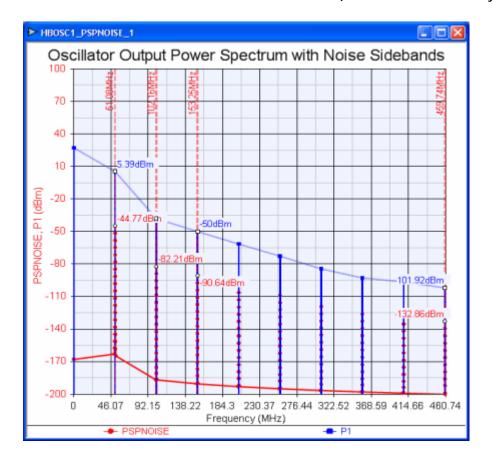
The next figure shows the results of the oscillator phase noise simulation for all carriers (from 1 to 9th harmonics); it shows that phase noise results around 9th harmonic comparing with fundamental is seen to be increased 20 log(9), or 19.1 dB, as expected.

Phase noise of all Oscillator Harmonics:



Below is the oscillator output power spectrum with noise sidebands calculated for all carriers in for noise frequency sweep from 1Hz to 1MHz.

Oscillator Output Power Spectrum with all noise sidebands absolute noise power spectrum:



Basics of Phase Noise Simulation

An oscillator phase noise analysis computes the noise sidebands of the oscillator carrier frequency as well as:

- Normal frequency conversion
- Amplitude-noise-to-frequency-noise conversion
- Frequency translation of noise, caused by component nonlinearities in the presence of large-signal oscillator signals. Up converted flicker noise is a commonly observed effect.
- Bias changes due to the oscillator signals. Any shift in DC bias that occurs in the presence of the oscillation waveforms is taken into account. This bias-shift calculation is needed for accurate calculations of nonlinear device noise.

The results from the phase noise analysis have NPM (phase noise, in dBc/Hz) and NAM (AM noise, in dBc/Hz) for specified output circuit nodes or port.

How Harbec Simulates Phase Noise

Phase noise in an oscillator can be analyzed from small-signal mixing of noise. The small-signal mixing of noise comes from the nonlinear behavior of the oscillator, where noise mixes with the oscillator signal and harmonics to mix to sideband frequencies on either side of the oscillator signal.

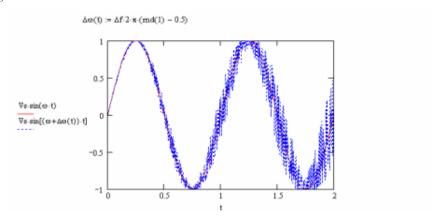
The phase noise computed is available to the user directly in dBc.

To model oscillator phase noise with a noise mixing analysis, the noise at the sidebands on either side of the carrier are obtained from a small-signal mixer analysis where noise sources mix with the oscillator large signals to produce noise sidebands. The noise at these two sideband frequencies and their correlation is then used to compute the phase noise. The mixing analysis additionally computes the AM noise as well as phase noise, and correlation between AM and PM noise.

Basic Phase Noise Theory

Phase noise occurs naturally in electronic circuits. It can be observed in the time domain as phase jitter of the signal on an oscilloscope display or as time fluctuations of the zero crossings (see the following figure).

The below figure shows Phase Noise in the Time domain:



Frequency and phase are related by equation:

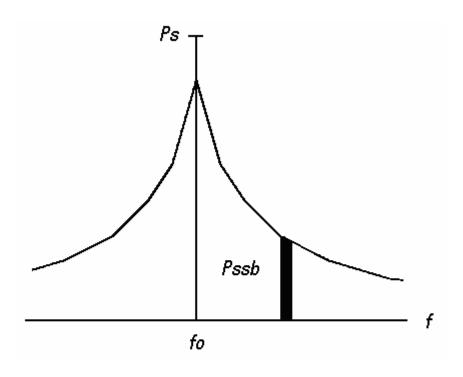
$$f(t) = \frac{1}{2 \cdot T} \cdot \frac{d\varphi(t)}{dt}$$

Phase noise and frequency fluctuations are the same physical phenomenon. Noise in angular frequency can be obtained from the derivative of phase with respect to time. The modulation of the signal phase manifests itself in the sidebands of the oscillator carrier as offsets from the carrier frequency; these offsets are related to the multiples of angle-modulation frequency. For small angle modulation, only the first term is important and

the relationship between the phase deviation and the sideband level is approximated as follows:

$$\frac{P_{\text{SSB}}(f)}{P_{\text{S}}} = \frac{1}{2} \cdot \Delta \varphi_{\text{rms}}^2(f)$$

A common but indirect representation of phase noise is denoted L(f) (see the following figure). This is the ratio of the single-sideband noise power (in a 1-Hz bandwidth at an offset frequency from the carrier) to the total carrier power. This common representation is applicable only to small phase deviations.



Phase noise definition

$$L(f) = \frac{P_{SSB}(per \ 1 \ Hz)}{P_{S}} \left[dBc \ / \ Hz \right]$$

Oscillator Phase-Noise Analysis

The simulator computes the noise at an offset from the unknown oscillation frequency. After the normal harmonic-balance noise analysis has determined the steady-state

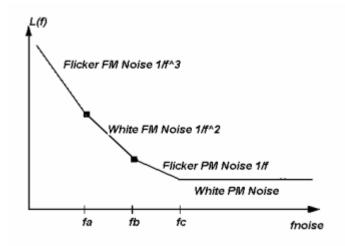
oscillation frequency and amplitude, the phase-noise analysis computes the noise amplitude as an offset from the carrier. With this noise spectral density Sv(f), the phase noise can be computed as

$$L(f) = \frac{P_{SSB}(per \ 1 \ Hz)}{P_{S}} \left[dBc \ / \ Hz \right]$$

where Ps is the amplitude of the carrier of oscillator output, for which the phase noise is measured.

There are four distinct regions of phase noise, as shown next. Note that not all oscillators will show all four regions.

Phase Noise dependence for frequency offset from a carrier:



- The lowest frequency is dominated by flicker FM noise, which is device flicker noise that causes a random frequency modulation. This has a slope of $1/f^3$.
- White FM noise, is white noise that causes a random frequency modulation. This has a slope of 1/f^2.
- Flicker PM noise is modeled by flicker noise that mixes up to the oscillation frequency. This has a slope of 1/f.
- White PM noise is simply white noise that mixes up to the oscillation frequency. This has the typical flat white-noise floor.

Mixer Noise Simulation

This section focuses on setting up and using noise simulations for mixers. It describes how to calculate:

• Noise analysis frequency translation of the noise

- Nonlinear spot noise
- Nonlinear swept noise

Determining Mixer Noise

Here we illustrate an example for determining mixer noise.

The noise figure computed by a harmonic balance noise simulation is a single sideband noise figure.

Note: Port sources and an output termination (port component) are necessary only if a noise figure simulation is being performed. The model used in the current design is a 2-port model, and allows controlling noise the input and output ports. Noise of other ports of the circuit (for example noise of LO port) are taken into account automatically, as noise of other circuit components.

To determine mixer noise, set the analysis temperature and Noise tab parameters.

• On General tab of Harbec options set simulation Temperature

Note: In nonlinear noise analyses, we recommend setting simulation temperature equal to 16.85 C or 290 K, which is the standard temperature for noise figure measurement as defined by the IEEE definition for noise figuration.

- On the "Noise" tab of Harbec options, define input and output ports and set the "Noisy" checkbox for Input and clear it for Output ports.
- Define noise frequency sweep parameters. For most applications of mixer noise simulation it may be only a single noise frequency point noise analysis, corresponding to equal values of Minimum and Maximum noise sweep frequencies.
- Set value of Output Carrier Index Vector; for example, for Fif = |Flo Frf| the value must be: 1;-1 (or -1;1).
- Simulate (See Performing a Nonlinear Noise Simulation for sample output data and graphs)

Harbec computes single sideband noise (NFSSB), using the IEEE standard definition of single sideband noise figure:

$$NF_{SSB}(f) = 10 \cdot \lg \left[\frac{u_{noise}^{2}(f) / R + k \cdot T_{0} \cdot (G_{1} + G_{2} + \dots + G_{n})}{k \cdot T_{0} \cdot G_{1}} \right]$$

$$(1)$$

where

k is Boltzmann's constant (1.389658x10-23),

To is the IEEE standard temperature for noise figure (290 K),

G1 is the conversion gain of the mixer,

G2 is the image conversion gain of the mixer,

G3,...,Gn are conversion gains of higher order mixing products,

R is the resistance of the output termination,

Unoise is the noise voltage at the output port at the output frequency where the input and output terminations do not contribute any noise.

The NFSSB may be also calculated, using post-processing equations:

$$NF_{SSB} = \frac{SN_{out}}{SN_{in}}$$
(2)

where

$$SN_{OUT} = \frac{P_{OUT}(F_{IF})}{PN_{OUT}(F_{IF})}$$

is the output port signal to noise ratio;

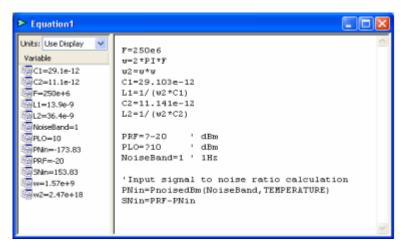
$$SN_{I\!N} = \frac{P_{I\!N}(F_{RF})}{k \cdot T_0}$$

is the input port signal to noise ratio;

$$PN_{OUT}(F_{IF}) = u_{noise}^2(F_{IF})/R + k \cdot T_0 \cdot (G_1 + G_2 + \dots + G_n)$$

is the total output port noise power density in 1 Hz bandwidth, including noise contributors from all circuit ports, excluding the output port. Noise figure SSB, calculated from the formulas (2) uses large signal conversion gain, while formula (1) uses small signal conversion gains, calculated at the steady state regime of the circuit. The results, calculated using formula (1) and (2) will be close each other for small nonlinearity of the circuit relatively to the input signal.

Harbec Equations block, including calculation of SNin:



The thermal noise in the equations is calculated using function:

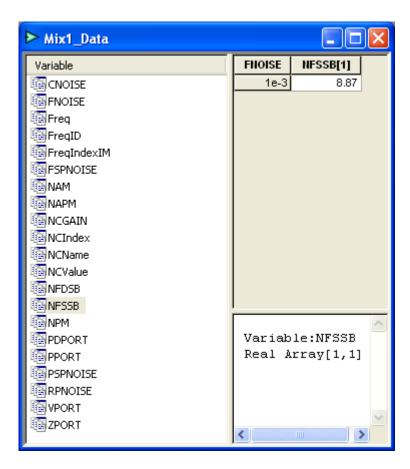
$$PnoisedBm(NoiseBand, Tc) = 10 * lg(k * (Tc+273.15) * NoiseBand)$$

where

Te ambient temperature, Celsius,

NoiseBand noise frequency bandwidth.

Harbec mixer analysis output dataset including equations that calculate PIF=POUT(FIF), SNOUT, and NF=NFSSB:



Harbec also computes the double sideband noise figure using the following equation:

$$NF_{DSB}(f) = 10 \cdot \lg \left[\frac{u_{noise}^2(f) / R + k \cdot T_0 \cdot (G_1 + G_2 + \dots + G_n)}{k \cdot T_0 \cdot (G_1 + G_2 + \dots + G_n)} \right]$$

This is the value that would be computed by a noise figure meter. Harbec calculates it internally and saves it in the dataset variable *NFDSB*.

If a noise simulation of a non-oscillating circuit has both input and output ports defined, Harbec calculates the SSB noise power conversion gain NCGAIN from the input port and input noise carrier frequency to the output port, with output noise carrier frequency (frequencies), defined as:

 $NCGAIN(Fnoise) = dBm(Noise\ power\ of\ the\ SSB\ noise\ of\ the\ Output\ noise\ carrier\ ,$ propagated from SSB noise of the input noise carrier) –

- dBm(Power of the SSB noise of the input noise carrier) =

$$= 10 \cdot \lg \left[\frac{k \cdot T_0 \cdot G_k(Fnoise)}{k \cdot T_0} \right] = dB(G_k(Fnoise)),$$

where G_k is the conversion gain of the input noise power for the input noise carrier frequency to the output noise power of the k-th output noise carrier,

Fnoise is a noise offset frequency.

At the zero noise offset frequency and small nonlinearity of the circuit relatively to the input signal the noise conversion gain is equal to the power conversion gain from the input port frequency to the k-th spectral component of the output port, which is calculated from the spectral analysis of the circuit.

$$G_k(0) = \frac{Vout_k \cdot Vout_k^*}{2 \cdot \text{Re}(Zout(F_k)) \cdot Pin}$$

where Vout(k) is the complex voltage amplitude of the k-th output noise carrier, and F(k) is the frequency of the k-th output noise carrier.

Zout(F(k)) is the impedance of the output load at the carrier frequency F(k); Pin is the available power of the input noise carrier.

Entering Nonlinear Models

GENESYS supports four different way to enter nonlinear models:

- Direct Schematic Entry
- Single Part Model
- Nonlinear Model Library

The simple way is to enter a nonlinear model is through direct schematic entry. You place a nonlinear device, such as an NPN transistor, from the schematic tool bar. Then double-click the device and type in the device parameters. The advantage of this technique is that it is simple. The disadvantage is that it is not as easy to reuse the device in another design.

Simulation

Another way to enter a nonlinear model is to create a single part model. This is similar to using a model statement in other simulators. See the Designs: Single Part Model section in this User's Guide for details.

A third way to enter nonlinear models is to choose one from the supplied library of parts. To do this, just enter the base nonlinear model that you would like (for example, a PNP), then change the model to the desired part using the "Model..." button on the element parameter dialog.

Chapter 7: Linear Analysis

Overview

Linear simulation calculates S-parameters and noise parameters of a schematic design. If the circuit contains nonlinear elements, DC simulation is first run automatically and the nonlinear devices are linearized at the DC operating point.

Port Impedance Usage

- The design must have input/output ports in sequential order.
- Balanced Ports are fully supported.
- All impedances are specified on the design's ports.
- To use a complex port impedance, you can either directly use a complex number in the port termination or you can use a 1-port data file.

To add a linear analysis:

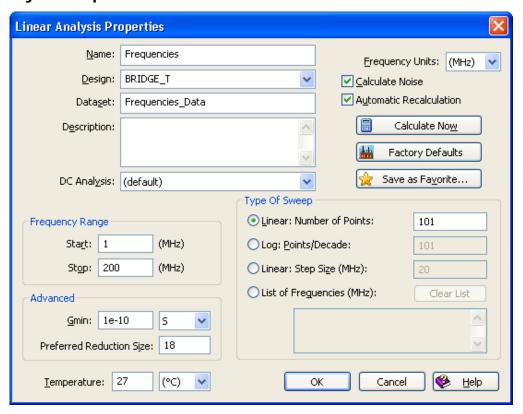
- 1. Create a design with a schematic.
- 2. Click the New Item button () on the Workspace Tree toolbar and choose "Add Linear Analysis" from the Analyses menu.
- 3. Define the Analysis Properties and click **OK**.
- 4. The analysis runs and creates a data set.

Note: S-Parameters are calculated with respect to ports; you must have ports in the schematic numbered in ascending order from 1 to run a linear analysis.

See also:

Measurements (later in this manual) Outputs Overview, User's Guide

Linear Analysis Properties



Name	Description
Name	Name of Analysis
Design	Design on which the Linear Analysis is run
Dataset	Dataset file in which the data is saved. If not specified, the dataset name will be the name of the analysis with "_Data" appended.
Description	Description of the analysis being run. For documentation purposes only, not otherwise used by GENESYS.

DC Analysis		If you select (default) it will use an internal DC Analysis (with default options) to set operating point. Or, you can select a DC Analysis to have operating point calculated using a custom DC set of options.	
Calculate No	W	Runs the analysis, regardless of whether or not any changes were made.	
Factory Defa	ults	Reset all values to their default	
Save As Favo	orite	Close the dialog and establish the analysis settings as a default for the "new" operation. When you create a new linear analysis it will look just like this favorite.	
Calculate No	ise	Enable this to have the linear analysis create a CS noise correlation matrix. If this is disabled, NF can not be calculated. Disable this to increase calculation speed and reduce storage requirements.	
Advanced	GMin	GMin is an admittance added into the circuit if the circuit is not invertible (for example a capacitor of infinite Q to ground). Change this only to increase dynamic range of the analysis if your circuit values are clumped higher.	
	Preferred Reduction Size	When Linear Analysis creates a matrix tree this is the optimal size of the branches. Increasing this may reduce execution time. Decreasing this will tend to increase tuning speed at the expense of overall execution speed.	
	Start Frequency	The lower bound (minimum frequency) of the linear simulation. Equations may be used here (no = needed).	
Fraguency	Stop Frequency	The upper bound (maximum frequency) of the linear simulation. Equations may be used here (no = needed).	
Frequency Range	Frequency Units	Unit of measure used to specify the frequency.	
	Temperature	Ambient temperature at which the linear analysis is performed, specified in the unit of measure chosen from the drop-down menu. Equations may be used here (no = needed).	

Type of Sweep	Linear: Number of Points	Number of points in entire simulation. Equations may be used here (no = needed).
	Log: Points/Decade	Number of points in every decade. Equations may be used here (no = needed).
	Linear: Step Size (MHz)	Allows specification of start and stop frequencies, and space between points. Equations may be used here (no = needed).
	List of Frequencies (MHz)	Allows the explicit specification of analysis frequencies. These points are entered into the List of Frequencies box separated by spaces. Equations may be used here (no = needed).

S Parameters

Overview

The purpose of this section is to summarize network analysis concepts and to define some of the parameters plotted by GENESYS. For further details on measurements, see the Measurements section of this manual.

Networks are considered as "black boxes". Because the networks are assumed to be linear and time invariant, the characteristics of the networks are uniquely defined by a set of linear equations relating port voltages and currents. A number of network parameter types have been developed for this purpose, including H, Y, Z, S, ABCD, and others. These parameters may be used to compute and display network responses and to compute quantities useful for circuit design such as Gmax (maximum gain) and gain circles. Each parameter type has advantages and disadvantages. Carson [1] and Altman [2] provide additional information.

S-Parameter Basics

S-parameters have earned a prominent position in RF circuit design, analysis, and measurement. Parameters used earlier in RF design, such as Y-parameters, require opens or shorts on ports during measurement. This is a nearly impossible constraint for high-frequency broadband measurements. Scattering parameters [3, 4] (S-parameters) are defined and measured with the ports terminated in a characteristic reference impedance.

Modern network analyzers are well suited for measuring S-parameters. Because the networks being analyzed are often employed by insertion in a transmission medium with a common characteristic reference impedance, S-parameters have the additional advantage that they relate directly to commonly specified performance parameters such as insertion gain and return loss.

Two-port S-parameters are defined by considering a set of voltage traveling waves. When a voltage wave from a source is incident on a network, a portion of the voltage wave is transmitted through the network, and a portion is reflected back toward the source. Incident and reflected voltage waves may also be present at the output of the network. New variables are defined by dividing the voltage waves by the square root of the reference impedance. The square of the magnitude of these new variables may be viewed as traveling power waves.

 $|a_1|^2$ = incident power wave at the network input

 $|b_1|^2$ = reflected power wave at the network input

 $|a_2|^2$ = incident power wave at the network output

 $|b_2|^2$ = reflected power wave at the network output

These new variables and the network S-parameters are related by the expressions:

$$b_1 = a_1 S_{11} + a_2 S_{12}$$

$$b_2 = a_1 S_{21} + a_2 S_{22}$$

$$S_{11} = b_1/a_1, a_2 = 0$$

$$S_{12} = b_1/a_2$$
, $a_1 = 0$

$$S_{21} = b_2/a_1$$
, $a_2 = 0$

$$S_{22} = b_2/a_2$$
, $a_1 = 0$

Terminating the network with a load equal to the reference impedance forces $a_2 = 0$. Under these conditions

$$S_{11} = b_1/a_1$$

$$S_{21} = b_2/a_1$$

 S_{11} is then the network input reflection coefficient and S_{21} is the gain or loss of the network.

Terminating the network at the input with a load equal to the reference impedance and driving the network from the output port forces $a_1 = 0$. Under these conditions

$$S_{22} = b_2/a_2$$

$$S_{12} = b_1/a_2$$

 S_{22} is then the network output reflection coefficient and S_{12} is the reverse gain or loss of the network.

Linear S-parameters are unitless. Since they are based on voltage waves, they are converted to decibel format by multiplying the log of the linear ratio by 20. It is not always obvious whether an author is referring to linear or decibel parameters. To avoid this confusion, the

book Oscillator Design and Computer Simulation and Versions 5.4 and earlier of SUPERSTAR use C for linear S-parameters and S for the decibel form. This is somewhat unconventional. Version 6.0 and later of GENESYS also supports the convention MAG[S21] which is linear and DB[S21] which is the decibel form. With reflection parameters, the linear form is often referred to as a reflection coefficient and the decibel form as return loss.

S₁₁(dB)=input reflection gain=20 log S₁₁

S₂₂ (dB)=output reflection gain=20 log S₂₂

S₂₁(dB)=forward gain=20log S21

S₁₂(dB)=reverse gain=20log S12

S₂₁ and S₁₂ are the forward and return gain (or loss) when the network is terminated with the reference impedance. The gain when matching networks are inserted at the input, output, or both is described later.

 S_{11} and S_{22} coefficients are less than 1 for passive networks with positive resistance. Therefore, the input and output reflection gains, S_{11} and S_{22} , are negative decibel numbers. Throughout Eagleware material, the decibel forms S_{11} and S_{22} are referred to as return losses, in agreement with standard industry convention. To be mathematically correct, they have been left as negative numbers. As such, the rigorous convention would be to call them return gain.

Input VSWR (VSWR₁) and S₁₁ are related by

$$VSWR_1 = (1 + |S_{11}|) / (1 - |S_{11}|)$$

The output VSWR is related to S₂₂ by an analogous equation. A circle of constant radius centered on the Smith chart is a circle of constant VSWR. The complex input impedance is related to the input reflection coefficients by the expression:

$$I_1 = Z_o (1 + S_{11}) / (1 - S_{11})$$

The output impedance is similarly related to S₂₂.

Stability

Because S12 of devices is not zero, a signal path exists from the output to the input. This feedback path creates an opportunity for oscillation. The stability factor, K, is

$$K = (1 - |S_{11}|^2 - |S_{22}|^2 + |D|^2) / (2 |S_{12}| |S_{21}|)$$

where

$$D = S_{11}S_{22} - S_{12}S_{21}$$

From a practical standpoint when K>1, S_{11} <1, and S_{22} <1, the two-port is unconditionally stable. These are often stated as sufficient to insure stability. Theoretically, K>1 is insufficient to insure stability, and an additional condition should be satisfied. One such parameter is B1 which should be greater than zero.

B1 = 1 +
$$|S_{11}|^2 - |S_{22}|^2 - |D|^2 > 0$$

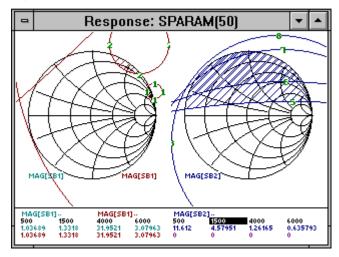
Stability circles may be used for a more detailed analysis. The load impedances of a network which ensure that $S_{11} < 1$ are identified by a circle of radius R centered at C on a Smith chart. The output plane stability circle is

$$C_{\text{out}} = (S_{22} - DS_{11}^*)^* / (|S_{22}|^2 - |D|^2), R_{\text{out}} = |S_{12}S_{21} / (|S_{22}|^2 - |D|^2) |$$

This circle is the locus of loads for which $S_{11} = 1$. The region inside or outside the circle may be the stable region.

The input plane stability circle equations are the same as the output plane equations, with 1 and 2 in the subscripts interchanged.

Shown in the figure below are the input plane stability circles on the left and the output plane stability circles on the right for the Avantek AT10135 GaAsFET. The shaded regions are potentially unstable. At the input, the stability circle with marker 1 indicates sources with a small resistive component and inductive reactance of about 200 ohms are unstable. Circles 2 and 3 are also unstable with low resistance and certain inductive source impedances. At the output plane on the right, at 500 MHz, a wide range of inductive loads is potentially unstable.



When designing an amplifier the first step is to examine the stability circles of the device without the matching circuit present. The grounding which will be present at the emitter or source should be included in the analysis. This stability data is used to 1) add stabilizing components such as shunt input and output resistors for bipolars or inductance in the source path for GaAsFETs and to 2) select an input and output matching network topology which properly terminates the device (at low and high frequencies) for stability.

In the example above, matching networks with a small series capacitor adjacent to the device would insure capacitive loads at low frequencies, thus enhancing stability. This is probably sufficient for the input. However, considering that device S-parameter data is approximate and since the output plane of this device is more threatening, it would be prudent to stabilize this device in addition to using series capacitors.

Note: Stability should be checked not only at the amplifier operating frequencies, but also over the entire frequency range for which S-Parameter data is available.

Matching

One definition of network gain is the transducer power gain, Gt: Transducer power gain is the power delivered to the load divided by the power available from the source.

```
Gt = P(delivered-to-load) / P(available-from-source)
```

Other gain definitions include the power gain, Gp, and the available power gain, Ga.

```
Gp = P(delivered-to-load) / P(input-to-network)
```

The S-parameter data for the network is measured with a source and load equal to the reference impedance. If the network is not terminated in the reference impedance, Gt can be computed from the reflection coefficients of the terminations on the network and the S-parameters of the network. At this point we have multiple sets of reflection coefficients: those of the terminations and S11 and S22 of the network. To avoid confusion the termination reflection coefficients are given a different symbol, G.

The transducer power gain with the network inserted in a system with arbitrary source and load reflection coefficients is [4]:

$$Gt = (|S_{21}|^2 (1 - |R_s|^2)(1 - |R_L|^2)) / |(1 - S_{11}R_s)(1 - S_{22}R_L) - S_{21}S_{12}R_LR_S|^2$$

where

 R_S = reflection coefficient of the source

 R_L = reflection coefficient of the load

If and are both zero, then

 $Gt=S_{21}$

or

$$Gt(dB)=20log S_{21}=S_{21}(dB)$$

Therefore, when a network is installed in a system with source and loads equal to the reference impedance, S_{21} is the network transducer power gain in decibels.

Because S₁₁ and S₂₂ of a network are not in general zero, a portion of the available source power is reflected from the network input and is dissipated in the source. The insertion of a lossless matching network at the input (and/or output) of the network could increase the gain of the overall system if reflections toward the source were reduced. Shown below is a two-port network with lossless matching networks inserted between the network and the source and load.

GMAX and MSG

When the input and output networks are simultaneously designed for maximum gain, there is no reflection at the source or load. The maximum transducer power gain, G_{max} , is given by

$$G_{max} = (|S_{21}| / |S_{12}|) * (K - sqrt(K^2 - 1))$$

The maximum stable gain, MSG, is defined as G_{max} with K=1. Therefore

$$MSG = |S_{21}| / |S_{12}|$$

A GENESYS plot of GMAX shows G_{max} when K>1 and MSG when K<1.

Again, achieving this maximum gain requires that the input network is designed such that R_S is the complex conjugate of S₁₁ and R_L is the complex conjugate of S₂₂. GENESYS returns the required reflection coefficients, impedance and admittance for the input and output networks as GM1, GM2, ZM1, ZM2, YM1 and YM2, respectively.

The Unilateral Case

Historically, to simplify the complex equation for Gt in the previous section on matching, S_{12} was set to zero. At higher frequencies, where the device S_{12} is typically larger, this assumption is less valid. The assumption simplifies manual and graphical design but is unnecessary in modern computer-assisted design. The assumption also allows factoring the above equation into terms that provide insight into the design process. If $S_{12} = 0$, then

$$Gtu = (|S_{21}|^2 (1 - |R_s|^2)(1 - |R_L|^2)) / |(1 - S_{11}R_S)(1 - S_{22}R_L)|^2$$

where

Gtu=unilateral transducer power gain

When both ports of the network are conjugately matched, and $S_{12} = 0$,

$$Gtu = |S_{21}|^2 / ((1 - |S_{11}|^2)(1 - |S_{22}|^2))$$

The first and third terms indicate the gain increase achievable by matching the input and output, respectively. If S_{11} or S_{22} approach 1, substantial gain improvement is achieved by matching. Matching not only increases the network gain, but reduces reflections from the network.

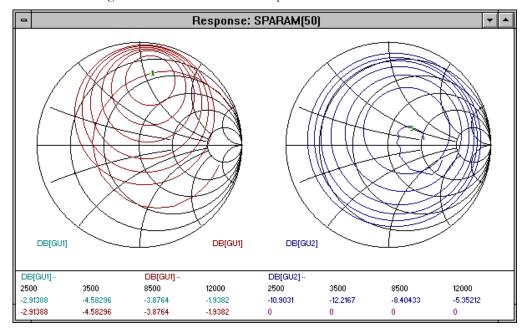
When network gain flatness across a frequency band is more desirable than minimum reflections, the lossless matching networks are designed to provide a better match at frequencies where the two-port gain is lower. By careful design of amplifier matching networks, it is possible to achieve a gain response flat within fractions of a decibel over a bandwidth of an octave or more.

Gain Circles

When the device is complex conjugately matched, the transducer gain is Gmax and if the device is terminated with the same resistance used to measure the device S-parameters the transducer gain is S_{21} . The gain with arbitrary terminations can be visualized on the Smith chart using gain circles.

GENESYS plots three forms of gain circles: transducer gain unilateral circles, GU1 for the input network and GU2 for the output network, power gain output network circles, GP, and available gain input network circles, GA.

Shown below are the input and output unilateral transducer gain circles, GU1 and GU2, of the Avantek AT10135 GaAsFET transistor. The measurement circles are plotted at the frequency of the first marker, in this case 2500 MHz. Marker 1 is plotted at the center of the smallest circle, the point of maximum gain. The gain at the circumference of each circle of increasing radius is 1 dB lower than the previous inside circle.



The arc which is orthogonal to the gain circles is the locus of smallest circle center points from the lowest to highest sweep frequency. Tuning the first marker frequency moves the center of the circles along this arc.

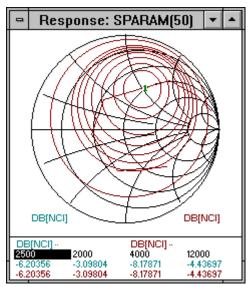
Notice that a complex conjugate match at the input improves the gain by over 3 dB in relation to an unmatched 50 ohm source impedance. However, matching the output provides less than 1 dB gain improvement. An examination of the device S-parameter data at 2500 MHz reveals that the output is originally closer matched to 50 ohms and it is not surprising that a matching network would be less beneficial.

Noise Circles

To achieve the best available noise figure from a device the correct impedance must be presented to the device. The impedance resulting in the best noise performance is in general neither equal to 50 ohms or the impedance which results in minimum reflection at the source.

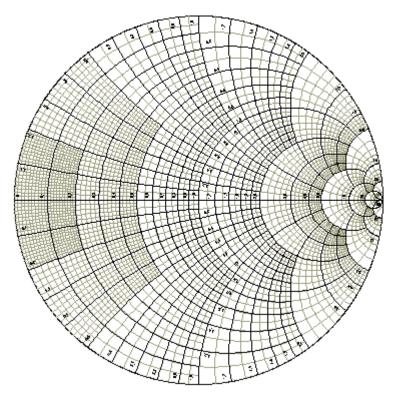
The Avantek AT10135 GaAsFET transistor S-parameter data given earlier includes noise data. This data is comprised of four numbers for each frequency. These numbers are NFopt(dB), the optimum noise figure when correctly terminated, Gopt magnitude and angle, the terminating impedance at the device input which achieves NFopt and Rn/Zo, a sensitivity factor which effects the radius of the noise circles.

Noise circles plotted by GENESYS for the AT10135 at 2500 MHz are given below. Circles of increasing radius represent noise figure degradations of 0.25, 0.5, 1, 1.5, 2, 2.5, 3 and 6 dB. In this case, direct termination of the device with a 50 ohm source results in a degradation of the noise figure of 1 dB. The arc orthogonal to the circles is the locus of Gopt versus frequency.



Smith Chart

In 1939, Philip H. Smith published an article describing a circular chart useful for graphing and solving problems associated with transmission systems [36]. Although the characteristics of transmission systems are defined by simple equations, prior to the advent of scientific calculators and computers, evaluation of these equations was best accomplished using graphical techniques. The Smith chart gained wide acceptance during the development of the microwave industry. It has been applied to the solution of a wide variety of transmission system problems, many of which are described in a book by Philip Smith [37]. The Smith chart as displayed by GENESYS is shown in below. Labels for normalized real and reactive components are displayed when the level of detail permits it.



The design of broadband transmission systems using the Smith chart involves graphic constructions on the chart repeated for selected frequencies throughout the range of interest. Although the process was a vast improvement over the use of a slide rule, it is tedious. Modern interactive computer programs with high-speed tuning and optimization procedures are much more efficient. However, the Smith chart remains an important tool for instructional use and as a display overlay for computer-generated data. The Smith chart provides remarkable insight into transmission system behavior.

The standard unity-radius impedance Smith chart maps all positive resistances with any reactance from - to + onto a circular chart. The magnitude of the linear form of S_{11} or S_{22} is the length of a vector from the center of the chart, with 0 length being a perfect match to the reference impedance and 1 being total reflection at the circumference of the chart. The underlying grids of the Smith chart are circles of a given resistance and arcs of impedance.

The reflection coefficient radius of the standard Smith chart is unity. Compressed Smith charts with a radius greater than 1 and expanded charts with a radius less than 1 are available.

High impedances are located on the right portion of the chart, low impedances on the left portion, inductive reactance in the upper half, and capacitive reactance in the lower half. Real impedances are on a line from the left to right, and purely reactive impedances are on the circumference. The angle of the reflection coefficient is measured with respect to the

real axis, with zero degrees to the right of the center, 90° straight up, and -90° straight down.

The impedance of a load as viewed through an increasing length of lossless transmission line, or through a fixed length with increasing frequency, rotates in a clockwise direction with constant radius when the line impedance equals the reference impedance. If the line and reference impedances are not equal, the center of rotation is not about the center of the chart. One complete rotation occurs when the electrical length of the line increases by 180°. Transmission line loss causes the reflection coefficient to spiral inward.

The length of a vector from the center to a given point on the Smith chart is the magnitude of the reflection coefficient. The angle of that vector with respect to the real axis to the right is the phase angle of the reflection coefficient. Several common definitions are used to represent the length of this vector. They are referred to as radially scaled parameters because they relate to a radial distance from the center towards the outside circle of the chart.

Linear Analysis Output

Linear simulation produces the following variables:

Variable	Description	Shape
CS	Noise correlation matrix in S-Parameter form	[N x N] x M swept complex matrix
F	Frequencies being swept	[M] independent vector
S	S parameter, normalized to port impedances ZPORT	[N x N] x M swept complex matrix
ZPORT	Port impedances taken from the port elements in the schematic	[N] x M swept complex vector

Where M is the number of frequencies and N is the number of ports. All variables and shortcuts (except F) are swept over all frequencies.

The following shortcuts are available, see the "Measurements: Linear" section of the Simulation manual for more details:

Variable	Description	Equivalent Equation	Shape
VSWR	VSWR at all ports	vswr(diag(S))	[N] real vector
VSWRi	VSWR at port <i>i</i>	vswr(S[i,i])	Scalar
	Input impedance at all ports, including all other port terminations.	zin(diag(S),ZPORT)	[N] vector

Simulation

ZINi	Input impedance at port <i>i</i>	zin(S[i,i],ZPORT[i])	Complex
YIN	Input impedance at all ports, including all other port terminations.	yin(diag(S),ZPORT)	[N] vector
YINi	Input admittance at port <i>i</i>	yin(S[i,i],ZPORT[i])	Complex
Sij	Specific S parameter. For <i>i</i> or <i>j</i> greater than 9, use the S[<i>i,j</i>] form.	S[<i>i,j</i>]	Complex
YP	Y Parameters of circuit	stoy(S,ZPORT)	[N x N] complex matrix
ΥΡ <i>ij</i>	Specific Y parameter. For <i>i</i> or <i>j</i> greater than 9, use the YP[<i>i,j</i>] form.	YP[<i>i,j</i>]	Complex
ZP	Z Parameters of circuit	stoz(S,ZPORT)	[N x N] complex matrix
ZPij	Specific Z parameter. For i or j greater than 9, use the $Z[i_j]$ form.	ZP[i,j]	Complex
Н	H parameters, two-port only	stoh(S,ZPORT)	[2 x 2] complex matrix
H <i>ij</i>	Specific H parameter	H[i,j]	Complex
Εij	Voltage gain from port <i>j</i> to port <i>i</i> at port terminals with all termination impedances in place.	voltage_gain(S,ZPORT, <i>i,y</i>)	Complex
K	Stability factor, only available for two-port circuits	stab_fact(S)	Scalar
B1	Stability measure, only available for two-port	stab_meas(S)	Scalar

	circuits				
SBi	Stability circles at port <i>i</i> , only available for two-port circuits	stab_circle(S,i)	[2] Complex vector, contains center, radius, and sign		
All noise to		ch do not specify ports use port	1 as input and		
NF	Noise figure from port 1 to port 2.	noise_figure(S,CS,2,1)	Scalar		
RN	Noise Resistance	noise_rn(S,CS,ZPORT,2,1)	Scalar		
GOPT	Noise optimum reflection coefficient (gamma)	noise_gamma_opt(S, CS,2,1)	Complex		
ZOPT	Noise optimum input impedance	zin(noise_gamma_opt(S, CS,2,1), ZPORT[1])	Complex		
YOPT	Noise optimum input impedance	yin(noise_gamma_opt(S, CS,2,1), ZPORT[1])	Complex		
NFMIN	Minimum noise figure	noise_nfmin(S,CS,2,1)	Scalar		
NCI	Noise Circles	noise_circles(S,CS, [0.25;0.5;1;1.5;2;2.5;3;6], 2,1)	Complex vector, two entries for every circle (including zero dB)		
All noise n	All noise measurements below use port i as input and port j as output.				
NF <i>ji</i>	Noise figure arbitrary ports from port <i>i</i> to port <i>j</i> .	noise_figure(S,CS,j,i)	Scalar		
RNji	Noise Resistance	noise_rn(S,CS,ZPORT, j,i)	Scalar		
GOPT <i>ji</i>	Noise optimum reflection coefficient (gamma)	noise_gamma_opt(S, CS, <i>j,i</i>)	Complex		
ZOPTji	Noise optimum input impedance	zin(noise_gamma_opt(S, CS, <i>j,i</i>), ZPORT[1])	Complex		

Ү ОРТ <i>јі</i>	Noise optimum input impedance	yin(noise_gamma_opt(S, CS, j,i), ZPORT[1])	Complex
NFMIN <i>ji</i>	Minimum noise figure	noise_nfmin(S,CS, j,i)	Scalar
NCIji	Noise Circles	noise_circles(S,CS, [0.25;0.5;1;1.5;2;2.5;3;6], <i>j,i</i>)	*
GM <i>i</i>	Simultaneous match gamma at port <i>i</i> (2-port circuit only)	sm_gamma <i>i</i> (S)	Complex
YMi	Simultaneous match admittance at port <i>i</i> (2-port circuit only)	sm_y <i>i</i> (S)	Complex
ZMi	Simultaneous match impedance at port <i>i</i> (2-port circuit only)	sm_z <i>i</i> (S)	Complex
GUi	Unilateral gain circles at port <i>i</i>	gu_circles(S, [-1,-2,-3,-4,-5,-6], <i>i</i>)	*
GP	Power gain circles	gp_circles(S, [-1,-2,-3,-4,-5,-6])	*
GA	Available gain circles	ga_circles(S, [-1,-2,-3,-4,-5,-6])	*

^{*}All circle measurements are in packed complex vector form. Each circle (including any zero radius circles for zero dB) is represented by two complex entries. The first entry is the center of the circle. The second complex entry has the radius of the circle in the real part and extra information (the dB level of the circle) in the imaginary part.

Momentum GX Basics

Momentum is an electromagnetic simulator that computes S-parameters for general planar circuits, including microstrip, slotline, stripline, coplanar waveguide, and other topologies. Vias and airbridges connect topologies between layers, so you can simulate multilayer RF/microwave printed circuit boards, hybrids, multichip modules, and integrated circuits. Momentum gives you a complete tool set to predict the performance of high-frequency circuit boards, antennas, and ICs.

This section discusses the Typical Use Process for Momentum GX and how to Select the Correct Mode to use.

Momentum Major Benefits

Momentum enables you to:

- Simulate when a circuit model range is exceeded or the model does not exist
- Identify parasitic coupling between components
- Go beyond simple analysis and verification to design automation of circuit performance

Momentum Major Features

Key features of Momentum include:

- An electromagnetic simulator based on the Method of Moments
- Adaptive frequency sampling for fast, accurate, simulation results
- Comprehensive data display tools for viewing results
- Equation and expression capability for performing calculations on simulated data

Typical Use Process

The following steps describe a typical process for creating and simulating a design with Momentum.

- 1. **Create a physical design**. You start with the physical dimensions of a planar design, such as a patch antenna or the traces on a multilayer printed circuit board. There are three ways to enter a design into GENESYS:
 - Convert a schematic into a physical layout

- Draw the design in a Layout
- Import a layout from another simulator or design system. GENESYS can import files in a variety of formats.

For information on converting schematics, drawing in Layout, or importing designs, refer to the User's Guide.

- 2. **Assign port properties**. Ports enable you to inject energy into a circuit, which is necessary in order to analyze the behavior of your circuit. When you create the circuit, you apply ports, and then assign port properties in Layout. There are several different types of ports that you can use in your circuit, depending on your application. For more information, refer to Ports.
- 3. **Define the layer stack characteristics**. This is done on the Layers page of the layout properties dialog. A substrate is the media upon which the circuit resides. For example, a multilayer PC board consists of various layers of metal, insulating or dielectric material, and ground planes. Other designs may include covers, or they may be open and radiate into air. A complete layer stack definition is required in order to simulate a design. The definition includes the number of layers in the substrate and the composition of each layer. For more information, refer to Adding and Changing Substrates.
- 4. **Simulate the circuit**. You set up a simulation by specifying the frequency sweep, the Simulation Options, and the Mesh options. The simulation process computes the Green's functions for the layer stack, then the mesh pattern, and finally the currents in the design. S-parameters are computed based on the currents. If the Adaptive Frequency Sample sweep type is chosen, a fast, accurate simulation is generated, based on a rational fit model. For more information, refer to Adaptive Frequency Sampling.
- 5. View the results. The data from a Momentum simulation is saved in the analysis dataset. It includes board S-parameters, feeding T-lines wave impedances, and results of full circuit co-simulation.

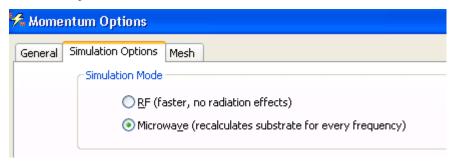
Selecting the Correct Mode

Momentum can operate in two simulation modes: microwave or RF. Select the mode based on your design goals. Use Microwave mode for designs requiring full-wave electromagnetic simulations that include microwave radiation effects. Use RF mode for designs that are geometrically complex, electrically small, and do not radiate. You might also choose RF mode for quick simulations on new microwave models that can ignore radiation effects, and to conserve computer resources.

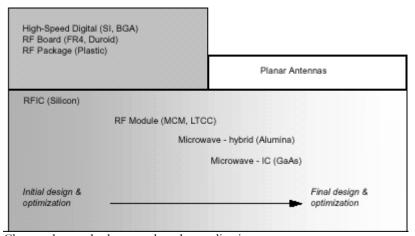
RF Mode provides accurate electromagnetic simulation performance at RF frequencies. At higher frequencies, as radiation effects increase, the accuracy of the Momentum RF models declines smoothly with increased frequency. RF Mode addresses the need for faster, more stable simulations down to DC, while conserving computer resources. Typical

RF applications include RF components and circuits on chips, modules, and boards, as well as digital and analog RF interconnects and packages.

The simulation mode is defined in the Momentum GX analysis properties window/ Simulation options tab:



Deciding which mode to use depends on your application. Each mode has its advantages. In addition to specifically RF applications, RF mode can simulate microwave circuits. The following graph identifies which mode is best suited for various applications. As you can see, some applications can benefit from using either mode depending on your requirements. As your requirements change, you can quickly switch modes to simulate the same physical design. As an example, you may want to begin simulating microwave applications using RF mode for quick, initial design and optimization iterations, then switch to microwave mode to include radiation effects for final design and optimization.



Choose the mode that matches the application.

RF mode is usually the more efficient mode when a circuit

- is electrically small
- is geometrically complex
- does not radiate

Simulation

For descriptions about electrically small and geometrically complex circuits, see Matching the Simulation Mode to Circuit Characteristics.



For infinite ground planes with a loss conductivity specification, the microwave mode incorporates the HF losses in ground planes, however, the RF mode will make an abstraction of these HF losses.

EM Ports

Ports enable energy to flow into and out of a circuit. Energy is applied to a circuit as part of the simulation process. A circuit solved using Momentum can have, at the minimum, one port.

Ports are defined in a two-step process. First, ports are added to a circuit when the circuit is drawn. Then, in Momentum, you specify the type of port in order to tailor the port to your circuit. This facilitates the simulation process.

This chapter begins with suggestions to keep in mind when adding ports to a circuit that will be simulated using Momentum. The remainder of this chapter describes the various port types in Momentum and gives instructions on how to specify a port type.

Sections in this chapter:

Adding an EM Port to a circuit

Port Calibration

Determining the Port Type to Use

Defining a Single "Normal" Port

Defining an Internal Port

Defining a Differential Port

Defining a Coplanar Port

Defining a Common Mode Port

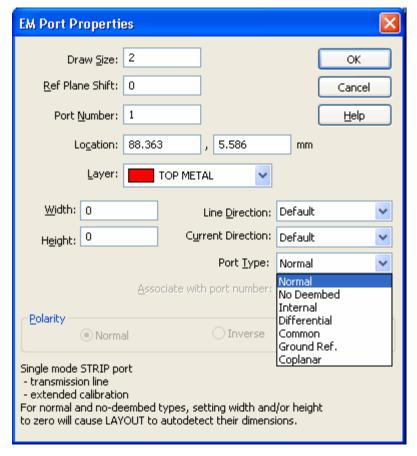
Defining a Ground Reference

Re-mapping Port Numbers

Adding an EM Port to a Circuit

You can add a port to a circuit from the Layout window. If a layout has been created from a schematic, all of the schematic ports will be created "normal" (singular calibrated) EM ports in the Layout, and "internal" ports for all lumped element terminals. You may

manually change the port modes in the Port Properties dialog, or add any additional ports in the Layout editor.



Considerations

Keep the following points in mind when adding ports to circuits to be simulated using Momentum:

- Momentum does not use **Current Direction** which is an EMPOWER parameter only.
- Associate with port number, and Polarity are used only for Momentum, to
 define a group of ports (Differential, Common, Ground Reference and Coplanar
 mode ports only).
- The parameter **Line direction**, defines the feeding T-line direction that the port is connected to. Depending on the value, it rotates the ports to be perpendicular to the closest edge of the T-line. If the parameter has the default value, the port connector pad will be oriented to be perpendicular to the closest box wall. For Momentum it does not matter what the port orientation is, the simulator will

- orient any EM calibrated port internally to be perpendicular to the closest metal edge and snaps it to the center of the edge.
- The components or shapes that ports are connected to, must be on layout layers that are mapped to metalization layers that are defined as strips or slots. Ports cannot be directly connected to via. For information on how to define strips and slots, refer to the Layout Layers properties page.
- Make sure that the port and the object you are connecting it to are on the same layout layer. For convenience, you can set the entry layer in the Layout layer combo box.
- A port must be applied to an object. If a port is applied in open space,
 Momentum will automatically snap the port to the edge of the closest object.
 This will not be apparent from the layout, because the position of the port will not change.
- If the Layout resolution is changed after adding ports that are snapped to edges, you must delete the ports and add them again. The resolution change makes it unclear which edges the ports are snapped to, causing errors in mesh calculations.

Port Calibration

In Momentum GX, there are two different lumped sources used in the calibration process to feed the circuits with calibration lines: a grounded source and a floating source. The grounded source works well for low frequencies, however at higher frequencies, when the port-ground distance becomes electrically large, this source provides less accurate results due to unwanted substrate coupling in the calibration process. The floating source works well at higher frequencies (unwanted substrate coupling is reduced), however it fails at low frequencies because the capacitive internal impedance of the source blocks the flow of the low frequency currents. Momentum automatically switches between these two sources, depending on the frequency range of the simulation

Determining the Port Type to Use

There are seven port types in Momentum. The purpose of ports is to inject energy into a circuit and to allow energy to flow into and out of a circuit. The different port types enable you to tailor the ports in your circuit according to your type of circuit and its function in the circuit. In general, you should select the port type that best matches the intended application of your layout.

The table below gives a brief description of each port type. You can use a combination of port types in your circuit, although you should note that port types have limitations on where they can be applied. Only the Single port type can be applied to objects that are on either strip or slot metallization layers. Only the Internal and Ground Reference types can be applied to ports that are on the surface of an object, the remaining types can be applied to ports that are connected to an edge of an object.

If you elect not to assign port types, any port in the circuit will be treated as a Single (Normal) port type during simulation.



Strips and slots refer to metallization layers. For more information, refer to Layout Layers.



All port types can be defined in both of Momentum's simulation modes (microwave and RF). However, de-embedding (reference offset) is not available in RF mode.

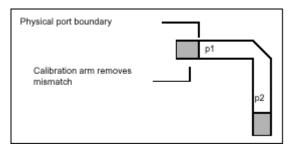
Port Type	Description	Port Connected to	Object on
Normal Single (default)	The port is calibrated to remove any mode mismatch at the port boundary. Single ports on slot layers have polarity. Unless a port is given another type, it will be treated as a single port.	Edge of object	Strip or slot layer
No Deembed	Empower: Noncalibrated single port Momentum GX: Calibrated non grouped single port with 0 reference offset. Non grouping is used to exclude from Momentum analysis grouping single port coupling effects.	Edge of object	Strip or slot layer
Internal	The port is not calibrated. It is useful for making a connection with lumped elements or for representing other connections in the circuit.	Edge or surface of object	Strip layer
Differential	Two ports with opposite polarity. The port pair is simulated as a single port.	Edge of object	Strip layer
Coplanar	Two ports with opposite polarity. The port pair is simulated as a single port.	Edge of object	Slot layer
Common mode	Two or more ports excited with the same absolute potential and the same polarity. The ports are simulated as a single port.	Edge of object	Strip layer
Ground reference	Use an explicit ground for a single (strip), internal, or common mode port. Implicit ground is made available through the closest infinite metal, when no explicit ground port is present.	Edge or surface of object	Strip layer

Additional details about each port type and how to define them are given in the following sections.

Defining a Single Normal Port

Single is the default port type. It has the following properties:

- It is connected to an object that is on either a strip or slot metallization layer.
- It can be applied only to the edge of an object.
- The port is external and calibrated. The port is excited using a calibration process that removes any undesired reactive effects of the port excitations (mode mismatch) at the port boundary. This is performed by extending the port boundary with a half-wavelength calibration (transmission) line. The frequency wavelength selected during the mesh or simulation process is used to calculate the length of the calibration line. For more information about the calibration process, refer to Calibration and De-embedding of the S-parameters.
- The port boundary can be moved into or away from the geometry by specifying a reference offset. S-parameters will be calculated as if the port were at this position. For more information, refer to Applying Reference Offsets.
- When two or more single ports are on the same reference plane, coupling effects
 caused by parasitics affects the S-parameters. The calibration process groups the
 ports so that any coupling in the calibration arms is included in the S-parameter
 solution. For more information, refer to Allowing for Coupling Effects.
- If the port is connected to an object on a strip layer, the substrate definition must include at least one infinite metal layer: a top cover, ground plane, or a slot layer, or a ground reference must be used in addition to the port. For more information on ground references, refer to Defining a Ground Reference.
- If the port is connected to an object that is on a slot layer, the port has polarity.



To define a single port type, open the property dialog and select the type from the combo box.

Avoiding Overlap

Be aware that when using single ports, the calibration arm applied to a port may be long enough to overlap another element in the circuit. In this case, the port will be changed to an internal port type, and no calibration will be performed on it. If this occurs, a message

will be displayed during simulation in the Status window indicating the change. For information about internal ports, refer to Defining an Internal Port.

Applying Reference Offsets

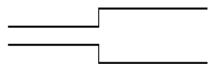
Reference offsets enable you to reposition single port types in a layout and thereby adjust electrical lengths in a layout, without changing the actual drawing. S-parameters are returned as if the ports were placed at the position of the reference offset.

Why Use Reference Offsets?

The need to adjust the position of ports in a layout is analogous to the need to eliminate the effect of probes when measuring hardware prototypes. When hardware prototypes are measured, probes are connected to the input and output leads of the Device Under Test (DUT). These probes feed energy to the DUT, and measure the response of the circuit. Unfortunately, the measured response characterizes the entire setup, that is, the DUT plus the probes. This is an unwanted effect. The final measurements should reflect the characteristics of the DUT alone. The characteristics of the probes are well known, so measurement labs can mathematically eliminate the effects of the probes, and present the correct measurements of the DUT.

There are significant resemblances between this hardware measurement process and the way Momentum operates. In the case of Momentum, the probes are replaced by ports, which, during simulation, will feed energy to the circuit and measure its response. The Momentum port feeding scheme also has its own, unwanted effect: low-order mode mismatch at the port's boundary, although this is eliminated by the calibration process. However, in order for this calibration process to work well, it is necessary that the fundamental mode is characterized accurately. This can only be accomplished when the distance between the port boundary and the first discontinuity is sufficiently large, that is, there exists a feedline that is long enough to provide this distance.

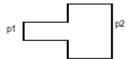
As a basic example, consider a linewidth that varies abruptly in some part of your circuit, as shown in the example below.



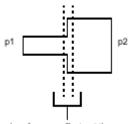
Strictly speaking, all you need is to characterize is the variation of the step-in-width itself, as shown below.



As mentioned previously, it takes a little distance for the fundamental mode to settle, which means that this "short" structure might not yield the accuracy that you expect from an Momentum simulation. In this case, allow for some feed line length:



Now the simulation will yield accurate results, but the results will also contain the extra line lengths. To remedy this, use reference offsets. Although the circuit has been calculated with the long lines, reference offset shifting allows you to produce the Sparameters as if the short structure had been simulated instead:



apply reference offsets at these locations

The effect of the extra feed lines is mathematically eliminated from the S-parameter solution.

This process of adding or subtracting line length is generally referred to as de-embedding.

This is the basic process:

During the solution process, the impedance and propagation constant has been calculated for the ports, based on their physical location in the circuit. When you know the impedance, propagation constant, and the distance of de-embedding, you can cancel out the extra lengths of line from the S-parameter results, by compensating for the loss and phase shifts of those lines. The net result is a set of S-parameters, calculated as if the extra line lengths were not there.

De-embedding Considerations

It is possible to de-embed right up to the discontinuity itself. However, make sure that you do not shift the reference offset beyond the first discontinuity. This would yield incorrect simulation results, as there is another linewidth beyond that discontinuity, which means that there is another set of impedance and propagation values that applies there.



You can de-embed away from the circuit, by placing reference offsets beyond the edges of the layout. This enables you to simulate the effect of a long feed line that was not drawn in the simulated structure.

Allowing for Coupling Effects

If you have two or more single ports that lie on the same reference plane, the calibration process will take into account the coupling caused by parasitics that naturally occurs

between these ports. This yields simulation results that more accurately reflect the behavior of an actual circuit.

The following figure helps illustrate which ports will be grouped in order for the calibration process to account for coupling among the ports. In this setup, only the first two ports will be grouped, since the third port is an internal port type and the fourth port is on a different reference plane. Note that even though the second port has a reference offset assigned to it, for this process they are considered to be on the same plane and their reference offsets will be made equal.

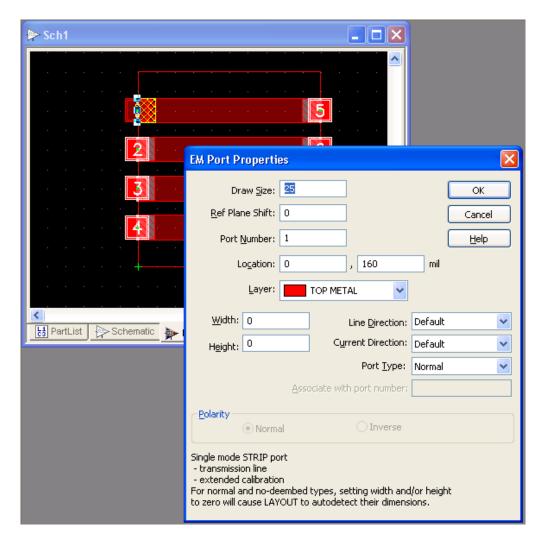
If you do not want the ports to be grouped, you must add metal to the edge of the object that one of the ports is connected to. The ports will no longer be on the same plane, and will not be considered part of the same group.



If you would like to exclude the coupling effect calculation between single ports with the same reference plane, slightly shift the feeding line edges of the ports, or use the "No Deembed" port mode instead of single.

For Momentum GX the "No Deembed" port mode means: calibrated, with 0-reference plane offset, and without accounting coupling between ports.

For example, this design has 4 single mode ports at each side (left and right). All the ports from each side are connected to metal edges having same X-coordinates, and therefore the same reference plane. Momentum will calculate coupling between ports (1-4) and between ports (5-8):



Defining an Internal Port

Internal ports enable you to apply a port to the surface of an object in your design. By using internal ports, all of the physical connections in a circuit can be represented, so your simulation can take into account all of the EM coupling effects that will occur among ports in the circuit. These coupling effects caused by parasitics are included in your simulation results because internal ports are not calibrated. You should avoid geometries that allow coupling between single and internal ports to prevent incorrect S-parameters.

An example of where an internal port is useful is to simulate a bond wire on the surface on an object. Another example of where an internal port is necessary is a circuit that consists of transmission lines that connect to a device, such as a transistor or a chip capacitor, but this device is not part of the circuit that you are simulating. An internal port can be placed at the connection point, so even though the device is not part of the circuit

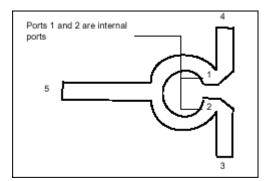
you are simulating, the coupling effects that occur among the ports and around the device will be included in your simulation.

Internal ports are often used in conjunction with ground references. For more information, refer to Defining a Ground Reference and to Simulating with Internal Ports and Ground References.

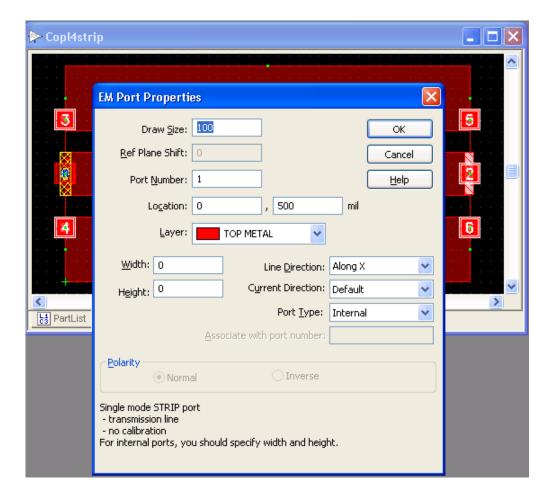
An internal port type has the following properties:

- It can be applied to the interior of a circuit by applying it to the surface of an object.
- It can be applied to the edge of an object.
- It can be applied to objects that are on strip layers only.
- The orientation of the port is not considered if it is on the surface of an object. If an internal port is placed on an edge, it is oriented to be perpendicular to it.
- No calibration is performed on the port.

Because no calibration is performed on the port, the results will not be as accurate as with a single port. However, the difference in accuracy is small.



This design has 2 internal ports (1) and (2). To define the port mode, set the Port Type to "Internal":



Defining a Differential Port

Differential ports should be used in situations where an electric field is likely to build up between two ports (odd modes propagate). This can occur when:

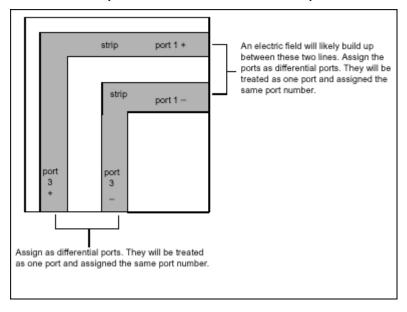
- The two ports are close together
- There is no ground plane in the circuit or the ground plane is relatively far away
- One port behaves (to a degree) like a ground to the other port, and polarity between the ports is developed.
- The ports are connected to objects that are on strip metallization layers.

The electric field that builds up between the two ports will have an effect on the circuit that should be taken into account during a simulation. To do this, use differential ports.

Differential ports have the following properties:

• They can be applied to objects on strip layers only.

- They are assigned in pairs, and each pair is assigned a single port number.
- Each of the two ports is excited with the same absolute potential, but with the
 opposite polarity. The voltages are opposite (180 degrees out of phase). The
 currents are equal but opposite in direction when the ports are on two
 symmetrical lines, and the current direction is approximated for other
 configurations.
- The two ports must be on the same reference plane.

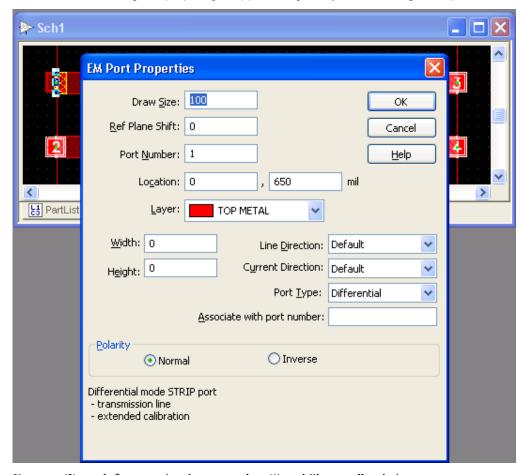


To define a differential port:

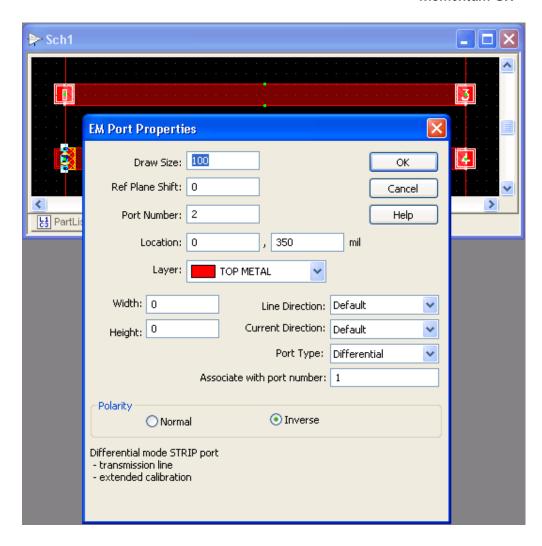
- 1. Place a new EM port in layout, or select any port that you want to assign this type to. Note the port number.
- 2. Open the port dialog (double click, or select and click **Enter**)
- 3. For the Port Type, select **Differential**.
- 4. Under Polarity, make sure that **Normal** is selected.
- 5. Click **OK**.
- 6. Place another new EM port in layout, or select the second port. Note the port number.
- 7. For the Port Type, select **Differential**.
- 8. Under Polarity, select Inverse.
- 9. Under Associate with port number, enter the number of the previously-selected port.

10. Click **OK**.

For example, this design has 2 groups of differential ports (1-2) and (3-4). Each differential port consists of 2 EM-ports with different polarity, associated each other. To define the differential port (1-2) for port (1) we use polarity "**Normal**" (positive).



For port (2) we define associated port number (1) and "inverse" polarity:



Defining a Coplanar Port

This type of port is used specifically for coplanar waveguide (CPW) circuits. It is similar to a differential port, but coplanar ports are applied to objects on slot layers (that is, where slots are used in the design). Coplanar ports should be used in situations where an electric field is likely to build up between two ports. This can occur when:

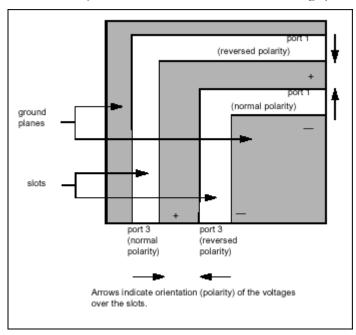
- The two ports are close together
- Polarity between the ports develops
- The ports are connected to objects that are on slot metallization layers

The electric field that builds up between the two ports will have an effect on the circuit that should be taken into account during a simulation. To do this, use coplanar ports.

Coplanar ports have the following properties:

- They can be applied to objects on slot layers only.
- They are assigned in pairs.
- Each of the two ports is excited with the same absolute potential, but with the opposite polarity. The voltages are opposite (180 degrees out of phase). The currents are equal but opposite in direction when the ports are on two symmetrical lines, and the current direction is approximated for other configurations.
- The two ports must be on the same reference plane.

The illustration below shows ports pairs applied to a layout of coplanar waveguide slots. The coplanar port type is applied to each pair of ports in the design. The arrows in this illustration indicate the polarity assigned to each port and the direction of the voltages over the slots (arrows indicate the direction of the voltages).

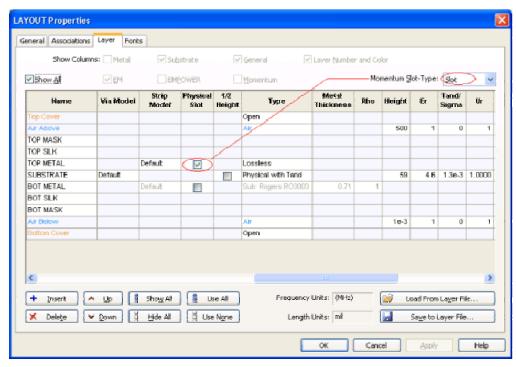


Be careful when assigning polarity to coplanar ports. An incorrect choice of polarity can change the phase of transmission type S-parameters by 180 degrees.



Coplanar ports can be applied to objects on slot layers only.

To define the Slot metal layer, **Physical Slot** must be checked, and the combo box for Momentum Slot-type must be set to **Slot**:



This means that Momentum GX will use the layer as a physical slot, where all metal areas are swapped with non-metal (dielectric areas). The combo box for Momentum Slot-type only works for Momentum GX, and is ignored by other Genesys EM-simulators (Empower, Sonnet,). Other EM simulators use the Physical slot checkbox setting for internal modeling of the slot layer without swapping the layer metal areas in Layout.

To define coplanar ports:

- 1. Place a new EM port in layout, or select any port that you want to assign this type to. Note the port number.
- 2. Open the port dialog (double click, or select it and click **Enter**)
- 3. For the Port Type, select **Coplanar**.
- 4. Under Polarity, make sure that **Normal** is selected.
- 5. Click **OK**.
- 6. Place another new EM port in layout, or select the second port. Note the port number.
- 7. For the Port Type, select **Coplanar**.
- 8. Under Polarity, select **Reversed**.
- 9. Under Associate with port number, enter the number of the previously-selected port.

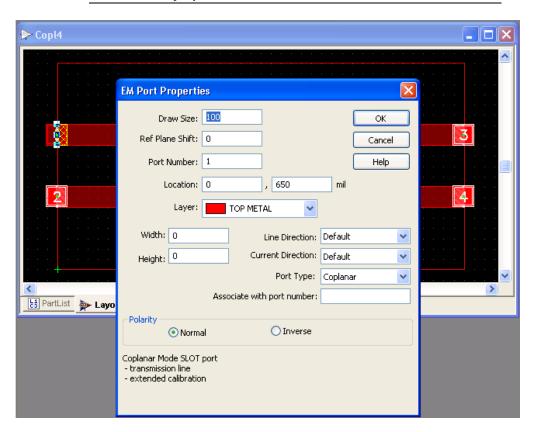
10. Click **OK**.

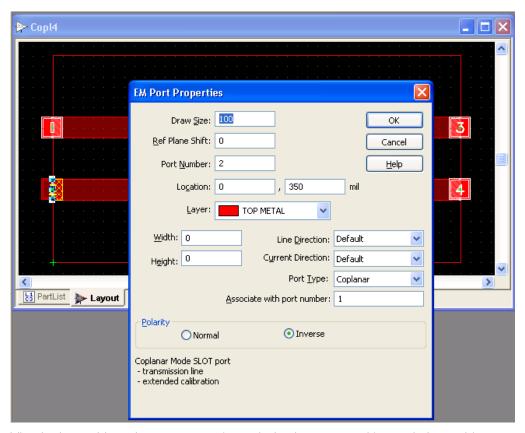
For example, this layout has defined 2 pairs of coplanar ports: (1-2), and (3-4). You do not need to set the Associate with port number value for both ports of a coplanar pair. In this example only port (2) of the coplanar ports pair (1-2) has value of the port association (1).

The coplanar port consists of pair of coplanar mode ports with different polarity. The polarity must match to the polarity of signal sources connected to the ports; otherwise corresponding to the incorrectly defined polarity coplanar port S-parameters get negative values (π -phase shift).

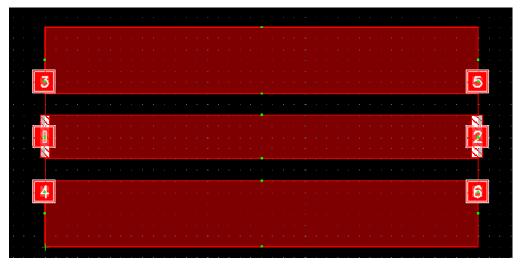


Any objects drawn on slot metal layers are slots (holes in metal), where open areas define metal. In Genesys, layout slots are displayed identically to metal in strip layers.





The slot layer with coplanar ports may be equivalently represented by a strip layer with non-calibrated internal ports with ground reference ports located as close to signal internal ports as possible:



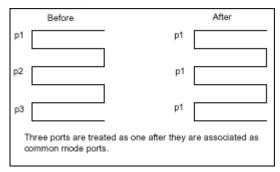
In this case, the internal port (1) has two ground reference ports (3) and (4), and the internal port (2) has ground reference ports (5) and (6). The closer the ground reference ports to their internal ports, the closer the results of the strip equivalent to the slot layer with coplanar ports. The slot layer model is more accurate than its strip equivalent, because coplanar ports are calibrated, and minimum possible distance is used between signal port location and locations of its ground reference ports.

Defining a Common Mode Port

Use common mode ports in designs where the polarity of fields is the same among two or more ports (even modes propagate). The associated ports are excited with the same absolute potential and are given the same port number.

Common mode ports have the following properties:

- They can be applied to objects on strip layers only
- A ground plane or other infinite metal (such as a cover) is required as part of the design
- Two or more ports can be associated
- Associated ports are excited with the same absolute potential (and same polarity)
- The ports must be on the same reference plane



To define a common port:

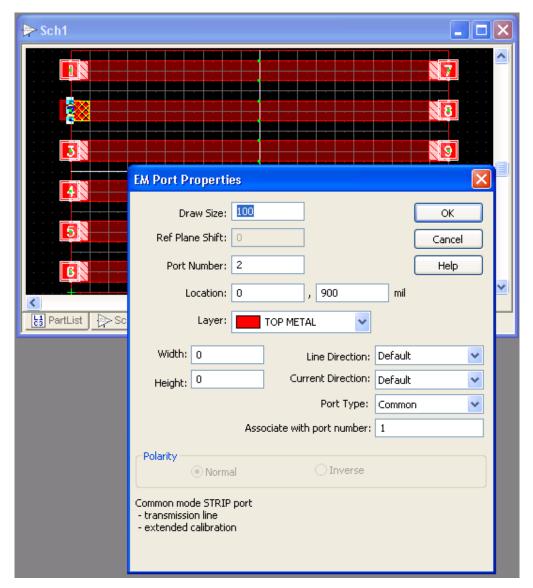
- 1. Place a new EM port in layout, or select any port that you want to assign this type to. Note the port number.
- 2. Open the port dialog window (double click, or clicking **Enter** for selected port).
- 3. For Port Type, select **Common** mode.
- 4. Click **OK**.
- 5. Select the second port, and open its dialog.
- 6. For Port Type, select **Common** mode.

7. Under Associate with port number, enter the number of the port that you selected first.

Make sure that the value in the **Associate with port number field** is the same for additional ports. For example, if you were associating three ports and the first port was assigned as port 1, for the second and third port, the value entered into the **Associate with port number field** would be 1. (For the first port you choose, no value is entered in this field.)

- 8. Click **OK**.
- 9. Repeat these steps for other common mode ports in the circuit.

For example, we created 2 groups of common mode ports (1-6) and (7-12) in this layout:



It's not necessary to define the association with other ports for the first defined port in a group. Other ports of a port group must have association to the first port of its group, or be associated to other ports of the group. It does not matter how grouped ports are associated, just that they are associated to other ports of the group.

For example, ports 1-6 may be associated in a group, by defining **Associate with port number**:

1

2 -> 1

- 3 -> 14 -> 1 5 -> 1 6 -> 1or using any other possible combination without closed loops
- 2 -> 1
- 3 -> 2
- 4 -> 2
- 5 -> 6
- 6 -> 1

Incorrect group port association:

- 2 -> 1
- 3 -> 1
- 4 -> 5
- 5 -> 6
- 6 -> 4

This is incorrect because the port association creates 2 independent (not connected) port groups (1-3) and (4-6) instead of one port group (1-6).

Only ports having the same reference plane and feeding line direction may be grouped as a common mode ports.



Momentum GX does not take into account the "Line direction" parameter of EM-port properties. The direction is defined as the direction of the perpendicular to the closest port metal edge.

Defining a Ground Reference

Ground references enable you to add explicit ground references to a circuit, which may be necessary if no implicit grounds exist in your design.

Implicit ground is the potential at infinity, and it is made available to the circuit through the closest infinite metal layer of the substrate. Implicit grounds are used with internal ports and with single ports that are connected to objects on strip metallization layers.

Simulation

There are instances where the distance between a port and its implicit ground is too large electrically, or there are no infinite metal layers defined in the substrate. In these cases, you need to add explicit ground references to ensure accurate simulation results. For more information on using ground references, refer to Simulating with Internal Ports and Ground References.

You can apply ground references to the surfaces of object. The object must be on strip metallization layers.



Multiple ground reference ports can be associated with the same port. To be associated with a single port, the ground reference port should be a port attached to an edge of an object in the same reference plane as the single port.

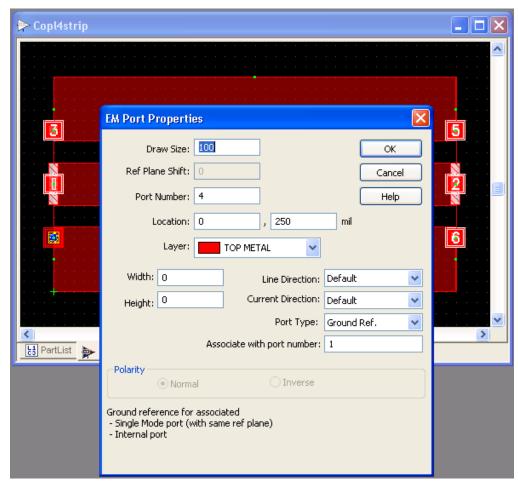
To add a ground reference:

- 1. Place a new EM port in layout, or select any port that you want to assign this type to. Note the port number.
- 2. Open the port dialog window (double click, or clicking **Enter** for selected port).
- 3. Under Associate with port number, enter the number of the single or internal port that you want to associate with this ground reference. Make sure that the distance between the port and ground reference is electrically small.
- 4. Click **OK**.

In this design ports 3 and 4 are ground references for internal port 1, and ports 5 and 6 are ground references for internal port 2.



Ground reference ports may be associated the only with "Normal" (single mode calibrated ports), with same reference plane, or with an internal port. Any of the ports may be associated with more than one ground reference port.



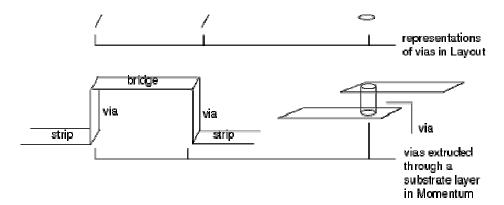
The following table provides specific information about the Port Dialog Info section.

Port Selection	Port Info
On STRIP layer	
Single Mode	Single Mode strip port transmission line excitation extended calibration
Internal	Internal strip port lumped source excitation no calibration
Differential Mode	Differential Mode strip port transmission line excitation extended calibration
Common Mode	Common Mode strip port transmission line excitation

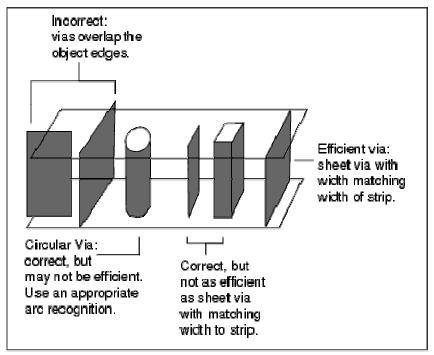
	extended calibration
Ground Reference	Ground Reference for associated Single Mode port (with same reference plane) Internal port
On SLOT layer	
Single Mode	Single Mode slot port transmission line excitation extended calibration
Coplanar Mode	Common Mode strip port transmission line excitation extended calibration

Applying and Drawing Vias

Momentum GX creates a via by extruding the object that is mapped as a via through the substrate layer it is applied to. Vias are drawn as lines or closed polygons. A line segment via is the simplest and most practical way of drawing a via. Vias drawn as lines are often called sheet vias because, when the line is extruded through the substrate, it is treated as a horizontal metal sheet. For vias of other shapes, you draw a closed polygon. For example, for a cylinder via you would draw a circle. When the shape is mapped to a via metalization layer in Momentum GX, another dimension is added to the object in order for the shape to cut through the substrate. Thus a line becomes a sheet, a circle becomes a cylinder.



Regardless of how you draw vias, avoid having them extend over the sides of the objects that they connect to. Vias must be on the edge or inside the object. Any portion of the via outside of the object boundaries will not be taken into account during the simulation. The figure below illustrates various vias connecting two strips.



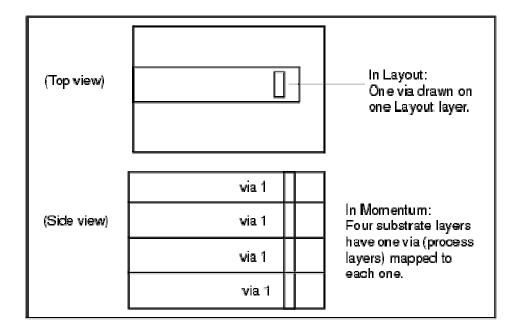
Vias are treated in the following manner:

- Vias are represented as infinitely thin vertical sheets of metal. If a cylinder is drawn as a via, then it is also treated as separate sheets of metal that comprise the cylinder walls.
- Vias are assumed to be opened, not covered, with current traveling on the sheet. Vias can be
 drawn as covered, using a cap (cover) of the same size as the via end, which is a terminating
 metal strip layout layer.
- A via cannot be coincident with another via if they cut through the same substrate layer and
 they are on different layout layers. But two vias can be coincident on the same layout layer.
- Vias should be wholly contained within any primitives that are to be connected.
- Vias can be specified with loss but are considered to have zero thickness.

Vias through Multiple Substrate Layers

Vias can be applied to multiple layers so that they cut through one or more layers.

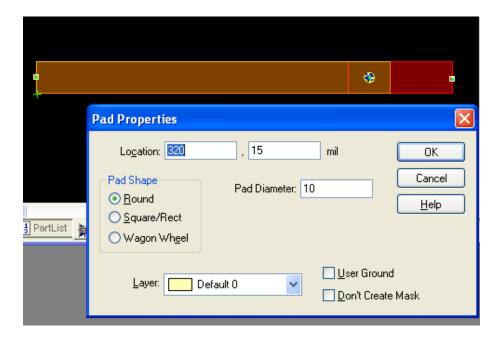
When drawing vias that cut through multiple substrate layers, each via must be drawn only once on a single layout substrate layer. The Momentum GX simulator expands the via object in both directions (up and down) up to the 1st metal layer met in each direction.



In Genesys Layout, vias for Momentum may be drawn different ways:

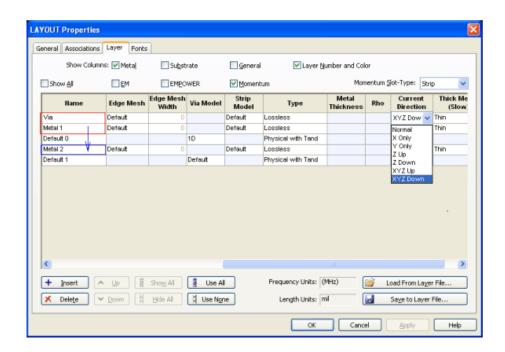
1. Any layout object (line, polygon, circle, pad, etc.), drawn in a dielectric (substrate) layer, expanded in both directions up to a first metal layer (or metal cover) in each direction, creates a via. This is a "Momentum" type via.

For example, we use the substrate stack with 2 metal layers and the dielectric layer "Default 0" between them. To create a via by this method, draw any layout object in the dielectric layer "Default 0" – for example place a pad:

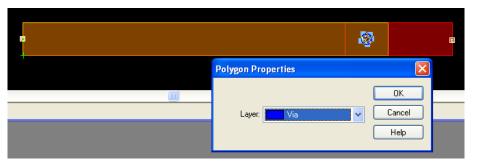


 Any layout object (line, polygon, circle, pad, etc.), drawn in a metal layer, with Z-directed current expanded from the 1st metal layer in the direction of the current to the next metal layer (or metal cover) creates a via. This is an EMPOWER type via.

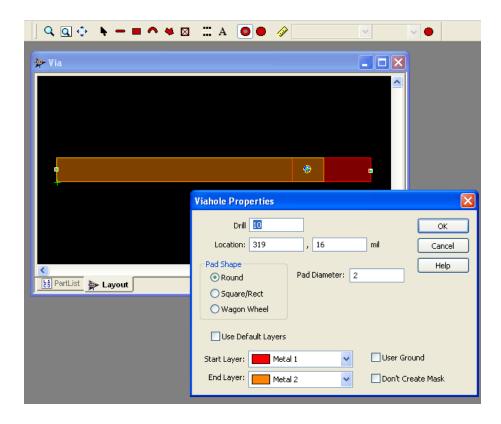
For example, to create a via between the 2 metal layers "Metal1" and "Metal2", we add a new metal layer "Via" under metal layer "Metal1", and define its current direction as "XYZ down" (down to the substrate stack). Any layout object drawn on the "Via" layer creates a via between the "Metal1" and "Metal2" layers. The via model may be defined in the substrate layer, located between the 2 metal layers. A *Default* via model means use the model defined by the Momentum Analysis.



For example, in this layout we created the via by drawing a polygon on the "Via" layer:



Any holes drilled create a round via between the metal layers defined in the hole properties.
 For example, we used the Layout tool: "Draw viahole including pads" to define the via.



To create a via for Momentum analysis, you may use any of the methods described above. Keep in mind:

- Methods (1) and (3) do not need require creating an additional "Via" layer with a Z-directed current.
- Methods (1) and (2) may be used to create a via with an arbitrary shape.
- Method (1) (drawing in the dielectric layer) is not compatible with Empower and Sonnet simulators.

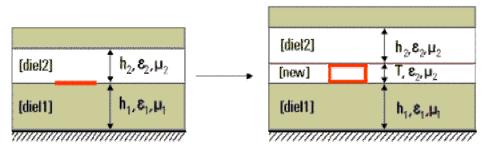
Thick Conductor Modeling

Simulations with automatic expansion require more simulation time and memory, but result in more accurate simulation results. In Momentum GX simulations, when the height/thickness aspect ratio is smaller than a factor of 5, the effect of accounting for the finite thickness of the conductors will need to be allowed for.

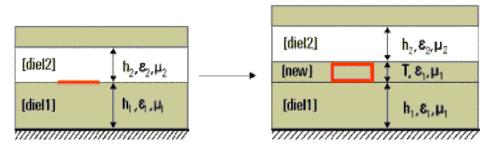
The following figure illustrates the internal substrate model when using an "up" and "down" expansion for a conductor. In both cases, an extra dielectric layer is inserted (indicated with [new] in the figure), which in the case of an "up" expansion has the

dielectric properties of the layer above the metal layer. In the case of a "down" expansion, the new layer has the material properties of the layer below the metal layer.

'up' expansion



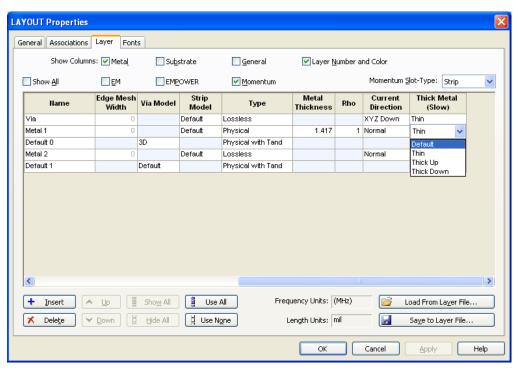
'down' expansion



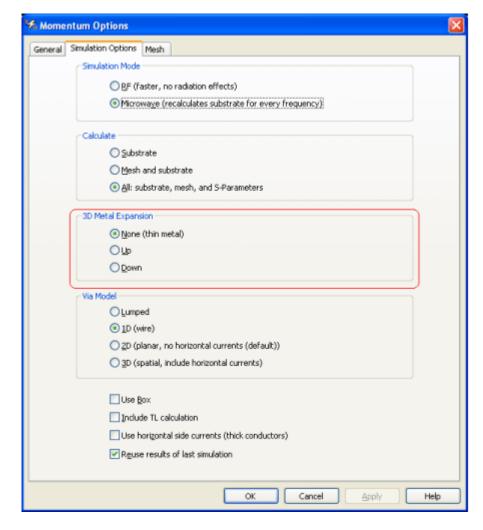


Extra internal metalization layers are *automatically* added in Momentum GX to model the currents on all four sides of the finite thickness conductor.

To simulate metal thickness in Momentum GX, open the Layout dialog properties Layer Tab, and set the metal layer type to **Physical**. In the Thick Metal column of the table, set the metal expansion to: **Default, Thin, Thick Up,** or **Thick Down. Default** will use Momentum GX analysis settings, **Thin** does not use metal thickness (sheet metal layer).



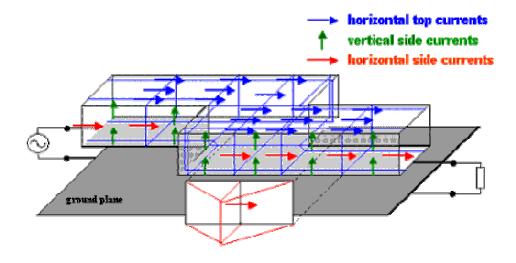
The default metal 3D-expansion parameters are defined in the Momentum analysis properties, Simulation Options tab:



Modeling Horizontal Side Currents for Thick Conductors

Horizontal side currents for thick conductors can be modeled automatically by enabling **Use horizontal side currents** in Momentum Analysis properties, Simulation Options tab.

When the Horizontal side current toggle is set, the horizontal current components will be added on all conductors, which have been specified as automatically expanded. This results in a modeling of the current as illustrated on the following figure:





Horizontal current components are not added on regular vias or when users manually expand finite thickness conductors.

For backward compatibility reasons, by default the new horizontal side currents toggle is not set.

Different levels of mesh granularity on the metalization side are possible:

 One cell in the horizontal direction: in case edge mesh is turned off and no Transmission Line Mesh specification is entered.



This is the advised setting in case the conductors are specified as automatically expanded.

- Multiple mesh cells in the horizontal direction: in case edge mesh is turned off and Transmission Line Mesh specification is entered.
- Edge mesh in the horizontal direction: in case the global edge mesh toggle is turned on, an
 edge mesh is generated on all sides (top, bottom and both sides) of the automatically expanded
 conductor.

Boxes

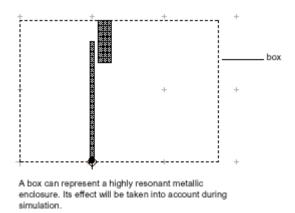
When the substrate definition of a circuit is specified from the **Layout Properties** dialog > **Layers** tab, the layer stack specifies only the vertical dimension of the circuit and not the horizontal dimension. Given this definition, the layers extend all the way to infinity in the horizontal direction. For many circuit designs this is not relevant and does not affect

Simulation

the simulation. However, there may be instances where you want to introduce horizontal boundaries. For these instances, you can use boxes.

Boxes enable you to specify substrate boundaries in a horizontal direction, on four sides of the substrate.

More specifically, for a box, you define four perpendicular vertical planes of metal as the horizontal boundaries of the substrate. These four vertical planes, or walls, form a rectangle, if you are looking at the circuit from the top, along the z-axis. A box can be used only where the top and bottom layers in the substrate definition are groundplanes or impedance termination. The four vertical metal walls, plus the top and bottom groundplanes result in a box, hence the name (the walls are the sides, and the top and bottom ground planes are lid and base of the box).



The next section describes how to apply a box to a circuit. For more information about applications for this item, refer to About Boxes.

Using a Box

A box defines the boundaries on four sides of the circuit substrate. One box can be applied to a circuit at a time. A box can be applied to a circuit only if the top and bottom layers of the substrate definition are defined as groundplanes or impedance termination. The walls of the box are perfect metal. The ground planes can be defined either as perfect metals or a lossy metal.

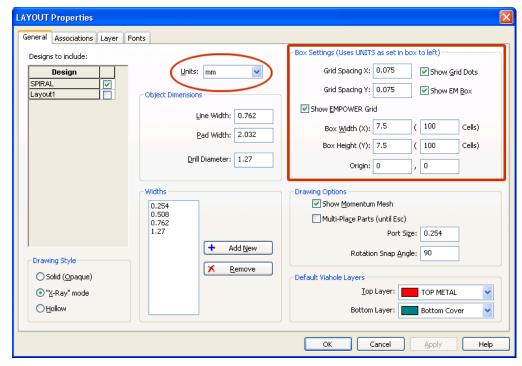
Using a box in the circuit enables you to analyze the effects of enclosing the circuit in metal, for example, to identify box resonance. Box resonance can have a significant effect on S-parameters in a small band centered around the box resonance frequency. When a simulation is performed, the resonance frequencies will be noted in the status window when the circuit is simulated, along with the frequency bands where no smooth S-parameters can be calculated.

During a simulation, all current directions on the sidewalls of the box are taken into account.

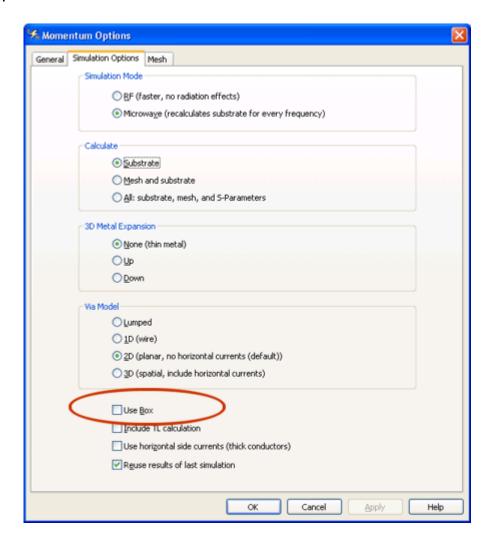


Calibrated ports in the circuit (i.e., Single, Differential, Coplanar and Common mode ports) must be located on and perpendicular to the box edge, or an error will occur. Internal (uncalibrated) ports may be placed anywhere in the circuit and point in any direction.

GENESYS Layout always creates the sidewalls of a box using specifications in the Layout properties dialog.



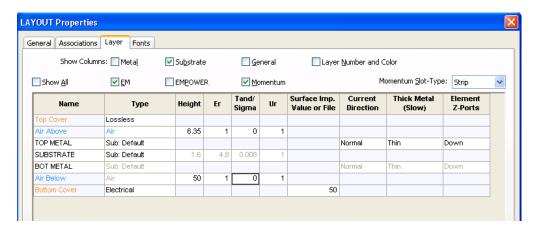
The top and bottom characteristics of the box are set in the **Layer** tab of the **Layout Properties** dialog. The Momentum GX simulator can ignore the box sidewalls or use them. Select box usage on the **Simulation Options** page of the dialog.



Viewing Layout Layer Settings of a Box

To view the box layer specifications:

- 1. Choose Layout Properties and go to the Layers tab.
- 2. The box top cover and bottom cover are defined there.



About Boxes

There are a variety of reasons why you would want to simulate a circuit in a box:

The actual circuit is enclosed in a metal box

Circuits are often encased in metal enclosures. By adding a box to your design, the metal sidewalls that are present in the real structure may be included in the simulation. This is useful is you suspect that the presence of these sidewalls will have an immediate effect on the behavior of the circuit. For example, "broad-coupled filters" are placed in metal enclosures (a box) and the sidewalls can have an significant influence on the filter characteristics.

• Nearby metal sidewalls may affect circuit performance

You may want to use a box because metal sidewalls are present in the real structure and there may be an effect from these sidewalls on the characteristics of the circuit. This can be a parasitic, unwanted effect. If the effects of the sidewalls were not taken into account while designing the circuit, you can verify any effect that the sidewalls may have on your circuit. In most cases, when the sidewalls are not too close to the actual circuit, the effect of the sidewalls on the simulation results will be marginal. There is, however a specific, significant condition, which is unique for structures with sidewalls.

• The box may resonate

In the case of a box, this is the occurrence of one or more box resonances. A box resonance is a physical effect where, under the condition of certain frequency and box size combinations, the box actually starts resonating at a certain frequency. Because a box resonance has a significant effect on S-parameters in a (small) band centered around the box resonance frequency which cannot be represented by a smooth function, no smooth adaptive S-parameters will be available in this frequency band. When simulating such a circuit, Momentum will inform you of

these box resonance frequencies, of the frequency bands where there will not be smooth S-parameters available and of the quality factor (a measure for the sharpness of the box resonance, depending on the losses).

• Propagating modes may be present

You may have a situation where there are no metal sidewalls in the structure, but the substrate definition is bounded by other material (for example, you have a finite-size substrate where the dielectric material abruptly ends, so you have a dielectric-air transition). Although Momentum boxes are defined as perfect metals and not dielectric material, you may decide that defining a metallic enclosure in the simulated circuit may be more representative of the real structure than using no enclosure.

Adding Absorbing Layers under a Cover

You may want to model your box as having absorbing layers between the covers and the layout. Use the air above and air below layers to define absorbing layers for the box. If the top cover is open then the height of the air layer is ignored, but all other parameters are still used for free space absorption. Similarly for the bottom cover.

Boxes and Radiation Patterns

If you have a structure enclosed in a box and you want to calculate radiation patterns for it after the simulation, you need to set the top and bottom planes to values between 376 and 378.

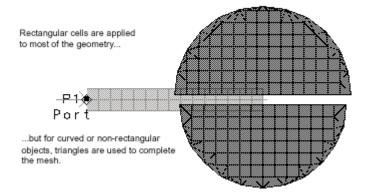


Mesh

Defining a Mesh

A mesh is a grid-like pattern of triangles and rectangles, and each triangle or rectangle is a cell. This pattern of cells is based on the geometry of a circuit and, optionally, user-defined parameters, so each circuit will have a unique mesh calculated for it. The mesh is then applied to the circuit in order to compute the current within each cell and identify any

coupling effects in the circuit during simulation. From these calculations, S-parameters are then calculated for the circuit. The mesh that was calculated for the double patch example is shown below.



Creating a mesh consists of two parts:

- Defining mesh parameters
- Pre-computing the mesh

It is not necessary to set up mesh parameters, default parameters can be used instead. The more cells, the more accurate the simulation will be, but too many cells will slow down a simulation and provide little improvement in accuracy. You can pre-compute the mesh before simulating in order to view the mesh, otherwise the mesh will be computed as part of the simulation process. A mesh is required in order to simulate.

If you choose to define mesh parameters, you can set them for:

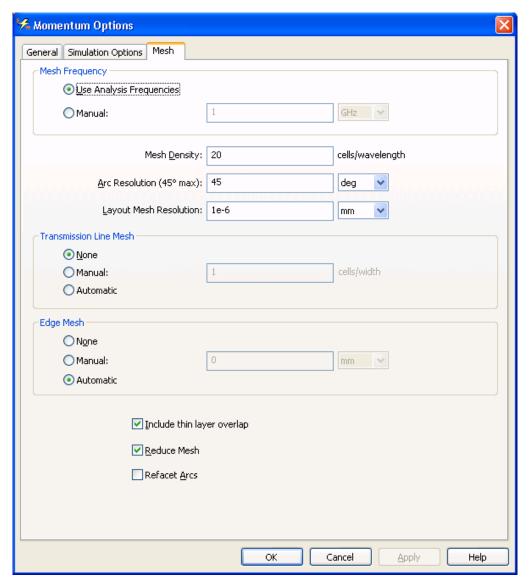
- The entire circuit
- The objects on a layout layer

It is not necessary to specify parameters for all levels. You can, for example, specify mesh parameters for a single layer, and use default values for the rest of the circuit.

For more information about how a mesh is generated, refer to About the Mesh Generator. For suggestions to consider when setting mesh parameters, refer to Guidelines for Meshing.

Defining Mesh Parameters for the Entire Circuit

The global mesh parameters affect the entire circuit. They are specific to the current Momentum analysis. To set up global parameters, open the Momentum Options dialog > **Mesh**:

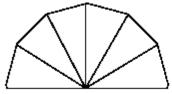


- 1. The global parameters are displayed.
- 2. Enter the mesh frequency in the Mesh Frequency field and select the units. The wavelength of this frequency will be used to determine the density of the mesh. In general, set the value of the mesh frequency to the highest frequency that will be simulated. For more information, refer to Adjusting Mesh Density.
- 3. Enter the Number of Cells per Wavelength. This value will also be used to determine the density of the mesh. The relationship between wavelength and cells per wavelength can be described by the following example:

If the circuit is 3 wavelengths long and the number of cells per wavelength is 20,

the length of the circuit will be divided into 60 cells. For more information, refer to Adjusting Mesh Density.

4. Enter the arc resolution. Any curved areas in the circuit will be meshed using facets. In the Arc Facet Angle field, enter the number of degrees that will be included in a single facet. The maximum is 45 degrees per facet. The lower the value, the better the resolution and the denser the mesh will be. The minimum value is equal to the Arc/Circle Resolution which is set when the object is drawn. For more information, refer to Processing Object Overlap.



Arc Facet Angle is 30 degrees

Arc Facet Angle is 18 degrees

- 5. Enter Layout Mesh resolution. Any 2 points that differ less than this value will be considered identical.
- 6. Enable Transmission Line Mesh to specify the number of cells along the width of a geometry. It is most useful for circuits with straight-line geometry.

Enter the number of cells that the width will be divided into in the Number of Cells Wide field. This will be the total number of cells along the width of the circuit. For more information about the transmission mesh, refer to About the Transmission Line Mesh.

7. Enable Edge Mesh to add a relatively dense mesh along the edges of objects. Since most current flows along the edges of objects, the edge mesh can improve the accuracy and speed of a simulation. For more information about the edge mesh, refer to About the Edge Mesh.



An edge mesh that is specified with a width larger than the cell size set by the wavelength/number_of_cells_wavelength, will be ignored. This is because such edge meshes would be very inefficient. However, if these edge mesh values must be used, you can decrease the number_of_cells_wavelength, which is specified in the Number of Cells per Wavelength field.

- Enable Thin layer overlap extraction in order to extract objects for the following situations:
 - Two objects on different layers overlap
 - The objects are separated with a thin substrate layer

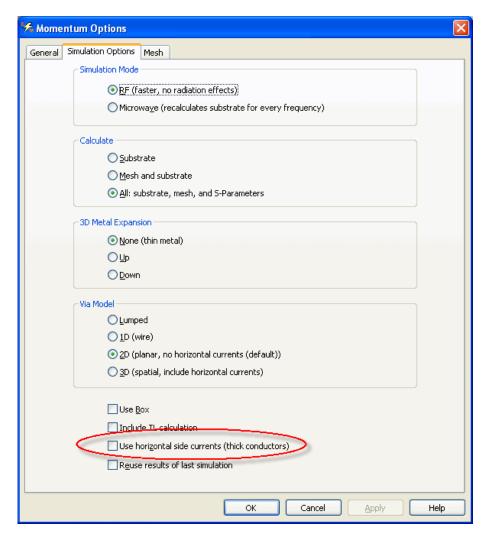
If this is enabled, the geometry will be altered to produce a more

accurate model for the overlap region. For more information, refer to Processing Object Overlap.



This should always be enabled when modeling thin layer capacitors.

- 9. Enable Mesh reduction in order to obtain an optimal mesh with fewer small cells and an improved memory usage and simulation time. For more information on Mesh Reduction, refer to Effect of Mesh Reduction on Simulation Accuracy.
- 10. On the **Simulation Options** tab, Enable Horizontal side currents (thick conductors) to activate horizontal side currents on thick conductors.



When enabled, this feature provides improved modeling of thick conductors by using the horizontal currents on side walls.

This feature:

- Automatically uses edge mesh on side walls when the global mesh option is enabled
- Provides higher accuracy for thick conductors with a width/thickness aspect ratio up to and below 1.0.
- Makes substrate database recalculation unnecessary, by taking advantage of new reconstruction technology for the Green functions.

For optimal simulation performance, we recommend that you disable the edge mesh for expanded layers. To do this, select **None** on the Edge Mesh section of the Mesh tab. If edge mesh is required for individual layers, use the Layer tab to set the edge mesh for a specific layer.



Only in simulations using extremely high frequencies, or in cases where extreme coupling is present between neighboring conductors, is it necessary to use a combination of edge mesh and horizontal side currents.

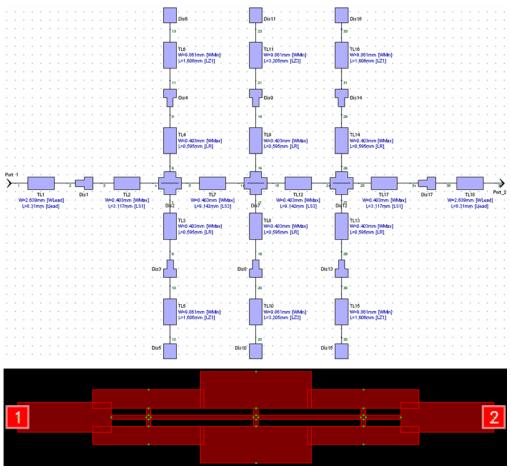
When the Horizontal side current option is disabled, meshing reverts to the previous model for thick conductors (i.e., only the vertical currents on side walls are used).

- 11. If you want to revert to default parameters, click **Cancel**.
- 12. Click **OK** to accept the global mesh parameters.

Calculating Pre-Mesh

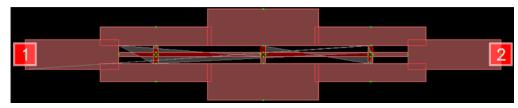
Momentum calculates pre-mesh, which is the union of all metal layers on polygons. You can use this as an early diagnostic tool, to allow checking the initial mesh formulation before calculating Momentum mesh.

In some cases the initial geometry is not correctly setup to create an accurate mesh. For example, using the synthesis tool M/Filter, a filter is produced which has right schematic, but the wrong layout (contains overlapping metal areas):



Momentum needs all pieces of layer metal to have closing contours, which is not satisfied for this layout. As a result, Momentum can not calculate the mesh for it, and fails.

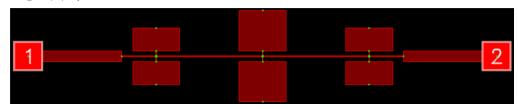
But as Momentum creates the pre-mesh:



With all hidden layers, it looks like this:



which clearly shows that the pre-mesh does not have the right contours. The topology may be fixed by changing the layout drawing, or the substrate parameters. In this example it is fixed by increasing the dielectric constant (Er) by 2 times, and decreasing dielectric height (H) by 2 times.

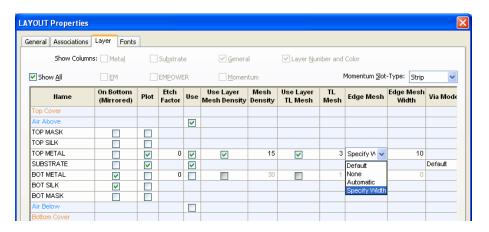


Defining Mesh Parameters for a Layout Layer

You can define mesh parameters that affect the objects on a single layout layer. If you have global parameters set in an analysis, they will be overridden by the mesh parameters defined for a layout layer.

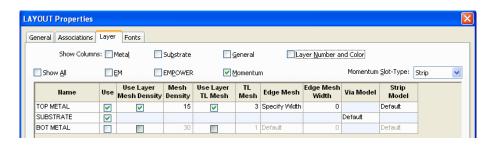
To set up layout layer mesh parameters:

- 1. Open the Layout Properties dialog (double click the layout window, or its use the right click pull down menu command for Layout Properties)
- 2. Select the **Layer** tab.
- 3. Select **Show All** to display all the layer parameters.



Or you can reduce visible information in this table just choosing show

"Momentum" checkbox:



- 4. Select the checkbox for **Use Layer Mesh Density** for the metal layer, and enter the Mesh Density value cells/wavelength for it.
- 5. To use a layer TL mesh density select the checkbox **Use Layer TL Mesh** for the metal layer, and enter the TL Mesh value cells/wavelength for it.
- 6. To use a layer edge mesh:
 - Specify how it's calculated: Default, None, Automatic, or manual
 - Specify Width: enter the value of the **Edge Mesh Width** (in layout length units, in this screen units = mil).

The relationship between wavelength and cells per wavelength is best described by this example. If the portion of the circuit on this layer is 2 wavelengths long and the number of cells per wavelength is 20, the length of the circuit on this layer will be divided into 40 cells

- 7. Select another metal layer and repeat these steps for setting the mesh parameters.
- 8. Click **OK** to accept the mesh parameters for the layers.



You also may specify a metal layer strip model and a dielectric layer via model in this table.

Default settings are defined in Momentum Analysis.

Precomputing a Mesh



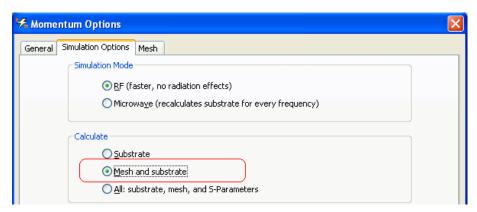
In order to calculate a mesh, you must first pre-compute the substrate and apply ports to the circuit.

Using the specified frequency and any user-defined mesh parameters, a pattern of rectangles and triangles is computed and applied to the circuit. During a simulation, the

surface current in each cell is calculated, and this information is then used to solve S-parameters for the structure.

To precompute the mesh without calculating the S-Parameters:

1. Open the Momentum Options dialog and select the **Simulation Options** tab



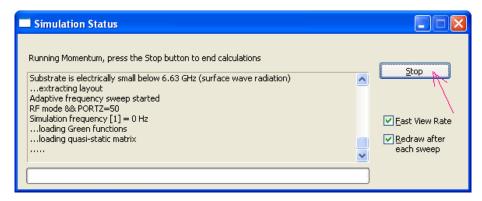
- 2. In the Calculate section, select **Mesh and substrate**
- 3. Click **OK**

Run Momentum analysis, when computations of substrate and mesh are complete, the mesh will be displayed on the layout.

Viewing Mesh Status

After mesh computations have started, any messages regarding the computations will appear in the **Simulation Status** window. Messages usually refer to any errors or warnings, or indicate when the mesh is complete.

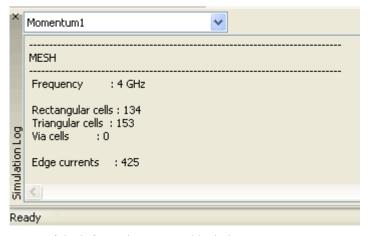
- All messages sent by the Momentum analysis are saved in the Momentum Analysis dataset text variable "LogOutput". The value of LogOutput is shown in the Simulation Log window.
- You may stop Momentum simulation at any time by clicking the **Stop** button on the Momentum Simulation status window.



• It may take a few moments for Momentum to stop.

Viewing the Mesh Summary

If the mesh computation is successful, you can view mesh statistics in the in the Simulation Log window (the Momentum Analysis dataset text variable "LogOutput").



Some of the information returned includes:

- The number of rectangular cells in the structure
- The number of triangular cells
- The number of vertical rectangular cells used to model the vias
- The number of unknown currents
- Computer resources used and time to solve

The number of cells and the number of unknown currents will affect simulation time. The more cells, the denser the mesh, and the longer the simulation will be. Each unknown current is a variable in the matrix equation that is solved by the simulator. The greater the

number of unknown currents, the larger the matrix, and the longer the simulation time will be. The memory required to solve the structure increases as well.

About the Mesh Generator

The mesh generator provides the algorithm that divides the circuit geometry into cells (rectangles and triangles). When the Mesh Reduction option is selected, the mesh is automatically reduced to remove slivery cells of low quality and to remove electromagnetically redundant cells resulting in a mesh with polygonal cells. By discretizing the surface, it is possible to calculate a linear approximation of the arbitrary, varying surface current. The linear approximation involves applying a rooftop function to the cells. The better the linear approximation fits the actual current, the more accurate the results. Thus, a dense mesh generally provides better results at microwave frequencies.

The mesh generator attempts to apply an optimal pattern of cells so that an accurate simulation can be achieved with a minimal number of cells. In Momentum mode, the minimal number of cells can be rather high, resulting in a dense mesh. For a given mesh density, the mesh reduction technology achieves an optimal mesh with significantly fewer cells, hence improving the simulation performance with reduced memory usage and simulation time. Since the current in each cell is calculated in a simulation, a very dense mesh can increase simulation time.

The mesh parameters that you specify provide the mesh maker with the information required to divide your geometry into the various cell shapes and sizes. If you do not want to set mesh parameters, default ones will be used instead. The default mesh setting is 30 cells/wavelength using edge mesh.

Topics in this section:

Adjusting Mesh Density

Effect of mesh reduction on simulation accuracy

About the Edge Mesh

About the Transmission Line Mesh

Combining the Edge and Transmission Line Meshes

Using the Arc Resolution

Mesh Patterns and Simulation Time

Mesh Patterns and Memory Requirements

Processing Object Overlap

Mesh Generator Messages

Adjusting Mesh Density

Two mesh parameters, Mesh Frequency and cells/wavelength are used in combination in determining mesh density.

Simulation

Using the wavelength of the frequency, a linear function is approximated, also referred to as a rooftop basis function. The higher the frequency, the more wavelengths fit across the structure. The cells/wavelength is the minimum number of cells that fit under each wavelength. The more cells, the better the sinusoid is represented, and the more accurate the simulation is. For example, if you use 30 cells per wavelength, the maximum deviation between the sinusoid and the linear approximation is about 1%. These parameters affect longitudinal current.

Higher frequencies will result in a greater number of cells (increased density) for a mesh. Similarly, increasing the minimum number of cells per wavelength will also increase the density. In general, for optimal density, it is better to increase the number of cells per wavelength rather than increasing the mesh frequency. The optimal value for the mesh frequency is the highest frequency that will be simulated. This may avoid having to recalculate the substrate frequency band if it is not sufficient.

You should be aware that the value entered for the number of cells per wavelength is only a lower limit and not the exact value used by the mesh generator. The following discussion explains how the actual number of cells used by the mesh generator may be greater. For example, suppose you enter 20 for Cells per Wavelength. In general, the cell size used when the geometry is infinitely large corresponds with the number of cells per wavelength. But when other details, edges, and user-defined mesh settings are included, cells might

appear that are smaller than $\frac{\lambda}{20}$ resulting in more cells per wavelength than the value of 20 that you entered. Here are two specific cases where the actual number of cells per wavelength is greater:

- When the layout has details that are smaller than $^{\lambda/20}$, the mesh follows the shape of the details. Since the mesh consists of triangles and rectangles only, the cells will be less than $^{\lambda/20}$.
- When you change the default settings in the Mesh Setup Controls dialog box, such as the number of cells per transmission line width, you directly influence the number of cells over the width of the transmission lines. This might lead to cells that are smaller than $\lambda/20$.

Effect of mesh reduction on simulation accuracy

Mesh reduction is a technology that aims at removing mesh complexity originating from the meshing of geometrically complex shapes. In a normal situation, the user specifies the mesh density (the number of cells per wavelength) that needs to be used in the simulation in order to obtain a specific accuracy. However, due to geometrical constraints, the mesher can be forced to use more cells than strictly needed by the wavelength criterion. In this case, the mesh introduces "redundant" degrees of freedom in the solution process. ("redundant" with respect to the electromagnetic behavior). Mesh reduction is a technology that automatically removes these redundant degrees of freedom, prior to the solution of the problem. Hence, it should have a negligible impact on the accuracy of the results.

About the Edge Mesh

The edge mesh feature automatically creates a relatively dense mesh pattern of small cells along the edges of metal or slots, and a less dense mesh pattern of a few large cells in all other areas of the geometry. Because most of the current flow occurs along the edges of slots or metals, the edge mesh provides an efficient solution with greater accuracy.

Use the edge mesh to improve simulation accuracy when solving circuits where the modeling of current flow in any edge area is a critical part of the solution. This includes circuits where the characteristic impedance, or the propagation constant are critical for determining the electrical model, circuits in which close proximity coupling occurs, or circuits where edge currents dominate the circuit behavior. Applications for using the edge mesh include:

- Tightly coupled lines
- Patch antennas
- Resonant circuits
- Delay lines
- Hairpin filters

Edge mesh is available for all levels of meshing: global, layout layer, and object meshing.

Setting the Width of the Edge Mesh

When using an edge mesh, you can either specify the edge mesh width or leave it blank. If you leave it blank, an appropriate width will be determined and used to create the mesh.

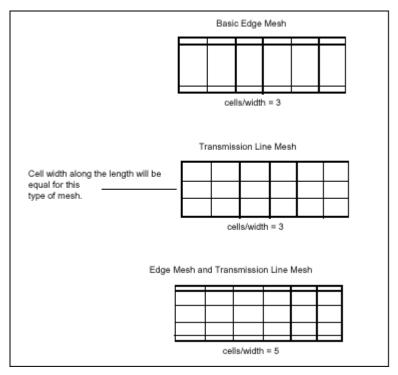
About the Transmission Line Mesh

Use the transmission line mesh when you want to specify the number of cells between parallel lines in a layout. This feature can save computation time and memory because it will create a mesh that is appropriate for straight line geometry.

For example, the simulation results for a single transmission line with one or two cells across the width will be equal. If you have coupled lines, the results will differ.

Combining the Edge and Transmission Line Meshes

Both transmission line mesh and edge mesh can be used together. The total number of cells wide will be the total number of transmission line cells plus edge cells. The minimum value permitted when using this combination is 3.



The edge and transmission line mesh affect the transverse current in the circuit. The more cells specified using edge mesh and transmission line mesh, the more accurate transverse current approximations will be.

The plot below illustrates the hairpin example simulated with and without and edge mesh. Although the simulation that includes the edge mesh takes more time, the results are closer to the actual measured results of the filter.

Using the Arc Resolution

The Arc Resolution parameter enables you to control the number of triangular cells that appear in the mesh. Triangular cells are used to generate a mesh on the curved area of an object. The larger the value in the Arc Resolution field, the fewer the number of triangular segments will be used on the curved object.

The maximum value for the Arc Resolution is 45 degrees. The minimum value depends on the original faceting used when the curved object was drawn. For example, the Double Patch Antenna is drawn with an Arc/Circle Resolution of 30 degrees, and the Arc Resolution is set to 45 degrees. The actual value used to refacet the object will be in between these values. The angle is chosen so that the facet length is smaller or equal to the cell size, so refacetting will not affect the cells per wavelength that is specified for computing mesh density.

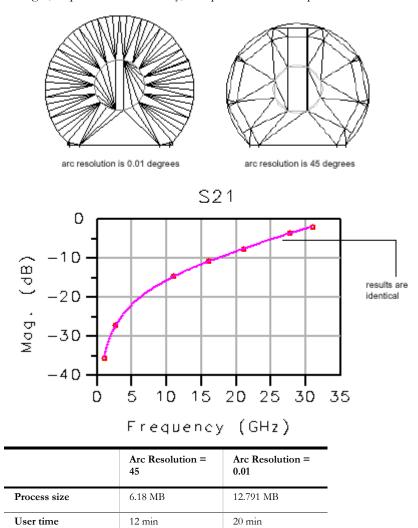


Elapsed time

15 min

In order for the mesh generator to produce an accurate mesh, the mesher must be able to recognize the polygon translation it receives as an arc. Therefore, a poorly defined layout resolution may prevent arc recognition and by that arc refacetting. For more information on layout resolution, refer to Mesh Precision and Gap Resolution.

The VIASTUB example is shown below, the Arc Resolution is set to 45 degrees, the coarsest setting, and 0.01degrees, which effectively turns off refacetting. The mesh for a stub based on each angle setting is displayed. The simulation for the denser mesh was longer, required more memory, and produced little improvement in the results.



24 min

Rectangular cells	96	80
Triangular cells	108	200
Via cells	16	36
Unknown currents	337	453

Mesh Patterns and Simulation Time

The mesh generator is relatively fast, even for complex meshes. But be aware that the complexity of the mesh can have a significant on effect simulation time. In particular, the number of cells in the mesh (especially triangular cells) and the number of unknown currents, can affect simulation time.

Simulation times will be faster when the mesh consists mostly of rectangular cells. A simple mesh is one consisting of a few rectangles of similar size. A worst-case complex mesh would consist of many dissimilar triangles. You should try to minimize the number of triangular cells in the mesh.

The second variable, number of unknown currents, depends on the density, or total number of cells in the mesh. You should try to minimize the total number of cells in the mesh. This reduces the number of unknown currents, and thus reduces the size of the matrix to be solved during simulation. The amount of time required to solve the matrix is N*N*N, where N is the number of unknown currents.

For example, a thru-line at a global seeding of 30 might produce a 50×50 matrix to solve. Since the time required to solve the matrix is proportional to the matrix size, the same thru-line at a seeding of 60 might produce a 200×200 matrix because number of cells would be twice as dense in both X and Y dimensions. This means that it will take longer to solve.

Adjustments to your mesh parameters can be made to control complexity of the mesh and, in turn, the amount of time required to simulate.

For complex circuits, where simulation times may be long even with a simple mesh, reducing the complexity of a mesh can save significant amounts of simulation time.

Mesh Patterns and Memory Requirements

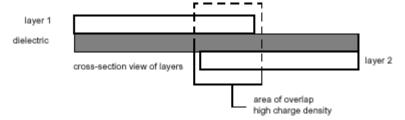
The number of unknown currents, which is calculated when the mesh is precomputed, is based on the complexity of the mesh. The more unknowns, the larger the matrix that must be solved during simulation. The amount of memory required to solve is proportional to N*N, where N is the number of unknown currents.

Processing Object Overlap

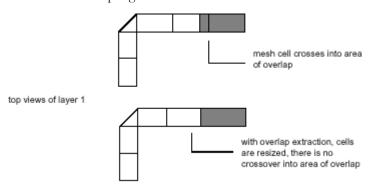
The parameter Thin layer overlap extraction should be used in designs that include thin layers that are both close together and overlapping. It is possible that mesh cells can be generated that cross the overlap region, and this is not desirable.

As an example, consider two layers, one above the other, and close together. They carry a large charge density where they overlap, which increases proportionally to 1/distance. If

there is no metal above the layers, the charge density is nearly zero where there is no overlap, and the change is very rapid—nearly a step—at the point of overlap.



If no overlap extraction is performed, the mesher can create cells that will cross the border of the overlap. In the actual circuit, this cell would have a partially high charge density area where the overlap is present, and a partially low charge density area where there is no overlap. However, Momentum simulates cells with a constant charge density, and approximating the strongly-varying charge in the cell with a constant is not an adequate representation. Thus, by enabling thin layer extraction, no cells will be created that cross an overlap region.



Because enabling this feature for all possible overlap in a circuit would create too dense a mesh, some empirical rules are implemented that switch the overlap extraction off if the layers are not close (h > 0.02 estimated cell size) or if the overlap area is small. To calculate the estimated cell size, the mesh frequency, the global number of cells per wavelength, and an estimation of the effective refractive index of the substrate are used.

If you are calculating your mesh at low frequencies, the estimated cell size is high, and you may not want thin layer overlap extraction. In this case, disable the Thin layer overlap function.

Mesh Generator Messages

When a mesh is generated, you may see a message similar to this:

On some layers, the mesher used the maximum allowable cell size for the given substrate. You will not be able to generate a coarser mesh on these layers.

This means that the coarsest mesh has been achieved for the objects on certain layers. This is because the maximum cell size has been limited due to the accuracy of the Green's functions that were calculated for the substrate.

For example, consider a layout with 20-cell mesh when the mesh frequency is 10 GHz. Generally, you would get a 10-cell mesh if you set the mesh frequency to 5 GHz. But if, with the lower mesh frequency, the cell size would be larger that the maximum allowed (the limit being based on the accuracy of the Greens' function of the substrate), the mesh would contain more than 10 cells.

Another message that may occur at meshing reports:

POLYLINE requires two unique points

This occurs if the layout mesh resolution (set in the Momentum GX Mesh tab) is inadequate for slanting the meshing line. Increase the resolution to a finer value to make the error disappear.

Guidelines for Meshing

The default mesh will provide an adequate and accurate answer for many circuit applications. For most other circuit applications, the using the global mesh parameters will be all that is needed to provide greater accuracy. In a few special cases, you may need to use the layer or primitive mesh controls.

For applications such as highly accurate discontinuity modeling or for geometries that have tightly coupled lines, the default mesh may not be dense enough in particular areas to provide enough accuracy. In such cases, edge mesh should be used or the mesh density must be increased. For example, noise floor and dynamic range are typically small numbers. In some cases, geometry solutions may show a low value of S21, like -60 dB, using a dense mesh. Such values are different for a default mesh, which may result in -40 dB for the same circuit.

In any one design, you can use any combination of the four types of mesh control. In general, greater mesh density can provide more accuracy. But greater density takes more computation time (more cells to solve) and, additionally, triangles always take longer to compute than rectangles.

Topics in this section:

Meshing Thin Layers

Meshing Thin Lines

Meshing Slots

Adjusting the Mesh Density of Curved Objects

Discontinuity Modeling

Solving Tightly Coupled Lines

Mesh Precision and Gap Resolution

Meshing Thin Layers

Thin layers must be meshed so that the mesh cells are entirely within or entirely outside of the overlapping area. If the mesh cells and object boundaries are not aligned correctly, the simulation data may be less accurate.

For more information, refer to Processing Object Overlap.

Meshing Thin Lines

When the geometry has narrow lines, like thin transmission paths in a spiral, it may be difficult to have a mesh that is more than one cell across the width if the default global mesh is used. If needed, use Edge Mesh or Transmission Line Mesh to capture the current distribution across the line.

Meshing Slots

Slots should be meshed exactly the same as strips—there is no difference. For example, the edge mesh can be used for slots because the current distribution is basically the same, that is, it is concentrated on the edges of a slot.

Adjusting the Mesh Density of Curved Objects

Vias or other curved objects, when drawn in a layout, have a default value for the number of facets used to draw the object. If the value is small, a relatively large number of facets are used to draw the circle, and this can result in more triangular cells created the curved areas during the mesh process. Be aware that changing the facets of an object does alter the geometry of the circuit.

For information on how the mesh parameter Arc Resolution affects a mesh, refer to Processing Object Overlap.

Discontinuity Modeling

A microstrip transmission line with a bend, using the default mesh, may have a cell size equal to the width of the line (one cell per line-width). If it is long and the bend is not severe, then the default mesh may be adequate because the discontinuity is proportionally small compared to the line length. However, if the reference planes are moved inward or if the bend is more severe, the discontinuity and resulting parasitics are in greater proportion to the rest of the line. In that case, the default mesh may result in simulation data with an error.

To correct this inaccuracy, the mesh should be increased and edge mesh used. When the area near the discontinuity is meshed so that the cell size is equal to a third of the linewidth (three cells per line-width) the resulting error is reduced. The denser mesh allows for current crowding (parasitic series inductance) at the interior corner of the bend and charge build-up (parasitic shunt capacitance) at the outer edge of the bend.

Solving Tightly Coupled Lines

An example of a tightly coupled line would be a microstrip coupled line filter on a 25 mil Alumina substrate (Er = 9.8) where the line width is 25 mils and the separation between the lines is 2.5 mils. The filter response is sensitive to coupling between the lines and the

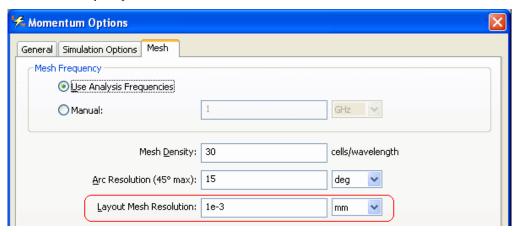
Simulation

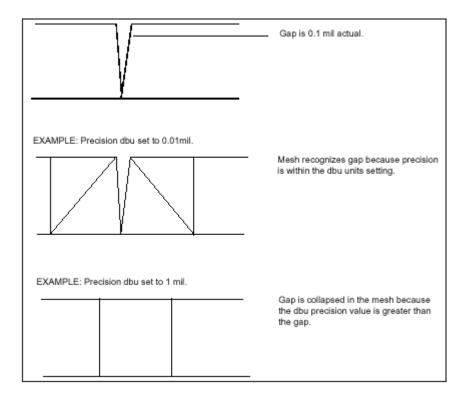
default mesh is 1 cells per line-width. In this case, the reflection coefficient data does not match measurement data. To solve this design properly, edge mesh must be used.

Mesh Precision and Gap Resolution

Mesh resolution is directly related to the Layout Precision dbu (data base units) value. All gaps or other unresolved layout vertices will be resolved by the mesh generator if their distance is less than 2 dbu.

Use the Momentum Analysis Properties dialog to change the Layout resolution for your fabrication or layout process as needed.





Adaptive Frequency Sampling

Adaptive Frequency Sampling (AFS) is a method of comparing sampled S-parameter data points to a rational fitting model. In order to accurately represent the spectral response of the circuit, the AFS feature in Momentum takes a minimal number of frequency samples and then applies its algorithm to the sampled data. Wherever the S-parameters vary the most, more samples are taken. When the fitting model and the sampled data converge, the AFS algorithm is then complete and the S-parameter data is written into the dataset. In this way, the maximum amount of information can be obtained from the minimum amount of sampling.

By using the AFS feature, you can greatly reduce the amount of time required to simulate circuits that have resonances or other sharp responses that are difficult to detect. Data that would have remained hidden using other types of analyses can now be obtained.

Even in the case of a low-pass filter, AFS can solve for the S-parameters faster and more accurately than discrete data sampling. For example, if you were measuring a 2 GHz low-pass filter, you would enable the AFS feature and then enter a start frequency of 500 MHz and a stop frequency of 4 GHz. AFS would then sample the two end points, construct the fitting model, and then sample points in between as needed. As this occurs, the model is automatically refined and appropriate sample points are taken until the model and the sampled data converge. When convergence is reached, both sampled data and the AFS

Simulation

data are written into two separate datasets and can be presented as S-parameter traces on a plot. If the max sample size is reached before converging, the partial results will be saved and can be reused by simulating the circuit again.



AFS data must converge in order to be accurate. Be sure the data is converged by checking the message in the Momentum Status window. If data is not converged, you will see inaccurate results.

AFS Convergence

Convergence is determined by how close the fitting model is to the sampled data. Convergence is achieved when the sampled points are accurate to -75 dB, and the overall accuracy is -60 dB.

When AFS is used, be sure that the sampled data has converged with the fitting model. This can be checked by the messages in the status window. If converged, the message will be that AFS is complete. If not converged, a warning will appear. Examples of such warning messages are:

Maximum number of adaptive frequency samples reached!

Fitting models not (completely) converged.

Consider: - increasing maximum number of sample points.
- activating the reuse option.

If you encounter errors, try decreasing the frequency range of the frequency plan and increasing the number of sample points. Theoretically, some circuits may require several dozen points to converge if they are electrically long. This is because the AFS program samples the data at about each 60 degree rotation, in the Smith chart, of the S-parameter with the most phase variation.

If you simulation does not converge, to help you assess the quality of the simulation, you can view convergence results in the Simulation Log window.





Setting Sample Points

If you are using the Adaptive sweep type in a simulation, you may want to select specific sample points to be used in the AFS process. In general, this is not necessary (and is in fact, discouraged), but there may be instances where it is beneficial. An application where this may be beneficial is simulating a structure that has a distinct variation in response at some point over a frequency range, such as a resonant structure. To set up the simulation:

- 1. Select the Single sweep type, enter either the value of the resonant frequency or a value near it in the Frequency field, and add this to the frequency plan list.
- 2. Select the Adaptive sweep type, set up the plan, then add it to the list of frequency plans.

For this situation, the sample point aids the AFS process by identifying an area where there is clearly a variation in the response of the circuit.

Applying extra sample points may be necessary for visualization or far-field calculations.

It is not beneficial to attempt to add sample points for other purposes, such as attempting to force smoothing to occur at specific points, without taking into consideration the response at these points. For example:

- 1. Selecting the Linear sweep type, adding sample points spread linearly across the frequency range, and adding the frequency plan to the list.
- 2. Adding an Adaptive sweep type, selecting the same frequency range, and adding it to the list.

For this situation, the sample points from the linear simulation will be included in the adaptive simulation. This impedes the AFS process of selecting the optimal distribution of samples over the frequency range, and this can produce poor simulation results.

To remedy this situation, either run the Adaptive sweep plan first or make sure that the frequency ranges of the two plans do not overlap.

Viewing AFS S-parameters

When viewing the S-parameters in an AFS dataset, if you zoom in you may see small, unexpected spurious ripples or oscillations, with an amplitude less than 0.0002. The amplitude of these oscillations is always less than the AFS accuracy level, which is approximately -60 dB. Generally, these ripples will only appear if the dynamic behavior of the S-parameters is limited, for example, an S-parameter that is nearly 1 over the frequency range simulated. This is likely due to the rational fitting model have too many degrees of freedom and being too complex for this situation

Momentum Cosimulation

Any Momentum GX simulation performs these two internal steps:

1. EM-analysis of the design board, producing the "raw" parameters of the board:

Sraw[Nports_{raw}][Nports_{raw}] [Nfreqs_{raw}] - S-parameters of the board;

ZPORTraw[Nports_{raw}] [Nfreqs_{raw}] - reference impedances of the board ports;

Fraw [Nfreqs_{raw}] - array of the Momentum analysis frequencies;

Yraw[Nports_{raw}][Nports_{raw}][Nfreqs_{raw}] - Y-parameters of the board (converted from Sraw, and ZPORTraw);

Nfreqs_{raw}- number of Momentum analysis frequencies;

Nports_{raw}- number of all board ports.

Nports_{raw} = Nports_{ext}+Nports_{int}, Nports_{ext} - number of external ports,

Nports_{int,}- number of internal ports, including internal ports automatically created for all pads of the circuit lumped elements.

- 2. Generation of the co-simulation design, consisting of
 - a. A board-modeling multiport object, defined by Yraw board parameters;
 - b. All circuit external ports, and lumped elements, connected to the board multiport.

After the co-simulation design has been created, Momentum GX

- creates a linear solver,
- calculates the DC operating point of the circuit,

- linearizes nonlinear elements at the DC point, and
- simulates the co-simulation design at all co-simulation frequencies, as defined in the Momentum analysis properties tab.

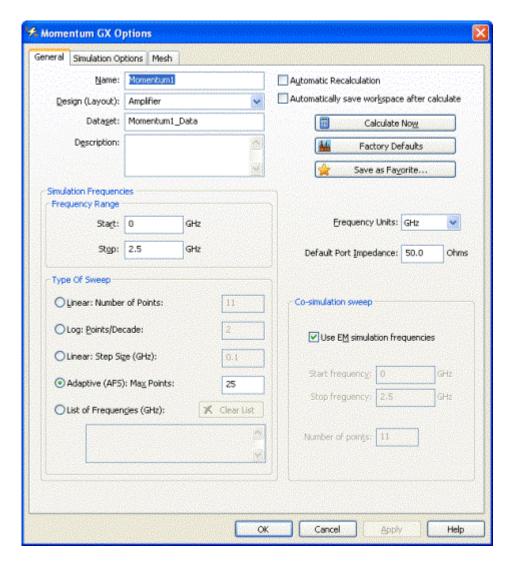
Finally the linear co-simulation creates:

S [Nports] [Nports] [Nfreqs] - S-parameters of the full co-simulation design;

ZPORT[Nports][Nfreqs] - reference impedances of the co-simulation design ports;

F[Nfreqs] - array of the co-simulation design linear simulation frequencies;

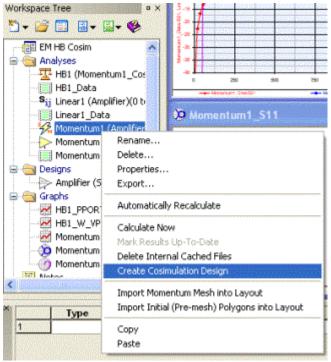
The co-simulation sweep frequencies are defined in the Momentum GX Options dialog/ General page:



The default co-simulation uses EM-simulation frequencies (**Use EM simulation frequencies** box is checked), but the frequencies may be defined independently by a frequency band (**Start** and **Stop** frequencies), and number of points. In this case, the EM-simulation **Yraw** parameters will be interpolated or extrapolated for all co-simulation frequencies missing in the EM-analysis simulation frequencies set by **Fraw**.

If a simulated circuit has nonlinear elements, its behavior is dependent on the accuracy of the DC operating point. The higher the lowest EM-simulation frequency, the larger the error of the EM-data extrapolation to the DC frequency. Be sure to include 0 (or close to 0) EM-analysis frequency for the nonlinear circuit, even if your analysis frequency band is far away from the 0-frequency.

After the Momentum GX analysis has calculated, the co-simulation design may be placed on the tree, to be available for any linear or nonlinear simulations. To create a design on tree, right click the Momentum analysis, and choose **Create Cosimulation Design**:



This will create a new design with name "<Momentum Analysis name>_cosim". In this case, it creates the co-simulation design "Momentum1_cosim". This design may be used like any other Genesys design, for any simulation engine. For more information, see the example located at Examples\MomentumGX\EM HB Cosim.

Momentum Theory of Operation

Momentum is based on a numerical discretization technique called the *method of moments*. This technique is used to solve Maxwell's electromagnetic equations for planar structures embedded in a multilayered dielectric substrate. The simulation modes available in Momentum (microwave and RF) are both based on this technique, but use different variations of the same technology to achieve their results.

Momentum has two modes of operation, microwave or full-wave mode and the RF or quasi-static mode. The main difference between these two modes lies within the Green functions formulations that are used. The full-wave mode uses full-wave Green functions, these are general frequency dependent Green functions that fully characterize the substrate without making any simplification to the Maxwell equations. This results in L and C elements that are complex and frequency dependent. The quasi-static mode uses frequency independent Green functions resulting in L and C elements that are real and frequency independent. Because of the approximation made in the quasi-static mode, the

RF simulations run a lot faster since the matrix L and C elements only have to be calculated for the first frequency simulation point. The approximation also implies that the quasi-static mode typically should be used for structures that are smaller than half the wavelength. Both engine modes are using the so-called star-loop basis function, ensuring a stable solution at all frequencies. Both engines also make use of a mesh reduction algorithm which reduces the number of unknowns in the simulation by generating a polygonal mesh. This mesh reduction algorithm can be turned on or off, with a toggle switch.

The sources applied at the ports of the circuit yield the excitations in the equivalent network model. The currents in the equivalent network are the unknown amplitudes of the rooftop expansion functions. Solving the equivalent network for a number of independent excitation states yields the unknown current amplitudes. A port calibration process is used to calculate the S-parameter data of the circuit from the current solution, when calibration is requested.

The following sections in this chapter contain more information about:

- The Method of Moments Technology
- The Momentum Solution Process
- Special Simulation Topics
- Limitations and Considerations

The Method of Moments Technology

The method of moments (MoM) technique is based upon the work of R.F. Harrington, an electrical engineer who worked extensively on the method and applied it to electromagnetic field problems, in the beginning of the 1960's. It is based on older theory which uses weighted residuals and variational calculus. More detailed information on the method of moments and Green's theorem can be found in *Field Computation by Moment Methods* [1].

In the method of moments, prior to the discretization, Maxwell's electromagnetic equations are transformed into integral equations. These follow from the definition of suitable electric and magnetic Green's functions in the multilayered substrate. In Momentum, a mixed potential integral equation (MPIE) formulation is used. This formulation expresses the electric and magnetic field as a combination of a vector and a scalar potential. The unknowns are the electric and magnetic surface currents flowing in the planar circuit.

Using notations from linear algebra, we can write the mixed potential integral equation in very general form as a linear integral operator equation:

$$\iint dS \overline{\overline{G}}(r, r') \cdot J(r) = E(r)$$
Equation 1

Here, J(r) represents the unknown surface currents and E(r) the known excitation of the problem. The Green's dyadic of the layered medium acts as the integral kernel. The unknown surface currents are discretized by meshing the planar metallization patterns and applying an expansion in a finite number of subsectional basis functions $B_1(r)$, ..., $B_N(r)$:

$$J(\mathbf{r}) \approx \sum_{j} I_{j} \mathbf{B}_{j}(\mathbf{r})$$

Equation 2

The standard basis functions used in planar EM simulators are the subsectional rooftop functions defined over the rectangular, triangular, and polygonal cells in the mesh. Each rooftop is associated with one edge of the mesh and represents a current with constant density flowing through that edge. The unknown amplitudes Ij, j=1,..,N of the basis function expansion determine the currents flowing through all edges of the mesh.

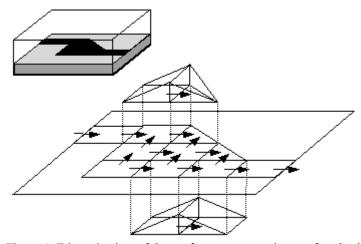


Figure 1. Discretization of the surface currents using rooftop basis functions.

The integral equation (1) is discretized by inserting the rooftop expansion (2) of the currents. By applying the Galerkin testing procedure, that is, by testing the integral equation using test functions identical to the basis functions, the continuous integral equation (1) is transformed into a discrete matrix equation:

for i=1,...,N

$$\sum_{i=1}^{N} Z_{i,j} I_j = V_i \quad \text{or} \quad [Z] \cdot [I] = [V]$$

Equation 3

with

$$Z_{i,j} = \iint_{S} \!\! \mathrm{d} S \pmb{B}_{i}(\pmb{r}) \cdot \iint \!\! \mathrm{d} S \, \overline{\overline{\pmb{G}}}(\pmb{r},\pmb{r}') \cdot \pmb{B}_{j}(\pmb{r})$$

Equation 4

$$V_i = \iint_S dS \boldsymbol{B}_i(\boldsymbol{r}) \cdot \boldsymbol{E}(\boldsymbol{r})$$

Equation 5

The left hand side matrix [Z] is called the interaction matrix, as each element in this matrix describes the electromagnetic interaction between two rooftop basis functions. The dimension N of [Z] is equal to the number of basis functions. The right-hand side vector [V] represents the discretized contribution of the excitations applied at the ports of the circuit.

The surface currents contribute to the electromagnetic field in the circuit by means of the Green's dyadic of the layer stack. In the MPIE formulation, this Green's dyadic is decomposed into a contribution from the vector potential $\mathbf{A}(\mathbf{r})$ and a contribution from the scalar potential $\mathbf{V}(\mathbf{r})$:

$$\overline{\overline{\boldsymbol{G}}}(\boldsymbol{r},\boldsymbol{r}^{t})=j\omega\boldsymbol{G}^{A}(\boldsymbol{r},\boldsymbol{r}^{t})\overline{\overline{\boldsymbol{I}}}-\frac{1}{j\omega}\nabla[\boldsymbol{G}^{V}(\boldsymbol{r},\boldsymbol{r}^{t})\nabla^{t}]$$

Equation 6

The scalar potential originates from the dynamic surface charge distribution derived from the surface currents and is related to the vector potential through the Lorentz gauge.

By substituting the expression (6) for the Green's dyadic in the expression (4) for the interaction matrix elements, yields the following form:

$$Z_{i,j} = j\omega L_{i,j} + \frac{1}{j\omega C_{i,j}}$$

Equation 7

with

$$L_{i,j} = \iint_{S} \mathrm{d}S \boldsymbol{B}_{j}(\boldsymbol{r}) \cdot \iint \mathrm{d}S \, G^{A}(\boldsymbol{r}, \boldsymbol{r}') \boldsymbol{B}_{j}(\boldsymbol{r}')$$

Equation 8

$$\frac{1}{C_{i,j}} = \iint_{S} dS \nabla \cdot \boldsymbol{B}_{j}(\boldsymbol{r}) \iint dS G^{V}(\boldsymbol{r}, \boldsymbol{r}^{i}) \nabla \cdot \boldsymbol{B}_{j}(\boldsymbol{r}^{i})$$

Equation 9

This allows the interaction matrix equation to be given a physical interpretation by constructing an equivalent network model (Figure 2). In this network, the nodes correspond to the cells in the mesh and hold the cell charges. Each cell corresponds to a capacitor to the ground. All nodes are connected with branches which carry the current flowing through the edges of the cells. Each branch has in inductor representing the magnetic self coupling of the associated current basis function. All capacitors and inductors in the network are complex, frequency dependent and mutually coupled, as all

basis functions interact electrically and magnetically (Figure 3). The ground in this equivalent network corresponds with the potential at the infinite metallization layers taken up in the layer stack. In the absence of infinite metallization layers, the ground corresponds with the sphere at infinity. The method of moments interaction matrix equation follows from applying the Kirchoff voltage laws in the equivalent network. The currents in the network follow from the solution of the matrix equation and represent the amplitudes of the basis functions.

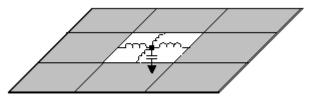


Figure 2. The equivalent circuit is built by replacing each cell in the mesh with a capacitor to the ground reference and inductors to the neighboring cells.

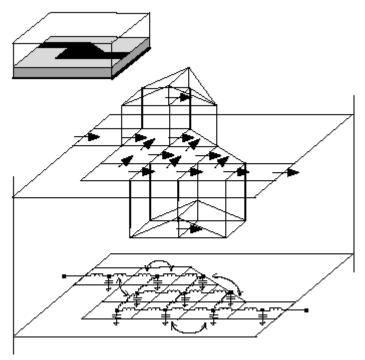


Figure 3. Equivalent network representation of the discretized MoM problem.

The Momentum Solution Process

Different steps and technologies enable the Momentum solution process:

• Calculation of the substrate Green's functions

- Meshing of the planar signal layer patterns
- Loading and solving of the MoM interaction matrix equation
- Calibration and de-embedding of the S-parameters
- Reduced Order Modeling by Adaptive Frequency Sampling

Calculation of the Substrate Green's Functions

The substrate Green's functions are the spatial impulse responses of the substrate to Dirac type excitations. They are calculated for each pair of signal (strip, slot and/or via) layers mapped to a substrate level. Although it is necessary to know which signal layers are mapped to a substrate level, since only impulse responses are being calculated, it is not necessary to know the patterns on these signal layers. This implies that the Green's functions can be pre-calculated and stored in a substrate database. This allows the substrate Green's functions to be reused for other circuits defined on the same substrate.

The high frequency electromagnetic Green's functions depend upon the radial distance and the frequency. The computations are performed up to very large radial distances over the entire frequency band specified by the user. The frequency points are selected adaptively to ensure an accurate interpolation with respect to frequency. Computations performed over very wide frequency ranges can consume more CPU time and disk space to store the results. To increase speed, the RF mode uses quasi-static electromagnetic Green's functions based on low-frequency approximation and scales the quasi-static Green functions at higher frequencies.

Meshing of the Planar Signal Layer Patterns

The planar metallization (strip, via) and aperture (slot) patterns defined on the signal layers are meshed with rectangular and triangular cells in the microwave simulation mode. As translational invariance can be used to speed up the interaction matrix load process, the meshing algorithm will maximize the number if uniform rectangular cells created in the mesh. The meshing algorithm is very flexible as different parameters can be set by the user (number of cells/wavelength, number of cells/width, edge meshing, and mesh seeding), resulting in a mesh with different density. It is clear that the mesh density has a high impact on both the efficiency and accuracy of the simulation results. Default mesh parameters are provided which give the best accuracy/efficiency trade-off. Both the RF and microwave modes use mesh reduction technology to combine rectangular and triangular cells to produce a mesh of polygonal cells, thus reducing demand for computer resources. Mesh reduction eliminates small rectangles and triangles which from an electrical modeling point of view only complicate the simulation process without adding accuracy. As mentioned previously, this feature may be turned on or off with a toggle switch on the Momentum Analysis properties window.

Loading and Solving of the MoM Interaction Matrix Equation

The loading step of the solution process consists of the computation of all the electromagnetic interactions between the basis functions and the filling of the interaction

matrix and the excitation vector. The interaction matrix as defined in the rooftop basis is a dense matrix, that is, each rooftop function interacts with every other rooftop function. This electromagnetic interaction between two basis functions can either be strong or weak, depending on their relative position and their length scale. The matrix filling process is essentially a process of order (N2), i.e. the computation time goes up with the square of the number of unknowns.

In the solving step, the interaction matrix equation is solved for the unknown current expansion coefficients. The solution yields the amplitudes of the rooftop basis functions which span the surface current in the planar circuit. Once the currents are known, the field problem is solved because all physical quantities can be expressed in terms of the currents. For large problem sizes, the iterative matrix solve performs as an order (N2) process. Momentum still uses a direct matrix solve process if the structure is small or when convergence problems are detected in the iterative matrix solver process.

Calibration and De-embedding of the S-parameters

Momentum performs a calibration process on the single type port, the same as any accurate measurement system, to eliminate the effect of the sources connected to the transmission line ports in the S-parameter results. Feedlines of finite length (typically half a wavelength at high frequencies, short lines are used at low frequencies) are added to the transmission line ports of the circuit. Lumped sources are connected to the far end of the feedlines. These sources excite the eigenmodi of the transmission lines without interfering with the circuit. The effect of the feedlines is computed by the simulation of a calibration standard and subsequently removed from the S-parameter data. A built-in cross section solver calculates the characteristic impedance and propagation constant of the transmission lines. This allows to shift the phase reference planes of the S-parameters, a process called de-embedding. Results of the calibration process includes the elimination of low-order mode mismatches at the port boundary, elimination of high-order modes, and removal of all port excitation parasitics.

Besides transmission line ports, Momentum offers the user the ability to define direct excitation or internal ports. These ports can be specified at any location on the planar metallization patterns as either a point or a line feed. They allow to connect both passive and active lumped components to the distributed model of the planar circuits. The S-parameters associated with these ports are calculated from the excitation consisting of a lumped source connected to the equivalent network model at the locations of the internal ports. The parasitic effects of these lumped sources are not calibrated out of the S-parameters results.

Reduced Order Modeling by Adaptive Frequency Sampling

A key element to providing fast, highly accurate solutions using a minimum of computer resources is the Adaptive Frequency Sampling (AFS) technology. When simulating over a large frequency range, oversampling and straight line interpolation can be used to obtain smooth curves for the S-parameters. Oversampling however implies a huge amount of wasted resources. Momentum allows the user to benefit from a smart interpolation scheme based on reduced order modeling techniques to generate a rational pole/zero

model for the S-parameter data. The Adaptive Frequency Sampling algorithm selects the frequency samples automatically and interpolates the data using the adaptively constructed rational pole/zero model. This feature allows important details to be modeled by sampling the response of the structure more densely where the S-parameters are changing significantly. It minimizes the total number of samples needed and maximizes the information provided by each new sample. In fact, all kinds of structure can take advantage of the AFS module. The Adaptive Frequency Sampling technology reduces the computation time needed for simulating large frequency ranges with Momentum significantly.

Special Simulation Topics

Some special simulation topics are discussed in this section:

- Simulating Slots in Ground Planes
- Simulating Metalization Loss
- Simulating Internal Ports and Ground References

Simulating Slots in Ground Planes

Slots in ground planes are treated in a special manner by Momentum. An electromagnetic theorem called the equivalence principle is applied. Instead of attempting to simulate the flow of electric current in the wide extent of the ground plane, only the electric field in the slot is considered. This electric field is modeled as an equivalent magnetic current that flows in the slot.

Momentum does not model finite ground plane metallization thickness. Ground planes and their losses are part of the substrate definition.

By using slot metallization definitions, entire structures, such as slot lines and coplanar waveguide circuits, can be built. Slots in ground planes can also be used to simulate aperture coupling through ground planes for multi-level circuits. Structure components on opposite sides of a ground plane are isolated from each other, except for intermediate coupling that occurs through the slots. This treatment of slots allows Momentum to simulate slot-based circuits and aperture coupling very efficiently.

Simulating Metallization Loss

When using Momentum, losses in the metallization patterns can be included in the simulation. Momentum can either treat the conductors as having zero thickness or include the effects of finite thickness in the simulation. In the substrate definition, the expansion of conductors to a finite thickness can be turned on/off for every layer. For more information, refer to Via Structures Limitation.

Momentum uses a complex surface impedance model for all metals that is a function of conductor thickness, conductivity, and frequency. At low frequencies, current flow will be approximately uniformly distributed across the thickness of the metal. Momentum uses this minimum resistance and an appropriate internal inductance to form the complex

surface impedance. At high frequencies, the current flow is dominantly on the outside of the conductor and Momentum uses a complex surface impedance that closely models this skin effect. Horizontal currents on the side metallization of finite thickness conductors and conductors with arbitrary height/width ratio can be accurately modeled with Momentum. The surface impedance model for thick conductors includes mutual internal coupling for currents at the top and bottom plane of the thick conductor.

The meshing density can affect the simulated behavior of a structure. A more dense mesh allows current flow to be better represented and can slightly increase the loss. This is because a more uniform distribution of current for a low density mesh corresponds to a lower resistance.

Losses can be defined for ground planes defined in the substrate definition. This uses the same formulation as for loss in microstrips (i.e., through a surface impedance approximation). It should be noted however that since the ground planes in the substrate description are defined as infinite in size, only HF losses are incorporated effectively. DC losses are zero by definition in any infinite ground plane. DC metallization losses in ground planes can only be taken into account by simulating a finite size ground plane as a strip metallization level.



For infinite ground planes with a loss conductivity specification, the microwave mode of Momentum incorporates the HF losses in ground planes, however, the RF mode will make an abstraction of these HF losses.

Simulating with Internal Ports and Ground References

Momentum offers the ability to use internal ports within a structure. Internal ports can be specified at any location on the planar metallization patterns, and they make possible a connection for both passive and active lumped components to the distributed model of the planar circuits. Refer to Figure 4.

The S-parameters associated with these ports are calculated from the excitation consisting of a lumped voltage source connected to the equivalent network model, as shown in Figure 3. The ground reference for these ports in the resulting S-parameter model is the ground of the equivalent network, and this ground corresponds physically to the infinite metallization layers taken up in the layer stack. In the absence of infinite metallization layers, the ground no longer has a physical meaning and corresponds mathematically with the sphere at infinity.

It is important to mention that in this case, the associated S-parameters also lose their physical meaning, as the applied voltage source is assumed to be lumped, that is electrically small, since it sustains a current flow from the ground to the circuit without phase delay. To overcome this problem, a ground reference must be specified at a distant electrically small from the internal port. Failure to do so may yield erroneous simulation results.

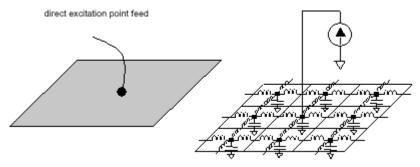


Figure 4. Internal port and equivalent network model.

The following sections illustrate the use of internal ports with ground planes and with ground references, and the results.

Internal Ports and Ground Planes in a PCB Structure

Figure 5 shows the layout for a PCB island structure with two internal ports. The infinite ground plane is taken up in the substrate layer stack and provides the ground reference for the internal ports. The magnitude and phase of the S21-parameter calculated with Momentum are shown in Figure 6. The simulation results are validated by comparing them with the measured data for the magnitude and the phase of S21.

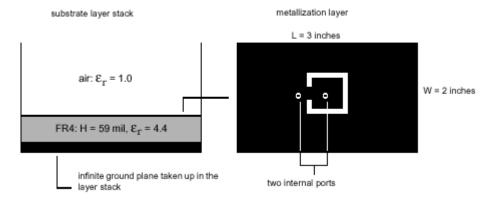


Figure 5. PCB Substrate layer stack and metallization layer.

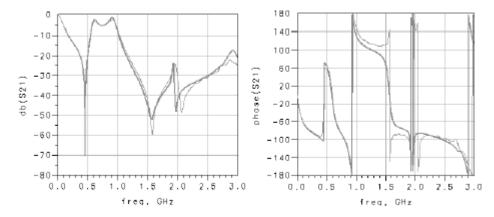


Figure 6. Magnitude and phase of S21. The thicker line is Momentum results, the thinner line is the measurement.

Finite Ground Plane, no Ground Ports

The same structure was resimulated with a finite groundplane (Figure 7). The substrate layer stack contains no infinite metallization layers. No ground reference was specified for the ports, so the sphere at infinity acts as the ground reference for the internal ports. The S-parameters obtained from a simulation for these ports no longer have a physical meaning. Using such ports in the simulation yields incorrect simulation results as shown in Figure 8.

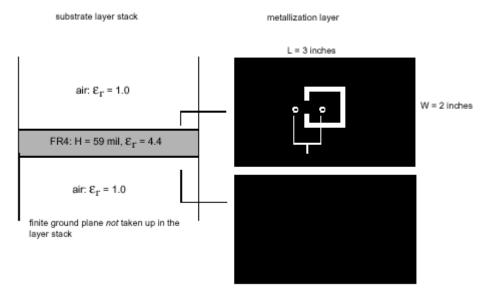


Figure 7. PCB substrate layer stack and metallization layers.

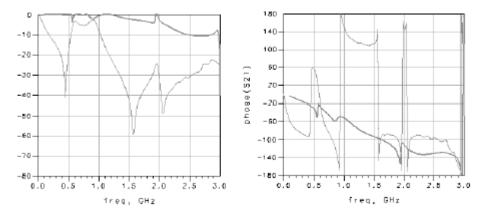


Figure 8. Magnitude and phase of S21. The thicker line is Momentum results, the thinner line is the measurement.

Finite Ground Plane, Internal Ports in the Ground Plane

One way to define the proper grounding for the internal ports is to add two extra internal ports in the ground plane (Figure 9). The resulting four-port structure is simulated with Momentum. Note that because no ground reference is specified for the internal ports, the resulting S-parameters for the four port structure have no physical meaning. However, by properly recombining the four ports, a two-port structure is obtained with the correct ground references for each of the ports. Care should be taken with this recombination, as the ground reference for the four individual ports does not act as the ground reference for the two recombined ports. Therefore, the top recombination scheme shown in Figure 10 is incorrect. The correct recombination scheme is the bottom one shown in Figure 10.

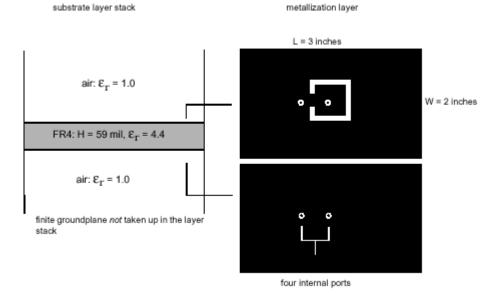


Figure 9. PCB substrate layer stack and metallization layers.

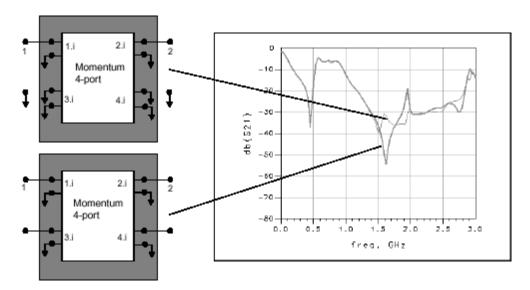


Figure 10. Simulation results. The bottom illustration shows the correct recombination of ports.

Finite Ground Plane, Ground References

The process of adding two extra internal ports in the ground plane and recombining the ports in the correct way can be automated in Momentum by defining two ground reference ports (Figure 11). The S-parameters obtained with Momentum are identical to the S-parameters of the two-port after the correct recombination in the section above, also shown in Figure 12.

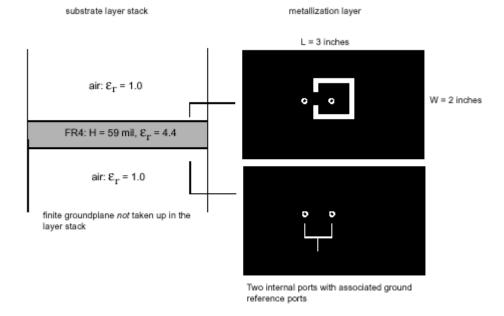


Figure 11. Substrate layer stack and metallization layers.

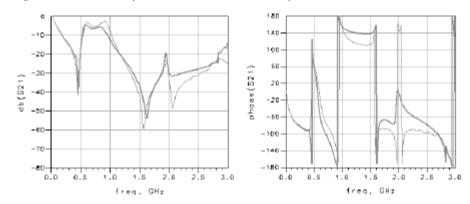


Figure 12. Magnitude and phase of S21. The thicker line is Momentum results, the thinner line is the measurement.

Internal Ports with a CPW Structure

Figure 13 and Figure 14 show the layout for a CPW step in width structure with an integrated sheet resistor (45 m x 50 m, 50). Six internal ports are added to the metallization layers. The six-port S-parameter model is recombined into a two-port model to describe the CPW-mode S-parameters. Different recombination schemes are possible, yielding different simulation results. Scheme (c) is the correct one, as the ground reference for the internal ports is the sphere at infinity and this cannot act as the ground reference for the CPW ports.

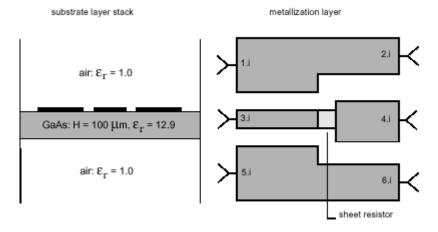


Figure 13. CPW step-in-width with integrated sheet resistor

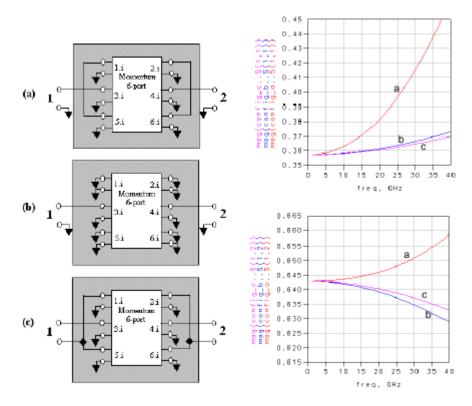


Figure 14. CPW Step-in-width structure with integrated sheet resistor, port configurations and results.

The process of adding extra internal ports to the ground metallization patterns and recombining the ports in the correct way can be automated in Momentum by defining ground reference ports (Figure 15). The S-parameters obtained with Momentum are identical to the S-parameters of the two-port for the correct recombination scheme (Figure 14 (c)).

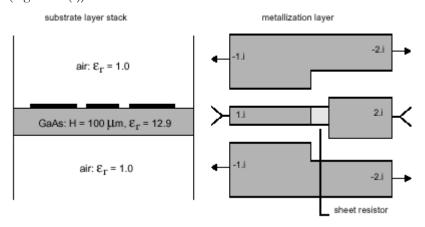


Figure 15. CPW step-in-width structure with ground references for the internal ports.

Limitations and Considerations

This section describes some software limitations and physical considerations which need to be taken into account when using Momentum:

- Matching the Simulation Mode to Circuit Characteristics
- Higher-order Modes and High Frequency Limitation
- Parallel Plate Modes
- Surface Wave Modes
- Slotline Structures and High Frequency Limitation
- Via Structures Limitation
- Via Structures and Substrate Thickness Limitation
- CPU Time and Memory Requirements

Matching the Simulation Mode to Circuit Characteristics

The RF mode can be used to simulate RF and microwave circuits, depending on your requirements. However, the RF mode is usually the more efficient mode when a circuit is electrically small, geometrically complex, and does not radiate. This section describes these characteristics.

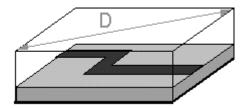
Radiation

RF mode provides accurate electromagnetic simulation performance at RF frequencies. However, this upper limit depends on the size of your physical design. At higher frequencies, as radiation effects increase, the accuracy of the RF mode models declines smoothly with increased frequency.

Similarly, if the substrate allows the propagation of surface waves (these are guided waves that propagate in the substrate layers) the accuracy of the RF mode will gradually decline because surface waves are not included in the RF calculation.

Electrically Small Circuits

RF mode works best for electrically small circuits as its accuracy smoothly decreases with increasing electrical size relative to a given frequency. A circuit is considered electrically small relative to a given frequency if its physical dimension is smaller than half the wavelength of the frequency. Depending on which value you know, maximum circuit dimension or maximum simulation frequency, you can determine a qualitative approximation of the circuit's electrical size. Suppose you have a circuit with dimension D as shown in the following figure:



For space wave radiation, you can use one of the following two expressions strictly as a guideline to have an awareness about the circuit's electrical size relative to the maximum frequency you plan to run the simulation. When you know the value of D, use the first expression to approximate the maximum frequency up to which the circuit is electrically small. When you know the maximum simulation frequency, use the second expression to approximate the maximum allowable dimension:

$$F < \frac{150}{D}$$

or

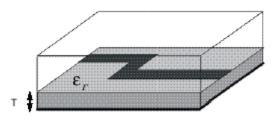
$$D < \frac{150}{F}$$

where:

D = the maximum length in mm diagonally across the circuit.

F = the maximum frequency in GHz.

The following expression provides a guideline up to which frequency the substrate is electrically small for surface wave radiation.



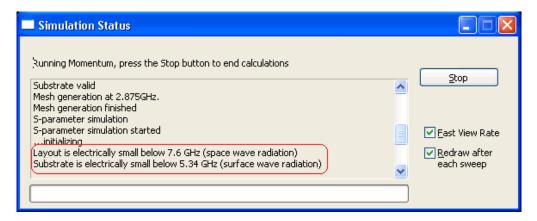
 $\alpha = 20$ (with groundplane)

 $\alpha = 10$ (without groundplane)

$$Thickness < \frac{WaveLength}{\alpha \sqrt{(\epsilon_r - 1)}}$$

$$Freq[_{GHZ}] < \frac{300}{\alpha \sqrt{(\varepsilon_r - 1)}} T_{mm}$$

During a simulation, RF mode calculates the maximum frequency up to which the circuit is considered electrically small, and displays that value in the status display. This is similar to using the expressions above since the dimension and thickness of a layout is typically fixed, and it is the simulation frequency that is swept.



Geometrically Complex Circuits

The mesh generated for a simulation establishes a geometric complexity for a circuit. A circuit is considered geometrically complex if its shape does not fit into a uniform, rectangular mesh, and the mesh generation produces a lot of triangles. Layouts containing shapes such as circles, arcs, and non-rectangular polygons usually result in meshes with many triangles. A measure of increasing geometric complexity is when the ratio of triangular cells to rectangular cells grows larger:

$$Complexity = \frac{Triangles}{Rectangles}$$

The mesh-reduction technology offered by RF mode and Microwave eliminates electromagnetically redundant rectangular and triangular cells. This reduces the time required to complete the simulation thus increasing efficiency. This mesh reduction algorithm can be turned on or off, using a toggle switch.

Higher-order Modes and High Frequency Limitation

Since Momentum does not account for higher-order modes in the calibration and deembedding process, the highest frequency for which the calibrated and de-embedded Sparameters are valid is determined by the cutoff frequency of the port transmission line higher-order modes. As a rule of thumb for microstrip transmission lines, the cutoff frequency (in GHz) for the first higher-order mode is approximately calculated by:

Cutoff frequency fc =
$$0.4 Z_0$$
 / height

where Z0 is the characteristic impedance of the transmission line. For a 10 mil alumina substrate with 50 ohm microstrip transmission line, we obtain a high frequency limit of approximately $f_c = 80 \text{ GHz}$.

Parallel Plate Modes

In the region between two infinite parallel plates or ground planes, parallel plate modes exist. Any current flowing in the circuit will excite all of these modes. How strong a mode

will be excited depends on how well the field generated by the current source matches with the field distribution of the parallel plate mode.

A distinction can be made between the fundamental mode and the higher order modes. The fundamental mode, which has no cut-off frequency, propagates at any frequency. The higher order modes do have a cut-off frequency. Below this frequency, they decay exponentially and only influence the local (reactive) field around the source. Above this frequency, they propagate as well and may take real energy away from the source.

Momentum takes the effect of the fundamental mode into account. The higher order modes are taken into account as long as they are well below cut-off. If this is not the case, a warning is issued saying that higher-order parallel plate modes were detected close to their cut-off frequency. Simulation results will start to degrade from then on.

The Effect of Parallel Plate Modes

Let's concentrate on the fundamental mode since this one is always present. The fundamental mode has its electric field predominantly aligned along the Z-axis from the top plate to the bottom plate. This means that this mode creates a difference in the potential between both plates. This mode can be excited by any current in your circuit: electric currents on a strip or via, magnetic currents on a slot. It behaves as a cylindrical wave that propagates to infinity where it feels a short circuit (since both plates are connected there). However, since infinity is very far away, no reflected wave ever comes back.

In a symmetric strip line structure, the current on the strip won't excite the fundamental mode due to this symmetry. However, the presence of a feature such as a slot in one of the plates creates an asymmetry. The slot will excite the fundamental mode!

The accuracy of the Momentum results for calibrated ports degrades when the parallel plate modes become important. For calibrated ports is assumed that they excite the circuit via the fundamental transmission line mode. However, this excitation is not pure. The source will excite the circuit via the parallel plate modes, too. This effect cannot be calibrated out, since those contributions are not orthogonal. The consequence is that the excitation doesn't correspond with a pure fundamental transmission line mode excitation.

Avoiding Parallel Plate Modes

Since we know the field orientation of the parallel plate modes, it is easy to understand that you can short circuit them by adding vias to your structure at those places where parallel plate modes will be excited.

Similar problems will exist with the measurements. Both plates must be connected explicitly with each other! This won't take place at infinity but somewhere at the side of the board. If no vias are used in the real structure, the fundamental mode may be excited. This mode will propagate to the borders and reflect. Thus, the real structure differs in that from the simulations where no reflection will be seen since a reflection only happens at infinity.

One way to counter the difference between measurements in reality and simulation is to take into account the package (box) around the structure. Another possibility is adding

vias to your structure, both in real life and in the simulations. Try to make the physical representation of your circuit as close as possible to reality. However, the actual shape of the via should not be that important. Small sheets can be used to represent the small circular vias that are realized in the real structure.

Surface Wave Modes

If the substrate is not closed (open or half open), and not homogeneous, surface wave modes can exist. The parallel plate mode can be seen as a special case of a surface wave mode. Their behavior is identical. Both are cylindrical waves that propagate radially away from the source. They are guided by the substrate. Both fundamental and higher order surface wave modes exist. Similar conclusions can be drawn with respect to limitations such as the effects of the modes.

Slotline Structures and High Frequency Limitation

The surface wave accuracy deterioration of the calibration process is somewhat more prominent for slotline transmission lines than for microstrip transmission lines. Therefore, slotline structures simulated with Momentum will exhibit a somewhat higher noise floor (10-20 dB higher) than microstrip structures. For best results, the highest simulation frequency for slotline structures should satisfy:

Substrate thickness < 0.15 * effective wavelength

Simulation of narrow slot lines are accurate at frequencies somewhat higher than the high frequency limit determined by this inequality, but wide slotlines will show deteriorated accuracy at this frequency limit.

Via Structures Limitation

In Momentum, the current flow on via structures is only allowed in the vertical direction; horizontal or circulating currents are not modeled. As via structures are metallization patterns, the modeling of metallization losses in via's is identical to the modeling of metallization loss in microstrip and slotline structures.

Via Structures and Substrate Thickness Limitation

The vertical electrical currents on via structures are modeled with rooftop basis functions. In this modeling, the vertical via structure is treated as one cell. This places an upper limit to the substrate layer thickness as the cell dimensions should not exceed 1/20 of a wavelength for accurate simulation results. Momentum simulations with via structures passing through electrically thick substrate layers will become less accurate at higher frequencies. By splitting the thick substrate layer into more than one layer, more via-cells are created and a more accurate solution is obtained.

CPU Time and Memory Requirements

Both CPU time and memory needed for a Momentum simulation increase with the complexity of the circuit and the density of the mesh. The size N of the interaction matrix

equation is equal to the number of edges in the mesh. For calibrated ports, the number of unknowns is increased with the edges in the feedlines added to the transmission line ports.

CPU Time

The CPU time requirements for a Momentum simulation can be expressed as:

CPU time =
$$A + B N + C N^2 + D N^3$$

where:

N = number of unknowns

A, B, C, D = constants independent of N

The constant term A accounts for the simulation set up time. The meshing of the structure is responsible for the linear term, BN. The loading of the interaction matrix is responsible for the quadratic term and the solving of the matrix equation accounts for:

- part of the quadratic term (when using the iterative solver)
- the cubic term (when using the direct solver)

It is difficult to predict the value of the constants A, B, C and D, because they depend on the problem at hand.

Memory Usage

The memory requirement for a Momentum simulation can be expressed as:

$$Memory = X + Y N + Z N^2$$

where

N = number of unknowns

X, Y, Z constants independent of N

Like with the CPU time expression, the constants X, Y and Z are difficult to predict for any given structure.

For medium to large size problems, the quadratic term, which accounts for storing of the interaction matrix, always dominates the overall memory requirement. For small structures, memory usage can also be dependent upon the substrate. The substrate database must be read and interpolated, which requires a certain amount of memory. Algorithms to make trade-off between time and memory resources are implemented in the simulator. These algorithms result in additional usage above that required to solve the matrix. Total memory consumption is typically less than 1.5 times what is required to store the matrix, for large matrices.

References

1. R. F. Harrington, Field Computation by Moment Methods. Maxillan, New York (1968).

Chapter 9: Sonnet Interface

Design Flow

Sonnet Flow Overview

The normal steps in the Sonnet interface flow are as follows:

- 1. Create a layout for electromagnetic analysis.
- 2. Create a Sonnet analysis.
- 3. Recalculate the Sonnet analysis. GENESYS does the following:
 - a. Translate the Layout into a Sonnet (.son) file, storing it in the workspace.
 - b. Write out the following directory structure and files in the same directory that the GENESYS workspace is stored, assuming that the GENESYS file is "WorkSpace.wsp" and the Sonnet analysis is "Sonnet1":
 - i. WorkSpace_Sonnet1 (Directory)
 - ii. WorkSpace_Sonnet\Sonnet1\Genesys.son (Sonnet geometry file)
 - iii. WorkSpace_Sonnet\Sonnet1\SonData\Genesys (Directory)
 - c. Runs Sonnet. The Sonnet file contains a "FILEOUT" directive instructing Sonnet to write out Y-Parameter data to WorkSpace_Sonnet\Sonnet\Genesys.yp.
 - d. Reads WorkSpace_Sonnet\Sonnet1\Genesys.yp and stores it in the workspace.
 - e. Creates results containing WorkSpace_Sonnet\Sonnet1\Genesys.yp plus any lumped elements on the layout.
- 4. Add the Sonnet results to a graph.
- 5. If any changes to the layout or Sonnet setup are made, the recalculation (step 3) is done again. However, before the recalculation step, the user has the option to delete the existing simulation data. See the Deleting Internal Simulation Data section for details.

Deleting Internal Simulation Data

When GENESYS detects a change to the layout or to the Sonnet simulation options, the user is offered a choice to delete the existing simulation data. Additionally, the user can

right-click the Sonnet simulation on the Workspace Window and select "Delete Internal Simulation Data". This does the following:

- Deletes all data stored inside the workspace, including the Genesys.son (Sonnet file) and Genesys.yp (simulation results) files.
- 2. The next time Sonnet is run, the "WorkSpace_Sonnet\Sonnet1\SonData\Genesys" directory will be emptied. This clears all of Sonnet's previously stored simulation results.

GENESYS cooperates with the Sonnet caching mechanisms, giving several benefits:

- Sonnet will check the simulation data for consistency before running
- If more frequency points are added, the previously calculated points do not need to be recalculated.

As a side effect of this cooperation, it is possible that Sonnet will see a change in the geometry and refuse to calculate. If this happens, simply right-click the Sonnet simulation on the Workspace Window and select "Delete Internal Simulation Data".

Manual Mode

In addition to the normal design flow described above, "Manual Mode" design flow is available. Manual Mode should only be used if you need to use a Sonnet feature not available through the GENESYS interface. Before attempting to use Manual Mode you should be very familiar with the operation of Sonnet. The design flow in Manual Mode is as follows:

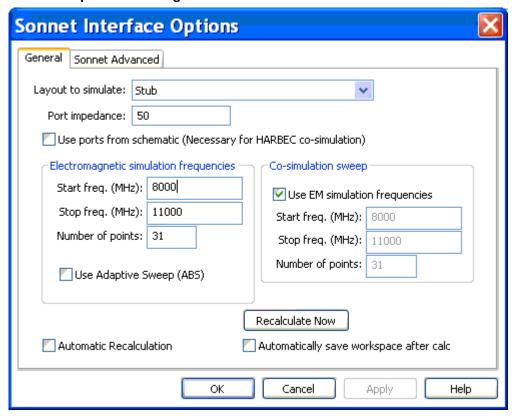
- 1. Create a layout for electromagnetic analysis. In this step, you must at least place EMPOWER ports down on the layout, as GENESYS counts these ports to determine how many ports to expect in the Y-Parameter data.
- 2. Create a Sonnet analysis.
- 3. If desired, recalculate the Sonnet analysis using the normal flow mode.
- Right-click the Sonnet simulation on the Workspace Window and select "Manual Mode".
- 5. Right-click the Sonnet simulation on the Workspace Window and select "Manual Mode: Create Sonnet Files and Export to Disk". This step exports the Genesys.son and Genesys.yp files to the WorkSpace_Sonnet\Sonnet1 directory after optionally recreating the Genesys.son file from the current layout.
- 6. Right-click the Sonnet simulation on the Workspace Window and select "Manual Mode: Edit in Sonnet Native Editor". Make any desired changes to the Sonnet file. The following restrictions apply:
 - a. Do not change the number of ports in the Sonnet file unless you also change the number of ports on the Layout.
 - Do not change the configuration of ports used for lumped elements, otherwise the results could be incorrect.

- c. Do not remove the Genesys.yp file output. However, you may change the Touchstone format options of this file.
- d. If you save the Sonnet file to a new name or location, GENESYS will not be able to read it back. If you want to do this, you can read the data back into GENESYS by creating a link to the resultant Y-Parameter data file.
- 7. While in the Sonnet editor, save and analyze your file.
- Right-click the Sonnet simulation on the Workspace Window and select "Manual Mode: Load Calculation Results into GENESYS". This loads the Genesys.son and Genesys.yp files into the GENESYS workspace and updates all output graphs.
- 9. If additional changes to the simulation are desired, repeat steps 6 and 7.

In Manual Mode, your updated Genesys.son file is saved back into the workspace (step 8 above), eliminating the need to store the Sonnet file separately. Passing this file to coworkers will allow them to export, edit, analyze, and update your modified Sonnet file.

Translation Details

Sonnet Options Dialog Box



General Tab

Layout to Simulate - Allows you to select which layout in the current workspace to simulate. Since workspaces can have multiple layouts and multiple simulations, you can simulate many different layouts within the same workspace.

Port Impedance - When Sonnet results are plotted on a graph, it will be normalized to this impedance. Different impedances can be used for each port by separating impedances with commas. A 1-Port Device Data File can be used in place of any impedance file to specify frequency dependent or complex port impedances.

Note: This impedance is not used in Sonnet, so any viewer data generated defaults to 50 ohms. You must change the port impedance inside the Sonnet current viewer for non-50 ohm ports.

Use ports from schematic - Check this box when co-simulating with HARBEC harmonic balance nonlinear simulation. This forces all sources and impedances to be considered in the simulation.

Note: Be sure to check "Use ports from schematic" if you will be using this simulation as the basis for a HARBEC Simulation, otherwise there will be no nonlinear sources available.

Electromagnetic Simulation Frequencies - Specifies the frequencies at which to run Sonnet If you have lumped elements in your simulation, you can often turn down the number of frequencies here and increase the number of frequencies in the Co-simulation sweep specified below.

Start Freq (MHz) - Specifies the minimum frequency to analyze.

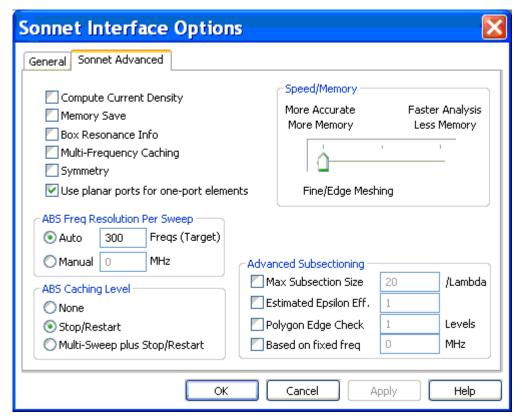
Stop Freq (MHz) - Specifies the maximum frequency to analyze.

Number of Points - Specifies the number of frequency points to analyze. Points are distributed linearly between the low and high freq specified above. For an ABS sweep, this number of points is used on the GENESYS graphs unless a different Cosimulation sweep is specified.

Use Adaptive Sweep (ABS) - Turns on Sonnet's Adaptive Sweep simulation. If this box is checked, the Number of Points entry above is not sent to Sonnet.

Co-Simulation Sweep - Specifies the frequencies at which to run simulate the lumped elements + Sonnet data combination. If you have no lumped elements in your simulation, you should normally check the "Use EM Simulation Frequencies" box. For circuits with lumped elements, you can often save much time by using fewer points in the electromagnetic simulation frequencies above, allowing the co-simulation to interpolate the Sonnet data *before* the lumped elements are added.

Automatically save workspace after calc - This checkbox is handy for overnight runs to help protect against a power outage. Note that checking this box will force the *entire* workspace to be saved after each run.



The Advanced tab allows you to customize advanced Sonnet options. For more details on these options, please consult your Sonnet reference manuals.

Use planar ports for one-port elements - This box should almost always be checked. When not checked, EMPOWER uses z-directed ports at each terminal for all devices. When it is checked, EMPOWER uses in-line ports for elements like resistors and capacitors (two-terminal, one-port devices). The only time this can cause a problem is when you have a line running "under" an element (for example, running a line between the two terminals on a resistor, in the same metal layer as the resistor pads).

Note: EMPOWER planar ports cannot be used for ground referenced elements, such as transmission lines, even though the element might only have terminals.

Sonnet features supported in GENESYS

- Last modify date Current date is always written
- Unit Setup Always output in MHz and mm. In manual mode, these units can be switched in Sonnet for easier editing.
- **Reference planes** Shifted inside the box only

- Top and Bottom Cover Waveguide load, free space, normal, resistive.
- **Metal Types** Normal, Resistor, TMM.
- Box Setup Dimensions and cell count come from layout Box Settings.
- Ports Standard, via, and ungrounded-internal ports. Layout X and Y directed ports turn into ungrounded-internal ports.
- Symmetry
- **Polygons** All entities on the layout (including text and pours) are supported.
- Via Polygons Supported both by drawing viaholes and by specifying XYZ or Z directed current for a layer

Frequency setup

- Both Adaptive Sweep (ABS) and standard sweeps (number of points) are supported.
- ABS Caching Level, Target for Manual Frequency Resolution for ABS Sweep, and Target for Automatic Frequency Resolution for ABS Sweep are supported.

• Simulation Options

- De-embedding
- Generate current density
- Box Resonance Info
- Memory Saver
- Multi-Frequency Caching
- Speed/memory/accuracy tradeoff
- Subsections per lambda
- Estimated Epsilon Effective
- Maximum Subsectioning Frequency
- Polygon Edge Checking.
- **Response file entry** Always outputs GENESYS.yp file.
- **Quick Start Guide Info** Outputs info about tasks completed by Sonnet Interface.

Sonnet features not supported in GENESYS Interface

Category 1 – Sonnet features directly affecting frequencies, geometry and subsectioning

- Auto-Grounded ports and their reference plane shifts
- Polygons Descriptions
 - Diagonal and conformal fill types (always staircase)
 - Min/Max subsection size (xmin,xmax,ymin,ymax)
 - Conformal mesh subsection maximum length
 - Edge mesh setting (always on)
- Geometry Subdividers
- Parallel Subsections
- Metal Types and Features
 - Current ratio
 - Rdc/Rrf type
 - General Metal (rdc, rrf, xdc, ls)
 - Sense metal
 - NumSheets is always set to 2 for thick metal
- Brick polygons and their dielectric materials
- Magnetic loss in a dielectric
- Z-Parts parameter for dielectric layers is always set to 2 from GENESYS
- All advanced & multiple frequencies sweeps are not supported
 - Exponential sweep
 - External file for frequencies
 - Find maximum and minimum frequency response
- Response file formats (eg, Databank, Scompact, Excel CSV)
- SPICE netlist generation
- Ports with negative and/or duplicate numbers (Push/Pull, etc.)

Category 2 – Features available in GENESYS other ways

- Port impedances in Sonnet file: Viewer data defaults to 50 ohms in Sonnet.
- Geometry parameters
- Optimization
- Parameter Sweep

Category 3 - Cosmetic Sonnet features which do not directly affect simulation

- Edge Vias (use regular viaholes or Z-directed polygon layers instead)
- Medium and High importance file change dates
- Comments in file
- Polygon snap for reference planes
- Metal pattern ID selection
- Sweep with step size (use number of points instead)
- Dimensions on the geometry

EMPOWER features not supported by the Sonnet Interface

The following EMPOWER features are not supported by the Sonnet Interface:

- Surface Roughness for metal
- Slot mode layers
- Magnetic cover
- Multi-mode ports and the multi-mode transmission line circuit model
- X-only and Y-only current direction (XYZ and Z directions are supported.)
- Thick metal going down
- Thick metal model for lossless metal or resistive films
- Line direction (determined automatically from touching polygon)
- Different reference plane shifts on the same sidewall
- Negative reference plane shifts (reference planes outside the box)
- Using specific HARBEC simulation frequencies (HARBEC co-simulation is otherwise fully supported).
- Mixing standard and no-deembed ports on the same layout
- Component pads will not use the Current Direction setting for the layer and are
 always output using XY currents. In other words, component pads on XYZ or Z
 layers will be output with the standard XY Current Direction. Pads manually
 placed (not part of a component) still respect the direction setting. Note that
 this behavior is different from EMPOWER where component pads also respect
 the current direction setting.

Tutorial

Introduction

The Genesys-Sonnet interface has been created to allow Eagleware and Sonnet's mutual customers to have an easy to use interface between GENESYS and Sonnet. Most common Sonnet features are supported directly by this interface. Additionally, a manual editing mode is available which allows access to all Sonnet features while maintaining connectivity with GENESYS. An added advantage to Eagleware's interface is direct lumped element support, just as in Eagleware's EMPOWER simulator.

Before using this interface, Sonnet Version 9.52 or later must be installed on your computer. This interface hides most of the Sonnet details and an in-depth knowledge of Sonnet is not required. However, we still recommend that you follow through the "Sonnet Tutorial" manual before attempting to use the Sonnet interface.

Creating a Layout Without a Schematic

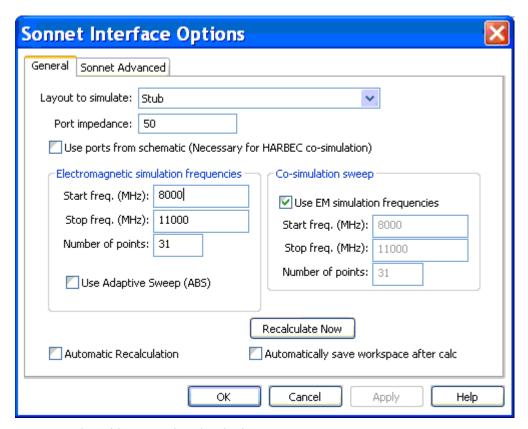
To create a layout for Sonnet you must follow essentially the same steps as when you create a layout for EMPOWER. In this tutorial, we will use the same stub example used in the EMPOWER tutorial. To create this layout, follow these sections in the EMPOWER Operation chapter:

- Creating a Layout Without a Schematic
- Box & Grid Settings
- General Layers
- EMPOWER Layers
- Drawing the Layout
- Centering the Layout
- Placing EMPOWER Ports

If you have already created this layout and simulated it with EMPOWER, you may use your existing file. If you do not want to create this layout yourself, you can load the file from "LayoutOnly.wsp" in the root of the examples directory.

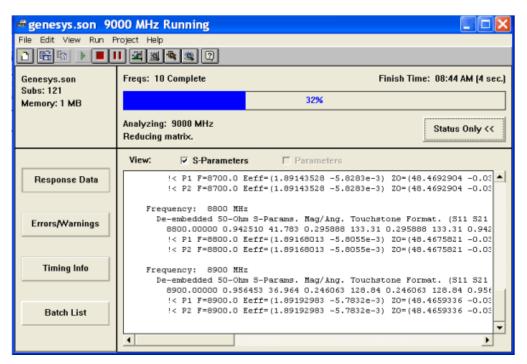
Simulating the Layout

To run Sonnet, you must create a simulation. Click on the "Create New" icon in the Workspace Window and select Analysis/Add Sonnet Simulation. Accept "Sonnet1" as the analysis name. The Sonnet Options dialog will be displayed as shown below. For a description of the dialog options, see the details in the Sonnet Translation chapter. For now, *just set the prompts as shown below.*



We are starting with 31 sample points in the range 8-11 GHz.

Click the "Recalculate Now" button. This launches Sonnet to simulate the layout. While Sonnet is calculating, a window similar to the one in below will be shown. This window shows the current status throughout the calculation mode. For more details on this window, see your Sonnet manuals.



While Sonnet is running, GENESYS will also display the simulation status window indicating the Sonnet is running. When Sonnet is finished calculating, GENESYS will automatically load the simulation results and update the screen.

Viewing Results

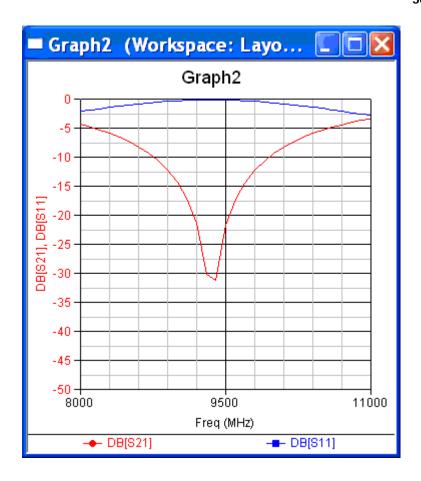
After Sonnet simulation of the layout, the data must be displayed in GENESYS. This is done by creating a Data Output such as a Rectangular Graph.

To create a rectangular graph in this workspace:

- 1. Click on the "Create New" icon in the Workspace Window and select Output/Add Rectangular Graph from the menu. Accept the default name "Graph2".
- 2. **Very Important:** Select Sonnet.Stub for "Default Simulation/Data or Equations".
- 3. Enter S21 for the first measurement and S11 for the second measurement.

Note: You can also use the Measurement Wizard to select simulation results.

This instructs GENESYS to display a window with S21 and S11 from the Sonnet Simulation as shown below. (For a complete description of rectangular graphs, see the GENESYS User's Guide.)



Using the Current and Far Field Viewers

Once the Sonnet run is completed, the current viewer can be used if "Generate Viewer Data" was selected in the Sonnet options dialog. Generating this data slows the simulation, so it's usually only checked during last-run simulations.

Note: The viewer will NOT include the effects of lumped elements.

Right-Click the Sonnet simulation in the Workspace Window and select "Run Sonnet Current Viewer" or "Run Sonnet Far Field Viewer". For more details on using these viewers, see your Sonnet manuals.

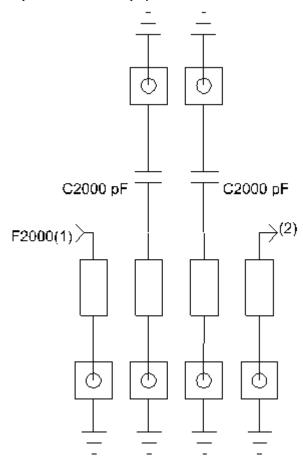
Creating a Layout From an Existing Schematic

The file used in this example is Filters\Tuned Bandpass.wsp. This circuit is a tunable bandpass filter. This example demonstrates the following topics:

- Creating a layout from an existing schematic
- "Tuning" with Sonnet data
- Using lumped elements with Sonnet

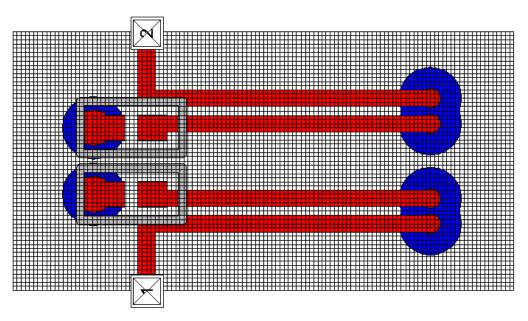
Note: This is the same circuit as was used in the EMPOWER tutorial.

In GENESYS, select Open Example from the File menu. Then, select "Tuned Bandpass.wsp" from the Filters directory. Double-Click F2000 under Designs in the Workspace Window to display the schematic for this filter (shown below).



This is the schematic of a 2nd order microstrip combline bandpass filter with 50 Ohm terminations and transformer coupling on the input and output. The lumped capacitors are gang-tuned to adjust the resonant frequency of the two center lines. Tuning in this manner affects only the center frequency, and keeps the passband bandwidth constant.

Double-Click Layout1 under Designs in the Workspace Window to display the layout for this schematic. The layout for this example is shown below.



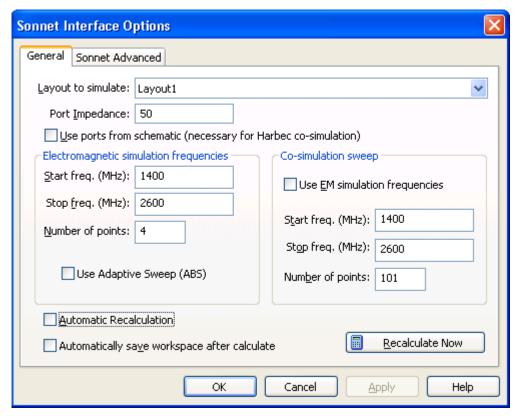
A 0402 Chip Capacitor footprint has been used for each of the lumped capacitors. Whenever a lumped element is used for an Sonnet run, GENESYS creates an internal ports for the element. These ports are placed:

- If "Use Planar Ports for two-port elements" is checked in the EMPOWER
 properties box, one port is created for 2-terminal elements (like resistors or
 capacitors) which are aligned horizontally or vertically.
- In all other cases, an internal via port is used for each terminal of the element. This port is placed at the center of the pad footprint, and EMPOWER writes data for each port created, whether internal or external.
- The "1" and "2" ports pictured in the figure above are examples of external ports.

This is a powerful technique, since real time tuning can be employed in GENESYS once the EMPOWER data for has been calculated.

Simulating the Layout with Lumped Elements

This workspace has an EMPOWER simulation but does not contain a Sonnet Simulation, so we will add one now. Click on the "Create New" icon in the Workspace Window and select Analysis/Add Sonnet Simulation. Accept "Sonnet1" as the analysis name. The Sonnet Options dialog will be displayed as shown below. For a description of the dialog options, see the details in the Sonnet Translation chapter. For now, *just set the prompts as shown below.*

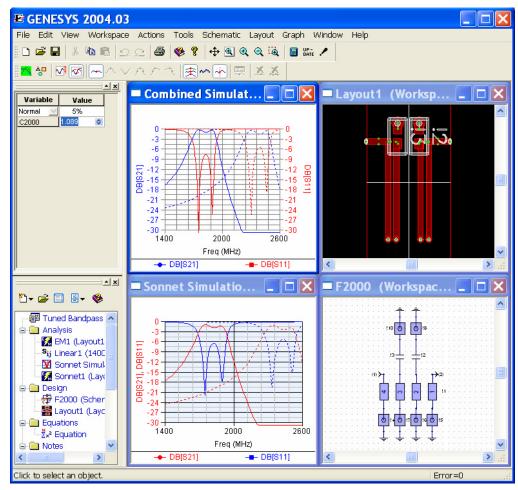


Click the Recalculate Now button. This launches Sonnet to simulate the layout.

Note: GENESYS has been given a lot of intelligence to determine when it needs to calculate. Clicking Recalculate Now will not do anything if GENESYS believes it is up to date. To force GENESYS to recalculate from scratch, right-click on the Sonnet simulation in the workspace window and select "Delete all internal files".

Once EMPOWER calculation is completed, you can display the calculated data:

Add a rectangular graph called "Sonnet Simulation" and change the Default Simulation to "Sonnet1.Layout1." Add S21 and S11 to the graph. The graphs below show GENESYS after Sonnet simulation. Note that the Sonnet simulation will be slightly different from the EMPOWER simulation which was previously displayed, mainly because EMPOWER was run without losses in this example.



The information in the EMPOWER Operation chapter on Lumped Elements and Real-Time Tuning also apply to Sonnet Simulations, so you should review those sections now.

Viewing the Geometry in the Sonnet Native Editor

Note: This command is only available when Manual Mode is off.

When using a Sonnet simulation, you may want to preview memory usage and subsectioning before running a simulation. To do this, right-click the Sonnet simulation in the Workspace Window and select "View in Sonnet Native Editor." This will bring up the native Sonnet geometry editor.

To estimate memory, select "Estimate Memory..." from the Analysis menu. To view subsectioning, press "View Subsections..." after selecting "Estimate Memory...".

Simulation

Note: Any changes you make will not be saved into the GENESYS workspace and may be overwritten at any time. If you need to make changes to the Sonnet geometry file, you should first switch to Manual Mode.

Spectral Propagation and Root Cause Analysis (SPARCA)

A new simulation technique has been created to simulate RF architecture. This technique is called Spectral Propagation and Root Cause Analysis. Every source spectrum at every node propagates both forward and backward to every node in the schematic. Along the way they create noise, intermods, harmonics, and phase noise and these spectrums propagate to every node in the schematic. These spectrums contain spectral density information so the effects of bandwidth are automatically accounted for. As spectrums propagate through the system spectral genealogy is maintained providing users with the ability to identify the propagation path of every spectrum. Furthermore, this parentage information also includes coherency identification, desired or undesired status, and the frequency equation associated with the given spectrum. Click here for more information on spectral identification. This simulation technique is extremely fast compared to other traditional non-linear simulation techniques such as harmonic balance that requires convergences criteria and mathematical inversions of large matrices to achieve simulation solutions.

Users specify arbitrary paths through a single block diagram to gather cascaded information along a given path. Each path contains several types of paths such as desired, total, noise, phase noise, etc. Each spectrum along the designated path will be placed in the appropriate path category. Measurements operate on specific path types to create desired affects. For example, the channel noise power measurement excludes all signal, intermods and harmonics, and phase noise spectrums from its path spectrums giving the user only noise within the channel regardless of whether or not a much stronger signal is located at the same frequency. This is a huge advantage allowing the user to see and measure true in-channel signal to noise ratio.

SPARCA Simulation advantages:

- Fast simulation speed
- Identification of every spectrum
- Signals can be seen underneath other signals
- True in-channel signal to noise ratio measurements
- Spectral directionality
- Bandwidths for all spectrums
- Broadband noise
- Phase noise
- Path VSWR effects

Simulation

- Multiple path analysis for single block diagram
- Restrictive assumptions from traditional cascaded equations are removed
- Flexibility for future growth

Getting Started

Spectrasys Walkthrough Overview

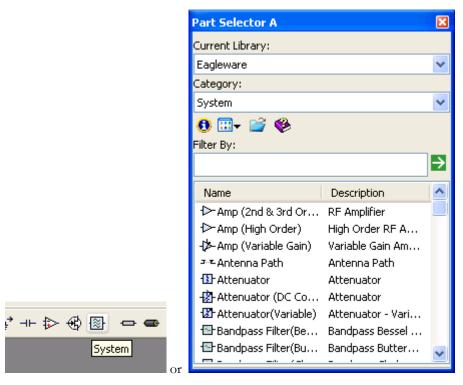
Spectrasys uses a new simulation technique called SPARCA that brings RF architecture design to a whole new level. This walkthrough will help you design a simple RF chain and measure the architectures noise and gain performance.

The **basic steps** to analyze an RF system is:

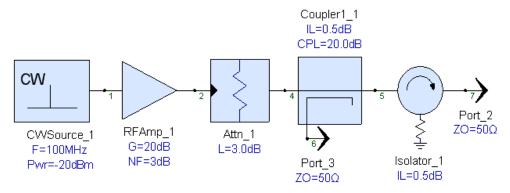
- 1. Create a schematic
- 2. Add a system analysis
- 3. Run the simulation
- 4. Add a graph or table

Create a System Schematic

Spectrasys supports all linear models and behavioral non-linear models. The behavioral models can be found on the system toolbar or in the part selector.



Create the following system schematic (default parameters for all models will be used). For additional help creating a schematic click here.



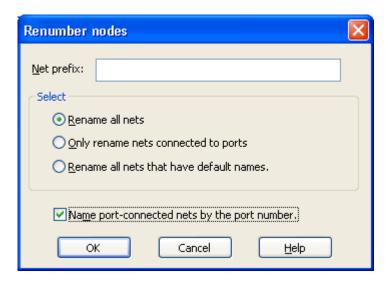
- 1. Select the 'RF Amplifier 2nd 3rd Order' from the system toolbar or part selector.
- 2. Move the cursor and click inside the schematic window to place the part.
- 3. Use the prior steps to place a fixed **attenuator**, **single directional coupler**, and **isolator**.

- 4. Place a **CW** source at the input.
- 5. Place a **output port** on the output of the isolator and the coupler. (*HINT: Press the "O" key on the keyboard to place an output port*)
- 6. Make sure each element output is wired to the subsequent element input.

HINT: Use the 'F4' key when a part is highlighted to repeatedly move the part text to default locations around the part.

Note: The node numbers seen on your schematic may vary due to the order of the parts placed on the schematic.

To 'Renumber Nodes...' select the schematic then select 'Renumber Nodes...' from the 'Schematic' menu. The following dialog box will appear:



Select the desired options and click 'OK'.

Back to "Overview"

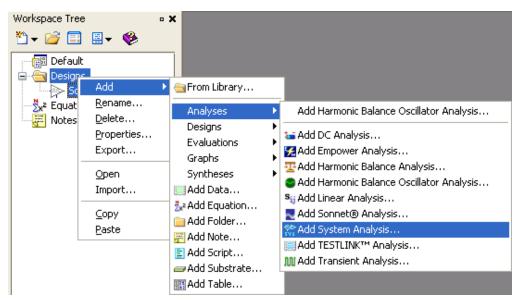
Next to "Add a System Analysis"

Add a System Analysis

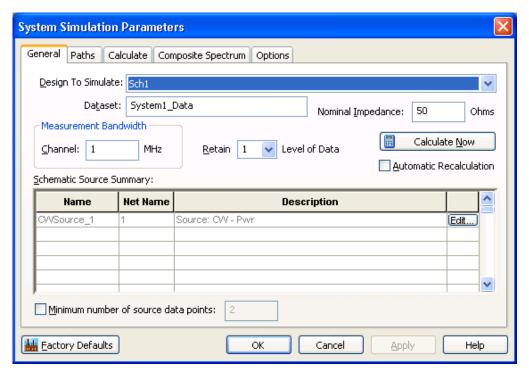
After creating a schematic a system analysis must be created. There a several ways to accomplish this. Only one way will be shown here. For additional information on adding analyses click here.

To add a system analysis:

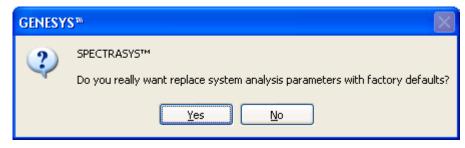
1. **Right click** on a **folder** in the **workspace tree** where you wan the analysis located.



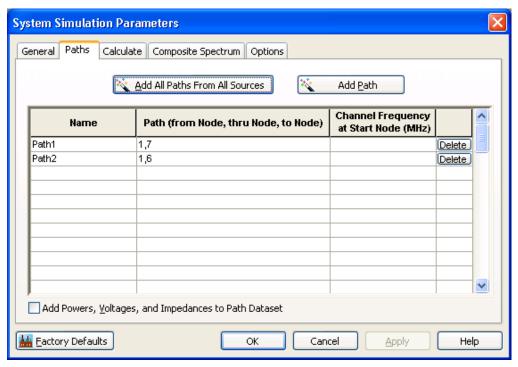
- 2. Select 'Add System Analysis...' from the selected submenus as shown above.
- 3. The following 'System Analysis' dialog box will appear.



- 4. Click the **'Factory Defaults'** button to initialize the dialog box to a known condition.
- 5. Click 'Yes' on 'Factory Defaults' dialog box



6. If path measurements are desired (i.e. cascaded gain or cascaded noise figure) click on the 'Paths' tab.



- 7. Click the 'Add All Paths From All Sources' button. Two paths should appear as shown above. NOTE: Node numbers may be different than shown above depending on the node numbers in your schematic. For additional information on specifying paths click here.
- 8. Click the dialog '**OK**' button.

Back to "Create a System Schematic"

Next to "Run the Simulation"

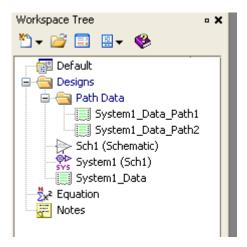
Run the Simulation

Analysis data must be created before it can be plotted or displayed in tables. The analysis can be enabled to 'Automatically Recalculate' or may need to be manually calculated.

If the analysis has been set to 'Automatically Recalculate' datasets will appear in the workspace tree after the analysis.

If manual calculation is needed the calculate button () will appear red and so will other items on the workspace tree. Click the calculate button to update the system analysis and create the necessary datasests.

After calculation the workspace tree should look like:



For more information on datasets click here.

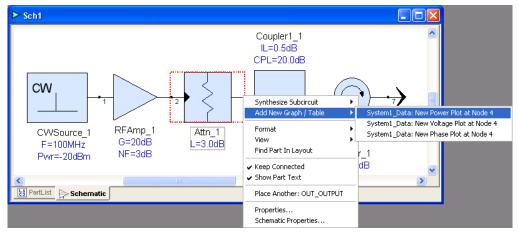
Back to "Add a System Analysis"

Next to "Add a Graph or Table"

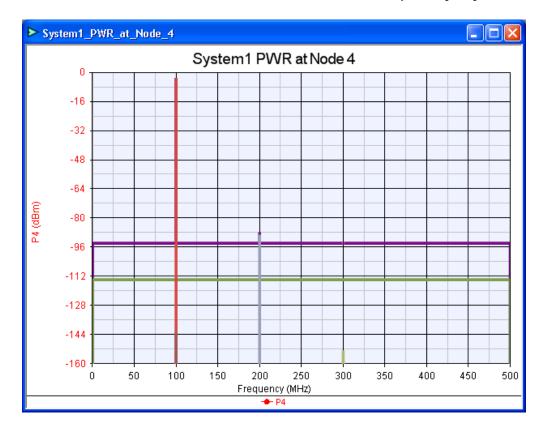
Add a Graph or Table

There are several ways to display data in GENESYS. Only one way will be demonstrated here. For additional information on graphs click here.

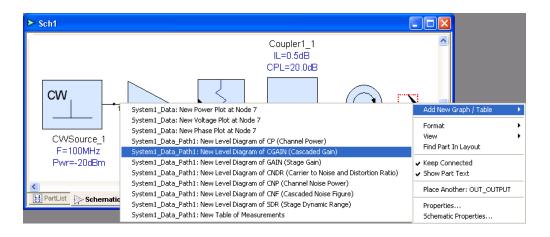
The easiest way to add a **spectral power**, **phase**, or **voltage plot** in Spectrasys is by right clicking the node to be viewed and selecting 'System1_Data: New Power Plot at Node **x'** from the submenu 'Add New Graph/Table'. (The output of the attenuator was selected in the following figure)



The following graph will appear:



To add a **level diagram** (a path number be defined first) **right click on the ending node** of the path and selecting 'System1_Data_Path1: New Level Diagram of CGAIN (Cascaded Gain)' from the 'Add New Graph / Table' submenu.



The following level diagram will appear:



Follow the same process as adding a level diagram to **add** a predefined **table** of common measurements except select 'System1_Data_Path1: New Table of Measurements' from the 'Add New Graph / Table' submenu. For additional path measurement information click here.

The default table will look like:



HINT: Right click on the table data to see additional table options.

Back to "Run the Simulation"

Fundamentals

General Behavioral Model Overview

Behavioral models are unique in Spectrasys. Because of the unique simulation technique that is used, Spectral Propagation and Root Cause Analysis (SPARCA), behaviors for different types of spectrums can be modeled. SPARCA supports the following types of spectrums:

- Signal
- Intermods and Harmonics
- Broadband Noise
- Phase Noise

The SPARCA simulation technique is so flexible that additional spectrum types can be added to support future needs.

Each model manages its behavior with respect these spectrum types. Furthermore, SPARCA knows which directions signals are flowing and which signals are desired or not. Every pin on a behavioral models serves both as an input and output pin. Each pin treats its input spectrum with the behavior appropriate to that pin and spectrum type.

Linear models (resistors, capacitors, transmission lines, etc) use a Y-matrix to determine the input to output transfer function for each spectrum. For linear models the same input to output transfer function is applied to all spectrum types.

Non-linear models (amplifier, multipliers, mixers, etc) use a Y-matrix that is dependent on non-linear parameters such as P1dB, PSAT, IP3, and IP2. Non-linear parameters are used to create the behavior associated with the given model, input pin, output pin, and spectrum type.

Since a Y-matrix is used for calculations VSWR effects along a path and at the schematic nodes is automatically accounted for.

Sources

Sources must be placed in the schematic and connected to the device under test before a system analysis can produce any useful data.

NOTE: Thermal noise is automatically added to the system analysis.

For specific source information of Element Catalog click the following links.

MultiSource

CW Source

Simulation

CW Source with Phase Noise

Wideband Source

Multicarrier Source

Intermod Source

Intermod Source (Receiver)

Continuous Frequency Source

Noise Source

Channels

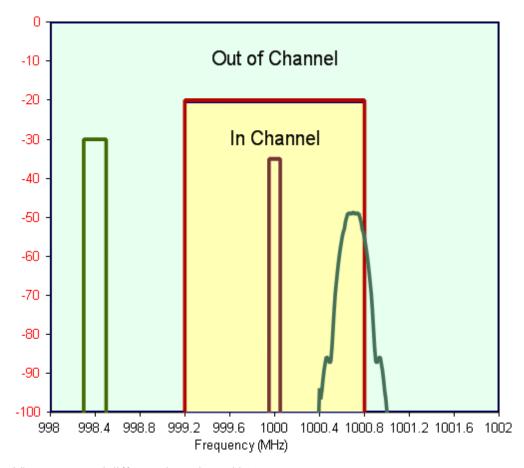
All measurements in Spectrasys are based on a channel.

Channels consist of:

- 1. Center Frequency
- 2. Bandwidth

Channel Example

The channel center frequency is 1000 MHz with a bandwidth of 1.6 MHz (999.2 to 1000.8 MHz). Only the spectrums located in the yellow region will be integrated by the channel measurements.



There are several different channels used in Spectrasys:

- 1. **Main** Channel of the Path
- 2. Offset Channel
- 3. **Interferer** Channel
- 4. Adjacent Channel
- 5. 1st Mixer Image Channel

NOTE: The bandwidth for **ALL** channels except the Offset Channel is the 'Channel Measurement Bandwidth'.

Main Channel of the Path - Most of the measurements are based on this channel. Each new path can have a new center frequency however the bandwidth for all paths will be identical.

Offset Channel - This is a user defined channel. This channel is specified as an offset from the main channel of the path. Click here for additional information on specifying this channel.

Simulation

Interferer Channel - This channel is used to determine input and output intercept points of a path. This channel frequency is specified as an absolute value. Click here for additional information on specifying this channel.

Adjacent Channel - This channel is adjacent to the main channel of the path. It is provided as a convenience to the user.

1st Mixer Image Channel - This channel is used to make image measurements of the first mixer.

NOTE: For measurements that require a channel only spectrum falling within the channel will be integrated. If the path center frequency is set incorrectly or the bandwidth is set too large or small measurement values may be different than expected. Mathematical integration is used and is precise. If a spectrum is split by the channel bandwidth then only that portion of the spectrum that falls within the channel will be measured. Of course, spectrum plots will show all spectrum regardless of whether they are in the channel or not.

Channel Bandwidth Caution: When the Channel Frequency is less than 1/2 the Channel Bandwidth the lowest integration frequency used for measurements will be 0 Hz. This will result is Channel Noise Power measurements being different than when the full bandwidth is used.

Specifying Paths

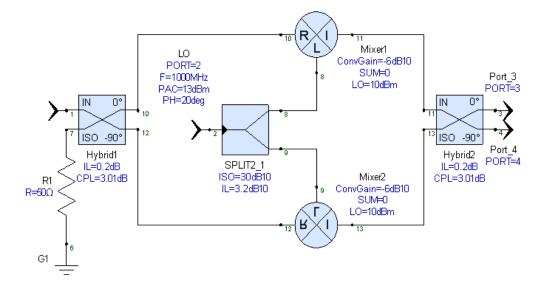
Spectrasys supports multiple paths through arbitrary architectures. Paths are not restricted to traditional 2 port cascaded lineups.

A path consists of:

- 1. Name
- 2. Beginning Node
- 3. Ending Node
- 4. Frequency

Spectrasys will find the shortest path between the specified nodes. If the user would like to select an alternate path then a **'thru node'** can be added to the path to uniquely identify the path. Through nodes can added until the path is uniquely identified.

For example,



Click here for path dialog box information.

Level Diagrams

Background

A level diagram can display measurements of cascaded stages along a user defined path. Each horizontal division of the X axis of the graph represents a stage along the path. The first division represents the input to the cascade and the last division represents the output of the cascade. Each vertical division is at the interface between the two stages. The value of the measurements are displayed on the vertical axis.

Level diagrams give the user a quick visual indication of the performance of the entire cascade. Node numbers are placed on the horizontal axis to show the node sequence of the path. Furthermore, schematic symbols are extracted from the schematic and placed at the bottom of the level diagram.

Sample Level Diagram:



Adding a Level Diagram

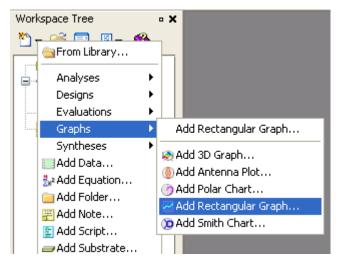
Level diagrams can be added to the workspace in many different ways.

Common Level Diagrams:

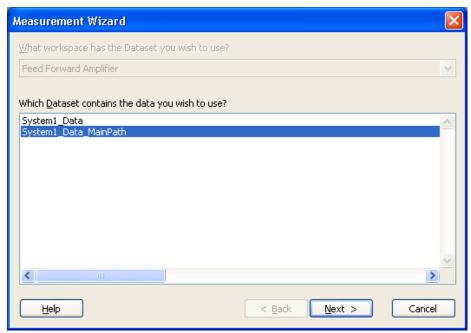
Click here for instructions on adding common level diagrams.

Manually Adding a Level Diagram:

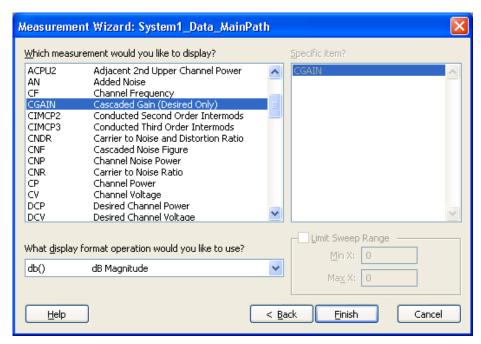
1. Click the New Item button () on the Workspace Tree toolbar and select "Add Rectangular Graph" from the Graph menu.



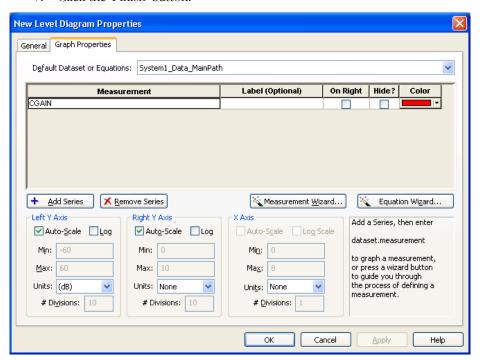
- 2. Click the 'Graph Properties' tab.
- 3. Click the Measurement Wizard button (Measurement Wizard...)
- 4. Select the desired path data set.



- 5. Click the 'Next' button.
- 6. Select the desired path measurement.



7. Click the 'Finish' button.



Click here for additional information on graphs.

Getting the most out of a Level Diagrams

- Use the **right Y axis** to examine additional path measurements.
- Change stage parameters directly from the level diagram by double clicking the part at the bottom of the level diagram.
- Use the mouse wheel to **zoom** in an out when the path contains many stages.
- The X axis range can be set manually by the user. NOTE: Indexes are used in this case NOT node numbers. Index '0' is the first node along the path.

HINT: Use tables not level diagrams when troubleshooting problems. More parameters can be examined at the same time with tables than level diagrams. Checking channel frequencies and power levels are very important during the troubleshooting process.

Spectrum Plots and Tables

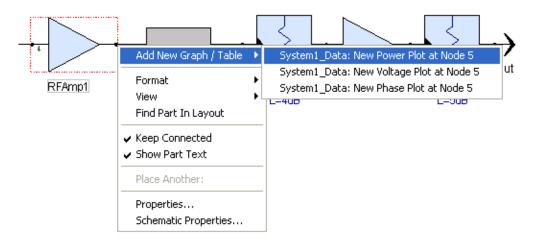
Spectrum plots in Spectrasys are unique because of the type of information displayed. They can display:

- Individual pieces of spectrum including signals, intermods and harmonics, thermal noise, and phase noise
- The total spectrum comprised of all individual pieces of spectrum in every direction through the node
- Spectrum analyzer trace for each total spectrum
- Spectrum like signals, intermods and harmonics, thermal noise, and phase noise can be grouped and shown instead of individual spectrums

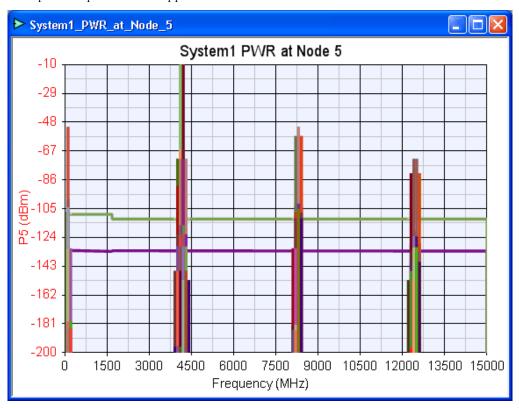
Click here for additional information on controlling what types of spectrums displayed.

Easiest Way to Add a Spectrum Plot

The easiest way to add a spectrum plot is to right click the node of interest then select the desired plot from the 'Add New Graph / Table ' submenu as shown below.

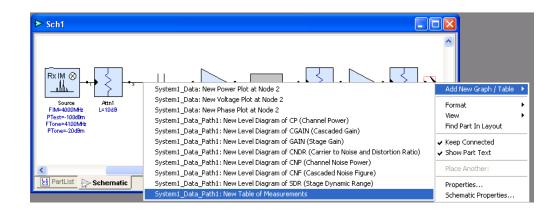


The spectrum plot will then appear.



Easiest Way to Add a Table

The easiest way to add a path table is to right click THE NODE WHERE THE PATH ENDS then select the 'System1_Data_Path1: New Table of Measurements' from the 'Add New Graph / Table ' submenu as shown below. **NOTE**: The path name may be different because this is based on the dataset and path name.



The following default table will appear.

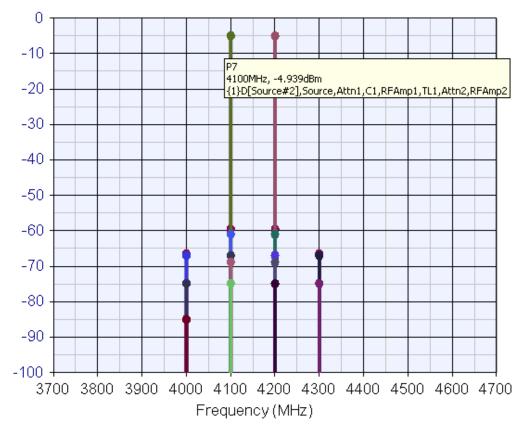


Identifying Spectral Origin

Since each spectrum is tracked individually the user can find the origin and path of each spectrum by placing a marker on the graph or placing the mouse cursor over the spectrum of interest. When a graph marker is added to a plot, the marker will attach itself to the closest spectral data point. The mouse flyover text ONLY appears when the mouse is over the spectrum data point or the marker text on the right side of the graph. These spectrum data points can be enabled or disabled.

NOTE: If you are having a difficult time getting the mouse flyover text the try enabling the spectrum data points to see the exact data locations for the mouse.

Placing the mouse over the data point on a spectrum yields the following.



The format of the spectral identification is as follows:

GENERAL FORMAT

- Line 1 Measurement Name
- Line 2 Marker Frequency, Marker Power (Voltage) Level
- Line 3 {Coherency Number} Signal Type [Frequency Equation], Origin Element, Next Element, ..., Current Element

Coherency Number

All signals in Spectrasys are grouped according to a coherency number. All signals with the same coherency number are coherent with each other. Click here for additional information on coherency.

Signal Type

D - Desired Signal. All spectrums are either marked desired or undesired. Desired spectrums are generally those of main interest in the simulation. Desired spectrums

consist of signal sources, selected multiplication or division values through frequency multipliers and dividers, and sum or difference products and determined by the user.

None - Undesired Signal. If there is no "D" displayed then the signal is an undesired signal.

Frequency Equation

From the frequency equation the user can identify which source frequencies created the spectrum. This equation is written like a typical mathematical equation. The equation will contain the name and combinations of all the sources that created the spectrum.

Analog to Digital Equations - Additional spectrum identification following an analog to digital converter is provided in the frequency equation. The originating Nyquist zone of the signal will we specified along with an indication of whether the spectrum was inverted or not in the downconversion / aliasing process.

Path

The path of the spectral component can be determined by examining the comma delimited sequence of reference designators which identify the element where the spectrum was created and the element sequence that the signal took to arrive at the destination node. The first reference designator after the closing frequency equation bracket shows the reference designator where the spectrum was created. The subsequent reference designators indicate the path that the spectral component took to arrive at the node under investigation.

Example

This example shows a spectrum at 4000 MHz whose power level is about -67 dBm. It has a coherency ID of 15 and is a 3rd order intermod between 'Source#2' and 'Source#3'. The intermod was created in 'RFAmp1' and then followed the path through 'TL1,Attn2,RFAmp2'. The output of 'RFAmp2' is where the spectrum is being viewed.

```
P7
4000MHz, -66.925dBm
{15}[-(Source#3)+2x(Source#2)],RFAmp1,TL1,Attn2,RFAmp2
```

NOTE: Spectrum identification information can only be displayed if 'Show Individual Spectrums' has been enabled.

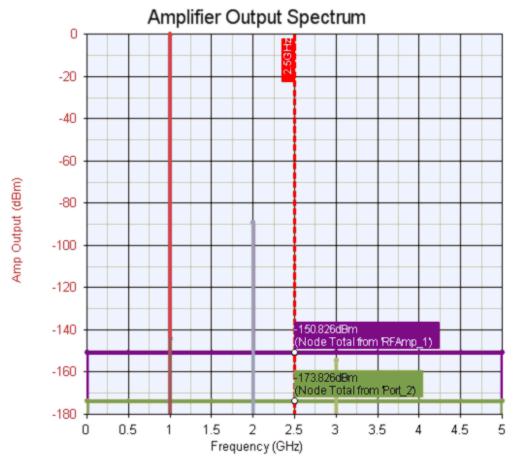
Broadband Noise

The SPARCA simulation technique enables Spectrasys to simulate broadband noise very quickly. The 'Ignore Frequency' limits are used to specify the frequency of the broadband noise along with the frequency range of the simulator. The entire broadband noise spectrum is simulated with a small number of simulation points. To ensure accurate noise measurements Spectrasys uses a special technique called smart noise point insertion to guarantee noise data is taken at desired spectrum frequencies. This allows to simulation to run much faster and reduce the number of noise data needed to make accurate noise measurements.

Broadband noise flows in all directions through a node. For example, if the output port was being examined then on a spectral plot the user would see the noise power flowing from the device driving the output port. This noise is obviously flowing toward the output port. The output port itself will also generate noise which will flow from the output port back towards the input. Impedances that these spectrums see may be different for every direction through the node. For this reason each of these total noise spectrum are displayed on a spectral plot.

Spectrasys uses complicated noise correlations matrices along with other special noise simulation techniques to be able to be able to propagate noise spectrums especially through multiport devices. The individual noise spectrums by default are not shown on spectral plots. However, user can view this information if so desired. There are times when debugging noise problems in an RF architecture that this information is extremely helpful.

The following figure illustrates multidirectional noise between an amplifier and output port. The amplifier has a gain of 20 dB and a noise figure of 3 dB. The measurement bandwidth is 1 Hz.



As can be seen from the figure the noise from the output port is thermal noise whereas the noise power from the amplifier output is thermal noise plus the amplifier gain of 20 dB plus an additional 3 dB for the amplifier noise figure.

Click here for additional information on noise analysis.

It is not the purpose of this documentation to elaborate on noise correlation matrices and other noise simulation techniques. For additional information on noise correlation matrices see, "Computer-Aided Noise Analysis of Linear Multiport Networks of Arbitrary Topology", Vittorio Rizzoli and Alessandro Lipparini, IEEE Transactions on Microwave Theory and Techniques, Vol. MTT-33, No. 12, December 1985.

Two Port Noise Amplifier Analysis

The noise figure of a two-port amplifier is given by

$$F = Fmin + (rn / gs) * (|Ys - Yo|^2)$$

where rn is the equivalent normalized noise resistance of the two-port (i.e., rn = Rn / Zo), Ys = gs + j bs represents the source admittance, and Yo = go + j bo represents that source admittance which results in the minimum noise figure, Fmin.

Ys and Yo can be expressed in terms of the reflection coefficients Gs and Go as

$$Y_s = (1 - G_s) / (1 + G_s)$$
 and $Y_o = (1 - G_o) / (1 + G_o)$

(See G Gonzalez, Microwave Transistor Amplifiers, pgs 142-142, Prentice-Hall Inc, New Jersey, 1984)

What this means in layman's terms is that the noise figure of an active device is very much a function of the source admittance or impedance.

NOTE: Cascaded noise figure equations make the assumption that noise figure of an active device is independent of the source impedance, which can clearly lead to erroneous results.

Propagation Basics

The basic operation of Spectrasys involves the propagation of individual source spectra and all of their derived products (intermods, harmonics, etc.) to every node in the system. These spectrums will keep propagating until no additional spectrums are created. For instance, any new inputs arriving at the input of an amplifier will cause intermods and harmonics to be created at the amplifier output at that particular time. If additional signals arrive at the amplifier input at a future time then new intermods, harmonics, and other spurious products will be created at the amplifier output. This process continues until no additional spectrums are created. If loops exist in the system, then the output from one element will feed the input of the next element and spectrum propagation could continue forever unless special features are placed within the software to limit spectral creation in this infinite loop. Spectrasys has special features to control loops and limit the total number of created spectrums.

Loops

Elements in parallel (parallel amplifiers connected via a 2 way splitter at the input and combined back together with a 2 way combiner at the output) can cause spectrums to be created that will propagate around this parallel path (or loop). If the gain of the amplifier is greater than its reverse isolation the spectrums will keep on growing as they travel around the path and will never die out (we would have an oscillator). The key point here is that if there are loops in the system schematic then it is very important to make sure that the element parameters are entered correctly so that signals don't grow in amplitude as they traverse around a loop. Once loop spectrums fall below the 'Ignore Spectrum Level Below' threshold the spectrum will stop propagating around the loop.

Frequency Ranges

Since SPARCA is a continuous frequency simulation technique there is no upper frequency limit. As such, unnecessary simulation time and data may be taken on spectrums adding no value to the solution of interest. Two parameters are used to control which frequencies will be propagated through the simulation engine. These are 'Ignore Spectrum Frequency Below' and 'Ignore Spectrum Frequency Above'. By default the lowest frequency limit is set to 0 Hz and the upper frequency limit is set to 5 times the highest source frequency.

Controlling Analysis Data

Spectrasys saves data in 1 or more datasets. There is a main dataset associated with the system analysis that stores all the node spectral data such as frequencies, voltages, powers, and voltages. When paths are defined then a dataset is created for each path. The path dataset contains all measurements for the given path. Powers, voltages, and impedances for the path can also be saved to the dataset.

Spectrasys is a continuous frequency simulator and as such no frequency is outside the bounds of the simulator. However, since users work in frequency bands of interest the simulator can be speeded up by ignoring frequency bands outside a given window. Furthermore, spectral amplitudes can have large dynamic ranges. These dynamic ranges can be restricted to ranges of interest. As a general rule, the more data collected the longer the simulation time is.

Spectrasys supports several different spectrum types. The user can select which types of spectrum to simulate.

Controlling Frequency Ranges

There are 2 parameters that control the simulation frequency range. ALL frequencies outside this window will be ignored by the simulator under any condition. Thermal noise is automatically generated in this frequency range (as long as 'Calculate Noise' has been enabled).

- Ignore Frequency Below
- Ignore Frequency Above

Controlling Spectrum Amplitude Ranges

There is 1 parameter used to control the simulation amplitude range. ALL spectrums whose power levels fall below the given amplitude value will be ignored.

• Ignore Amplitude Below

Controlling Spectrum Types

The following spectrum types can be ignored during simulation

- Intermods
- Harmonics

- Thermal Noise
- Phase Noise

Controlling Path Data

Every measurement is dependent on one or more types of spectrum. All measurements whose spectrum types have been enabled are added to the path dataset. Furthermore, path powers, voltages, and impedances can also be added to the dataset.

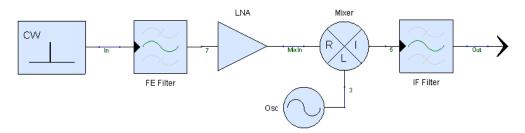
Sweeps of a Path

Sweeps of path measurements can be plotted in one of two ways:

- On a Level Diagram
- On a rectangular graph showing a Swept Variable vs Measurement at a given node

Background

The following schematic will be used for the discussion of this topic.



Notice that 3 of the nodes have been manually renamed to help illustrate concepts that will be shown hereafter. To rename a net right click the net then select 'Net' and then 'Rename...' from the sub menu.

In this example the source frequency is swept from 2110 to 2170 MHz. An equation is used to slave the LO frequency to the input frequency so the IF frequency will remain constant across the frequency sweep.

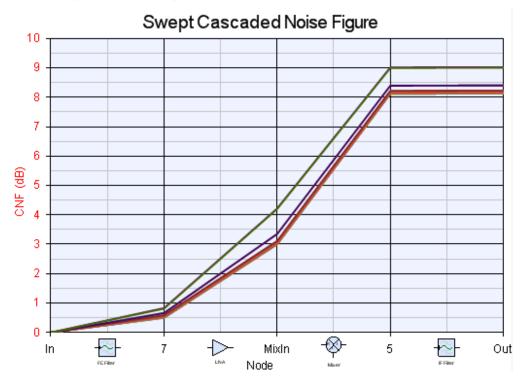
Click here for additional information on setting up parameter sweeps.

When a sweep is performed on a system analysis the spectrum data is swept and a new swept main system dataset will be created. If the system analysis contains paths then each path will be swept and a new swept path dataset will be created for each path.

Swept Level Diagram

To create a swept level diagram do the following:

- Add a rectangular graph
- Set the 'Default Dataset or Equations' to the swept path dataset of interest
- Type in or select the path measurement

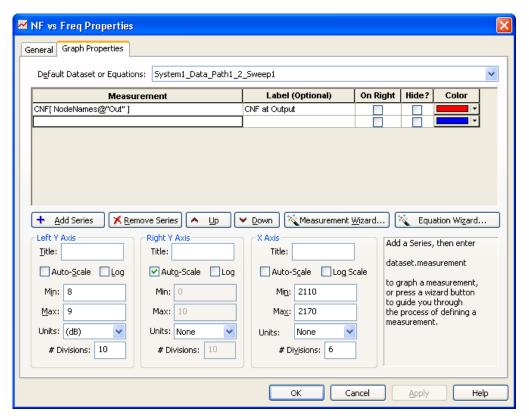


Swept Variable versus Measurement at a given node

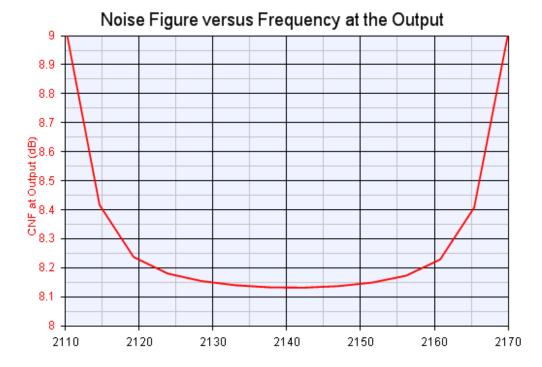
Many times users need a measurement at an input, output, or some other intermediate node. For example, the user may want to examine the cascaded noise figure at the output node versus the input frequency or the channel power at the output node versus a sweep of the input power.

To create a plot of a swept variable versus a measurement do the following:

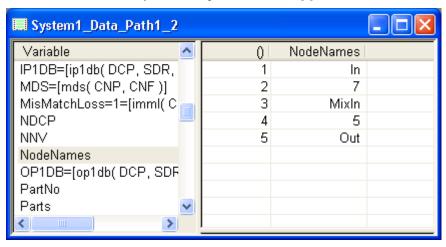
- Add a rectangular graph
- Set the 'Default Dataset or Equations' to the swept path dataset of interest
- Add the measurement and then selected the array entry in the measurement for the node of interest. To do this use the following syntax:
 - Measurement[NodeNames@"Name of Node"]
 - In this example this would be **CNF**[NodeNames@"Out"] as shown below



The resulting graph is shown below

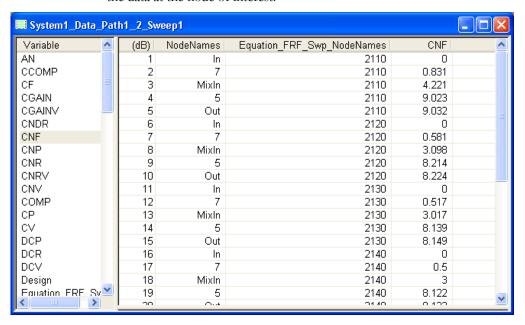


NodeNames is a variable placed in the path dataset which is the dependent variable for every path measurement. Note that the 'NodeNames' variable is really just an array of strings. The left most column is really just a row number like a spreadsheet or the *i*th entry in the array. For example, NodeNames[3] = "MixIn".



• The @ operator returns the index in the array of the operand. For example, the index of NodeNames@"MixIn" is 3.

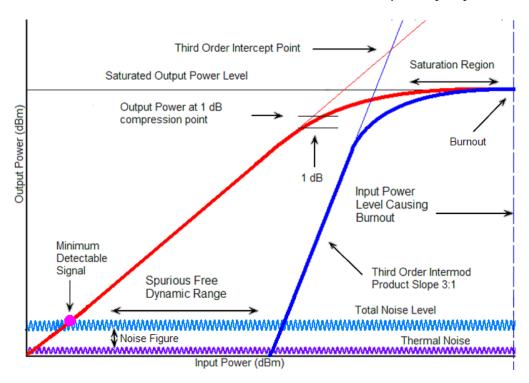
- In summary then the measurment **CNF**[NodeNames@"Out"] will return all the swept values of **CNF** at the node named "Out".
- By default, the names of the nodes used in the schematic are numbers so the syntax of **CNF**[NodeNames@"2"] where "2" is the output node is very common.
- Another way to understand this is to examine the CNF measurement in the swept path dataset. The dependent data is in the right most column titled CNF. This variable has two independent variables 1) the swept frequency and 2) the name of the node. The units of this measurement are show in the header row of the first column. Or in other words dB. The left most column is simply a row or index number. For example, CNF[12] of the swept path dataset would be 0.517 dB which is the 12 entry of the CNF array. The @ operator must be used to extract only the data at the node of interest.



Intermods

Non Linear Model Behavior

In the real world components and stages exhibit non linear distortion such as gain compression and power output saturation. To characterize non linear behavior compression points, saturation, intercept points, and spurious free dynamic ranges are defined according to the following diagram.



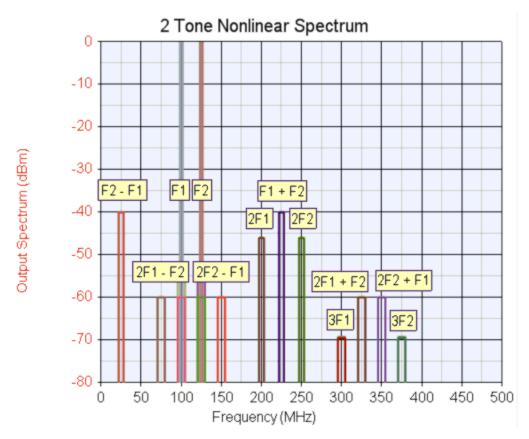
The above figure illustrates 3rd order intermod and noise performance boundaries. As shown a higher intercept point yields larger dynamic range. Consequently, intercept points are commonly used as a performance characteristic of RF systems. In general the higher the intercept point the more tolerant the system is to interference.

In a cascade of RF behavioral models a diagram similar to that above can be derived to determine the overall system performance. The cascaded intercept point is generally referred to the input or output for convenience. Transmitters and amplifiers generally have their intercept points referred to the output and receivers have them referred to their input.

Intermod and Harmonic Basics

This section will help the user understand fundamental relationships between intermods, harmonics, and intercept points. When 'Calculate Intermods' and 'Calculate Harmonics' are enabled intermods and harmonics will always be created by nonlinear behavioral models. The 'Maximum Order' parameter on the 'Calculate' tab of the system analysis determines the maximum intermod and harmonic order used in the simulation.

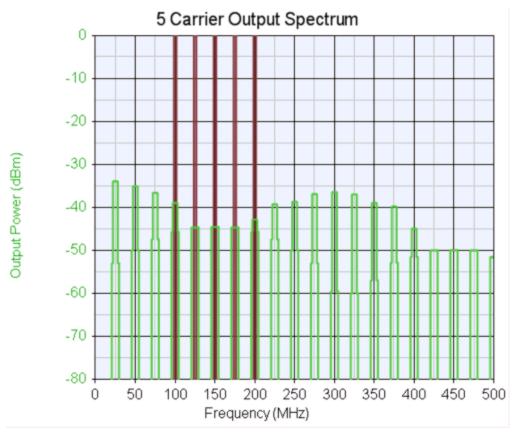
Here is an example of the output spectrum of an amplifier with a two tone input.



The 2 tones are located at 100 and 125 MHz. Notice that the bandwidth of 2nd order products is twice that of the fundamentals and the 3rd order products are 3 times the bandwidth of the fundamentals. The amplifier OIP3 is +30 dBm and the OIP2 is +40 dBm.

NOTE: The channel measurement bandwidth must be set to at least 3 times the bandwidth of the fundamental tones in order to view the full intermod power of 3rd order products. This bandwidth must be increased accordingly for higher order products.

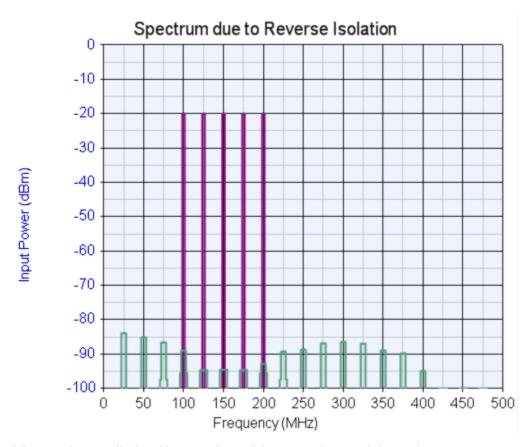
Here is an example of the intermod spectrum due to 5 carriers through the same amplifier. Spectrum groups are being displayed instead of individual spectrums. Signals are shown in one color and all intermods are grouped together and shown in another color.



Notice the peaking effects of the intermods around 300 and 25 MHz as well as the inchannel effects associated with carrier triple beats and 2nd order products.

Reverse Isolation

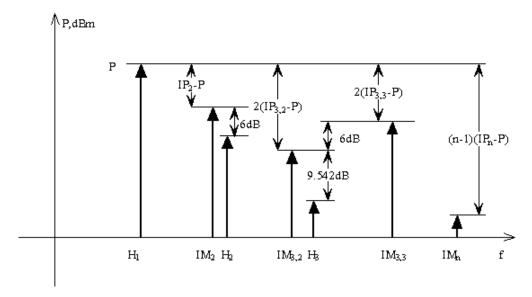
Intermods can and do appear at the input to a nonlinear stage due to the reverse isolation of the device as shown in the following figure.



The 5 carriers are displayed in one color and the reverse intermods in another.

Calculated Products

The following figure shows the nonlinear second and third order products created for two input signals F1 and F2 where F2 is greater in frequency than F1.



The relative levels of spectral components for the small signal regime and equal amplitudes of the signal's tones is shown above.

Definitions of symbols

P - Fundamental Tone Power

IP_n - Nth Order Intercept Point

 \mathbf{H}_1 - Fundamental Tone

H₂ - 2nd Harmonic

H₃ - 3rd Harmonic

 IM_n - Nth Order Intermods

 $\mathbf{IM}_{n,m}$ - Nth Order Intermods due to M tones

2nd Order Intermod Products

The amplitude of the second order intermod products (F2 - F1 and F1 + F2) are equal to the tone power level minus IP2 or in other words IM2 = Ptone - IP2.

2nd Harmonics

The amplitude of the second harmonics are calculated as follows. The amplitude of the second harmonic is equal to the tone power level minus the difference between IP2 (second order intercept) and the tone power level of the device.

3rd Order 2 Tone Products

The amplitude of the third order products (2F1 - F2, 2F2 - F1, 2F1 + F2, and 2F2 + F1) are equal to 2 times the quantity of the tone power level minus IP3 or in other words IM3 = 2 (Ptone - IP3).

Carrier Triple Beats (3rd Order 3 Tone Products)

When more than two carriers are present in a channel, 3rd order intermod products can be created by the multiplication of three carriers. These intermods are called carrier triple beats. Spectrasys automatically creates triple beats for all combinations of 3 or more carriers. Working out the math, carrier triple beats will be 6 dB higher that the 3rd order 2 tone products. This calculation of the triple beat level assumes that the amplitude of all input signals is the same. The frequency combinations of the carrier triple beats are as follows:

F1 - F2 + F3 F1 - F2 - F3 F1 + F2 + F3 F1 + F2 - F3

3rd Harmonics

The amplitude of the third harmonics are 9.542 dB below the 3rd order 2 tone products.

Higher Orders

The 'Maximum Order' parameter on the 'Calculate' tab of the system analysis determines the maximum intermod and harmonic order used in the simulation. The intermod levels and frequencies are calculated based on a complicated mathematical process. This process description is beyond the scope of this text. Please see other resources for additional information.¹

Tone Dissimilar Amplitude

Spectrasys automatically accounts for the amplitude of all input signals that create a given intermod. This yields accurate intermod results since cascaded intermod equations ignore the effects of unequal amplitudes.

Channel Bandwidth and Intermods

The bandwidth of third order products is greater than the individual bandwidth of the sources that created them. For example, if two 1 Hz tones were used to create intermods, the resulting bandwidth would be 3 Hz. The bandwidth follows the intermod equation that determines the frequency except for the fact that bandwidth cannot be subtracted. For example, if the third order intermod equation is: Fim3 = F1 - 2*F2 then the equation for the resulting bandwidth would be: BWim3 = BW1 + 2*BW2. If BW1 = 30 kHz and BW = 1 MHz, then the resulting bandwidth would be 2.03 MHz. The user needs to make sure that the 'Channel Measurement Bandwidth' is set wide enough to integrate all of this energy.

Jose Carlos Pedro, Nuno Borges Carvalho, "Intermodulation Distortion in Microwave and Wireless Circuits", Artech House, 2003

Cascaded Intermod Equations

Cascaded intermod equations are NOT used by Spectrasys. There are serious drawbacks using these cascaded equations.

Background

Using basic assumptions the intercept point for a cascade can be determined. Cascaded equations come in two flavors, coherent and non-coherent. If the intermods throughout the cascade are assumed to be in phase then coherent addition should be used. This will yield a worst case intercept point. However, if the intermods are assumed to be out of phase then non-coherent addition can be used.

Cascaded Intercept (Coherent Addition)

```
1 / ITOIcascade = 1 / ITOI1 + 1 / ( ITOI2 / G1 ) + \dots + 1 / ( ITOIn / G1G2 \dots Gn-1 )
```

Cascaded Intercept (Non-Coherent Addition)

```
1 / ( ITOIcascade )2 = 1 / ( ITOI1 )2 + 1 / ( ITOI2 / G1 )2 + ... + 1 / ( ITOIn / G1G2 ... Gn-1 )2
```

Where

ITOI - Numeric Stage Input Third Order Intercept

G - Number Stage Gain

See McClaning K., and T. Vito (2000). Radio Receiver Design Atlanta, GA: Noble, pp. 605-626 for additional information.

The basic assumptions are:

- 1. There is no concept of frequency
- 2. All stages have been perfectly matched
- 3. No consideration for filtered tones that generate the intermods
- 4. Multiple paths are ignored (only valid for two port lineups)
- 5. Gain is assumed to be independent of power level
- 6. Intermods never travel backwards (reverse isolation is assumed to be infinite)

The calculation of cascaded intermods is generally in a spreadsheet. Note there is no relationship between these calculations and the physical measurements of the intercept points in the lab. There is no mention of frequencies and power levels of tones that are need to make measurements in the lab.

Because of these serious restrictions new intermod measurements were created to eliminate these issues. See 'Intermod Path Measurement Basics' for additional information.

Intercept Measurements in the Lab

Intercept measurements in the lab are broken down into two groups, in-band and out-of-band. In-band measurements are used when tones are not attenuated by filtering through the cascade. For example, intercept point for a power amplifier is generally done with 2 tones that exhibit the same power throughout the system. Out-of-band measurements are used when they are attenuated like filtering in an Intermediate Frequency (IF).

In-Band Intercept Measurements

For in-band measurements two tones, f1 and f2 are created by two signal generators and combined before entering the Device Under Test (DUT). Care needs to be taken in the setup to ensure reverse intermods will not be generated in the signal generators before appearing at the DUT input. A typical setup is as shown below using two tones.

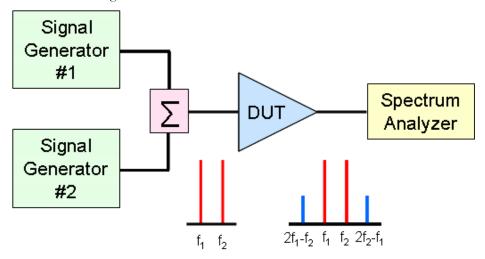


Figure 1 - In-Band Intermod Measurement Setup

The intercept point is determined from the measured power level of the two tones and the power level of the intermods themselves on a spectrum analyzer as shown in the following figure.

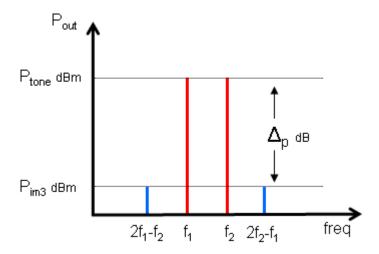


Figure 2 - In-Band DUT Output Spectrum

From this information the output third order intercept is determined as follows:

OTOIdBm = Ptone out, dBm + $\Delta p / 2$

The input third order intercept is:

ITOIdBm = OTOIdBm - GainDUT

Out-of-Band Intercept Measurements

Out-of-band measurements are more complicated since the tones have been attenuated at the IF output. This is illustrated in the following two figures.

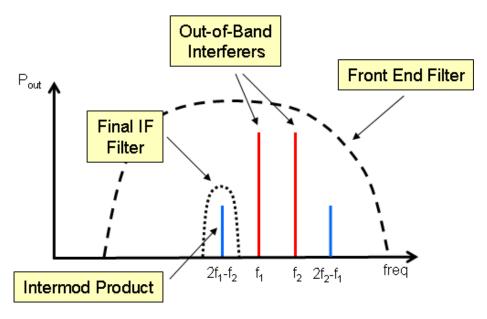


Figure 3 - Third-Order Distortion Inside the Receiver Input Filter

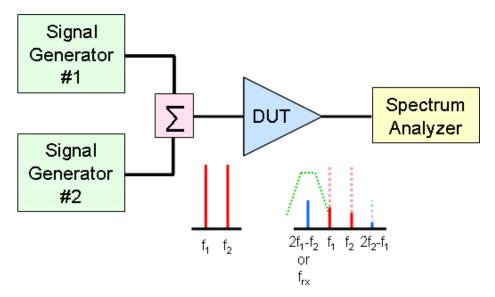


Figure 4 - Out-of-Band Intermod Measurement Setup (Won't Work)

Without knowing what the un-attenuated tone power level is the intercept point cannot be determined as shown in the following diagram.

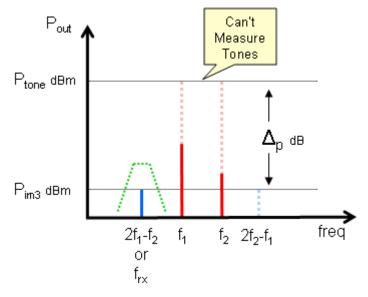


Figure 5 - Out-of-Band DUT Output Spectrum (Won't Work)

To remedy this additional steps are needed to determine an out-of-band intercept point.

To solve this problem a virtual tone can be determined which, is the power of the tone at the DUT input plus the in-channel cascaded gain. Once the virtual tone power and the in-channel gain are determined then both input and output intercept points can be found.

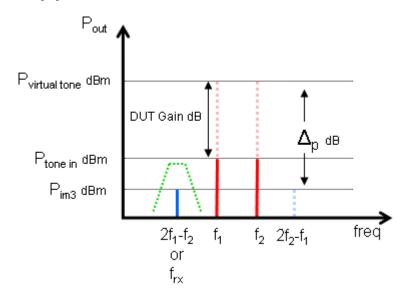


Figure 6 - Out-of-Band DUT Output Spectrum (Virtual Tone)

In the lab measuring the in-channel cascaded gain and intermod power is a two step process. First, the in-channel gain is measured using a single signal generator as shown below.

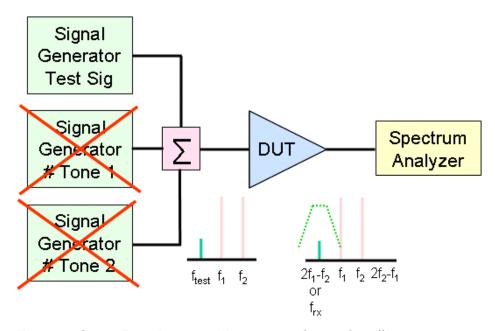


Figure 7 - Out-of-Band Intermod Measurement Setup - Step #1

Next, the in-channel signal generator is disabled and the two tone generators are enabled and the in-channel intermod power is measured as shown below.

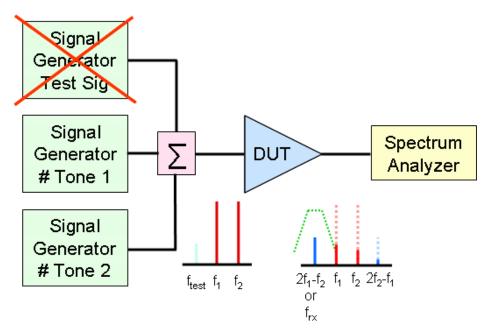


Figure 8 - Out-of-Band Intermod Measurement Setup - Step #2

Be aware that it is very difficult in practice to measure intermod power levels near the noise floor of the receiver. One common technique is to measure the S/N ratio at the receiver output given a known on-channel signal generator input power level. When the on-channel signal generator is disabled and two tones are injected into the receiver the power level of the two tones can be adjusted until the S/N ratio decreases by 3 dB. At this point we know that the power level of the intermod is equivalent to the power level of the on-channel signal generator.

Intercept Measurement Summary

The process of measuring the intercept point is very different than using cascaded equations. When determining the intercept point in the lab the user must physically create both tones at the frequencies of interest. The spacing between the tones needs to be such that the third order intermods will appear at the desired locations. The power level of the input tones needs to be sufficiently low to keep the DUT in linear operation but large enough to be seen in the dynamic range of the spectrum analyzer. When measuring the intermod and tone power levels the user must select the appropriate frequencies on the spectrum analyzer to place the markers. Out-of-band intermod measurements require an additional step to measure the in-channel cascaded gain. This is a very different process than using cascaded intermod equations that remain ignorant of frequencies, impedances, directions, and power levels.

Intercept Points Other Than 3rd Order

Thus far only 3rd order intercept points have been addressed. However, for a two tone source the general intercept equation is:

$$IPn = (Ptone - Pintermod, n) / (n - 1) + Ptone$$

Where:

IPn is the nth order intercept point

n is the intercept order

Pintermod, n is the power level of the nth order intermod (created by the two tones)

All power levels are measured in dBm

This equation only applies for intermods created with two tones. Intermods created with more than two tones have slightly different amplitudes and don't fit the above relationship directly. However, the measurement technique in the lab follows the same process except the frequency of the intermod will changed based on the order of the intermod. For instance, even order products are generally located at twice the frequency of the two tones or closed to DC.

Intermod Path Measurement Basics

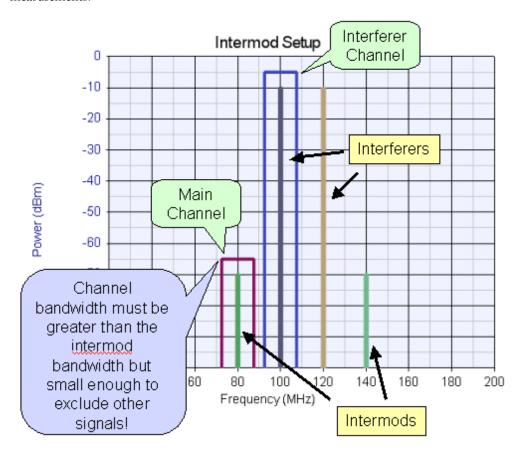
Intermods are automatically created by all nonlinear behavioral models as long as intermod and harmonic calculation has been enabled.

Measuring intermods in Spectrasys is very similar to measuring intermods in the lab. Cascaded intermod equations are NOT used in Spectrasys because of their serious limitations. As such new measurements were created to removed these restrictions.

A model with either create (generate) intermods and conduct them from a prior stage or just conduct them from a prior stage. All nonlinear behavioral models will both create intermods and conduct them from the input. Linear models will only conduct intermods from the prior stage.

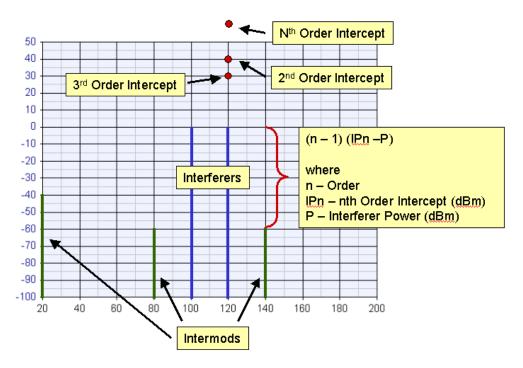
Intermod measurements can show both the generated, conducted, and total intermods channel powers along a path. Furthermore, these measurements can also segregate the data based on intermod order. These channel based measurements should not be confused with a measurement called 'Total Intermod Power' which contains the total intermod power of the entire spectrum at the given node and cannot segregate its data based on order.

Here is a simple diagram showing how to setup Spectrasys to make intermod path measurements.



Determining the Intercept Point

Intercept point measurements are assumed to be from two interfering tones. The calculations are based on what would be done in a laboratory as shown in the following figure. As can be seen two measurements are needed to determine the power of the intercept point. These measurements are the power level of the intermod and that of the one of the two tones. If the interfering tones are attenuated through the system like in a receiver IF a virtual interfering tone must be created by the simulator to correctly determine the intercept point. This is done by injecting a small test signal at the intermod frequency to measure the in-channel gain. Knowing the power level of the two interfering tones to the system plus the in-channel cascaded gain a virtual tone power can be determined at the output of the system which will be used to find the intercept point. In the laboratory this would be done in a two step process since a spectrum analyzer is unable to separate out the cascaded gain test signal and the intermod. However, in Spectrasys this presents no problems and both signal can co-exist at the same time.



Remember: Intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. For example, CW signals have a 1 Hz bandwidth. Therefore, a third order intermod generated from CW signals will have a 3 Hz bandwidth. If the channel bandwidth is set smaller than 3 Hz not all of the third order intermod energy will appear in the intermod measurements.

Intercept points can only be determined by measuring and interferer signal in an interferer channel. The user must set the main channel frequency in Spectrasys to the frequency where the intermods are to be measured and the interferer channel must be set to the frequency of the interferer to get the correct interferer channel power.

Intercept points can be determined from an in-band or out-of-band method. Both techniques will give identical results in-band. However, if an in-band method is used in a system where the interfering signals are attenuated (like in the IF filter in a receiver) incorrect intercept points will be reported.

Caution: The method used to determine the intercept point is only valid for 2 tones with equal amplitude.

Remember: Intermods travel **BACKWARDS** as well as forward. Backward traveling intermods (like those through reverse isolation paths) will be included in channel measurements and must be considered when making comparisons to cascade intermod equation results. Please consult the specific intermod measurements of interest for details.

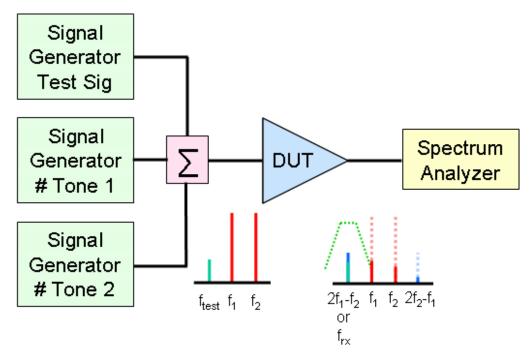
Intermod Path Measurement Summary

- Add a source that will create an intermod at the path frequency.
- Set the 'Path Frequency' to the frequency of the intermod.
- Set the 'Channel Measurement Bandwidth' to the widest order of interest (not too wide to include interfering tones).
- Set the 'Path (Interferer) Frequency' in the Edit Path dialog box to the frequency of the (interfering) tone.
- Make sure the 'Maximum Order' is set high enough to include the intermods of interest.
- Add intermod measurements to a level diagram or table.
- Remember: Intermod can and do travel backwards be careful when only
 expecting forward traveling results.

Cascaded Intermod Equations and Spectrasys

Spectrasys doesn't use cascaded intermod equations and is not restricted to their limitations. Measuring intercept points in Spectrasys is akin to making measurements in the lab. Spectrasys needs to know both the frequency of the intermod and the frequency of one of the tones. These values are specified on a path. The path frequency is the frequency of the intermod being measured and the 'Tone (Interferer) Frequency' is the frequency of the tone used to determine the intercept point. Unlike a marker on a spectrum analyzer Spectrasys has the ability to measure the power of a spectrum across a channel. Care must be given to ensure the channel bandwidth is wide enough to cover the bandwidth of the intermod yet narrow enough to exclude the power level of any tones used to create the intermods.

Because Spectrasys has the ability to differentiate between signals and intermods the two step out-of-band process can be done in a single step as shown in the following figure. The out-of-band configuration is the general case and will also work for in-band intercept measurements.



The user can view measurements showing frequencies and power levels of the tones and intermods being used in intercept calculations.

The following tables show a mapping of Spectrasys measurements to the intermod test setup and results.

Table 1 - Spectrasys Intercept Setup Measurements

Measurement	Description	Intermod Setup
CF	Channel Frequency	Intermod Frequency
TIMCP	Total Intermod Channel Power	Intermod Channel Power for each Order up to the Maximum Order
TIMCPn	Total Intermod Channel Power for Order n	Only Intermod Channel Power for the given Order n
ICF	Interferer (Tone) Channel Frequency	Tone Frequency used for Intercept Calculations

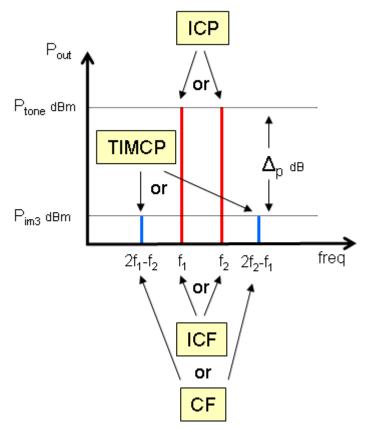
Simulation

ICP	Interferer (Tone) Channel Power	Power Level of the Tone (Used for In-Band Measurements)
VTCP	Virtual Tone Channel Power	Power Level of the Virtual Tone based on the Desired Channel Power of the Test Signal (Used for Out-of-Band Measurements)

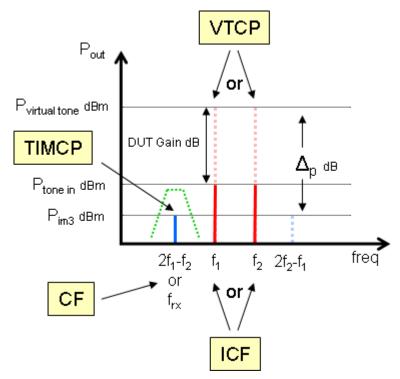
Table 2 - Spectrasys Intercept Results Measurements

Measurement		Description	Intermod Results
	IIP	Input Intercept Point	Input Intercept Point for each Order up to the Maximum Order
In-Band (Uses ICP)	IIPn	Input Intercept Point for Order n	Only Input Intercept Point for the given Order n
	OIP	Output Intercept Point	Output Intercept Point for each Order up to the Maximum Order
	OIPn	Output Intercept Point for Order n	Only Output Intercept Point for the given Order n
Out-of- Band (Uses VTCP)	RX_IIP	Input Intercept Point	Input Intercept Point for each Order up to the Maximum Order
	RX_IIPn	Input Intercept Point for Order n	Only Input Intercept Point for the given Order n
	RX_OIP	Output Intercept Point	Output Intercept Point for each Order up to the Maximum Order
	RX_OIPn	Output Intercept Point for Order n	Only Output Intercept Point for the given Order n

NOTE: In-Band and Out-of-Band intercept measurements will yield the same results if the tones are attenuated.



In-Band Spectrasys Measurements



Out-of-Band Spectrasys Measurements

From the intermod power level and the measured tone power level intercept points for all orders up to and including the maximum order are calculated. However, only one of them will be valid since the intermod frequency will be different for each order.

In-Band Intercept Simulation

- 1. Create a two tone source and connect it to the DUT.
- 2. Create a path and set its frequency to the intermod frequency.
- 3. Set the 'Tone (Interferer) Frequency' of the path to the tones that will be used to calculate the intercept point.
- 4. Set the Channel Bandwidth to a value wider than the intermod but narrow enough to exclude any power from the tone.
- 5. Add the IIPn or OIPn measurement to a graph or table when n is the intercept order.

Out-of-Band Intercept Simulation

- 1. Create a three tone source and connect it to the DUT.
- 2. Set the frequency of the third test signal to the frequency of the intermod.
- 3. Create a path and set its frequency to the intermod frequency.

- 4. Set the 'Tone (Interferer) Frequency' of the path to the tones that will be used to calculate the intercept point.
- 5. Set the Channel Bandwidth to a value wider than the intermod but narrow enough to exclude any power from the tone.
- 6. Add the RX_IIPn or RX_OIPn measurement to a graph or table when n is the intercept order.

Troubleshooting Intermod Path Measurements

Here are a couple of key points to remember when troubleshooting and intermed measurement problems. Using a table is generally much better at troubleshooting than level diagrams.

- Look at the 'Channel Frequency (CF)' measurement in a table. This must be the frequency of the intermods of interest.
- Make sure there are intermods within the channel by looking at the 'Total Intermod Channel Power (TIMCP)'.
- If there are no intermods in the channel look at the spectrum and verify that an intermod of the order of interest has been created at the **'Channel Frequency'** of the path.
- If there are no intermods at the channel frequency make sure 'Calculate Intermods' has been enabled.
- If there are still no intermods make sure the nonlinear models have their nonlinear parameters set correctly.
- If the 'Total Intermod Channel Power' doesn't seem to be too low verify that
 the 'Channel Measurement Bandwidth' is wide enough to include the intermod
 order of interest.
- If the 'Total Intermod Channel Power' still doesn't seem to be correct then verify that the 'Channel Power (CP)' measurement is showing the approximate expected power. The 'Channel Measurement Bandwidth' may be set so wide that other interferer frequencies fall within the channel and the 'Channel Power' measurement will be very high.
- IF the 'Total Intermod Channel Power' seems to be too high the intermods may be traveling backwards from a subsequent stage. The reverse isolation of this stage can be increased to verify this effect.
- If the 'Input Intercept Point' measurements (IIP, OIP, RX_IIP, RX_OIP) don't seem to be correct then first verify that the 'Interferer Tone Channel Frequency (ICF)' is set to the interfering frequency.
- If the 'Interferer Channel Frequency' is set correctly then look at the 'Interferer Channel Power (ICP)' measurement for in-band intermod measurements or 'Virtual Tone Channel Power (VTCP)' measurement for

- out-of-band intermod measurements to verify an expected level of interferer channel power.
- If the 'Output Intercept Point' looks correct but the 'Input Intercept Point' doesn't then verify that the 'Interferer Cascaded Gain (ICGAIN)' measurement is correct for the in-band intermod measurement case or the 'Cascaded Gain (CGAIN)' measurement is correct for the out-of-band intermod measurement case.

See the 'Intermod Path Measurement Basics' section for illustrations of intermod path measurements and additional information.

Advanced

Cascaded Noise Analysis

Cascaded noise figure is an important figure of merit especially for receiver design. Traditional cascaded noise figure equations are not used in Spectrasys. A more elaborate technique is used to include the effects of frequency, impedances or VSWR, bandwidth, image frequencies, and multiple paths in cascaded noise measurements.

NOTE: Because traditional cascaded noise figure equations are not used in the Spectrasys a new formulation to calculate noise figure was developed. This formulation relies on the cascaded gain measurement to accurately determine the cascaded noise figure. The cascaded gain measurement requires a signal to be present in the channel for this measurement to be made. Only noise or intermods in the channel are insufficient.

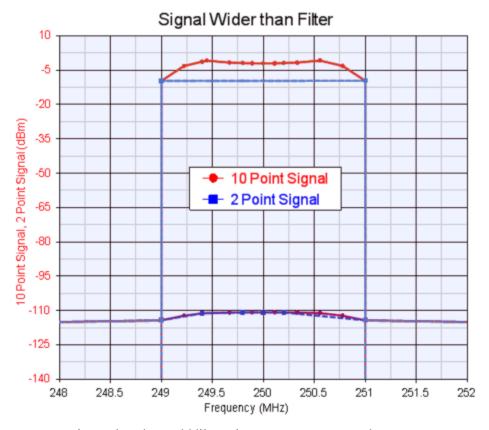
In general, no adjustments in the noise set up is need to obtain accurate noise analysis. There are a few cases where noise accuracy can be improved:

Signal bandwidths are as wide or wider than the narrowest filter bandwidths in the simulation

Traditional cascaded noise figure equations assume NO bandwidth and that the cascaded noise figure is ONLY valid at a single frequency where noise factor and gain values are taken. In practice bandwidths must be considered. Rarely, do impedances remain constant across a channel especially when any type of filter is involved. Consequently, channel signal and noise power may not be constant across a channel. When using wide channel bandwidths relative to narrow filter bandwidths channel noise power may appear to decrease through a cascaded. This is due to bandwidth reduction. Furthermore, power levels due to channel integration can be less accurate if only a few points are used to represent either the signal or noise through a device whose impedances vary across the channel. Click here for more information about adding additional data points to signal sources.

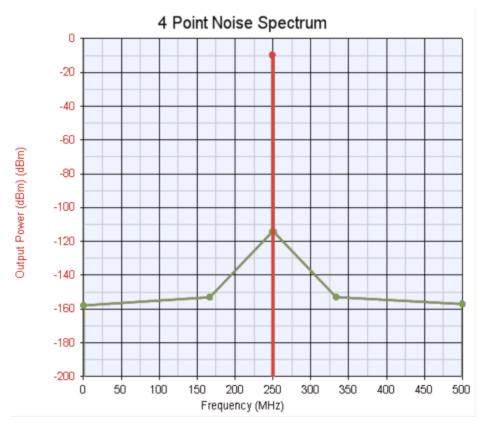
As can be seen in the following figure a wideband signal is slightly larger than the narrowest filter bandwidth. If only 2 points are used to represent the signal then the channel power will only be as accurate as those 2 points. If additional data

points are add to the signal a better representation of the signal and noise will be achieved. Remember, cascaded noise figure in not only dependent on the channel noise power but also the cascaded gain.

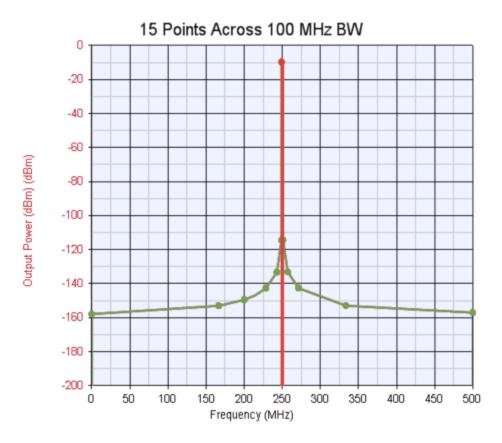


More accurate noise pedestals would like to be seen on spectrum plots

By default Spectrasys uses a very small number of noise points to represent the entire noise spectrum. The following figure shows what noise would look like in was only represented by 4 points. These 4 noise points are evenly spaced between 0 and 500 MHz (0, 166.67, 333.33, and 500 MHz). You see additional noise points around 250 MHz because of smart noise points insertion which is discussed later. The number of noise points can be changed in 2 ways: 1) adding more evenly spaced noise points across the entire noise spectrum and/or 2) adding more evenly spaced noise points around a user specified bandwidth of desired frequencies.



Adding 15 noise points across a 100 MHz bandwidth around the desired signal of 250 MHz show a more accurate representation of the filter noise pedestal. NOTE: Improving the noise spectral shape will generally not improve the accuracy of cascaded noise measurements unless wide measurements are used in systems with narrow filters.



Smart Noise Point Insertion

Another great benefit of the SPARCA simulation technique is that we know which spectrums are desired and which are not. Having this knowledge noise points can be added at the correct frequencies to ensure noise data is collected at the frequency of interest. Adding these noise points to the simulation is called 'Smart Noise Point Insertion'. Without this technique noise simulation through filters would assuredly fail as shown in the figure using 4 noise simulation points. This technique is crucial for all frequency translation models such as mixers, multipliers, and dividers.

Noise Point Removal

As more and more noise points are added to the simulation the simulation will become slower and slower. For this reason noise points that add no value are removed from the spectrum.

NOTE: The 'Calculate Noise' option must be enabled before noise figure measurements will be added to the path dataset.

Cascaded Noise Figure Equations

The traditional cascade noise equation is as follows:

$$F_{cascade} = F_1 + (F_2 - 1) / G_1 + (F_3 - 1) / (G_1G_2) + ... + (F_n - 1) / (G_1G_2...G_{n-1})$$

where F_n is the noise factor of stage n and G_n is the linear gain of stage n

Note: This equation contains no information about:

- frequency
- impedances or VSWR (see Two Port Amplifier Noise)
- bandwidth
- image frequencies
- or multiple paths

These **limitations** are very restrictive and **lead to additional design spins**. For these reasons traditional cascaded noise figure equations are NOT used in Spectrasys. A more general formulation is used which will include all the effects of frequency, VSWR, bandwidth, images, and multiple paths and will reduce to the traditional case under traditional assumptions.

The general formulation is:

Cascaded Noise Figure[n] = Channel Noise Power[n] - Channel Noise Power[0] - Cascaded Gain[n] (dB), where n = stage number

Cascaded Gain[n] = Desired Channel Power[n] - Desired Channel Power[0] (dB)

Basically, the way to look at this is the cascaded noise figure is equivalent to the noise power added between the first and last stage minus the cascaded gain. Channel noise power includes the amplified noise as well as the noise added by each model. Therefore, cascaded gain must be subtracted to get just the noise added by the system.

Coherency

Since all signals in Spectrasys are treated on a individual basis so must coherency for each of the spectrums created during the simulation. Coherent signals will add in voltage and phase, whereas non-coherent signals will add in power. For example, if two coherent voltages had the same amplitude and phase the resulting power would be 6 dB higher. If they were exactly 180 degrees out of phase having the same amplitude the two signals would cancel each other. If the two signals where non-coherent then the power would only increase by 3 dB irrespective of the phase.

Some of the coherency of Spectrasys can be controlled by the user. The user can determine whether intermods and harmonics add coherently and whether mixer output signals consider the LO signal when determining coherency. See the 'Calculate Tab' of the System Simulation Dialog Box for more information on this setting.

How it Works

When a new spectrum is created a coherency number is assigned to each spectrum. These coherency numbers are used to group spectrums together to determine what the resulting total spectrum is after a coherent addition. Coherent additions are especially important at the input to non-linear devices since the total spectrum from coherent signals will yield a different power than individual spectrums. This total power is needed to correctly determine the operating point of the non-linear devices. The coherency number can be viewed by the user when examining the spectrum identification.

The coherency number of a new spectrum will use an existing coherency number if the two spectrums are coherent. Several rules are followed to determine if a newly created spectrum is coherent with an existing spectrum.

All of these rules must be followed before any two signals can be considered coherent:

NOTE: If the 'Coherent Addition' option is unchecked then all intermods and harmonics will always be non-coherent and well as any mixed products out of a mixer regardless of the following comments.

1. Each source is only coherent with itself **OR** if the sources have the same reference clock.

When no reference clock is specified for the source only signals created from this source will be coherent assuming the other coherency constraints are met. When multiple sources have the same reference clock name and the other coherency constraints are met then the signal is considered to be coherent.

2. Signals must be of the same type.

Signals generally have the following categories: Source, Intermod, Harmonic, and Thermal Noise. Coherent signals only apply to the same category of signals. For example, a source spectrum can never be coherent with an intermod spectrum and vice versa. Source spectrum can be coherent with source spectrum and intermod spectrum can be coherent with intermod spectrum, etc. Coherency of phase noise is determined by the coherency of the phase noise parent spectrum. If the two parent spectrums that have phase noise are coherent then the phase noises themselves are coherent.

3. Signals must have the same center frequency and bandwidth.

All coherent signals must have the same center frequency and bandwidth. For example, a 2nd harmonic cannot be coherent with a 3rd harmonic since both the center frequency and bandwidths are not the same. However, if we had a cascade of two amplifiers then the 2nd harmonic generated in 1st amplifier would be coherent with the 2nd harmonic generated in the 2nd amplifier from the same

signal source. In this case both the center frequency and bandwidth are the same with both harmonics being created from the same signal source.

4. Must have the same LO source (mixers only).

When a new spectrum is created at the output of a mixer Spectrasys will determine the coherency of the mixer input signal as well as the LO signal. A new coherency number will be assigned for unique input and LO signals. If there is more than one mixer in the simulation then coherency numbers for the second mixer may come from the first mixer if the all of the above rules are met for the input signal as well as the LO signal. A good example of this is an image reject mixer. A single input port is split 2 ways that drive the input to 2 mixers. A single LO signal is also split 2 ways and phase shifted before being applied to the mixer LO ports. The mixer outputs are combined back together to form the image reject mixer output. Since both mixers have the same input source as well as LO source then all signals that have the same type, frequency, and bandwidth will have the same coherency number.

NOTE: The coherency number is displayed in the spectrum identification information. This will aid the user in understanding their circuit operation as well debugging any problems. See the 'Spectrum Identification' section for more information.

NOTE: Phase noise uses the coherency of its parent signal spectrum.

Coherent vs. Noncoherent Addition

"Coherent addition is more conservative than noncoherent addition, i.e., the coherent assumption indicated a less linear system than the noncoherent equations indicated. In a worst-case scenario, coherent addition should be used."

"When designing low-noise receiving systems, it was found that well-designed cascades usually behave as though the distortion products are adding up noncoherently. For the most part, these system have achieved the equivalent of noncoherent summation plus one or two dB. With wide-band systems, the cascaded SOI [Second Order Intercept] or TOI [Third Order Intercept] will stay at noncoherent levels over most of the frequency range of the system. However, over narrow frequency ranges, the SOI and TOI will increase to coherent summation levels."

"In a well-designed system (where the equivalent intercept points of all the devices are equal), the difference between coherent and non-coherent summation is 4 to 5 dB. When designing a system, it is best to calculate the numbers for both the coherent and noncoherent cases to assess the variation likely to be expected over time and frequency." (McClanning, Kevin and Vito, Tom, *Radio Receiver Design*. Noble Publishing, 2000)

Comparing Coherency with Harmonic Balance

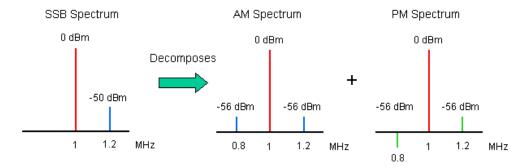
Harmonic balance is a well established nonlinear circuit simulation technique. Signals used it this technique have no bandwidth and all spectrums are of the same type. In harmonic balance it is assumed that two spectrums having the same frequency by definition are coherent.

Coherency and SPARCA

One of the great advantages of SPARCA is that not only is the coherent total spectrum available (which is the only type of spectrum available in harmonic balance) to the user but so are the individual spectrums that make it up. This aids the user in understanding how the design is behaving and is also a great help during the architecture debugging process.

Single Sideband to AM and PM Decomposition

This section will help the user understand how single sideband (SSB) signals are decomposed into AM and PM components. Non linear devices like digital dividers, frequency multipliers, and frequency dividers will treat all input spectrum other than the peak as single sideband input spectrum which can be decomposed into its AM and PM counterparts. These AM and PM counterparts are then processed as well as the peak spectrum by the non linear element. Please refer to chapter 3 'Modulation, Sidebands, and Noise Spectrums' in William F. Egan's book *Frequency Synthesis by Phase Lock, 2nd Ed¹* for more information.



The above illustration shows how the -50 dBm SSB signal located at 1.2 MHz is decomposed into its AM and PM counterparts. The AM sidebands will drop in power by 6 dB and both have the same phase. Whereas the PM sidebands will also drop in power by 6 dB but the lower sideband will be 180 degrees out of phase with the lower sideband in the AM spectrum. When the AM and PM spectrums are added together the lower sidebands cancel out and the -56 dBm upper sidebands add coherently to yield the single upper sideband of -50 dBm.

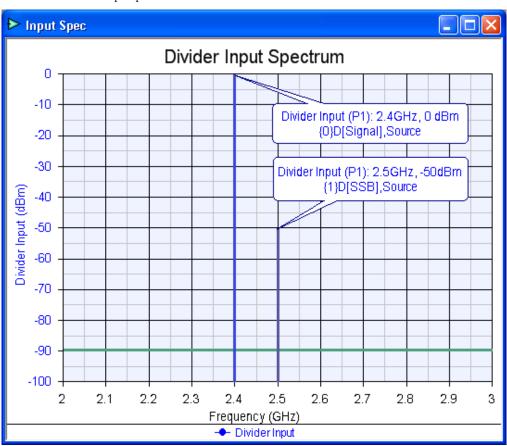
Digital Dividers, Frequency Multipliers and Dividers

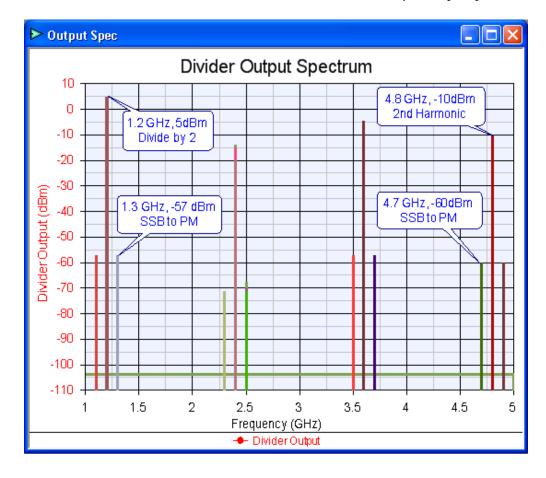
Since digital dividers, frequency multipliers and dividers operate in hard limiting the decomposed AM spectrum is removed leaving only the PM spectrum. Every input spectrum other than the peak spectrum is treated as a SSB component. There may be multiple SSB components along with the peak input spectrum driving one of these

devices. Each SSB component is decomposed into its AM and PM counterparts. Consequently, each harmonic output signal will contain all of the decomposed PM components. Obviously, without filtering between multiplier and dividers stages the number of spectrums grows rapidly due to the multiplication and SSB to AM and PM decomposition. If input SSB spectrum are within 10 dB of the peak input spectrum a warning is given to the user indicating that the decomposition may not be accurate.

The PM component will change in amplitude according to $20 \operatorname{Log}(N)$ where N is the multiplication ratio. For a divider N = M / D where M is the harmonic of the divider output and D is the division ratio. For example, in the multiplier output PM spectrum was -56 dBm as shown above before multiplication the 2nd harmonic PM spectrum would be 6 dB higher (-56 dBm + $20\operatorname{Log}(2)$) or -50 dBm. Likewise the 4th harmonic PM spectrum would be -44 dBm (-56 dBm + $20\operatorname{Log}(4)$). For a divide by 2 device the divide by 2 PM spectrum would be -62 dBm (-56 dBm + $20\operatorname{Log}(1/2)$) and the 4th harmonic to the divide by 2 device would have PM spectrum at -50 dBm (-56 dBm + $20\operatorname{Log}(4/2)$).

The following figures and input and output spectrum from a digital divider whose division ratio is 2 and the output power is +5 dBm.



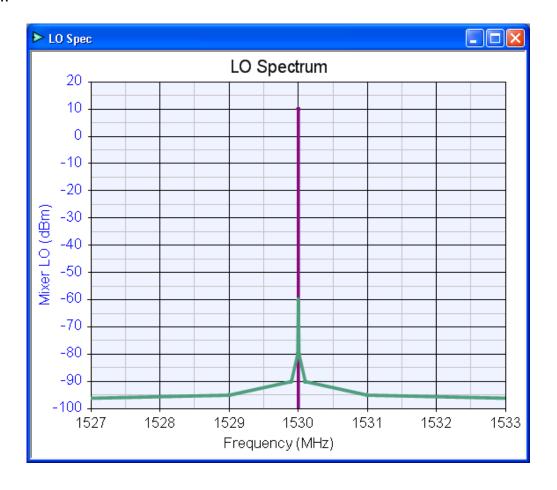


1. William F. Egan (2000), "Frequency Synthesis by Phase Lock", 2nd Ed., John Wiley & Sons, pp. 71-78s

Behavioral Phase Noise

The SPARCA engine supports behavioral phase noise. Phase noise can be specified on certain source and oscillator models. Phase noise is an independent type of spectrum and as such measurements can operate on this spectrum in the presence of others spectrums of different types. This independence allows phase noise to be modified through mixers, multipliers, and dividers without affecting the parent spectrum. This is illustrated in the figure below where the signal spectrum type is shown in one color and the phase noise in another.

NOTE: Phase noise must be enabled on the 'Calculate' tab of the system analysis AND enabled on the source model.



Phase Noise Specification

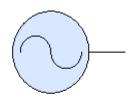
Phase noise is specified by two lists.

- A list of frequency offsets
- A list of power levels in dBc/Hz

Phase noise can also be specified single or double sided. If double sided negative offset frequencies must be used.

NOTE: There must be the same number of entries in both frequency and amplitudes lists. If not a warning will be issued and the lists will be truncated to the smaller of the two lists.

The following example shows the single sided specification of an oscillator. In this example, phase noise is specified for -70, -90, -100, -105, and -110 dBc/Hz for the respective offset frequencies of 1, 10, 100, 1000, 10000 kHz. The carrier center frequency is 1530 MHz.



Osc F=1530MHz

Foff=1;10;100;1000;10000KHz PhaseN=-70;-90;-100;-105;-110dB10

The list data does not need to occur in ascending frequency order, though this is a more likely readable format. However, the first frequency entry will be associated with the first phase noise power level entry, the 2nd frequency entry with the 2nd phase noise power level entry, etc, etc.

Enabling Phase Noise

Phase noise must be enable in two places before phase noise spectrums will propagate through the analysis.

- In the source itself (see the phase noise enable parameter)
- In the system analysis

Phase Noise Simulation

Each phase noise spectrum is associated with a parent signal spectrum. The phase noise goes through the same transfer function as its parent. Through all linear models the phase noise will be transformed as is the signal spectrum. Through nonlinear models the phase noise may remain the same or increase or decrease in amplitude relative to its parent spectrum. For example, through a frequency doubler the phase noise will increase 6 dB relative to its parent spectrum.

Phase noise is also processed by the mixer. Mixed output spectrum inherit the phase noise of the LO. When input spectrum have phase noise and there is no LO phase noise specified then the mixed spectrum will retain the phase noise of the input spectrum.

Phase Noise Coherency

The coherency of the phase noise is the same as the coherency of the parent spectrum.

Viewing Phase Noise Data

In graphs phase noise is always displayed in dBm/Hz even though the channel measurement bandwidth is something other than 1 Hz. However, when the mouse is placed over the phase noise bandwidth scaling and other information it provided as shown below.

```
IF Output (P2)
219.1MHz, -170.176dBm
Phase Noise at Carrier 70.0 dBc/Hz
Bandwidth Adjustment 53.0 dB
{3}[(Interferer)-Osc],Interferer,Splitter,Mixer,Filter
```

The absolute frequency point with its power in a 1 Hz bandwidth is displayed. The phase noise power at the carrier frequency is displayed in dBc/Hz. The bandwidth scaling factor (20 Log(Channel Bandwidth)) is also displayed. The last line shows the spectrum coherency number in braces then the phase noise equation in square brackets followed by the path that the phase noise took to get to the view destination.

Before any of the phase noise path measurements are made the phase noise is scaled to the appropriate bandwidth before spectrum identification begins.

Spectrum Analyzer Display

The spectrum analyzer mode is a display tool to help the user visualize what the simulation would like on a spectrum analyzer. This mode is extremely useful when out of phase signals may cause the total spectrum to cancel.

NOTE: This mode is NOT used for any path measurement data and is for display purposes only. The parameters used in this mode have NO bearing on the accuracy of the real simulation results.

The spectrum analyzer mode performs a convolution of a 5 pole gaussian filter on the total spectrum trace. A gaussian filter is used because this is the type of filter used in real spectrum analyzers.



The challenges associated with convolving the spectrum is as follows.

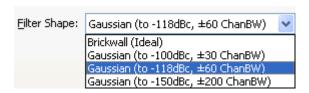
• Because of broadband noise frequencies can literally go from DC to daylight

- Frequencies are not evenly spaced
- Spectrums generally appear in groups with larges spacing between groups

Because of practical issues associated with performing a convolution several parameters have been added to this mode to decrease the simulation time and restrict the amount of collected data.

Filter Shape

The user can use a brick wall filter or the traditional spectrum analyzer gaussian filter. The variations in gaussian filters are used to determine frequency at which the convolution will begin and end. These values are specified in terms of channel bandwidths. Obviously, the wider the filter end frequency is the longer the simulation time will be and the more data will be collected. The amplitude range of the filter that is associated with the given end frequency is also given for convenience.



The analyzer modes settings are found on the 'Composite Spectrum' tab of the system analysis.

Analyzer Simulation Process

The analyzer goes through the following steps before the analyzer trace is ready to display in a graph.

- 1. The total spectrum trace for the path is created.
- 2. This spectrum is broken down into bands to find groups of spectrums. Each group will have guard bands equivalent to the stop band of the selected filter.
- 3. Before the convolution occurs the group must be discretized. Since some spectrums have bandwidths as small as 1 Hz they can be completed ignored during a standard discretization process. To eliminate skipped spectrum the discretization process will keep track of peak spectrum values that may fall in between discretization points. This process guarantees that peaks will not be missed.
- 4. The analyzer noise floor will be added.
- 5. The discretized spectrum will be convolved with the gaussian filter.

Simulation

- 6. Noise randomization is added.
- 7. Analyzer spectrum will be displayed on a graph.

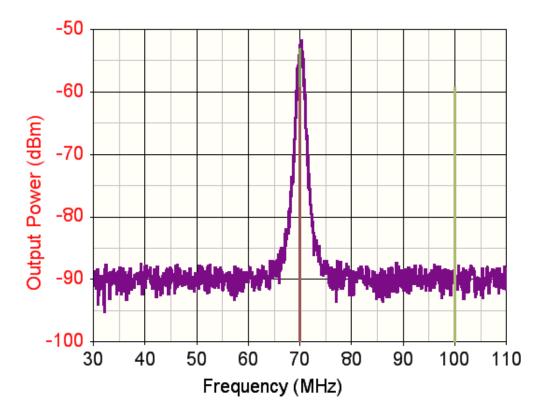
NOTE: Noise floor spectrums between spectrum groups is not shown in the spectrum analyzer mode.

Frequency Limits

Frequency limits have been added as a simulation speedup. There is a lot of data and simulation time required for the analyzer mode especially as the frequency ranges become very large. The users can specify a frequency band of interest to apply the spectrum analyzer mode to. These settings require a start, stop, and step frequency. The step frequency can be set within a given range. Warnings will be given to the user if the step size becomes so small that maximum number of analyzer simulation points are exceeded. On the other end of the range, a warning will also be given if the step size becomes so large that the accuracy has been compromised. In these cases the analyzer will select a good default.

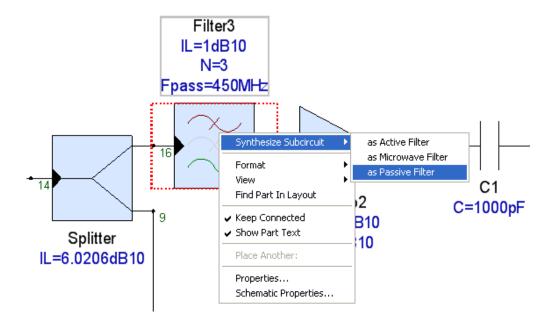
Example

The following figure shows a good example of the spectrum analyzer mode. This plot is taken from an 'Image Rejection Mixer' example where 2 signals at 70 MHz add coherently to give an increase of 6 dB and where 2 signals at 100 MHz are 180 degrees out of phase and thus cancel. Using the spectrum analyzer mode we quickly see the peak at 70 MHz and even though we see the individual spectrums at 100 MHz we know their total must be equivalent to or lower than the noise floor. Random noise is also shown in the example.

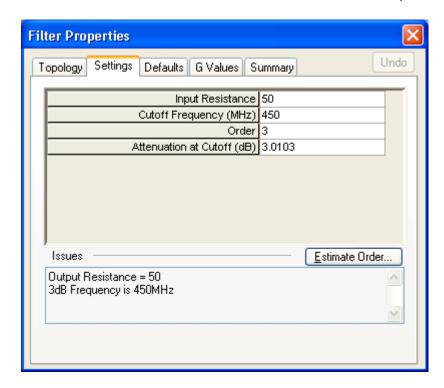


Synthesis

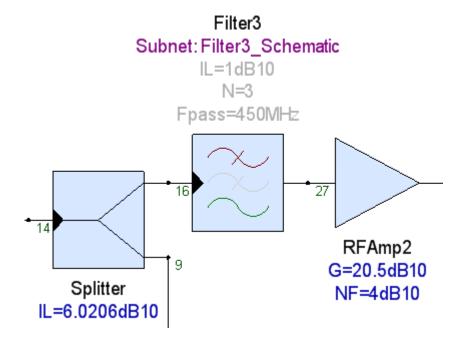
Some behavioral models can directly synthesized from Spectrasys. Right clicking on the behavioral model will bring a context sensitive menu. This menu will list the synthesis modules available for the given model.



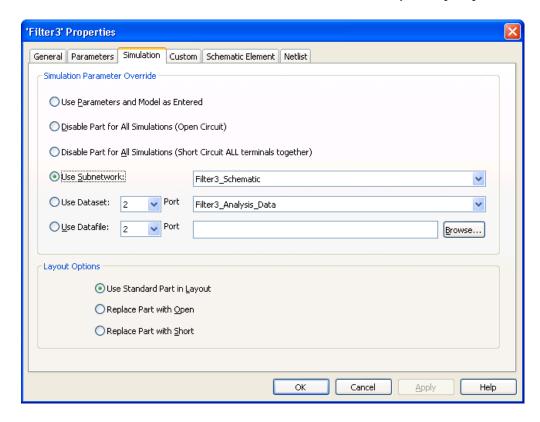
The selected synthesis module will be invoked and the parameters of the behavioral model will be passed to this synthesis module as shown below.



Once the model has been synthesized the synthesized circuit is substituted back into the behavioral model.



At this point the parameters for the behavioral model will be disabled.



See the specific synthesis section for more information about each synthesis tool.

Directional Energy (Node Voltage and Power)

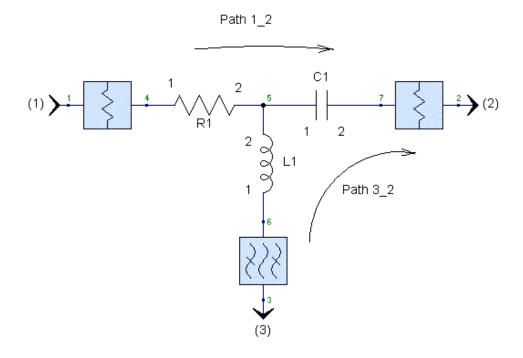
When three or more connections occur at a node a convention must be established in order to make sense of the information along path.

NOTE: The path value reported for a node along a path that has more than three or more elements is the value seen by the series element in the path entering the node.

For example, in the following example we have defined two paths 'Path1_2' which is the path from node 1 to node 2 and 'Path3_2' which is the path from node 3 to node 2. On a level diagram or in a table the value reported at node 5 for 'Path1_2' would be the value of the measurement leaving terminal 2 of the resistor R1 entering node 5. Likewise, the impedance seen along this path is that seen looking from terminal 2 of the resistor R1 into node 5. Consequently, the impedance seen by R1 is the L1 to port 3 network in parallel with the C1 to port 2 network. In a similar manner the value reported at node 5 for the 'Path3_2' would be the value of the measurement leaving terminal 2 of inductor L1 entering node 5. The impedance for the node looking from terminal 2 of inductor L1 is most likely to be completely different from the impedance seen by R1 or even C1 because from the inductors perspective, the R1 to port 1 network is in parallel with the C1 to port 2 network.

SPECTRASYS knows about the direction of all of the paths and will determine the correct impedance looking along that path. As a result all measurements contain the correct values as seen looking along the path of interest.

Remember, absolute node impedance and resulting measurements based on that impedance don't make any sense since they are totally dependent on the which direction is taken through the node.



Transmitted Energy

When an incident propagating wave strikes a boundary of changing impedances a transmitted and reflected wave is created. Obviously, the transmitted wave is only the energy of the wave flowing in the forward direction. The SPARCA engine calculates the transmitted wave ONLY from the incident wave. This transmitted energy is what is used for all path measurements.

See 'No Attenuation Across a Filter' for an illustration of this principle.

Increasing Simulation Speed

There are several options available to increase the simulation speed of Spectrasys.

NOTE: For additional understanding of why these parameters affect the speed of the simulation see 'Propagation Basics'.

Loops

The larger the gain around a closed loop the longer it will take for spectrums to fall below the 'Ignore Spectrum Level Below' threshold. Furthermore, more data is collected each time spectrums are propagated around a loop.

A quick test to verify if this is the problem with the simulation is to increase the isolation of one of the main elements in the loop to a very high value, like 200 or 300 dB. This will force loop spectrum to fall below the 'Ignore Spectrum Level Below' threshold.

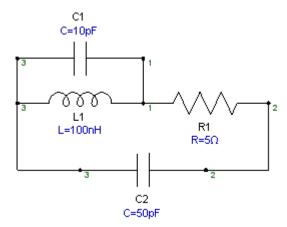
Ignore Spectrum

There are 3 Ignore spectrum parameters that affect the simulation speed and the amount of data collected. They are 1) 'Ignore Spectrum Level Below', 2) 'Ignore Spectrum Frequency Below', and 3) 'Ignore Spectrum Frequency Above'. These parameters can be changed to reduce the frequency range and amplitude dynamic range for which the simulator is collecting and analyzing the data. The biggest speed improvement usually comes from raising the 'Ignore Spectrum Level Below' threshold.

Tight Loops

The more nodes and elements in a design, the more spectrums that will be created and propagated. Linear elements formed in tight loops should be moved to a subcircuit and called from the parent design. If **only** linear elements exist in the a subcircuit a linear analysis is used for the subcircuit instead of the spectral propagation engine. If the system simulator finds a nonlinear behavioral model on the subcircuit the spectral propagation engine will be used.

For example, a circuit such as the following should be moved to a **LINEAR ONLY** subcircuit.



Intermods

One of the largest time consuming operations in Spectrasys is the calculation of a large number of intermods. The number of intermods generated is determined by the 'Maximum Order' of intermods and the number of carriers used to create the intermods. Besides reducing the maximum intermod order raising the 'Ignore Spectrum Level Below' threshold will eliminate all intermods below this threshold.

Spectrum Analyzer Display Mode

During the system simulation an analyzer trace will be created for every node in the system. Consequently, for systems with large number of nodes the integrated analyzer traces alone can be time consuming if the analyzer properties are not optimized. The simulation speed can be reduced by a careful selection of "Analyzer Mode" settings. If large frequency ranges are integrated with a small resolution bandwidth then the amount of data collected will be much larger and the simulation speed will decrease. Furthermore, enabling the 'Randomize Noise' feature may also slow down the simulation. In order to increase the simulation speed with the 'Analyzer Mode' enabled the user can disable the 'Randomize Noise' feature, increase the 'Resolution Bandwidth', and/or limit the frequency range over which a spectrum analyzer trace will be created. See the 'Spectrum Analyzer Display' section for additional information.

Paths

The more paths contained in the simulation the longer it will take to simulate and the more data that will be collected. Delete all unnecessary paths.

Noise

The more noise points that are simulated, generally the longer it takes the simulation to run. See 'Broadband Noise' and 'Cascaded Noise Analysis' sections for additional information on controlling noise.

Mixers

The more LO Signals used or the higher the 'Maximum Order' to create new mixed spectrum the longer simulation time and more data that will be collected. The number of LOs used in the simulation can be reduced to increase the simulation speed. The intermod 'Maximum Order' can be decreased to reduce the number of spectrums created.

Reducing the File Size

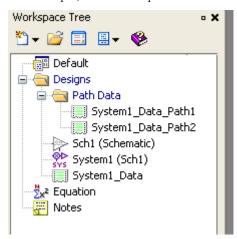
Most of the size of a file is due to simulated data.

The file size can be reduce in one of two ways: 1) completely removing the datasets and 2) only keeping the node data of interest.

Completely Removing Datasets

- 1. Closing all graphs and tables (this will keep these items from complaining when they have no data to show).
- 2. Deleting all system analysis and path datasets. Be sure to include all those associated with sweeps. NOTE: Be careful not to delete static data like S parameters and other data that doesn't change during the simulation.
- 3. Save the file.

For example, if the workspace tree was:

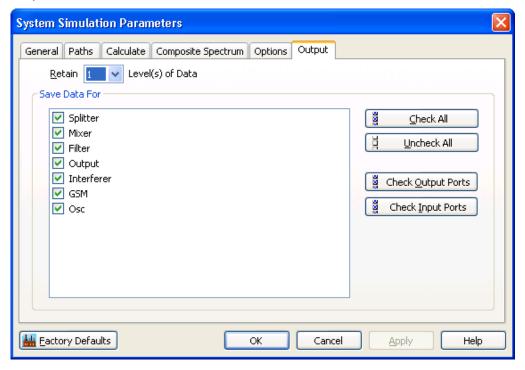


Then the file size could be reduced by deleting:

- System1_Data_Path1
- System1_Data_Path2
- System1_Data

Keeping Node Data of Interest

The node data that the simulator retains is controlled on the 'Output Tab' of the system analysis.



Only checking the devices of interest will reduce the file size.

NOTE: Even though some devices are not checked all data for these devices are calculated during the simulation. These output options only affect the data being saved to the system analysis dataset.

Measurements

Spectrasys Measurement Index

Spectrasys measurements are broken up into 3 groups General, Power and Voltage.

Spectrasys General Measurements

Name	Description	Syntax	Spectrum Type	Equation
ACF	Adjacent Channel Frequency	ACF(Side, iChanNo)	None	
		Side: U or L – Upper / Lower		
		iChanNo: any int > 0		
CF	Channel Frequency	CF	None	
OCF	Channel Frequency (Offset)	OCF	None	
DCR	Desired Channel Resistance	DCR	Desired	Average resistance at CF
	Group Delay			
ICF	Interferer Channel Frequency	ICF	None	
IMGF	Image Channel Frequency	IMGF	None	

Spectrasys Power Measurements

Name	Description	Syntax	Spectrum Type	Equation
ACP	Adjacent Channel Power	ACP(Side, iChanNo)	Total	Channel power at ACF(Side, Chan No)
AN	Added Noise Power	AN	Same as CNF	AN[i] = CNF[i] - CNF[i-1], Where $AN[0] = 0 dB$
CNR	Carrier to Noise Ratio	cnr(DCP, CNP)	Same as DCP & CNP	CNR[i] = DCP[i] - CNP[i]
CNDR	Carrier to Noise and Distortion Ratio	cndr(DCP, NDCP)	Same as DCP & NADP	CNDR[i] = DCP[i] - NDCP[i]

CGAIN	Cascaded Gain	cgain(X)	Same as X	CGAIN[i] = X[i] - X[0]
CNF	Cascaded Noise Figure	cnf (DCP, CNP)	Same as CNP	CNF[i] = CNP[i] - CNP[0] – cgain(DCP)[i]
CCOMP	Cascaded Compression Point	ССОМР	None	CCOMP[i] = Summation(COMP[i]) from 1 to i dB
CNP	Channel Noise Power	CNP	Noise	Noise power at CF
COMP	Compression Point	COMP	None	Calculated compression of each stage
СР	Channel Power	СР	Total	Total power at CF
DCP	Channel Power (Desired)	DCP	Desired	Desired power at CF
OCP	Channel Power (Offset)	ОСР	Total	Total power at OCF
GAIN	Power Gain	gain(X)	Same as X	GAIN[i] = $X[i] - X[i-1]$, Where GAIN[0] = 0 dB
IIP	Input Intercept Point (All Orders)	iip(OIP, ICGAIN)	Same as OIP & ICGAIN	IIP[i] = OIP[i] - ICGAIN[i], where OIP and IIP contain all orders
IIP2	2 nd Order Input Intercept Point	iipn (IIP, 2)	Same as IIP	IIP for 2 nd Order
IIP3	3 rd Order Input Intercept Point	iipn (IIP, 3)	Same as IIP	IIP for 3 rd Order
IP1DB	Input 1 dB Compression Point	ip1db(DCP, SDR)	Same ast DCP & SDR	IP1DB[i] = DCP[1] + min(SDR[i]) dBm
RX_IIP	Input Intercept Point (Receiver) (All Orders)	rx_iip(RX_OIP, CGAIN)	Same as RX_OIP & CGAIN	RX_IIP[i] = RX_OIP[i] - CGAIN[i], where RX_OIP and IIP contain all orders
RX_IIP2	Receiver 2 nd Order Input Intercept Point	iipn(RX_IIP, 2)	Same as RX_IIP	RX_IIP for 2 nd Order
RX_IIP3	Receiver 3 rd Order Input	iipn(RX_IIP, 3)	Same as RX_IIP	RX_IIP for 3 rd Order

	Intercept Point			
ICGAIN	Interferer Cascaded Gain	cgain(ICP)	Same as ICP	ICGAIN[i] = ICP[i] - ICP[0]
ICP	Interferer Channel Power	ICP	Desired	Interferer power at ICF
IGAIN	Interferer Gain	gain(ICP)	Same as ICP	IGAIN[i] = ICP[i] – ICP[i-1], Where IGAIN[0] = 0 dB
IMGNP	Image Channel Noise Power	IMGNP	Noise	Noise power at IMGF
IMGP	Image Channel Power	IMGP	Total	Total power at IMGF
IMGNR	Image Channel Noise Rejection	imgnr(CNP, IMGNP)	Same as CNP & IMGNP	IMGNR[i] = CNP[i] - IMGNP[i]
IMGR	Image Channel Rejection	imgr(DCP, IMGP)	Same as DCP & IMGP	IMGR[i] = DCP[i] - IMGP[i]
MDS	Minimum Detectable Signal	mds(CNP, CNF)	Same as CNP & CNF	MDS[i] = CNP[0] + CNF[i]
NDCP	Noise and Distortion Channel Power	ndcp(CNP, TIMP, PNCP)	Same as PNCP, CNP, & TIMP	NDCP[i] = PNCP[i] + CNP[i] + TIMP[i]
OIP	Output Intercept Point (All Orders)	oip(ICP, DELTA)	Same as ICP	OIP[i] = ICP[i] + Delta[i] / (Order-1) Delta[i] = ICP[i] – TIMCP[i]
OIP2	2 nd Order Output Intercept Point	oipn(OIP, 2)	Same as OIP	OIP for 2 nd Order
OIP3	3 rd Order Output Intercept Point	oipn(OIP, 3)	Same as OIP	OIP for 3 rd Order
OP1DB	Output 1 dB Compression Point	op1db(DCP, SDR)	Same as DCP & SDR	OP1DB[i] = DCP[LastStage] + min(SDR[i]) dBm

RX_OIP	Output Intercept Point (Receiver) (All Orders)	rx_oip(VTCP, DELTA)	Same as VTCP	OIP[i] = VTCP[i] + Delta[i] / (Order-1) Virtual Tone Channel Power[i] = ICP[0] + CGAIN[i]
				Delta[i] = VTCP[i] - TIMCP[i]
RX_OIP2	Receiver 2 nd Order Output Intercept Point	oipn(RX_OIP, 2)	Same as RX_OIP	RX_OIP for 2 nd Order
RX_OIP3	Receiver 3 rd Order Output Intercept Point	oipn(RX_OIP, 3)	Same as RX_OIP	RX_OIP for 3 rd Order
PNCP	Phase Noise Channel Power	PNCP	Phase Noise	Phase noise power at CF
PRNF	Percent Noise Figure	PRNF	Same as AN & CNF	PRNF[i] = AN[i]/CNF[iLastStage]
PRIM	Percent Intermods (All Orders)	prim(GIMCP, ICGAIN, TIMCP)	Same as GIMP, CGAIN, & TIMP	IMREF = GIMCP[i] + (CGAIN[iLastStage] - CGAIN[i]) PRIM[i] = IMREF[i]/TIMP[iLastStage](this is a ratio in Watts), Where PRIM[0] = 0 %
PRIM2	Percent 2 nd Order Intermods	primn(PRIM, 2)	Same as PRIM	See PRIM
PRIM3	Percent 3 rd Order Intermods	primn(PRIM, 3)	Same as PRIM	See PRIM
SFDR	Spurious Free Dynamic Range	SFDR	Same as IIP3 & MDS	SFDR[i] = 2/3 [IIP3[i] - MDS[i]]
RX_SFDR	Receiver Spurious Free Dynamic Range	RX_SFDR	Same as RX_IIP3 & MDS	RX_SFDR[i] = 2/3 [RX_IIP3[i] - MDS[i]]
SDR	Stage Dynamic Range	SDR	Same as TNP	SDR[i] = SOP1DB[i] - TNP[i]
SGAIN	Stage Gain	SGAIN	None	Stage entered value
SNF	Stage Noise Figure	SNF	None	Stage entered value

Spectrasys (System)

SIP1DB	Stage Input 1 dB Compression Point	sip1db(SOP1DB, SGAIN)	Same as SOP1DB & SGAIN	SIP1DB[i] = SOP1DB[i] – SGAIN[i]
SIIP	Stage Input Intercept Point (All Orders)	siip(SOIP, SGAIN)	Same as SOIP & SGAIN	SIIP[i] = SOIP[i] – SGAIN[i]
SIIP2	Stage 2 nd Order Input Intercept Point	sipn(X, 2)	None	SIIP for 2 nd Order
SIIP3	Stage 3 rd Order Input Intercept Point	sipn(X, 3)	None	SIIP for 3 rd Order
SIPSAT	Stage Input Saturation Point	sipsat(SOPSAT, SGAIN)	Same as SOPSAT & SGAIN	SIPSAT[i] = SOPSAT[i] – SGAIN[i]
SOP1dB	Stage Output 1 dB Compression Point	SOP1dB	None	Stage entered value
SOIP	Stage Output Intercept Point (All Orders)	SOIP	None	Stage entered value
SOIP2	Stage 2 nd Order Output Intercept Point	SOIP2	None	Stage entered value
SOIP3	Stage 3 rd Order Output Intercept Point	SOIP3	None	Stage entered value
SOPSAT	Stage Output Saturation Point	SOPSAT	None	Stage entered value
CIMCP	Intermod Channel Power (Conducted) (All Orders)	CIMCP	Same as TIMP & DCP	CIMCP[i] = TIMP[i-1] + gain(DCP)[i], Where CIMCP[0] = - 300 dBm
CIMCP2	2 nd Order Conducted Intermod	cimcpn(CIMCP, 2)	Same as CIMCP	CIMCP for 2 nd Order

Simulation

	Power			
CIMCP3	3 rd Order Conducted Intermod Power	cimcpn(CIMCP, 3)	Same as CIMCP	CIMCP for 3 rd Order
GIMCP	Intermod Channel Power (Generated) (All Orders)	GIMCP	Generated Intermod	Generated intermod power at CF for all orders
GIMCP2	2 nd Order Generated Intermod Power	gimcpn(GIMCP, 2)	Same as GIMCP	GIMCP for 2 nd Order
GIMCP2	3 rd Order Generated Intermod Power	gimcpn(GIMCP, 3)	Same as GIMCP	GIMCP for 3 rd Order
TIMCP	Intermod Channel Power (Total) (All	TIMCP	Total Intermod Order N	Total intermod power for all orders at CF
	Orders)			
TIMCP2	Orders) Total 2 nd Order Intermod Channel Power	TIMCP, 2)	Same as TIMCP	TIMCP for 2 nd Order
TIMCP2 TIMCP3	Total 2 nd Order Intermod	TIMCP, 2)		TIMCP for 2 nd Order TIMCP for 3 rd Order
	Total 2 nd Order Intermod Channel Power Total 3 rd Order Intermod	timcpn(TIMCP, 3)	TIMCP Same as	
TIMCP3	Total 2 nd Order Intermod Channel Power Total 3 rd Order Intermod Channel Power Total Intermod	timcpn(TIMCP, 3)	TIMCP Same as TIMCP Total	TIMCP for 3 rd Order

Spectrasys Voltage Measurements

Name	Description	Syntax	Spectrum Type	Equation
CV	Channel Voltage	CV	Total	Average voltage at CF
CGAINV	Cascaded Voltage Gain	cgain(DCV)	Same as DCV	CGAINV[i] = DCV[i] – DCV[0]
CNRV	Carrier to Noise Voltage Ratio	cnr(DCV, CNV)	Same as DCV and CNV	CNRV[i] = DCV[i] - CNV[i]
CNV	Channel Noise Voltage	CNV	Noise	Average noise voltage in the channel
DCV	Channel Voltage (Desired)	DCV	Desired	Desired average voltage at CF
GAINV	Voltage Gain	gain(DCV)	Same as DCV	GAINV[i] = DCV[i] – DCV[i-1], Where GAINV[0] = 0 dB
ICV	Interferer Channel Voltage	ICV	Desired	Average interferer voltage at ICF
NNV	Node Noise Voltage	NNV	Noise	Peak average noise voltage at the node
OCV	Offset Channel Voltage	OCV	Total	Average voltage at OCF
PNCV	Phase Noise Channel Voltage	PNCV	Phase Noise	Average phase noise voltage at CF
SIIV	Stage Input Voltage Intercept Point (All Orders)	siiv(SOIV, SVGAIN)	Same as SOIV and SVGAIN	SIIV[i] = SOIV[i] - SVGAIN[i]
SIIV2	Stage 2 nd Order Input Voltage Intercept Point	sivn(SIIV, 2	None	SIIV for 2 nd Order
SIIV3	Stage 3 rd Order Input Voltage Intercept Point	sivn(SIIV, 2)	None	SIIV for 3 rd Order
SIV1DB	Stage Input 1 dB Voltage Compression Point	siv1db(SOV1DB, SVGAIN)	Same as SOV1DB and SVGAIN	SIV1DB[i] = SOV1DB[i] - SVGAIN[i]

Simulation

SIVSAT	Stage Input Voltage Saturation Point	sivsat(SOVSAT, SVGAIN)	Same as SOVSAT and SVGAIN	SIVSAT[i] = SOVSAT[i] - SVGAIN[i]
SOIV	Stage Output Voltage Intercept Point (All Orders)	SOIV	None	Stage Entered Intercept Point
SOIV2	Stage 2 nd Order Output Voltage Intercept Point	sivn(SOIV, 2	None	Stage Entered Intercept Point
SOIV3	Stage 3 rd Order Input Voltage Intercept Point	sivn(SOIV, 3)	None	Stage Entered Intercept Point
SOV1DB	Stage Output 1 dB Voltage Compression Point	SOV1dB	None	Stage Entered Compression Point
SOVSAT	Stage Output Voltage Saturation Point	SOVSAT	None	Stage Entered Output Saturation Voltage
SVGAIN	Stage Voltage Gain	SVGAIN	None	Stage Entered Voltage Gain
SVNI	Equivalent Input Noise Voltage	SVNI	None	Conversion from stage entered noise figure
TNV	Total Node Voltage	TNV	Total	Peak average voltage at the node
VDC	DC Voltage	VDC	Total	DC voltage
VNI	Equivalent Input Noise Voltage	NFtoVNI (CNF, DCR, Temperature)	Same as CNF and DCR	VNI[i] = NFtoVNI(CNF[i], DCR[i], Temperature)

General

Adjacent Channel Frequency (ACF[U or L][n])

This measurement is the frequency of the specified adjacent channel. All adjacent channel frequencies are relative to the main 'Channel Frequency'. Consequently, channels exist above and below the main reference channel frequency. The user can specify which side of the main or reference channel that the adjacent channel is located on and also the channel number. The channel number is relative to the main or reference

channel. Therefore, channel 1 would be the first adjacent channel, channel 2 would be the second adjacent channel, and so on.

- U Upper Side
- L Lower Side
- n Channel Number (any integer > 0)

For example, ACFU1 if the first adjacent channel above that specified by the 'Channel Frequency'. If CF was 100 MHz and the channel bandwidth was 1 MHz then the main channel would be 99.5 to 100.5 MHz. Consequently, then ACFU1 would then be the channel 100.5 to 101.5 MHz and ACFL1 would be 98.5 to 99.5 MHz.

NOTE: Only the first 2 adjacent channels on either side of the reference channel is listed in the 'Measurement Wizard". However, there is no restriction on the Adjacent Channel Number.

Channel (or Path) Frequency (CF)

Since each spectrum can contain a large number of spectral components and frequencies Spectrasys must be able to determine the area of the spectrum to integrate for various measurements. This integration area is defined by a 'Channel Frequency' and a 'Channel Measurement Bandwidth' which become the **main channel** for the specified path. Spectrasys can automatically identify the desired 'Channel Frequency' in an unambiguous case where only one frequency is on the 'from node' of the designated path. An error will appear if more than one frequency is available. For this particular case the user must specify the intended frequency for this path in the 'System Simulation Dialog Box'.

A 'Channel Frequency' exists for each node along the specified path. Consequently, each node along the path will have the same 'Channel Frequency' until a frequency translation element such as a mixer or frequency multiplier is encountered. Spectrasys automatically deals with frequency translation through these elements. The individual mixer parameters of 'Desired Output (Sum or Difference)' and 'LO Injection (High of Low)' are used to determine the desired frequency at the output of the mixer.

The 'Channel Frequency' is a critical parameter for Spectrasys since most of the measurements are based on this parameter. If this frequency is incorrectly specified then the user may get unexpected results since many measurements are based on this frequency.

The easiest way to verify the 'Channel Frequency' that Spectrasys is using is to look at this measurement in a table or the dataset.

Offset Channel Frequency (OCF)

The 'Offset Channel Frequency' and 'Offset Channel Power' are very useful measurements in Spectrasys. These measurements give the user the ability to create a user defined channel relative the main channel. The user specifies both the 'Offset Frequency' relative to the main 'Channel Frequency' and the 'Offset Channel Bandwidth'. As with the

'Channel Frequency' measurement Spectrasys automatically deals with the frequency translations of the 'Offset Channel Frequency' through frequency translations elements such as mixers and frequency multipliers. Both the 'Offset Frequency' and the 'Offset Channel Bandwidth' can be tuned by creating a variable for each of these parameters. This measurement simply returns the 'Offset Channel Frequency' for every node along the specified path.

Desired Channel Resistance (DCR)

This measurement is the desired average resistance across the main channel along the specified path. This is not the magnitude of the impedance but its real part.

This measurement includes ONLY DESIRED SIGNALS on the beginning node of the path, traveling in FORWARD path direction. All other intermods, harmonics, noise, and phase noise signals are ignored.

Note: A 'D' is placed next to the equation in the identifying flyover help in a spectrum plot to indicate desired signals.

For example, if the 'Channel Measurement Bandwidth' was specified to .03 MHz and the 'Channel Frequency' was 220 MHz then the DCR is the average resistance from 219.985 to 220.015 MHz. This resistance measurement will not even be affect by another 220 MHz signal traveling in the reverse direction even if it is much larger in amplitude.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: ONLY DESIRED SIGNALS

Travel Direction: Only in the FORWARD direction

Group Delay (System)

This section will demonstrate how to measure group delay in Spectrasys.

BACKGROUND

"Group Delay measures the differential time delay caused by a filter, i.e., it indicates if certain frequency components will be delayed more than other components and by how much" (Radio Receiver Design, Kevin McClaning and Tom Vito, Noble Publishing, pg 174)

Spectrasys has the ability to show group delay results, including across frequency translations, by using a wide carrier source and the linear simulator. The group delay measurement function will then be applied to any path voltage gathered by Spectrasys.

The path voltage in Spectrasys is equivalent to the voltage gain E21. To convert E21 to S21 for group delay calculation the following equation must be used:

Sij = Eij * (conj(ZPortj) + ZPortj * Sjj) / (ZPorti * sqrt(real(ZPortj) / real(ZPorti)), where ZPort is the port impedance the circuit sees.

For ZPorti = ZPortj = R + j0

```
Then
Sij = Eij * (1 + Sjj)
or
S21 = E21 * (1 + S11)
```

Since Spectrasys doesn't have an S11 measurement the linear simulator must be used. A frequency vector can be retrieved from the Spectrasys path dataset so that the frequencies gathered by the linear simulator are the same as those used in Spectrasys.

STEPS FOR GROUP DELAY MEASUREMENT

- Add a wideband signal source. The bandwidth should be wide enough to cover the group delay range of interest. Caution must be exercised when setting the carrier power since a wideband carrier can easily drive non-linear devices into saturation. Note: A multisource can be used here and the number of points for the wideband carrier can be specified per source.
- Increase the number of simulation points for the carrier on the 'General' tab of
 the System Analysis. The default number of simulation points per carrier is 2.
 Note: This will increase the number of simulation points used by all spectrums
 derived from the source spectrum and will increase the simulation time and file
 size.
- 3. Add a path to the System Analysis on the 'Path' tab.
- 4. Include option "Add Powers, Voltages, and Impedances to Path Dataset" located on the 'Edit/Add Path' dialog box of the System Analysis.
- 5. Add a linear analysis so the S11 of the system can be determined.
- 6. Place the Spectrasys path frequency vector (i.e. 'F2_Desired' in the 'System1_Data_Path1' dataset) in the 'List of Frequencies' used by the linear analysis so S11 will be determined at the same frequencies as the Spectrasys path voltages.
- 7. S21 for the system will need to derived from the equation relating E21 to S21, where the desired Spectrasys path voltage at the output node is equivalent to E21. Copy the following equation block code to the equation block in the workspace. This code assumes the output node is named "2". The path frequency vector in the linear analysis and the voltage vector in the equation block must be change if the output node is other than 2 (i.e if the output node was 6 then 'F6_Desired' would be used in the linear analysis and 'V6_Desired' would be used in the equation block.
- 8. Use the group delay function 'gd(SystemS21)' to plot the group delay.

Equation Block Code

```
using( "System1_Data_Path1" )
'------ Convert Spectrasys E21 (V2_Desired) to S21 ------
```

```
SystemS21 = V2_Desired * (1 + [Linear1_Data].S11) setunits("SystemS21", "dB") 'Set the units to dB

GroupDelay = gd(SystemS21) 'Get the group delay
```

NOTE: See Spectrasys group delay examples that ship with the product for illustration of this.

Interferer Channel Frequency (ICF)

This measurement is the frequency of the interferer used for intermod measurements such as: IIP, OIP, SFDR, etc.. The 'Interferer Channel Frequency' is determined set on the 'Calculate Tab' of the System Analysis Dialog Box.

As with other frequency measurements Spectrasys is able to deal with frequency translation through mixers, frequency multipliers, etc.

Image Frequency (IMGF)

This measurement is the image frequency from the input to the first mixer.

Since Spectrasys knows the 'Channel Frequency' of the specified path it also has the ability to figure out what the image frequency is up to the 1st mixer. After the 1st mixer the 'Image Frequency' measurement will show the main channel frequency. This measurement will show what that frequency is.

For example if we designed a 2 GHz receiver that had an IF frequency of 150 MHz using low LO side injection then the LO frequency would be 1850 MHz and image frequency for all stages from the input to the first mixer would be 1700 MHz.

Power

Adjacent Channel Power (ACP[U or L)[n))

This measurement is the integrated power of the specified adjacent channel. All adjacent channels are relative to the main channel (identified by the 'Channel Frequency' and 'Channel Measurement Bandwidth'). Consequently, channels exist above and below the main reference channel frequency. The user can specify which side of the main channel the adjacent channel is located on along with the channel number. The channel number is relative to the main channel. Therefore, channel 1 would be the first adjacent channel, channel 2 would be the second adjacent channel, and so on.

U - Upper Side

L - Lower Side

n - Channel Number (any integer > 0)

For example, ACPL2 is the power of the second adjacent channel below that specified by the channel frequency. If CF was 100 MHz and the channel bandwidth was 1 MHz then the main channel would be 99.5 to 100.5 MHz. Consequently, then ACPL2 would then be the integrated channel power between 97.5 and 98.5 MHz and ACPL1 would be the integrated channel power between 98.5 and 99.5 MHz.

Note: Only the first 2 adjacent channels on either side of the reference channel are listed in the 'Measurement Wizard". However, there is no restriction on the Adjacent Channel Number other than it must be non-negative and greater than or equal to 1.

This measurement is simply a 'Channel Power' measurement at the 'Adjacent Channel Frequency'.

Channel Used: Corresponding Adjacent Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CP

Travel Direction: Same as CP

Added Noise (AN)

This measurement is the noise contribution of each individual stage in the main channel along the specified path as shown by:

$$AN[n] = CNF[n] - CNF[n-1]$$
 (dB), where $AN[0] = 0$ dB, $n = stage$ number

This measurement is simply the difference in the 'Cascaded Noise Figure' measurement between the current node and the previous node. This measurement is very useful and will help the user identify the contribution to the noise figure by each stage along the path.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CNF

Travel Direction: Only spectrum traveling in the forward direction are included in this measurement

Carrier to Noise Ratio (CNR)

This measurement is the ratio of the 'Desired Channel Power' to 'Channel Noise Power' along the specified path as shown by:

CNR[n] = DCP[n] - CNP[n] (dB), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP and CNP

Travel Direction: Same as DCP and CNP

Carrier to Noise and Distortion Ratio (CNDR)

This measurement is the ratio of the 'Desired Channel Power' to 'Channel Noise and Distortion Power' along the specified path as shown by:

CNR[n] = DCP[n] - NDCP[n] (dB), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP and NDCP

Travel Direction: Same as DCP and NDCP

Cascaded Compression (CCOMP)

This measurement is the cascaded compression of each stage along the path.

CCOMP[n] = Summation(COMP[0 to n]) (dB), where n = stage number

For each stage n a summation is performed on the compression point of all previous stages.

Channel Used: Same as COMP

Types of Spectrums Used: Same as COMP

Travel Direction: Same as COMP

Cascaded Gain (CGAIN)

This measurement is the cascaded gain of the main channel along the specified path. The 'Cascaded Gain' is the difference between the 'Desired Channel Power' measurement at the nth stage minus the 'Desired Channel Power' measurement at the input as shown by:

CGAIN[n] = DCP[n] - DCP[0] (dB), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP

Travel Direction: Same as DCP

NOTE: Under matched conditions CGAIN and S21 from a linear analysis are the same. As shown in the above equation the cascaded gain at the first node by definition is 0 dB. This may not be true if there is an impedance mismatch between the source and the first model in the path. The cascaded gain measurement does not take into account this initial mismatch because cascaded gain is always assumed to be 0 dB at the first stage. This mismatch can be accounted for by taking the difference between the power level specified in the source with the 'Channel Power (CP)' at the first node and adding this value to the cascaded gain. In this case cascaded gain + source mismatch will equal S21.

Cascaded Noise Figure (CNF)

This measurement is the cascaded noise figure in the main channel along the specified path. The 'Cascaded Noise Figure' is equal to the 'Channel Noise Power' measurement at the output of stage n minus the 'Channel Noise Power' measurement at the path input and the 'Cascaded Gain' measurement at stage n as shown by:

$$CNF[n] = CNP[n] - CNP[0] - CGAIN[n]$$
 (dB), where $n = stage$ number

Caution: When wide channel bandwidths are used channel noise power and cascaded gain are affected more by VSWR and frequency effects. In this case is it extremely important that sufficient noise points are used to represent the noise in the channel of interest. Furthermore, it is very possible because of these frequency effects that the channel noise power and the cascaded gain can change in a nonlinear way so that cascaded noise figure appears to drop from a prior node. Additionally, looking at cascaded noise figure through a hybrid combining network may also be deceptive since the cascaded gain used to determine the cascaded noise figure is from the current path and not all paths in the system.

See the 'Broadband Noise' section for more information.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CNP and CGAIN

Travel Direction: Same as CNP and CGAIN

Traditional Cascaded Noise Figure

NFcascade =
$$F_1$$
 + $(F_2$ - 1) / G_1 + $(F_3$ - 1) / G_1G_2 + ... + $(F_n$ - 1) / G_1G_2 ... G_{n-1}

Note: Traditional cascaded noise figure equations are not used. The are very restrictive and suffer from the following conditions:

- Ignore effects of VSWR, frequency, and bandwidth
- Assume noise contributions are from a single path
- Ignore mixer image noise
- Can ignore effects of gain compression

The SPARCA (Spectral Propagation and Root Cause Analysis) technique used SPECTRASYS does not suffer from these restrictive assumptions. Occasionally users are troubled if SPECTRASYS simulations give different answers than the traditional approach. Using SPECTRASYS under the same assumptions as the traditional approach will always yield identical answers. To use SPECTRASYS under the same assumptions only frequency independent blocks like attenuators and amplifiers must be used. Even so, amplifiers must be used as linear devices with infinite reverse isolation. Filters cannot be used since their impedance varies with frequency. Mixers cannot be used since noise from the image band will be converted into the mixer output. Only 2 port devices must be used because of the single path assumption. Of course the bandwidth must also be very narrow.

Channel Noise Power (CNP)

This measurement is the integrated noise power in the main channel along the specified path.

For example, if the 'Channel Measurement Bandwidth' was specified to 100 kHz and the 'Channel Frequency' was 2000 MHz then the CNP is the integrated noise power from 1999.95 to 2000.05 MHz.

See comments in the 'Cascaded Noise Figure' measurement or 'Broadband Noise' section for additional insights.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY NOISE</u>

Travel Direction: Only spectrums traveling in the FORWARD path direction

Channel Bandwidth Caution: When the Channel Frequency is less than 1/2 the Channel Bandwidth the lowest integration frequency used for measurements will be 0 Hz. This will result is Channel Noise Power measurements being different than when the full bandwidth is used.

Channel Power (CP)

This measurement is the total integrated power in the main channel along the specified path.

This measurement includes ALL SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE traveling in ALL directions through the node that fall within the main channel.

For example, if the 'Channel Measurement Bandwidth' was specified to .03 MHz and the 'Channel Frequency' was 220 MHz then the CP is the integrated power from 219.985 to 220.015 MHz.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE</u>

Travel Direction: All directions through the node

Desired Channel Power (DCP)

This measurement is the total integrated power in the main channel along the specified path.

This measurement includes ONLY DESIRED SIGNALS on the beginning node of the path, traveling in FORWARD path direction. All other intermods, harmonics, noise, and phase noise signals are ignored.

Note: A 'D' is placed next to the equation in the identifying flyover help in a spectrum plot to indicate desired signals.

For example, if the 'Channel Measurement Bandwidth' was specified to .03 MHz and the 'Channel Frequency' was 220 MHz then the DCP is the integrated power from 219.985 to 220.015 MHz. This power measurement will not even be affect by another 220 MHz signal traveling in the reverse direction even if it is much larger in amplitude.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY DESIRED SIGNALS</u>

Travel Direction: Only in the FORWARD direction

Offset Channel Power (OCP)

The Offset Channel is a user defined channel relative to the main channel. The 'Offset Channel Frequency' and 'Offset Channel Bandwidth' are specified on the 'Options Tab' of the System Analysis Dialog Box. As with the 'Channel Frequency' measurement Spectrasys automatically deals with the frequency translations of the 'Offset Channel Frequency' through frequency translation devices such as mixer and frequency multipliers.

For example, if the 'Channel Frequency' was 2140 MHz, 'Offset Channel Frequency' was 10 MHz, and the 'Offset Channel Bandwidth" was 1 MHz then the OCP is the integrated power from 2149.5 to 2150.5 MHz.

This measurement is simply a 'Channel Power' measurement at the 'Offset Channel Frequency' using the 'Offset Channel Bandwidth'.

Channel Used: Offset Channel Frequency and Offset Channel Bandwidth

Types of Spectrums Used: Same as CP

Travel Direction: Same as CP

Calculated Stage Compression (COMP)

This measurement is the calculated compression point of each individual stage. This value is determined during the simulation process based on the total input power of the stage.

This measurement includes ALL SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE traveling in ALL directions through the node that fall within the main channel.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE

Travel Direction: All directions through the node

Gain (GAIN)

This measurement is the gain of the main channel along the specified path. The 'Gain' is the difference between the 'Desired Channel Power' output of the current stage minus the 'Desired Channel Power' output of the prior stage as shown by:

GAIN[n] = DCP[n] - DCP[n-1] (dB), where GAIN[0] = 0 dB, n = stage number

See the 'Desired Channel Power' measurement to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP

Travel Direction: Same as DCP

Input 1 dB Compression (IP1DB)

This measurement is the system input 1 dB compression point referenced to the path input. The value at the output of each stage represents that equivalent input compression from input to that stage output. The last entry will always be the performance of the entire chain referenced to the input.

IP1DB[n] = DCP[0] + min(SDR[n]) (dBm), where n = stage number

This measurement is made by determining the desired channel input power for the first stage and then adding to it the minimum 1 dB headroom or stage dynamic range along the path.

Channel Used: Same as DCP and SDR

Types of Spectrums Used: Same as DCP and SDR

Travel Direction: Same as DCP and SDR

Input Intercept [All Orders] (IIP)

This measurement is the intercept point referenced to the path input. This is an in-band type of intermod measurement.

```
IIP[n] = OIP[n] - CGAIN[n] (dBm), where n = stage number
```

This measurement simple takes the computed 'Output Intercept' and references it to the input by subtracting the cascaded gain. The last IIP value for a cascaded chain will always be the actual input intercept for the entire chain.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

See the 'Intermods Along a Path' section for information on how to configure these tests.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Caution: This method used to determine the intercept point is only valid for 2 tones with equal amplitude

Channel Used: Main Channel Frequency, Interferer Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as OIP and CGAIN

Travel Direction: Same as OIP and CGAIN

Input Intercept - Receiver [All Orders] (RX_IIP)

This measurement is the receiver input intercept point along the path. This is an out-of-band type of intermod measurement.

 $RX_{IIP}[n] = RX_{OIP}[n] - CGAIN[n]$ (dBm), where n = stage number

Simulation

This measurement simple takes the computed 'Output Intercept' and references it to the input by subtracting the cascaded gain. The last IIP value for a cascaded chain will always be the actual input intercept for the entire chain.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

See the 'Intermods Along a Path' section for information on how to configure these tests.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Caution: This method used to determine the intercept point is only valid for 2 tones with equal amplitude

Channel Used: Main Channel Frequency, Interferer Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as RX_OIP and CGAIN

Travel Direction: Same as RX_OIP and CGAIN

Interferer Cascaded Gain (ICGAIN)

This measurement is the interferer cascaded gain of the main channel along the specified path. The 'Interferer Cascaded Gain' is the difference between the 'Interferer Channel Power' measurement at the nth stage minus the 'Interferer Channel Power' measurement at the input as shown by:

ICGAIN[n] = ICP[n] - ICP[0] (dB), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as ICP

Travel Direction: Same as ICP

Interferer Channel Power (ICP)

This measurement is the total integrated power in the interferer channel. This power is used for intermod measurements such as: IIP3, OIP3, SFDR, etc..

This measurement is simply a 'Desired Channel Power' measurement at the 'Interferer Channel Frequency'.

Channel Used: Interferer Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP

Travel Direction: Same as DCP

Interferer Gain (IGAIN)

This measurement is the gain of the interferer (tone) channel along the specified path. The 'Gain' is the difference between the 'Interferer Channel Power' output of the current stage minus the 'Interferer Channel Power' output of the prior stage as shown by:

IGAIN[n] = ICP[n] - ICP[n-1] (dB), where IGAIN[0] = 0 dB, n = stage number

Channel Used: Interferer (Tone) Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as ICP

Travel Direction: Same as ICP

Image Channel Noise Power (IMGNP)

This measurement is the integrated noise power of the image channel from the path input to the first mixer. After the first mixer the 'Mixer Image Channel Power' measurement will show the same noise power and the main channel noise power.

For example if we designed a 2 GHz receiver that had an IF frequency of 150 MHz using low LO side injection then the LO frequency would be 1850 MHz and image frequency for all stages from the input to the first mixer would be 1700 MHz. If the receiver bandwidth was 5 MHz then the image channel would be from 1697.5 to 1702.5 MHz.

This measurement is simply a 'Channel Noise Power' measurement at the 'Image Frequency'.

Channel Used: Image Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY NOISE</u>

Travel Direction: Only spectrums traveling in the FORWARD path direction

Image Channel Power (IMGP)

This measurement is the image channel power from the path input to the first mixer. After the first mixer the this measurement will show the same power and the main channel power.

For example if we designed a 2 GHz receiver that had an IF frequency of 150 MHz using low LO side injection then the LO frequency would be 1850 MHz and image frequency for all stages from the input to the first mixer would be 1700 MHz. If the receiver bandwidth was 5 MHz then the image channel would be from 1697.5 to 1702.5 MHz. All

noise and interference must be rejected in this channel to maintain the sensitivity and performance of the receiver.

This measurement is simply a 'Channel Power' measurement at the 'Image Frequency'.

Channel Used: Image Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CP

Travel Direction: Same as CP

Image Noise Rejection Ratio (IMGNR)

This measurement is the ratio of the 'Channel Noise Power' to 'Image Channel Noise Power' along the specified path as shown by:

IMGNR[n] = CNP[n] - IMGNP[n] (dB), where n = stage number

This measurement is very useful in determining the amount of image noise rejection that the selected path provides.

For this particular measurement basically two channels exist both with the same 'Channel Measurement Bandwidth' 1) main channel and 2) 1st mixer image channel.

Channel Used: Main Channel Frequency, Image Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CNP and IMGNP

Travel Direction: Same as CNP and IMGNP

Image Rejection Ratio (IMGR)

This measurement is the ratio of the 'Channel Power' to 'Image Channel Power' along the specified path as shown by:

IMGR[n] = DCP[n] - IMGP[n] (dB), where n = stage number

For this particular measurement basically two channels exist both with the same 'Channel Measurement Bandwidth' 1) main channel and 2) 1st mixer image channel. The only difference is between these two channels are their frequencies, one is at the 'Channel Frequency' and the other is at the 'Mixer Image Frequency'.

Channel Used: Main Channel Frequency, Image Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCP and IMGP

Travel Direction: Same as DCP and IMGP

Minimum Detectable Signal (MDS)

This measurement is the minimum detectable (discernable) signal referred to the input and is equivalent to the input channel noise power plus the cascaded noise figure of the specified chain as shown by:

$$MDS[n] = CNP[0] + CNF[n]$$
 (dBm), where n = stage number

The MDS value at stage n represents the MDS of the entire system up to and including stage n. Consequently, the MDS of the entire system is the value indicated at the last stage in the path or chain. The minimum detectable signal is the equivalent noise power present on the input to a receiver that sets the limit on the smallest signal the receiver can detect.

For example, if the thermal noise power input to a receiver is -174 dBm/Hz and the channel bandwidth is 1 MHz (10 Log (1 MHz) = 60 dB) then the input channel power would be -114 dBm. For a cascaded noise figure of 5 dB the minimum detectable signal would be -109 dBm.

See the 'Channel Noise Power' measurement to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CNP and CNF

Travel Direction: Same as CNP and CNF

Noise and Distortion Channel Power (NDCP)

This measurement is the integrated noise and distortion channel power in the main channel along the specified path. The Noise and Distortion Channel Power is the sum of the 'Channel Noise Power' plus the 'Total Intermod Channel Power' plus the 'Phase Noise Channel Power' as shown by:

$$NDCP = CNP[n] + TIMP[n] + PNCP[n]$$
 (dB), where $n = stage$ number

See the above measurements to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as CNP, TIMP, and PNCP

Travel Direction: Same as CNP, TIMP, and PNCP

Output 1 dB Compression (OP1DB)

This measurement is the output 1 dB compression point along the path. The value at the output of each stage represents that output compression from input to that stage output. The last entry will always be the performance of the entire chain referenced to the ouput.

$$OP1DB[n] = DCP[LastStage] + min(SDR[n])$$
 (dBm), where $n = stage$ number

This measurement is made by determining the desired channel input power for the last stage and then adding to it the minimum 1 dB headroom or stage dynamic range along the path.

Channel Used: Same as DCP and SDR

Types of Spectrums Used: Same as DCP and SDR

Travel Direction: Same as DCP and SDR

Output Intercept - All Orders [All Orders] (OIP)

This measurement is the output intercept point along the path. This is an in-band type of intermod measurement.

OIP[n] = ICP[n] + Delta[n] (dBm), where n = stage number and Order = order of the intermod

$$Delta[n] = (ICP[n] - TIMCP[n]) / (Order - 1) (dB)$$

Delta is the difference in dB between the 'Total Intermod Channel Power' in the main channel and the interfering signal present in the 'Interferer Channel' including the effects of the order.

In order to make this measurement a minimum of two signals (tones) must be present at the input.

- first interfering signal
- second interfering signal

The Channel Frequency must be set to the intermod frequency and the Interferer frequency must be set the first or second interfering frequency. See the 'Calculate Tab' on the System Analysis Dialog Box to set the Interfering Frequency. Furthermore, the spacing of the interfering tones needs to be such that intermods will actually fall into the main channel. If these conditions are not met then no intermod power will be measured in the main channel.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel

bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Note: Cascaded intermod equations are not used in Spectrasys.

Caution: This method used to determine the intercept point is only valid for 2 tones with equal amplitude

Channel Used: Interferer Channel Frequency, Main Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as ICP and TIMCP

Travel Direction: Same as ICP and TIMCP

Output Intercept - Receiver [All Orders] (RX_OIP)

This measurement is the receiver output intercept point along the path. This is an out-of-band type of intermod measurement.

 $RX_OIP[n] = VTCP[n] + RX_Delta[n]$ (dBm), where n = stage number and Order = order of the intermod

```
VTCP[n] = ICP[0] + CGAIN[n] (dBm)

RX_Delta[n] = (VTCP[n] - TIMCP[n]) / (Order - 1) (dB)
```

Delta is the difference in dB between the 'Total Intermod Channel Power' in the main channel and the interfering signal present in the 'Interferer Channel' including the effects of the order. In order to correctly calculate OIP due to out-of-band interferers a Virtual Tone is created whose virtual power is that of an un-attenuated in-band tone. This power level is simply the 'Interferer Channel Power' at the input plus the 'Cascaded Gain'.

This Virtual Tone Channel Power is different than the 'Interferer Channel Power' measurement because the Virtual Tone Channel Power is not attenuated by out-of-band rejection whereas the 'Interferer Channel Power' can be. For in-band interferers the Virtual Tone Channel Power and the 'Interferer Channel Power' measurement will be identical.

In order to make this measurement a minimum of three signals (tones) must be present at the input.

- main channel signal (used for cascaded gain and total intermod channel power measurements)
- first interfering signal
- second interfering signal

The Channel Frequency must be set to the intermod frequency and the Interferer frequency must be set the first or second interfering frequency. See the 'Calculate Tab' on the System Analysis Dialog Box to set the Interfering Frequency. Furthermore, the spacing of the interfering tones needs to be such that intermods will actually fall into the main channel. If these conditions are not met then no intermod power will be measured in the main channel.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

See the 'Intermods Along a Path' section for information on how to configure these tests.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Cascaded intermod equations are not used in Spectrasys.

Caution: This method used to determine the intercept point is only valid for 2 tones with equal amplitude

Channel Used: Interferer Channel Frequency, Main Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as ICP, CGAIN, and TIMCP

Travel Direction: Same as ICP, CGAIN, and TIMCP

Percent Noise Figure (PRNF)

This routine calculates the Percent Noise Figure contribution by each stage to the final Cascaded Noise Figure of the path.

PRNF[n] = AN[n] / CNF[nLastStage] * 100 (this is a ratio of dB values), where PRNF[0] = 0, n is the current stage, and nLastStage is the last stage along the designated path.

This measurement will help the user pinpoint all stages and their respective contribution to the total cascaded noise figure of the selected path.

This measurement in unit-less since the measurement is a percentage. There can be a few cases where the percentage sum of all the stages in the path does not equal 100%. For instance, if the architecture contains parallel paths then each path would contribute to the total cascaded noise figure but only a single path is considered in the measurement. Another case would be where there is sufficient VSWR interactions between stages that effect the noise so it does not change linearly with the gain. Reducing the architecture to

the spreadsheet case will always yield the expected spreadsheet answers with respect to percentages. See the 'Cascaded Noise Figure' measurement for additional information.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as AN and CNF

Travel Direction: Same as AN and CNF

Percent Intermods - All Orders (PRIM)

This routine calculates the Percent Intermod Contribution by each stage to the final Total Intermod Channel Power of the path.

IMREF - Equivalent Intermod Power Referenced to the Output

IMREF = GIMCP[n] + (CGAIN[nLastStage] - CGAIN[n])

PRIM[n] = IMREF[n] / TIMCP[iLastStage] (this is a ratio in Watts), Where PRIM[0] = 0, n is the current stage, and nLastStage is the last stage along the designated path

This measurement will help the user pinpoint all stages and their respective contribution to the total third order intermod power of the selected path.

This measurement in unit-less since the measurement is a percentage. There can cases where the percentage sum of all the stages in the path does not equal 100%. For instance, if the architecture contains parallel paths then each path would contribute to the total third order intermod power but only a single path is considered in this measurement. Another case would be where there are sufficient VSWR interactions between stages that effect the intermod levels. Reducing the architecture to the spreadsheet case will always yield the expected spreadsheet answers with respect to percentages. Sometimes this measurement can be greater than 100% if the equivalent intermod power referenced to the output is greater than the actual total intermod channel power. A good example of this would be an amplifier where intermods are cancelled at the amplifier output. In this case the generated intermod power alone may be much higher that the total intermod output power.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as GIMCP, GAIN, and TIMCP

Travel Direction: Same as GIMCP, GAIN, and TIMCP

Phase Noise Channel Power (PNCP)

This measurement is the integrated phase noise power in the main channel along the specified path. Phase noise is displayed on the graphs in dBm/Hz and the channel bandwidth is ignored while displaying phase noise. However, for channel measurements like this one the phase noise is scaled by the channel bandwidth before being integrated.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY PHASE NOISE</u>

Travel Direction: Only spectrums traveling in the FORWARD path direction

Spurious Free Dynamic Range (SFDR)

This measurement is the spurious free dynamic range along the specified path as shown by:

SFDR[n] = 2/3 [IIP3[n] - MDS[n]] (dB), where n = stage number

The 'Spurious Free Dyanmic Range' is the range between the Minimum Detectable (Discernable) Signal (MDS) and the input power which would cause the third order intermods to be equal to the MDS. The MDS is the smallest signal that can be detected and will be equivalent to the receiver noise floor with a signal to noise ratio of 0 dB. In other words the MDS = -174 dBm/Hz + System Noise Figure + 10 Log(Channel Bandwidth).

See the 'Input Intercept' and 'Channel Noise Power' measurements to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency, Interferer Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as IIP and MDS

Travel Direction: Same as IIP and MDS

Spurious Free Dynamic Range - Receiver (RX_SFDR)

This measurement is the spurious free dynamic range along the specified path as shown by:

 $RX_SFDR[n] = 2/3 [RX_IIP3[n] - MDS[n]] (dB)$, where n = stage number

The 'Spurious Free Dyanmic Range' is the range between the Minimum Detectable (Discernable) Signal (MDS) and the input power which would cause the third order intermods to be equal to the MDS. The MDS is the smallest signal that can be detected and will be equivalent to the receiver noise floor with a signal to noise ratio of 0 dB. In other words the MDS = -174 dBm/Hz + System Noise Figure + 10 Log(Channel Bandwidth).

See the 'Input Intercept (Receiver)' and 'Channel Noise Power' measurements to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency, Interferer Channel Frequency, and Channel Measurement Bandwidth

Types of Spectrums Used: Same as RX IIP and MDS

Travel Direction: Same as RX_IIP and MDS

Stage Dynamic Range (SDR)

This measurement along the specified path as shown by:

SDR[n] = SOP1DB[n] - TNP[n] (dB), where n = stage number

This simple measurement shows the difference between the 1 dB compression point of the stage entered by the user and the 'Total Node Power' at the stage output. This measurement is extremely useful when trying to optimize each stage dynamic range and determine which stage that will go into compression first.

See the 'Stage Output 1 dB Compression Point' and 'Total Node Power' measurements to determine which types of signals are included or ignored in this measurement

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as TNP

Travel Direction: Same as TNP

Stage Gain (SGAIN)

This measurement is the stage gain entered by the user. For behavioral passive models the insertion loss parameter is used. When a stage doesn't have either a gain or insertion loss parameter 0 dB is used. This measurement is not dependent on the path direction through the model. For example, if the path was defined through backwards through an amplifier the forward path gain would be reported not the reverse isolation of the amplifier.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Noise Figure (SNF)

This measurement is the stage noise figure entered by the user. For behavioral passive models the insertion loss parameter is used. When a stage doesn't have either a noise figure or insertion loss parameter 0 dB is used. This measurement is not dependent on the path direction through the model. For example, if the path was defined through the coupled port of a coupler the insertion loss of the coupler would be reported and not the coupled loss.

Channel Used: No channel is used for this measurement

Simulation

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input Intercept - All Orders (SIIP)

This measurement is the stage input intercept point calculated by using the Stage Output Intercept Point and the Stage Gain. When a stage doesn't have this parameter +100 dBm is used.

SIIP[n] = SOIP[n] - SGAIN[n] (dBm), where n = stage number

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input 1 dB Compression Point (SIP1DB)

This measurement is the stage 1 dB compression point calculated by using the Stage Output 1 dB Compression Point and the Stage Gain. When a stage doesn't have this parameter +100 dBm is used.

SIP1DB[n] = SOP1DB[n] - SGAIN[n] (dBm), where n = stage number

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input Saturation Power (SIPSAT)

This measurement is the stage input saturation power calculated by using the Stage Output Saturation Power and the Stage Gain. When a stage doesn't have this parameter +100 dBm is used.

SIPSAT[n] = SOPSAT[n] - SGAIN[n] (dBm), where n = stage number

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output 1 dB Compression Point (SOP1DB)

This measurement is the stage 1 dB compression point entered by the user. When a stage doesn't have this parameter +100 dBm is used.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output Intercept - All Orders (SOIP)

This measurement is the stage output intercept point entered by the user. When a stage doesn't have this parameter +100 dBm is used.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output Saturation Power (SOPSAT)

This measurement is the stage saturation point entered by the user. When a stage doesn't have this parameter +100 dBm is used.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Conducted Intermod Channel Power [All Orders] (CIMCP)

This measurement is the total intermod power in the main channel conducted from the prior stage. This measurement includes all intermods that are traveling in the forward path direction. In equation for the conducted third order intermod power is:

CIMCP[n] = TIMCP[n-1] + GAIN[n] (dBm), where CIMCP[0] = 0 dB and n = stage number

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as TIMCP and GAIN

Travel Direction: Same as TIMCP and GAIN

Generated Intermod Channel Power [All Orders] (GIMCP)

This measurement is the generated intermod power in the main channel created at the output of the current stage. In equation form the generated third order intermod power is:

GIMCP[n] = integration of the intermods generated at stage n across the channel bandwidth (dBm)

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY INTERMODS and HARMONICS (separated according to their order)</u>

Travel Direction: All directions through the node

Total Intermod Channel Power [All Orders] (TIMCP)

This measurement is the integrated total intermod power conducted from the prior stage plus the intermod power generated by the current stage.

In equation form the conducted third order intermod power is:

TIMCP[n] = integration of the total intermod spectrum at stage n across the main channel

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Remember intermod bandwidth is a function of the governing intermod equation. For example, if the intermod equation is 2F1 - F2 then the intermod bandwidth would be: 2BW1 + BW2. Note: Bandwidths never subtract and will always add. The channel bandwidth must be set wide enough to include the entire bandwidth of the intermod to achieve the expected results. The 'Automatic Intermod Mode' will set the bandwidth appropriately.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: ONLY INTERMODS and HARMONICS (separated according to their order)

Travel Direction: All directions through the node

Total Intermod Power (TIMP)

This measurement is the total integrated power of all intermod orders in the main channel along the path. This measurement differs from the 'Total Intermod Channel Power' in that it is a sum of all the orders of intermods whereas the 'Total Intermod Channel Power' is separated by order.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: ONLY INTERMODS and HARMONICS

Travel Direction: All directions through the node

Total Node Power (TNP)

This measurement is the integrated power of the entire spectrum at the node. This is an extremely useful measurement in determining the total power present at the input of a device (i.e. amplifier or mixer LO). This measurement includes **ALL SIGNALS**, **INTERMODS**, **HARMONICS**, **NOISE**, and **PHASE NOISE** traveling in **ALL** directions through the node.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE

Travel Direction: All directions through the node

Virtual Tone Channel Power (VTCP)

This measurement is the virtual tone channel power. The virtual tone is the power level of an un-attenuated tone along that cascade of stages. This tone consists of the power level of one of the tones at the input of a cascade plus the in-channel cascaded gain.

See 'Intercept Measurements in the Lab' and 'Cascaded Intermods and SPECTRASYS' for additional information.

VTCP[n] = ICP[0] + CGAIN[n] (dB), where n = stage number

Channel Used: Same as ICP and CGAIN

Types of Spectrums Used: Same as ICP and CGAIN

Travel Direction: Same as ICP and CGAIN

Voltage

Voltage Gain (GAINV)

This measurement is the voltage gain of the main channel along the specified path. The 'Voltage Gain' is the difference between the 'Desired Channel Voltage' output of the current stage minus the 'Desired Channel Voltage' output of the prior stage as shown by:

GAINV[n] = DCV[n] - DCV[n-1] (dB20), where GAINV[0] = 0 dB20, n = stage number

See the 'Desired Channel Voltage' measurement to determine which types of signals are included or ignored in this measurement.

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCV

Travel Direction: Same as DCV

Carrier to Noise Voltage Ratio (CNRV)

This measurement is the ratio of the 'Desired Channel Voltage' to 'Channel Noise Voltage' along the specified path as shown by:

CNRV[n] = DCV[n] - CNV[n] (dB), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCV and CNV

Travel Direction: Same as DCV and CNV

Cascaded Voltage Gain (CGAINV)

This measurement is the cascaded voltage gain of the main channel along the specified path. The 'Cascaded Voltage Gain' is the difference between the 'Desired Channel Voltage' measurement at the nth stage minus the 'Desired Channel Voltage' measurement at the input as shown by:

CGAINV[n] = DCV[n] - DCV[0] (dB20), where n = stage number

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCV

Travel Direction: Same as DCV

Channel Voltage (CV)

This measurement is the average voltage across the main channel along the specified path.

This measurement includes ALL SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE traveling in ALL directions through the node that fall within the main channel.

For example, if the 'Channel Measurement Bandwidth' was specified to .03 MHz and the 'Channel Frequency' was 220 MHz then the CV is the average voltage from 219.985 to 220.015 MHz.

Default Unit: dBV

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Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE</u>

Travel Direction: All directions through the node

Channel Noise Voltage (CNV)

This measurement is the average noise voltage in the main channel along the specified path.

For example, if the 'Channel Measurement Bandwidth' was specified to 100 kHz and the 'Channel Frequency' was 2000 MHz then the CNV is the average integrated noise voltage from 1999.95 to 2000.05 MHz.

Simulation

Default Unit: dBV

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: <u>ONLY NOISE</u>

Travel Direction: Only spectrums traveling in the FORWARD path direction

Desired Channel Voltage (DCV)

This measurement is the desired average voltage across the main channel along the specified path.

This measurement includes ONLY DESIRED SIGNALS on the beginning node of the path, traveling in FORWARD path direction. All other intermods, harmonics, noise, and phase noise signals are ignored.

Note: A 'D' is placed next to the equation in the identifying flyover help in a spectrum plot to indicate desired signals.

For example, if the 'Channel Measurement Bandwidth' was specified to .03 MHz and the 'Channel Frequency' was 220 MHz then the DCV is the average voltage from 219.985 to 220.015 MHz. This voltage measurement will not even be affect by another 220 MHz signal traveling in the reverse direction even if it is much larger in amplitude.

Default Unit: dBV

Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: ONLY DESIRED SIGNALS

Travel Direction: Only in the FORWARD direction

Equivalent Input Noise Voltage (VNI)

This measurement is the stage equivalent input noise voltage. Noise figure, source resistance, and temperature are used to determine equivalent input noise voltage. The following equation is used to take the noise factor at each stage, the desired channel resistance at each stage, and the system analysis temperature in Celsius and converts these parameters to an equivalent input noise voltage.

 $\label{eq:VNI} VNI[n] = NFtoVNI(\ CNF[n],\ DCR[n],\ TempC\)\ (\ nV\ /\ sqrt(\ Hz\)\), where\ n=stage$ number

See SVNI for additional information.

Default Unit: nV / sqrt(Hz)

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Interferer Channel Voltage (ICV)

This measurement is the average voltage in the interferer channel.

This measurement is simply a 'Desired Channel Voltage' measurement at the 'Interferer Channel Frequency'.

Channel Used: Interferer Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: Same as DCV

Travel Direction: Same as DCV

Node Noise Voltage (NNV)

This measurement is the peak average noise voltage at the node along the specified path. This includes all noise signals both in and out of the channel.

Default Unit: dBV

Channel Used: No channel is used for this measurement

Types of Spectrums Used: <u>ONLY NOISE</u>

Travel Direction: Only spectrums traveling in the FORWARD path direction

Offset Channel Voltage (OCV)

The Offset Channel is a user defined channel relative to the main channel. The 'Offset Channel Frequency' and 'Offset Channel Bandwidth' are specified on the 'Options Tab' of the System Analysis Dialog Box. As with the 'Channel Frequency' measurement Spectrasys automatically deals with the frequency translations of the 'Offset Channel Frequency' through frequency translation devices such as mixer and frequency multipliers.

For example, if the 'Channel Frequency' was 2140 MHz, 'Offset Channel Frequency' was 10 MHz, and the 'Offset Channel Bandwidth" was 1 MHz then the OCV is the average voltage from 2149.5 to 2150.5 MHz.

This measurement is simply a 'Channel Voltage' measurement at the 'Offset Channel Frequency' using the 'Offset Channel Bandwidth'.

Channel Used: Offset Channel Frequency and Offset Channel Bandwidth

Types of Spectrums Used: Same as CV

Travel Direction: Same as CV

Phase Noise Channel Voltage (PNCV)

This measurement is the average phase noise voltage in the main channel along the specified path. Phase noise is displayed on the graphs in V/sqrt(Hz).

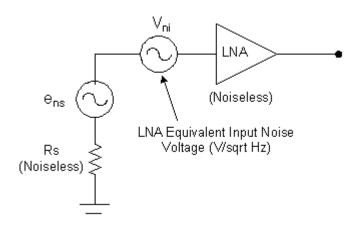
Channel Used: Main Channel Frequency and Channel Measurement Bandwidth

Types of Spectrums Used: ONLY PHASE NOISE

Travel Direction: Only spectrums traveling in the FORWARD path direction

Stage Equivalent Input Noise Voltage (SVNI)

This measurement is the stage equivalent input noise voltage entered by the user. Stage noise figure, source resistance, and temperature can be converted to stage equivalent input noise voltage using the following equations.



Source Noise Voltage (V/sqrt Hz): ens(Rs) = sqrt(4 k T Rs) for example ens(50) = $0.895~\rm{nV}$

Stage Equivalent Input Noise Voltage: Vni = sqrt(F - 1) * ens

Stage Noise Factor: $F = (Vni / ens)^2 + 1$

Stage Noise Figure (dB): NF = 10 Log(F)

where Rs is the input source resistance to the stage

Default Unit: nV / sqrt(Hz)

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input 1 dB Compression Voltage (SIV1DB)

This measurement is the stage 1 dB compression voltage point calculated by using the Stage Output 1 dB Compression Voltage Point and the Stage Voltage Gain. When a stage doesn't have this parameter $100~\rm kV$ is used.

SIV1DB[n] = SOV1DB[n] - SVGAIN[n] (dBV), where n = stage number

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input Intercept Voltage - All Orders (SIIV)

This measurement is the stage input intercept voltage point calculated by using the Stage Output Intercept Voltage and the Stage Voltage Gain. When a stage doesn't have this parameter 100 kV is used.

SIIV[n] = SOIV[n] - SVGAIN[n] (dBV), where n = stage number

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Input Saturation Voltage (SIVSAT)

This measurement is the stage input saturation voltage calculated by using the Stage Output Saturation Voltage and the Stage Voltage Gain. When a stage doesn't have this parameter 100 kV is used.

SIVSAT[n] = SOVSAT[n] - SVGAIN[n] (dBV), where n = stage number

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output 1 dB Voltage Compression Point (SOV1DB)

This measurement is the stage 1 dB voltage compression point entered by the user. When a stage doesn't have this parameter 100 kV is used.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output Intercept Voltage - All Orders (SOIV)

This measurement is the stage output intercept voltage point entered by the user. When a stage doesn't have this parameter 100 kV is used.

Each column in this measurement is for a different intermod order up to the Maximum Order specified on the 'Calculate Tab' of the System Analysis Dialog Box. The column number is the same as the order starting from the left with order 0.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Output Saturation Voltage (SOVSAT)

This measurement is the stage output voltage saturation point entered by the user. When a stage doesn't have this parameter 100 kV is used.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Stage Voltage Gain (SVGAIN)

This measurement is the stage voltage gain entered by the user. For behavioral passive models the insertion loss parameter is used. When a stage doesn't have either a gain or insertion loss parameter 0 dB20 is used. This measurement is not dependent on the path direction through the model. For example, if the path was defined through backwards through an amplifier the forward path gain would be reported not the reverse isolation of the amplifier.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: None

Travel Direction: N/A

Total Node Voltage (TNV)

This measurement is the peak average voltage of the entire spectrum at the node.

This is an extremely useful measurement in determining the total voltage present at the input of a device. This measurement includes ALL SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE traveling in ALL directions through the node.

Default Unit: dBV

Channel Used: No channel is used for this measurement

Types of Spectrums Used: All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE

Travel Direction: All directions through the node

Voltage DC (VDC)

This measurement is the DC voltage along the specified path.

This measurement includes ALL SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE traveling in ALL directions through the node.

Channel Used: No channel is used for this measurement

Types of Spectrums Used: <u>All SIGNALS, INTERMODS, HARMONICS, NOISE, and PHASE NOISE</u>

Travel Direction: All directions through the node

Troubleshooting

General RF Architecture Troubleshooting

These steps can be followed for general RF architecture troubleshooting.

Compare Measurements to Get an Understanding of the Problem

- Level diagrams are not as useful as tables when debugging problems. (A
 default table can be added to the workspace by right clicking on the node at the
 end of a path and then choosing 'System1_Data_Path1:New Table of
 Measurements' from the 'Add New Graph / Table' submenu.
- 2. First check all of the **channel frequencies** in question. Measurements are based on these frequencies. If these frequencies are NOT what the user expects then channel measurements will also not be what the user expects.
- Check channel power measurements. Remember: 'Channel Power (CP)' and
 'Desired Channel Power (DCP)' are two different measurements. Channel power
 includes forward and reverse traveling power whereas desired channel power only
 includes forward traveling power. Most measurements depend on desired
 channel power (i.e. GAIN, CGAIN, etc).
- 4. Use the desired channel resistance **(DCR)** measurement to quickly determine if there are VSWR related problems.
- 5. Click here for information on troubleshooting intermod path measurements.

Use Spectrum Identification on Graphs to Locate Root Spectrum Causing a Problem

- 1. Once the measurements have been use to identify the node where the problem occurs then add a graph at that particular node and examine the spectrum in the channel in question.
- 2. **Use the spectrum identification** capability to identify the suspect spectrum. NOTE: You can 'Zoom to Spectrum' by right clicking on the spectrum of interest and selecting 'Zoom to Fit Spectrum / Trace'.

Use Path Powers, Voltages, and Impedances

- 1. Enable path powers, voltages, and impedances so that these values can be added to the dataset.
- 2. The path dataset will now contain specific information regarding values that spectrums are seeing along the path such as impedances, etc.

VSWR Related Issues

Occasionally gains and noise figures may be unexpected. This is generally related to VSWR issues across the channel. SPREADSHEETS generally ignore all VSWR effects and assume power is always delivered to a perfectly matched load. Cascaded equations

make the same erroneous assumptions. The best way to determine VSWR issues is as follows.

- 1. **Compare** the **'GAIN'** (calculated gain) and **'SGAIN'** (user specified gain) measurements in a table. If these measurements are not in close agreement then there is a VSWR issue at the stages with the largest discrepancies.
- 2. All **filter blocks** should be **replaced with attenuators** to coincide with spreadsheet measurements.

Long Simulation Time and Convergence Issues

The number of 'passes' can be observed on the simulation status widow to determine convergence issues. A high pass count indicates continued spectrum propagation. To troubleshoot a convergence or long simulation time problem follow the given steps.

- 1. **Increase isolation** for components having more than 2 ports. Isolation can be increased to eliminate any loop.
- 2. **Increase reverse isolatio**n of active devices such as amplifiers.
- 3. **Reduce** the maximum **simulation order**.
- 4. Reduce number of carriers.
- 5. Disable noise calculations.

Once the problem has been isolated the root issue can be determined.

Reduce the Number of Unknowns

The more unknowns there are the more data that needs to be analyzed, most of which does not affect the answer in question.

- 1. **Disable** all possible calculations like **intermods and harmonics**, **thermal noise**, and **phase noise** that don't affect the answer in question.
- 2. Eliminate multiple carriers that don't affect the answer in question.
- 3. **Disable the spectrum analyzer** mode if being used (this is a display only type of tool and does not affect any path measurements)
- 4. **Increase** isolation for components having more than 2 ports. This eliminates spectrums propagating multiple times around a loop.
- 5. In really tough cases stages can be removed from the analysis by the option on the simulation tab of the part properties dialog box 'Disable Part for All Simulations (Short Circuit ALL terminals together)". This works well for 2 port devices.

How come my noise figure decreases through a cascade?

The equation for Cascaded Noise Figure measurement in Spectrasys is:

CNF[n] = CNP[n] - CNP[0] - CGAIN[n] (dB), where n = stage number and CNP is the Channel Noise Power

and the Cascade Gain measurement is:

CGAIN[n] = DCP[n] - DCP[0] (dB), where n = stage number and DCP is the Desired Channel Power

Cascade Gain is therefore a function of all forward traveling power in the channel which is subject to VSWR effects.

-Verify that Gain and Cascaded Gain are as expected

Another issue usually is that the Channel Measurement Bandwidth is much wider than the channel signals. This is ok but extra noise points may need to be added to improve the accuracy of the Channel Noise Power measurement. Spectrasys interpolates between all noise and signal data points. If there is a lot of amplitude ripple in the circuit sufficient noise points must be added for each signal to properly account for these variations. If the noise spectrum looks very stick-figure-ish then extra noise points may need to be added.

If cascaded noise figure is being examined through a hybrid combining network the cascaded noise figure will appear to artificially peak at the internal nodes due to the hybrid network. This occurs because the cascaded gain used is only for the current path and not all parallel paths used in the hybrid network.

See 'Broadband Noise', 'Cascaded Noise Analysis', and 'Cascaded Noise Figure Equations' for additional information.

Why don't I get the same answer as my spreadsheets?

Spectrasys accounts for VSWR between stages, sneak paths, reverse isolation, frequency response, channel bandwidth, gain compression, broadband noise and image noise. Spreadsheets do not! Cascaded noise figure equations assume no image noise and perfect matching between stages. Cascaded intermod equations assume no frequency rolloff for the interfering tones. This can be a bad assumption especially for a receiver blocking test.

In order to correlate Spectrasys data with a spreadsheet (or other math packages or programs) the schematic must be reduced to the spreadsheet case. That is:

1. Remove VSWR and frequency effects

- a. Behavioral filter have return loss which is a function of the ripple. Set the ripple to something really small like $0.001~\mathrm{dB}$
- b. Set all ports and stages to the same impedance
- c. Replace S Parameters elements (or other frequency dependent elements) with attenuators or amplifiers of the equivalent gain.

2. Remove sneak path effects

a. Set isolations very high (100 dB)

b. Set reverse isolation very high (100 dB)

3. Remove gain compression effects

- a. Gain compression is based on total node power not channel power. All unwanted signals including noise will contribute to the total node power.
- b. Increase the P1dB, PSAT, IP3, and IP2 points of all non-linear stages

4. Remove image noise effects

a. Set the image rejection high (100 dB) in all mixers (be sure to reject the image frequency band not the desired channel band)

After making these changes you will get excellent correlation.

See 'Cascaded Noise Figure Equations' and 'Cascaded Intermod Equations' for additional information.

No Attenuation Across a Filter

There are two kinds of loss produced by a filter 1) **dissipative** (resistive) and 2) **impedance mismatch**. The dissipative loss of a filter is the same as its insertion loss. For in-band frequencies the dissipative loss is typically more significant than the mismatch loss. However, for out-of-band frequencies the mismatch loss it typically several times greater than the insertion loss. Signals arriving at a filter input will either be reflected or transmitted. All transmitted signals through the filter will undergo the loss due to dissipation.

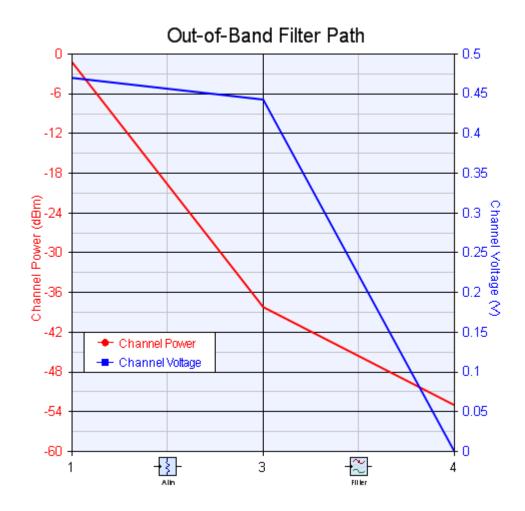
Dissipative loss is a function of the Q of the components that make up the filter. Ideal components have infinite Q and will have no insertion loss.

When looking at out-of-band channel power or voltage along a cascade of stages it will appear that the stage prior to a filter has more loss than expected and the filter attenuation is much less than expected. This seems counter intuitive at first but when we look at mismatch loss and transmitted and reflected power it all makes good sense. The out-of-band impedance looking into a filter is either really high or really low. There is an out-of-band impedance mismatch between the filter and the stage prior to it. The actual out-of-band voltage appearing at the filter input will be affected by mismatch impedance which automatically accounts for the out-of-band attenuation caused by the filter. In the lab the only way to accurately measure the out-of-band input voltage to a filter is to break the input node connection and measure the forward voltage, transmitted voltage, and reflected voltage (Vforward = Vtransmitted + Vreflected).

In order to simplify the simulation process all SPECTRASYS measurements and spectrums only use transmitted signals not the forward signals assumed by spreadsheets. Spreadsheets typically never account for mismatch loss so it is assumed that all forward traveling signals equal the transmitted signals ... which is really not the case!

Example

The following figure shows a 3 dB attenuator followed by a low pass filter. The source frequency is 1 GHz and which frequency the filter produces about 50 dB. The channel power and voltage is displayed on the following graph. As expected the voltage changes very little across the 3 dB attenuator. However, most of the power drop occurs across the attenuator. The input impedance to the filter at 1 GHz is about 336 ohms. For this reason there is more attenuation that appears across the attenuator due to the mismatch loss than the anticipated 3 dB.

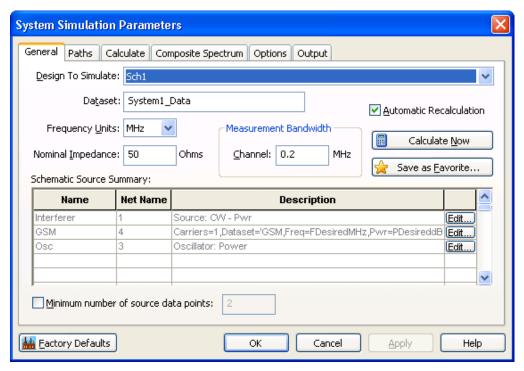


Dialog Box Reference

System Simulation Parameters - General Tab

This page sets the general settings for a Spectrasys Simulation.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

Design to Simulate

User specified name. This is the source name that will appear in the spectrum identification.

Dataset

Name of the dataset where the simulation data is stored.

Frequency Units

These are the frequency units used for the entire system simulation dialog box.

Nominal Impedance

Default impedance used for power measurements when no impedance information is available during the simulation.

Measurement Bandwidth

Width of the channel used in path measurements. This is analogous to the resolution bandwidth on a spectrum analyzer.

Automatic Recalculation

When checked enables Spectrasys to automatically recalculate the simulation every time the design or system simulation is out of date.

Calculate Now Button

Closes the dialog and initiates a simulation.

Save as Favorite Button

When clicked will save all the parameters associated with the system analysis dialog as the default to be used when the next system analysis is created.

SCHEMATIC SOURCE SUMMARY

This section summarizes all the sources found in the given design.

Name

This is the name of the source or part designator.

Net Name

This is the name of the net where the source is connected.

Description

This is a summary description of the source.

Edit Button

When clicked this button will bring up the edit parameters dialog for this part.

Minimum number of source data points

When checked each source signal is represented by the specified number of data points. When unchecked 2 points will be used. This parameter is ignored for all continuous frequency sources whose amplitude is dependent on several data points. This option is extremely useful when wideband signals are being simulated through filters since impedance can vary drastically across its bandwidth . If only 2 data points are used then spectrum power and noise will only be represented by these 2 points.

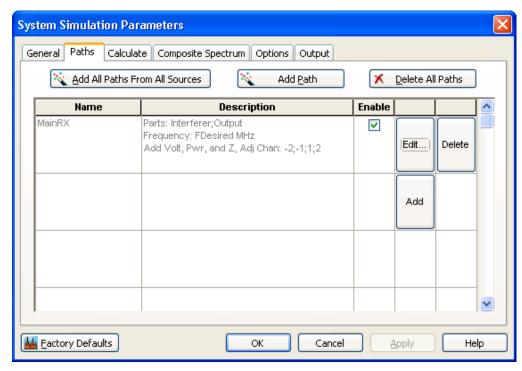
Factory Defaults

Sets all properties to their default values.

System Simulation Parameters - Paths Tab

Many measurements require the definition of a path. For more information on paths click here.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

Add All Paths From All Sources

Automatically adds all possible paths between sources and output ports.

Add Path

Invokes the Add / Edit Path dialog box.

Delete All Paths

Deletes all paths in the system analysis.

PATH SUMMARY TABLE

This table summarizes the aspects of the path.

Name

User defined name of the path.

Description

User defined description of the path.

Enable

When checked will create and add a path dataset to the workspace tree. When unchecked will remove the existing path dataset from the workspace tree.

Add / Edit Button

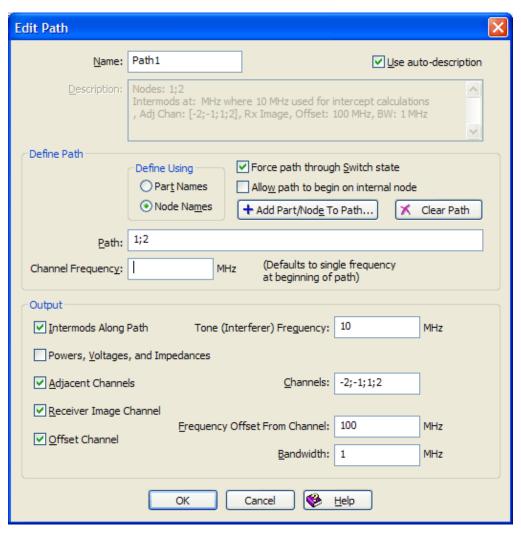
When clicked will invoke the Add / Edit Path dialog box.

Delete Button

Will delete the path from the system analysis.

Add / Edit Path Dialog Box

This dialog box is used to specify the characteristics of a path. A basic path consists of a beginning and ending location in a schematic and a channel frequency. Path measurements can be grouped into the following groups: fundamental, intermod, adjacent channel, receiver image channel, offset channel, and primitive path components of powers, voltages, and impedances. Through this dialog box the user will determine the locations in the schematic that the path should pass through along with the measurements to be calculated and saved to a dataset.



Parameter Information:

All fields can be numeric or a variable. When using a variable the name of the variable is entered into the field and the variable must be defined in an equations block. For example, if we wanted to use a variable for the offset channel frequency called MyOffset then we would type the string MyOffset into the 'Frequency Offset From Channel' field then define 'MyOffset = 10' in an equation block which is set to use display units or in other words the units used in the dialog box. If the equation units are changed to MKS then MyOffset = 10e6 would represent 10 MHz. To make a variable tunable a '?' is placed in front of the number in the equation block i.e. 'MyOffset = ?10'.

Name

This is the name used to identify the path.

Description – Description of the path. Used for identifying the path to the user. When 'Use auto-description' is checked the description will automatically be filled based on parameters set in the remaining fields of the dialog box.

Use auto-descrition – Description will automatically be created from specified path parameters.

DEFINE PATH

This section will define the path to be calculated by the system analysis. A path can be specified with either part names or node names. SPECTRASYS will always find the shortest path that contain the list of parts or node names specified by the path. Many times the input and output parts are sufficient. However, in the case where loops or parallel paths exits it may be necessary to specify intermediate part or node names to force the path through a direction of interest.

Part Names

When selected informs the system analysis that part names are being used for the simulation of the path.

Node Names

When selected informs the system analysis that node names are being used for the simulation of the path.

Force path through Switch state

When checked will force the path to follow the state of the any switches along the path. For example, this allows the path to track the state of a switch bank. When unchecked will allow the user the path to take through the switches.

Allow path to being on internal Node

When checked any desired signals within the channel will be used to determine the desired channel power, gain, and cascaded gain. When unchecked the desired signal at a source must be located or the desired channel power, gain, and cascaded gain cannot be determined.

NOTE: When a path begins on a internal node the total power of ALL desired signals at the channel frequency will be used to determine the desired channel power, gain, and cascaded gain. When unchecked a single signal at the source is used for these measurements and SPECTRASYS can distinguish this desired signal from other desired signals at the same frequency.

Add Part/Node to Path Button

When clicked provides the user with a menu of parts or node names that can be selected in sequence to determine the path. Each click on the menu will add the selected name to the path.

Clear Path Button

When clicked with clear the path list.

Path

This contains a list of part or node names that define the path. These names are specified as an array and can be separated either with semicolons or commas. SPECTRASYS will find the shortest path containing all the names in the path list. Additional names can be inserted into the path list to force a path in a given direction.

The path can be defined as a string array in an equation block to dynamically change the path based on an equation. For example, a string array for the variable 'MyPath' would be defined: 'MyPath = ["Input Part Name";"...Optional Names";"Output Part Name"]'

Note: This example uses part names but node names work equally as well. However the correct selection of 'Part Names' or 'Node Names' must be selected. Also, commas are NOT supported as a valid separator in a string array. A semicolon must be used.

Channel Frequency

Defines the frequency at which path measurements are made. The channel measurement bandwidth will be used in conjunction with the channel frequency to completely specify the channel location in the spectrum and bandwidth of the spectrum integration. If this field is empty the system analysis can determine the path frequency if there is a single signal source on the beginning node of the path. For multiple frequencies the system analysis doesn't know the intent of the user and will display an error. For intermod measurements this is the frequency of the intermod to be measured.

The channel frequency will automatically change along the path through frequency translation devices such as mixer, multipliers, dividers, etc.

If the user would like to force the channel frequency to a particular value at a given node along the path this can be done by adding an additional frequency to the channel frequency list by separating each frequency by commas. The channel frequency and path list are paired beginning at the start of the path. So the second channel frequency in the list will correspond to the second node or part in the path list. For example, if the user wanted to track the 2nd harmonic created at the output of the LNA and the path is specified as '1;5;2' where node 1 is the input, 5 the LNA output, and 2 the system output. If the input frequency was 1000 MHz then the channel frequency would be specified as '1000;2000'. What this means is that at node 1 the 1000 MHz frequency will be used. When the path calculation reaches the next name in the path list, node 5, the next channel frequency will be used which is 2000 MHz. The channel from this

point to the end of the path at node 2 will follows its normal course including through frequency translation devices. NOTE: When using multiple frequencies node names are a better path specification since part generally have more than 1 node and the system analysis doesn't know which terminal of the part to use.

OUTPUT

This section will determine which measurements are added to the dataset and some of the parameters needed by some of the measurements.

Intermods Along a Path

When checked with calculates intermod measurements and add them to the path dataset. This is not to be confused with intermods created during a simulation. Those will always be created as long as calculation of intermods has been selected on the 'Calculate Tab' of the system analysis.

Tone (Interferer) Frequency

This is the frequency where the tone or interferer is located that will be used to determine the intercept point. In order to determine the intercept point the system analysis must measure the intermod power and the power of the tone or interferer that created the intermod. The path channel frequency is set to the frequency of the intermod and an additional tone (interferer) channel must be created at the frequency of the tone or interferer. The intercept measurement technique used in the system analysis is the generally the same used in the laboratory using signal generators and spectrum analyzers.

See Intermod and Harmonic Basics, Intermod Path measurement Basics, Cascaded Intermod Equations, In-Band Intermod Path Measurements, Out-of-Band Intermod Path Measurements, and Troubleshooting Intermod Path Measurements for additional information.

Powers, Voltages, and Impedances

When checked will add path powers, voltages, and impedances to the path. These spectrums are grouped spectrum into various categories which are then integrated by corresponding measurements.

Adjacent Channels

When checked will calculate the specified adjacent channels and place the results in the path dataset. The bandwidth of the channel is the channel measurement bandwidth specified on the 'General Tab' of the system analysis.

Channels

These are the adjacent channels which reside on either the lower or upper side of the main channel. These values are specified as an integer array where values are separated by semicolons. Negative numbers represent the channels lower than the main path frequency and positive values represent channels higher than the main path frequency. For example, -2;-1;1;2 means that first and second lower and first and second upper adjacent channels will be measured.

Receiver Image Channel

When checked all measurements associated with the receiver image channel will be calculated and saved to the path dataset. The receiver image channel is defined as the channel from the input to the first mixer.

Offset Channel

When checked will calculate the offset channel power and frequency measurements and add them to the path dataset.

Frequency Offset from Channel

The is the frequency spacing between the main channel center frequency and the center frequency of the offset channel.

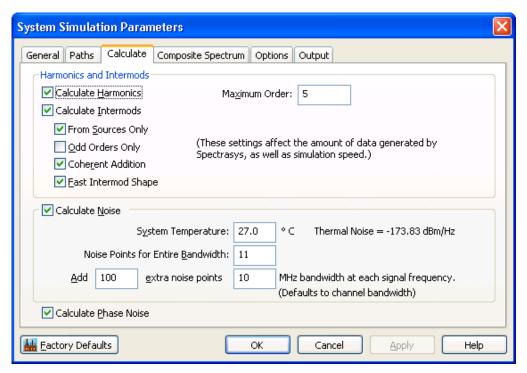
Bandwidth

This is the bandwidth of the offset channel power measurement.

System Simulation Parameters - Calculate Tab

This page controls calculation of Intermods, Harmonics, Noise, and Phase Noise.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

HARMONICS AND INTERMODS

This section controls calculation parameters for harmonics and intermods. See the 'Calculate Intermods, Harmonics' section for more information on intermods and harmonics.

Calculate Harmonics

When checked the system analysis will calculate and save harmonic data to the system analysis dataset. Calculation time for harmonics is typically very quick.

Calculate Intermods

When checked the system analysis will calculate and save intermod data to the system analysis dataset. Intermod simulation time depends on the number of input signals, levels of the resulting intermods, number of nonlinear stages, and how tightly coupled loops are. Unchecking this option can improve the simulation speed drastically during troubleshooting of a block diagram.

From Sources Only

When checked harmonics and intermods will only be created from source signals. All undesired products created along the path will be excluded from the calculation of harmonics and intermods. When unchecked harmonics and intermods will be created from all signals appearing at the input to the non-linear element. This includes intermods, harmonics, and other undesired signals. This option typically requires longer simulation time since more spectral components are being created.

Odd Order Only

When checked only odd order intermod and harmonics will be created.

Coherent Addition

When checked intermod, harmonics, and mixed signals will be added coherently. Generally, cascaded intermod equations assume coherent intermod addition. *Note: Desired signals will always be added coherently regardless of this setting.* See the 'Coherency' section for more information.

Fast Intermod Shape

When checked undesired intermods and harmonics will be represented by only 2 data points. In most cases this is adequate. However, if one desires to examine an undesired intermod or harmonic though a filter then more points may be needed to accurately represent the shape of the signal. When unchecked the average number of points from all input signals is used to represent the undesired intermod or harmonic. Note: Desired intermods and harmonics like the principle signal coming out of a frequency multiplier or divider will always be represented by the number of points of the input spectrum for a harmonic or the average number of points from all input signals in the case of an intermod.

Maximum Order

This parameter is used to limit the maximum order of the spectrums created in the simulation. This limit applies to all non linear elements. Each model has a limitation on the maximum order that it can generate. Please refer to the element help to determine the order limit for each model.

CALCULATE NOISE

This section controls calculation parameters for thermal noise. When checked noise is calculated. The option must be enabled for path noise measurements. Every component in the schematic will create noise. A complex noise correlation matrix is used to determine the noise power for each element at every node. Unchecking this option can improve the simulation speed drastically during troubleshooting of a block diagram.

System Temperature

This is the global ambient temperature of the entire design under simulation. This is the temperature needed to determine the thermal noise power level. The actual thermal noise is shown for convenience.

Noise Points for Entire Bandwidth

This is the number of points used to represent the entire noise spectrum. Noise will automatically be created beginning at the frequency specified by 'Ignore Frequency Below' and ending at the frequency specified by 'Ignore Frequency Above'. These noise points will be uniformly distributed across this bandwidth.

Note: The more noise points used in the simulation the longer the simulation time generally takes. Since each component generates noise the more components in a schematic will also increase the simulation time. Better speed performance can be achieved for a large number of components by disabling noise calculations or reducing the number of simulation points.

Add Extra Noise Points

This is the number of extra noise points that will be inserted across the 'Extra Points Bandwidth' parameter. These additional noise points will be uniformly distributed across this bandwidth. The center frequency of these noise points is the center frequency of the desired signal frequency. These noise points will be added to every created desired spectrum. However, unused noise points will be removed to improve simulation time. See 'Broadband Noise' and 'Cascaded Noise Analysis' sections for additional information.

Extra Points Bandwidth

This is the bandwidth where additional noise points can be inserted. The center frequency of these noise points is the center frequency of each desired signal. This parameter is used when the user wants greater resolution of the noise like through a narrowband Intermediate Frequency (IF) filter. This bandwidth defaults to the channel bandwidth.

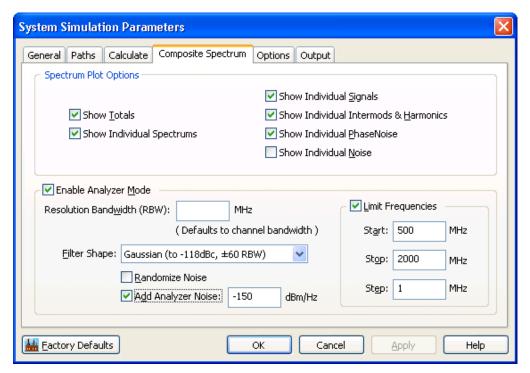
Calculate Phase Noise

When checked behavioral phase noise is calculated.

System Simulation Parameters - Composite Spectrum Tab

This page controls how the data is displayed on a graph.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

SPECTRUM PLOT OPTIONS

This information only affects the displayed output and not internal calculations. Spectrums can be displayed in groups or individually.

Show Totals

Shows a trace representing the total power traveling for each direction of travel through a node. For example, if three elements were connected at a particular node then power would be flowing in three different directions. A unique color would represent each trace.

Show Individual Spectrums

When checked individual spectrums will be displayed otherwise groups will be shown. *Note: Individual spectrum identification information cannot be shown for a group.* When grouping spectrum, all spectrums in the same group are represented by a single trace.

Show Individual Signals (Show Signal Group)

Shows a trace for each fundamental signal spectrum or signal group.

Show Individual Intermods & Harmonics (Show Intermods & Harmonics Group)

Shows a trace for each intermod and harmonic spectrum or intermod and harmonic group.

Show Individual PhaseNoise (Show PhaseNoise Group)

Shows a trace for each phase noise spectrum or phase noise spectrum group.

Show Individual Noise (Show Noise Group)

Shows a trace for each noise spectrum or noise spectrum group.

ENABLE ANALYZER MODE

This checkbox enables the analyzer mode and its settings. This mode can help the engineer visualize what the simulated spectrum would look like on a common spectrum analyzer. The analyzer mode has been added to allow the user to correlate the simulation data with spectrum analyzer data measured in the lab. <u>Note:</u> This mode affects only the display and in novise will affect the integrated measurements.

Resolution Bandwidth (RBW)

The analyzer mode can be thought of just like a spectrum analyzer that has a sweeping receiver and peak detects the total power within the resolution bandwidth. The user can specify the resolution bandwidth of this sweeping receiver. The default resolution bandwidth is the 'Measurement Channel Bandwidth'.

Filter Shape

This parameter determines the shape of the resolution bandwidth filter. This filter shape is analogous to the resolution bandwidth filter shape in a spectrum analyzer which uses a 5 pole Guassian filter. Likewise in the system analysis this same filter is also used. The user is able to select three widths for this particular filter which are based on an integer number of channel bandwidths. No spectrum integration will occur outside the width of this filter. This filter width is used to reduce the amount of data collected, saved, and processed. A brickwall filter can be created theoretically and is also included.

Brickwall (Ideal)

This filter is an ideal rectangular filter whose skirts are infinitely steep.

Gaussian (to -100 dBc, ± 30 Chan BW)

Data will be ignored that is farther than 30 channels away from the center frequency. Attenuation 30 channels from the center will be about -100 dBc.

Gaussian (to -117 dBc, ± 60 Chan BW)

Data will be ignored that is farther than 60 channels away from the center frequency. Attenuation 60 channels from the center will be about -117 dBc.

Gaussian (to -150 dBc, ± 200 Chan BW)

Data will be ignored that is farther than 200 channels away from the center frequency. Attenuation 200 channels from the center will be about -150 dBc.

Randomize Noise

When enabled, random noise will be added around the resulting analyzer sweep. The output trace will be more representative of a typical spectrum analyzer, at the expense of additional computation time.

Add Analyzer Noise

All spectrum analyzers have a limited dynamic range. They are typically limited on the upper end by intermods and spurious performance at an internal mixer output. On the lower end they are limited by noise of the analyzer. This noise is a function of the internal architecture of the specific spectrum analyzer and internal RF attenuator.

Analyzer Noise Floor

Specifies the noise floor in dBm/Hz of the spectrum analyzer mode.

Limit Frequencies

When checked the frequency range of the analyzer mode is limited. By default the entire spectrum from the 'Ignore Spectrum Frequency Below' lower frequency limit to the highest frequency limit of 'Ignore Spectrum Frequency Above' will be processed by the analyzer for every node in the system. In some cases this may be very time consuming. In order to improve the simulation speed and just process the area of interest, frequency limits can be enabled to restrict the computation range of the analyzer.

Start

Beginning frequency of the analyzer.

Stop

Ending frequency of the analyzer.

Step

This is the frequency step size between analyzer data points. The step size can be reduced until the maximum number of simulation points is reached.

<u>Number of Simulation Points</u>: The number of simulation points used for the graph is determined internally in SPECTRASYS. This parameter cannot be

changed by the user. Since SPECTRASYS can deal with large frequencies ranges, the amounts of data collected for a single spectrum analyzer trace could be enormous. Furthermore, the analyzer function is not a post processing function and the number of simulation points cannot be changed without rerunning the simulation. In order to better control the amount of data collected, which is proportional to the simulation time, SPECTRASYS internally determines the number of simulation points to

<u>Simulation Speed-Ups</u>: During the system simulation the analyzer will create an analyzer trace for direction of travel for every node in the system. Consequently, for systems with large number of nodes, the convolution routines used to calculate the analyzer traces alone can be time consuming if the analyzer properties are not optimized. If simulation speed is important then using the narrowest filter shape will have the best simulation speed.

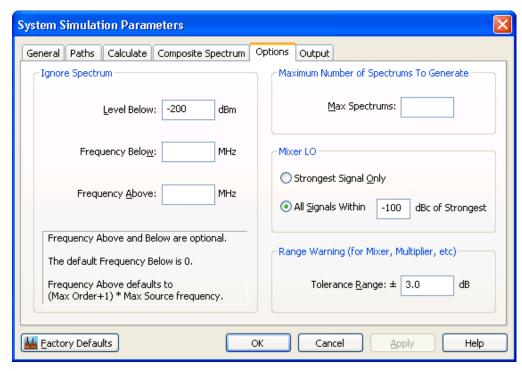
<u>File Size</u>: The size of the data file will increase when the analyzer mode is enabled. Furthermore, the file size can grow rapidly depending on the settings of the analyzer mode. For example, the smaller the resolution bandwidth the more data points are needed to represent the data, the larger the data file will be, and most likely the simulation time will increase.

Analyzer Troubleshooting. What does it mean when the signal doesn't seem to be lined up with the integrated spectrum? All this means is the frequency resolution isn't small enough to accurately represent the signal of interest. If this is the case, there are a few things that can be done to increase this resolution. First, the resolution bandwidth can be reduced. If this is inadequate, the 'Limit Frequencies' feature should be enabled and the user can specify the 'Start', 'Stop', and 'Step' frequencies used for the analyzer.

System Simulation Parameters - Options Tab

This page contains miscellaneous Spectrasys options.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

IGNORE SPECTRUM

This group is used to limit or restrict the number of spectrums created by Spectrasys. These thresholds apply at every calculated node. Consequently, if a signal is heavily attenuated or outside the given frequency range during a portion of the path and are then amplified or frequency translated back into the given frequency range then these thresholds must be set so that the spectrums will not be ignored along the calculation path. Once an individual spectrum is ignored it will not continue to propagate. However, all spectrums previously calculated will still be available at the nodes where there were within the specified limits. For example, If we had a 2 GHz transmitter that had an IF frequency of 150 MHz and we set the 'Ignore Frequency Below' limit to 200 MHz then the entire IF signal would not be present and consequently neither would the 2 GHz RF signal.

Level Below (default = -200 dBm)

All spectrums that are below this threshold will not be created or propagated. This threshold should be set to the highest acceptable level if faster simulations are important. Spectrums are not actually ignored unless they are more than about 20 dB below this threshold since several spectrums can be added together to give a total result that would be greater than this threshold.

Simulation Speed-Up: As with any other type of simulation the more spectral components that need to be processed the longer the simulator time. Setting these limits to only calculate the frequencies and amplitude ranges of interest can speed up the calculation process drastically especially when calculating intermods. However, take caution when setting these limits so that intentional spectrums are not ignored.

Frequency Below (default = 0 Hz)

All spectral components whose frequency is below this threshold will be ignored. Spectrums falling below this limit will not continue to propagate. However, there are several cases where negative frequencies may be calculated at interim steps (i.e. through a mixer) which will be folded back onto the positive frequency axis. This parameter will only affect the final folded frequencies and not the interim frequency steps. Likewise, this is the lower noise frequency limit.

Frequency Above (default = ['Max Order' + 1] times the highest source frequency)

All spectral components whose frequency is above this threshold will be ignored and will not be created. Spectrums falling above this limit will not continue to propagate. Likewise, this is the upper noise frequency limit.

MAXIMUM NUMBER OF SPECTRUMS TO GENERATE

This group is used to limit or restrict the maximum number of spectrums that will be created.

Max Spectrums

Limits the maximum number of spectrums that are created. Once this limit is reached during a simulation no additional spectrums will be created. <u>Note:</u> <u>This option must be used with care since a premature limitation of the number of total spectrums will more than likely affect the accuracy of all the results.</u>

MIXER LO

This section controls the effects of all mixer LOs in a simulation.

Strongest Signal Only

When selected, the frequency of strongest LO signal is used to determine the output frequency of all mixed signals regardless of the number of other signals that may be present on the LO.

All Signals Within X, dBc of Strongest

When selected, all frequencies of LO signals falling within the specified range of the peak LO signal will be used to create new mixed output spectrum.

RANGE WARNING (FOR MIXER, MULTIPLIER, ETC)

This group is used to control range warnings used by some elements.

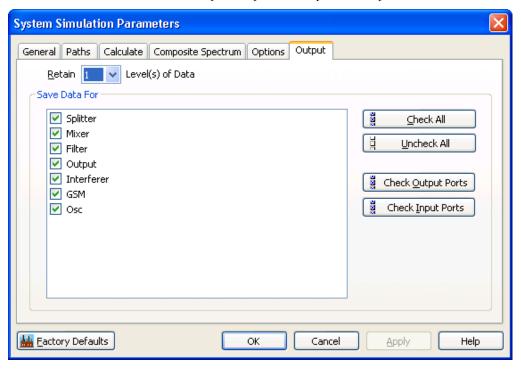
Tolerance Range

This threshold range is used by some elements to warn the user when a given power level falls outside the specified range. This range applies to each element on a case by case basis. For example the total LO power for the given mixer will be determined by integrating the LO spectrum and then comparing this power level to the 'LO Drive Level' for the given mixer. If this power level is outside the 'Tolerance Range' window then a warning will be issued for this mixer either indicating that the mixer is being starved or over driven.

System Simulation Parameters - Output Tab

This page contains miscellaneous Spectrasys options.

Tabs: General, Paths, Calculate, Composite Spectrum, Options, Output



Parameter Information:

Retain X Levels of Data

Specifies the number of data levels that will be saved to the dataset. For example, 1 level of data is the data for the top level design only. This parameters only refers to the data retained in the dataset and not the whether a subcircuit will be analyzed or not. All subcircuits will always be analyzed.

SAVE DATA FOR

This section controls the data that will be saved to the system analysis dataset. Each part in the schematic is listed and can be checked or unchecked. When checked the data for all nodes of the specified part will be saved. Several buttons have been added for convenience is selecting or unselecting parts.

Check All

When clicked with select all components.

Uncheck All

When clicked will unselect all components.

Check Output Ports

When clicked will select only the output ports.

Check Input Ports

When clicked will select only the input ports.

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